

ELECTROMAGNETIC EMISSION COMPLIANCE REPORT FOR PCS LICENSED TRANSMITTER

Test Report No. : E093R-039
AGR No. : A092A-147
Applicant : SOLiD Technologies, Inc.
Address : 18th Floor, KINS Tower, 25-1 Jeongja-Dong, Bundang-Gu, Seongnam-Si,
Gyeonggi-Do 463-811, Korea
Manufacturer : SOLiD Technologies, Inc.
Address : 18th Floor, KINS Tower, 25-1 Jeongja-Dong, Bundang-Gu, Seongnam-Si,
Gyeonggi-Do 463-811, Korea
Type of Equipment : RDU MODULE(800PS/900I/PA)
FCC ID. : W6U800PS900IPA
Model Name : RDU 800PS+900I+PA
Serial number : N/A
Total page of Report : 180 pages (including this page)
Date of Incoming : February 20, 2009
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SUMMARY

The equipment complies with the regulation; **FCC Part 90 Subpart I.**

This test report only contains the result of a single test of the sample supplied for the examination.

It is not a generally valid assessment of the features of the respective products of the mass-production.

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ONETECH Corp.

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1. VERIFICATION OF COMPLIANCE

APPLICANT : SOLiD Technologies, Inc.
 ADDRESS : 18th Floor, KINS Tower, 25-1 Jeongja-Dong, Bundang-Gu, Seongnam-Si,
 Gyeonggi-Do 463-811, Korea
 CONTACT PERSON : Mr. Kangyeob, Bae / Director
 TELEPHONE NO : +82-31-784-8585
 FCC ID : W6U800PS900IPA
 MODEL NAME : RDU 800PS+900I+PA
 SERIAL NUMBER : N/A
 DATE : March 17, 2009

EQUIPMENT CLASS	PCB - PCS Licensed Transmitter
EQUIPMENT DESCRIPTION	RDU MODULE(800PS/900I/PA)
THIS REPORT CONCERNS	Original Grant
MEASUREMENT PROCEDURES	ANSI C63.4: 2003, EIA/TAI-603B
TYPE OF EQUIPMENT TESTED	PRE-PRODUCTION
KIND OF EQUIPMENT AUTHORIZATION REQUESTED	CERTIFICATION
EQUIPMENT WILL BE OPERATED UNDER FCC RULES PART(S)	PART 90 Subpart I
MODIFICATIONS ON THE EQUIPMENT TO ACHIEVE COMPLIANCE	No
FINAL TEST WAS CONDUCTED ON	3 METER(S) OPEN AREA TEST SITE

-. The above equipment was tested by ONETECH Corp. for compliance with the requirement set forth in the FCC Rules and Regulations. This said equipment in the configuration described in this report, shows the maximum emission levels emanating from equipment are within the compliance requirements.

2. TEST SUMMARY

2.1 Test items and results

SECTION	TEST ITEMS	RESULTS
2.1046(a), 90.205	RF Power Output at Antenna Terminals	Met the Limit / PASS
2.1047	Modulation Characteristics	PASS (See Note 1)
2.1049, 90.210	Occupied Bandwidth, Bandwidth Limitation	Met the Limit / PASS
2.1049	Band Edge	Met the Limit / PASS
2.1051, 90.210	Spurious Emissions at Antenna Terminals	Met the Limit / PASS
2.1053, 90.210	Field strength of Spurious Radiation	Met the Limit / PASS
2.1055, 90.213	Frequency Stability with Temperature variation	Met the requirement / PASS
2.1055, 90.213	Frequency stability with primary voltage variation	Met the requirement / PASS
2.1093	RF Exposure	See Note 2

Note1: The Equipment under Test (EUT) is a repeater which reproduces the modulated input signal, so the EUT meets the requirement.

Note2: End Users and installers must be provided with antenna installation instructions and transmitter operating conditions for satisfying RF exposure compliance, because the applicant does not provide an antenna for sale with the EUT.

2.2 Additions, deviations, exclusions from standards

No additions, deviations or exclusions have been made from standard.

2.3 Related Submittal(s) / Grant(s)

Original Grant

2.4 Purpose of the test

To determine whether the equipment under test fulfills the requirements of the regulation stated in section 2.1.

2.5 Test Methodology

Radiated testing was performed according to the procedures in ANSI C63.4: 2003. Radiated testing was performed at a distance of 3 meters from EUT to the antenna.

2.6 Test Facility

The open area test site and conducted measurement facilities are located on at 307-51 Daessangryung-ri, Chowol-eup, Gwangju-si, Gyeonggi-do, 464-862, Korea. Description details of test facilities were submitted to the Commission on August 21, 2008. (Registration Number: 340658)

3. GENERAL INFORMATION

3.1 Product Description

The SOLiD Technologies, Inc., Model RDU 800PS+900I+PA (referred to as the EUT in this report) is a RDU MODULE(800PS/900I/PA) that shall be plugged in ROU (Remote Optic Unit). The ROU can be equipped with up to 3 RDUs (Remote Drive Unit), a RPSU (Remote Power Supply Unit), a RCPUs (Remote Central Processor Unit), a R-Optic (Remote Optic), a SIU (System Interface Unit) and a Multiplexer. The System, SMDR-NH124 consists of ROU, BIU (BTS Interface Unit), ODU (Optic Distribution Unit), and OEU (Optic Expansion Unit). Except for ROU, the RF output ports of other units are connected to coaxial cable each other. ROU receives TX optical signals from ODU or OEU and converts them into RF signals. The converted RF signals are amplified through High Power Amp in a corresponding RDU, combined with multiplexer module and then radiated to the antenna port.

When receiving RX signals through the antenna port, this unit filters out-of-band signals in a corresponding RDU and sends the results to Remote Optic Module to make electronic-optical conversion of them. After converted, the signals are sent to an upper device of ODU or OEU. ROU can be equipped with up to three RDUs (Remote Drive Unit) and the module is composed of maximal Dual Band, but this report only covers RDU 800PS+900I+PA, FCC ID:

W6U800PS900IPA and other modules shall be issued with other test report number. The product specification described herein was obtained from product data sheet or user's manual.

DEVICE TYPE		RDU MODULE(800PS/900I/PA)
LIST OF EACH OSC. or CRY. FREQ.(FREQ.>=1 MHz)		14.74 MHz
EMISSION DESIGNATOR		GXW(iDEN)
OPERATING FREQUENCY	800PS	851 MHz ~ 869 MHz
	900I	935 MHz ~ 941 MHz
	Paging	929 MHz ~ 930 MHz
RF OUTPUT POWER		23 dBm
CHANNEL SEPARATION		GXW(25 kHz)
DC VOLTAGE & CURRENT INTO FINAL AMPLIFIER		DC 27 V, 2 A
ELECTRICAL RATING		AC 120 V, 0.97 A, DC - 48 V
OPERATING TEMPERATURE		-10 °C ~ 50 °C

3.2 Alternative type(s)/model(s); also covered by this test report.

-. None

3.3 Peripheral equipment

Defined as equipment needed for correct operation of the EUT, but not considered as tested:

Model	Manufacturer	FCC ID	Description	Connected to
RDU 800PS+900I+PA	SOLiD Technologies, Inc.	W6U800PS900IPA	RDU MODULE (800PS/900I/PA) (EUT)	-
SMJ100A	Rohde & Schwarz	N/A	Vector Signal Generator	EUT
SMDR-NH124	SOLiD Technologies, Inc.	N/A	ODU (Optic Distribution Unit)	EUT
SMDR-NH124	SOLiD Technologies, Inc.	N/A	BIU (BTS Interface Unit)	EUT
105-10ST	Dong Yang	N/A	DC Power Supply	EUT

3.4 Mode of operation during the test

The EUT was received signal form signal generator and then each modulation, iDEN and SMR was configured for maximum signal gain and bandwidth. The EUT was operated in a manner representative of the typical usage of the equipment. During all testing, system components were manipulated within the confines of typical usage to maximize each emission. The applicant does not supply antenna(s) with the system, so the dummy loads were connected to the RF output ports on the EUT for radiated spurious emission testing.

4. EUT MODIFICATIONS

-. None

5. RF POWER OUTPUT at ANTENNA TERMINAL

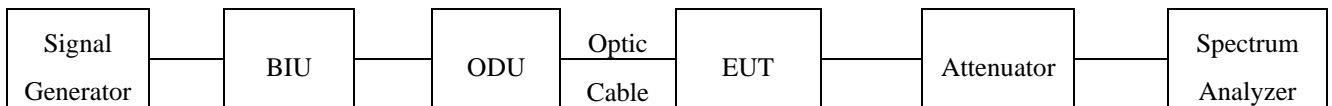
5.1 Operating environment

Temperature : 21.8 °C
Relative humidity : 47.4 %R.H.

5.2 Test set-up

The RF signal from the signal generator(s) was injected to BIU (BTS Interface Unit) and then output signal from the BIU was injected to the input of ODU (Optic Distribution Unit) by coaxial cable and then the output port of the ODU was connected to the input of the EUT by optic cable. The amplified RF signal at the output of the EUT was connected to the power meter or spectrum analyzer. The test was performed at three frequencies (low, middle, and high channels) at each band using all applicable modulation.

RF output power was measured by channel power measurement function of the spectrum analyzer.



5.3 Test equipment used

	Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ -	E4432B	HP	Signal Generator	US38440950	June 16, 2008
■ -	SMJ100A	R/S	Vector Signal Generator	100698	June 16, 2008
■ -	FSP	R/S	Spectrum Analyzer	100017	Mar. 11, 2009
□ -	8564E	HP	Spectrum Analyzer	3650A00756	June 16, 2008

All test equipment used is calibrated on a regular basis.

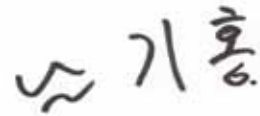
5.4 Test data

5.4.1 Test Result for 800PS

-. Test Date : March 10~11, 2009

-. Test Result : Pass

Modulation	Channel	Frequency (MHz)	Input Power (dBm)	Output Power (dBm)	Output Power (W)	Limit (W)
iDEN	Low	851.025 0	-18.70	23.00	0.199 526	100.00
	Middle	860.000 0	-18.90	23.00		
	High	868.975 0	-18.80	23.00		
SMR	Low	851.012 5	-18.80	23.00	0.199 526	
	Middle	860.000 0	-18.70	23.00		
	High	868.987 5	-18.80	23.00		



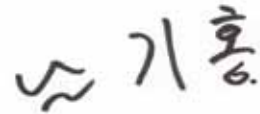
Tested by: Ki-Hong, Nam / Project Engineer

5.4.2 Test Result for 900I+PA (929 MHz ~ 930 MHz)

-. Test Date : March 10~11, 2009

-. Test Result : Pass

Modulation	Channel	Frequency (MHz)	Input Power (dBm)	Output Power (dBm)	Output Power (W)	Limit (W)
iDEN	Low	929.012 5	-18.80	23.00	0.199 526	100.00
	Middle	929.500 0	-18.90	23.00		
	High	929.987 5	-18.90	23.00		
SMR	Low	929.025 0	-18.80	23.00	0.199 526	
	Middle	929.500 0	-18.70	23.00		
	High	929.975 0	-18.90	23.00		



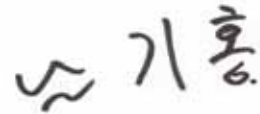
Tested by: Ki-Hong, Nam / Project Engineer

5.4.3 Test Result for 900I+PA (935 MHz ~ 940 MHz)

-. Test Date : March 10~11, 2009

-. Test Result : Pass

Modulation	Channel	Frequency (MHz)	Input Power (dBm)	Output Power (dBm)	Output Power (W)	Limit (W)
iDEN	Low	935.012 5	-18.80	23.00	0.199 526	100.00
	Middle	937.500 0	-18.70	23.00		
	High	939.987 5	-18.80	23.00		
SMR	Low	935.025 0	-18.90	23.00	0.199 526	
	Middle	937.500 0	-18.70	23.00		
	High	939.975 0	-18.80	23.00		



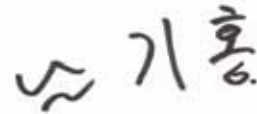
Tested by: Ki-Hong, Nam / Project Engineer

5.4.4 Test Result for 900I+PA (940 MHz ~ 941 MHz)

-. Test Date : March 10~11, 2009

-. Test Result : Pass

Modulation	Channel	Frequency (MHz)	Input Power (dBm)	Output Power (dBm)	Output Power (W)	Limit (W)
iDEN	Low	940.012 5	-18.80	23.00	0.199 526	100.00
	Middle	940.500 0	-18.80	23.00		
	High	940.987 5	-18.90	23.00		
SMR	Low	940.025 0	-18.90	23.00	0.199 526	
	Middle	940.500 0	-18.80	23.00		
	High	940.975 0	-18.80	23.00		



Tested by: Ki-Hong, Nam / Project Engineer

6. OCCUPIED BANDWIDTH

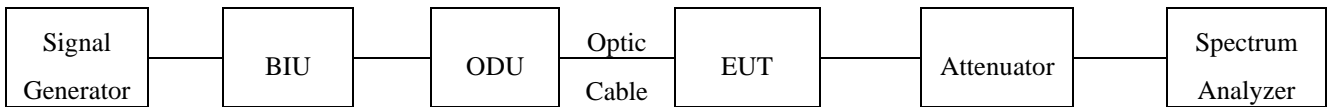
6.1 Operating environment

Temperature : 21.8 °C
Relative humidity : 47.4 %R.H.

6.2 Test set-up

The RF signal from the signal generator(s) was injected to BIU (BTS Interface Unit) and then output signal from the BIU was injected to the input of ODU (Optic Distribution Unit) by coaxial cable and then the output port of the ODU was connected to the input of the EUT by optic cable. The amplified RF signal at the output of the EUT was connected to the power meter or spectrum analyzer. The test was performed at three frequencies (low, middle, and high channels) at each band using all applicable modulation.

For the testing, the RBW was set to 1 % to 3 % of the -26 dB bandwidth. The VBW is set to 3 times the RBW and sweep time is coupled.



6.3 Test equipment used

	Model Number	Manufacturer	Description	Serial Number	Last Cal.
■	8564E	HP	Spectrum Analyzer	3650A00756	June 16, 2008
■	E4432B	HP	Signal Generator	US38440950	June 16, 2008
■	SMJ100A	R/S	Vecter Signal Generator	100698	June 16, 2008
□	FSP	R/S	Spectum Analyzer	100017	Mar. 11, 2009

All test equipment used is calibrated on a regular basis.

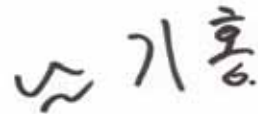
6.4 Test data

6.4.1 Test Result for 800PS

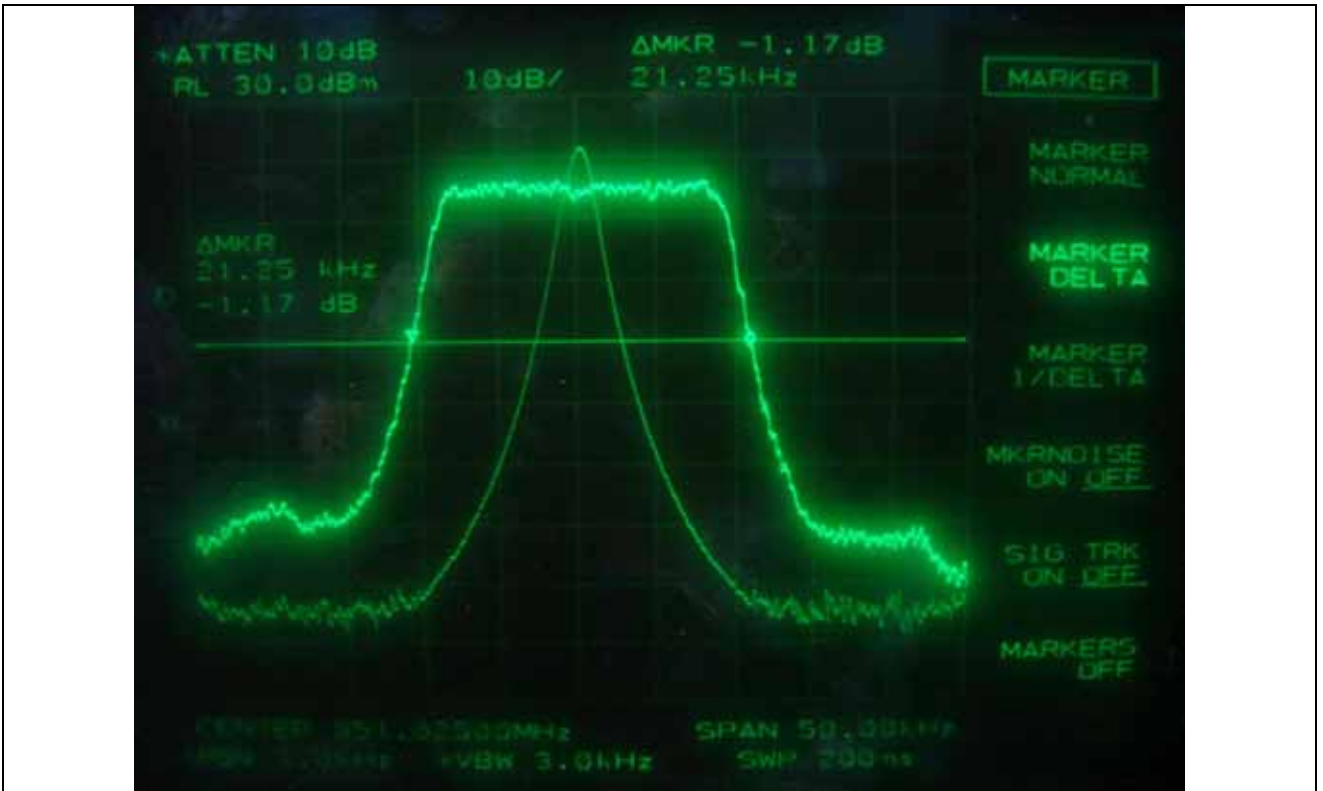
- . Test Date : March 10~11, 2009
- . Test Result : Pass

Modulation	Channel	26 dB Bandwidth (kHz)	99 % Occupied Bandwidth (kHz)
iDEN	Low	21.25	18.50
	Middle	21.25	18.33
	High	21.17	18.42
SMR	Low	14.67	12.42
	Middle	14.67	12.42
	High	14.67	12.50

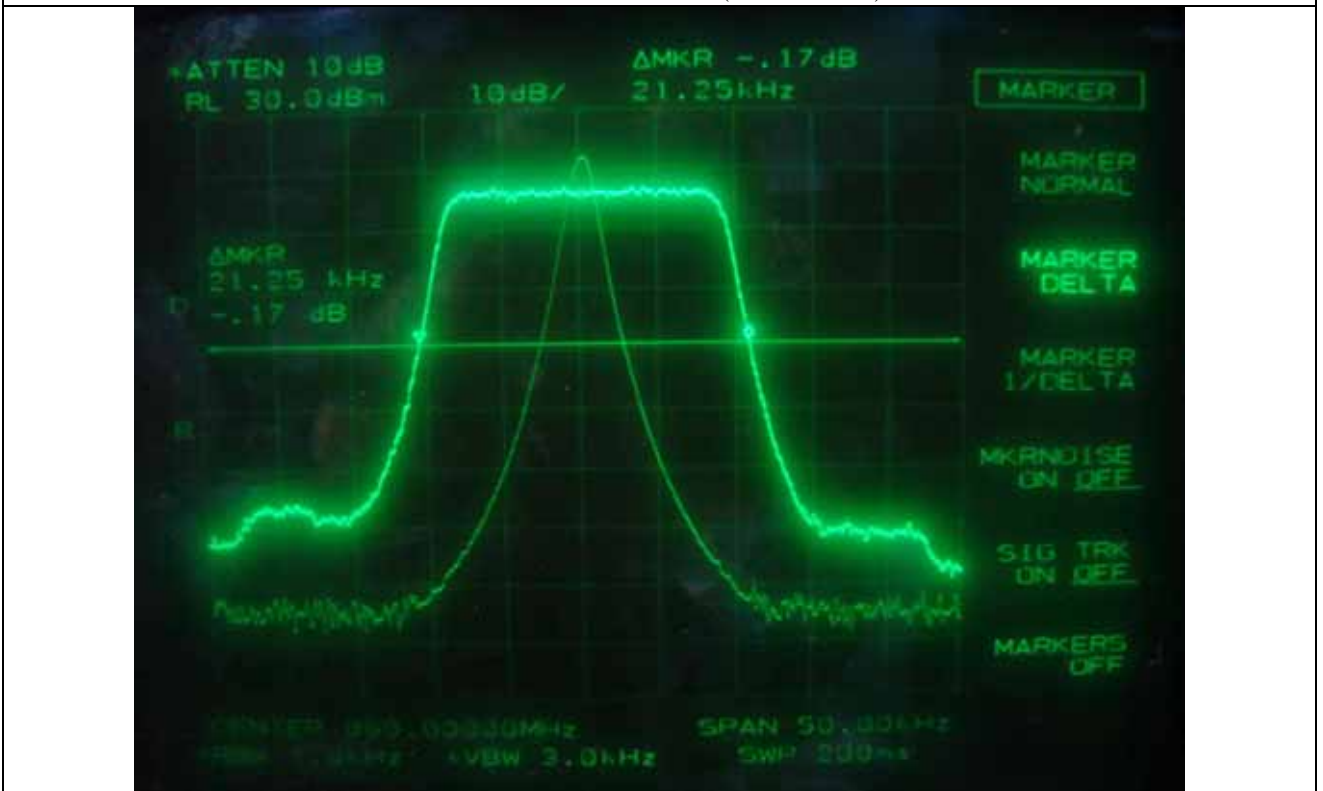
Remark: According to above result, the carrier frequency shall be within the frequency block edges.



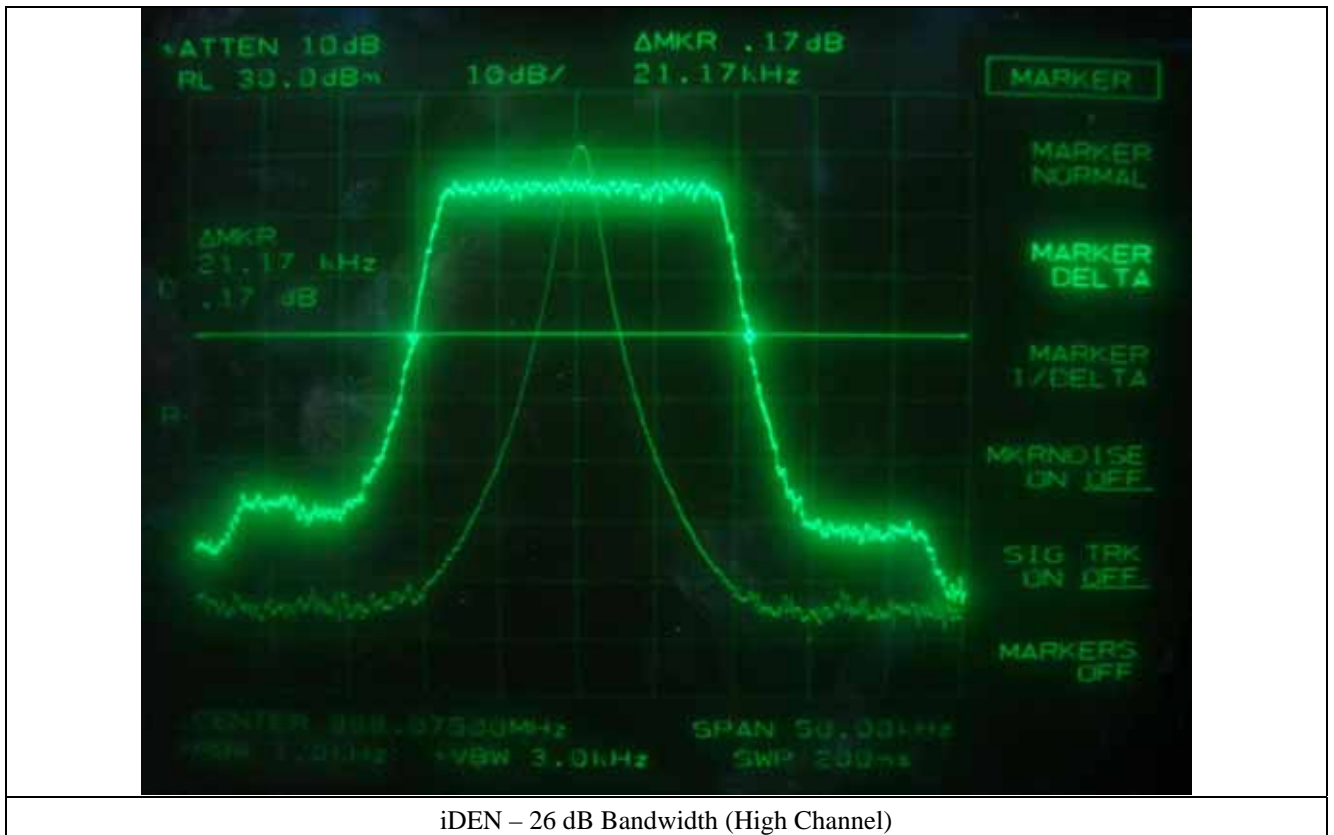
Tested by: **Ki-Hong, Nam / Project Engineer**



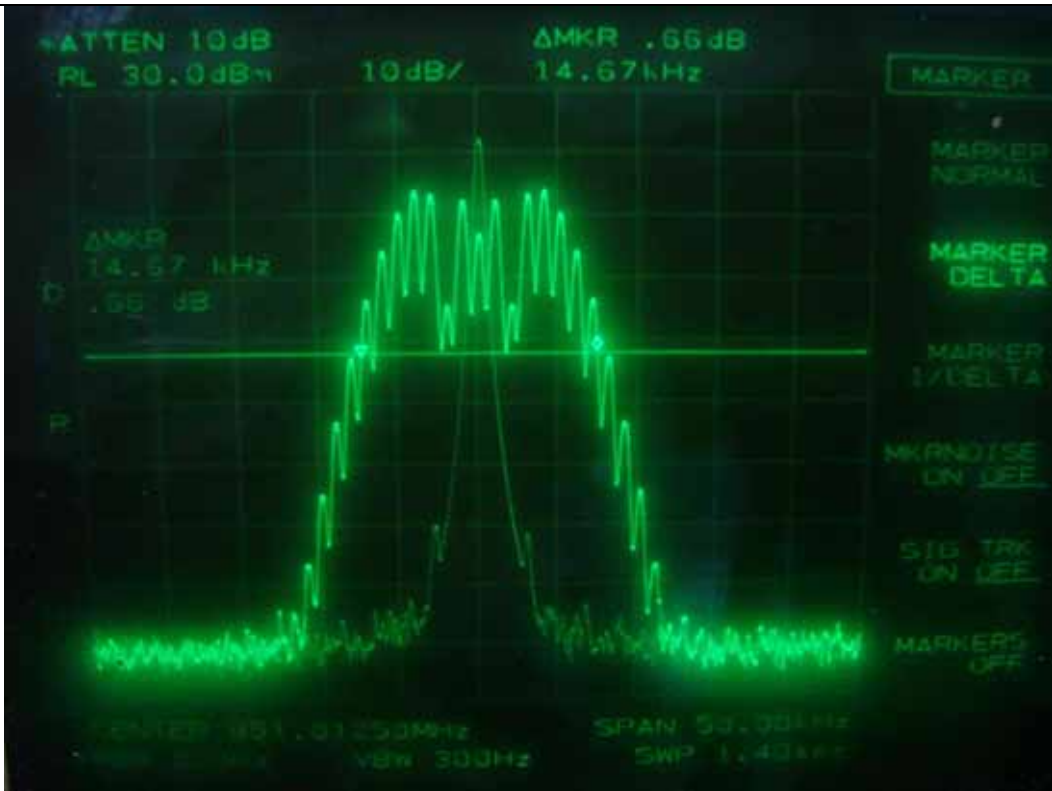
iDEN – 26 dB Bandwidth (Low Channel)



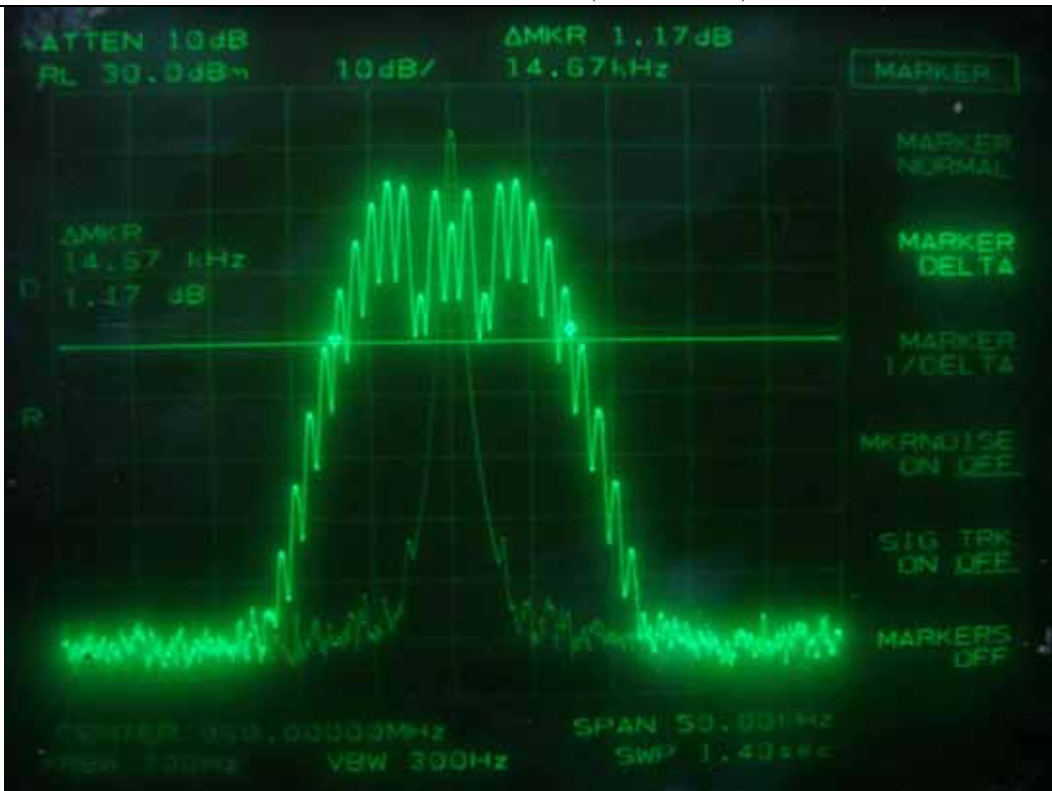
iDEN – 26 dB Bandwidth (Middle Channel)



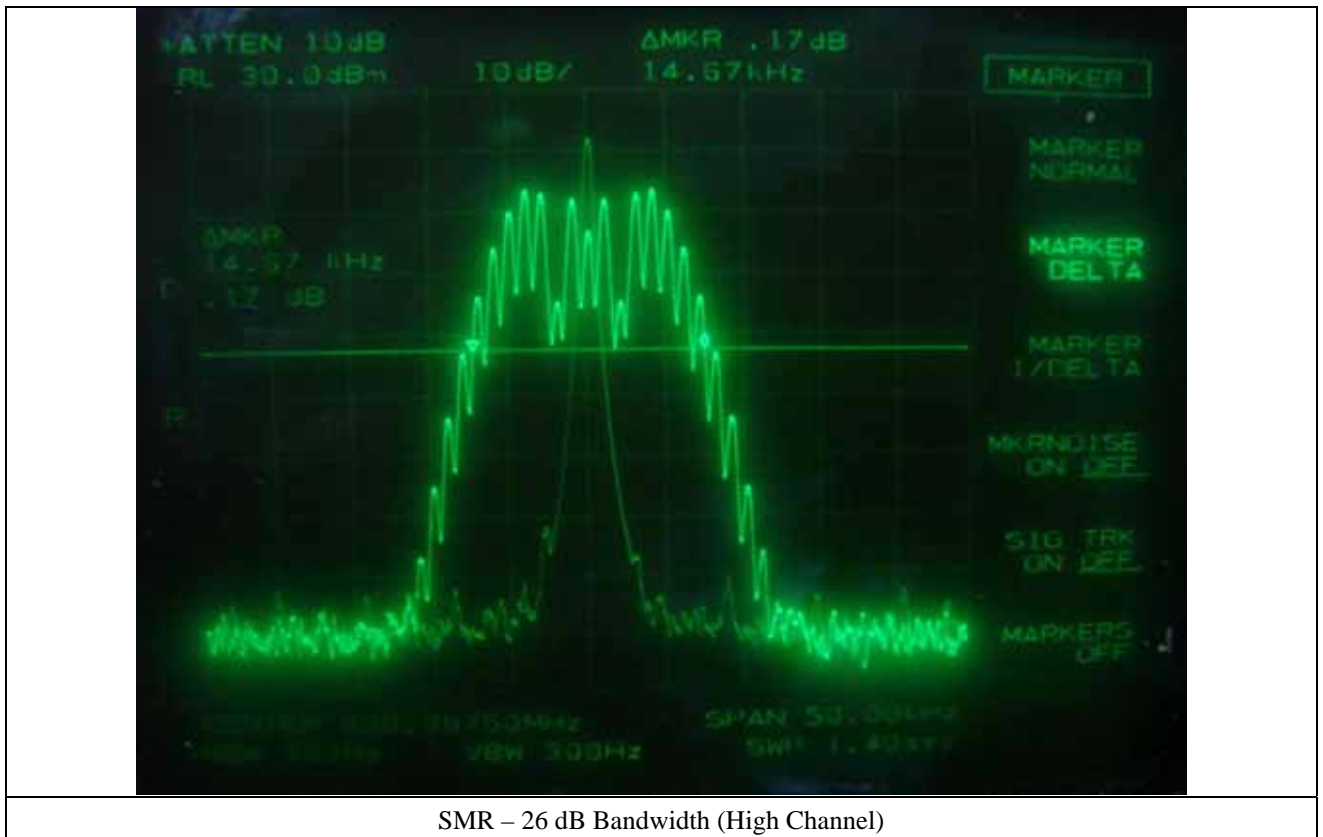
iDEN - 26 dB Bandwidth (High Channel)

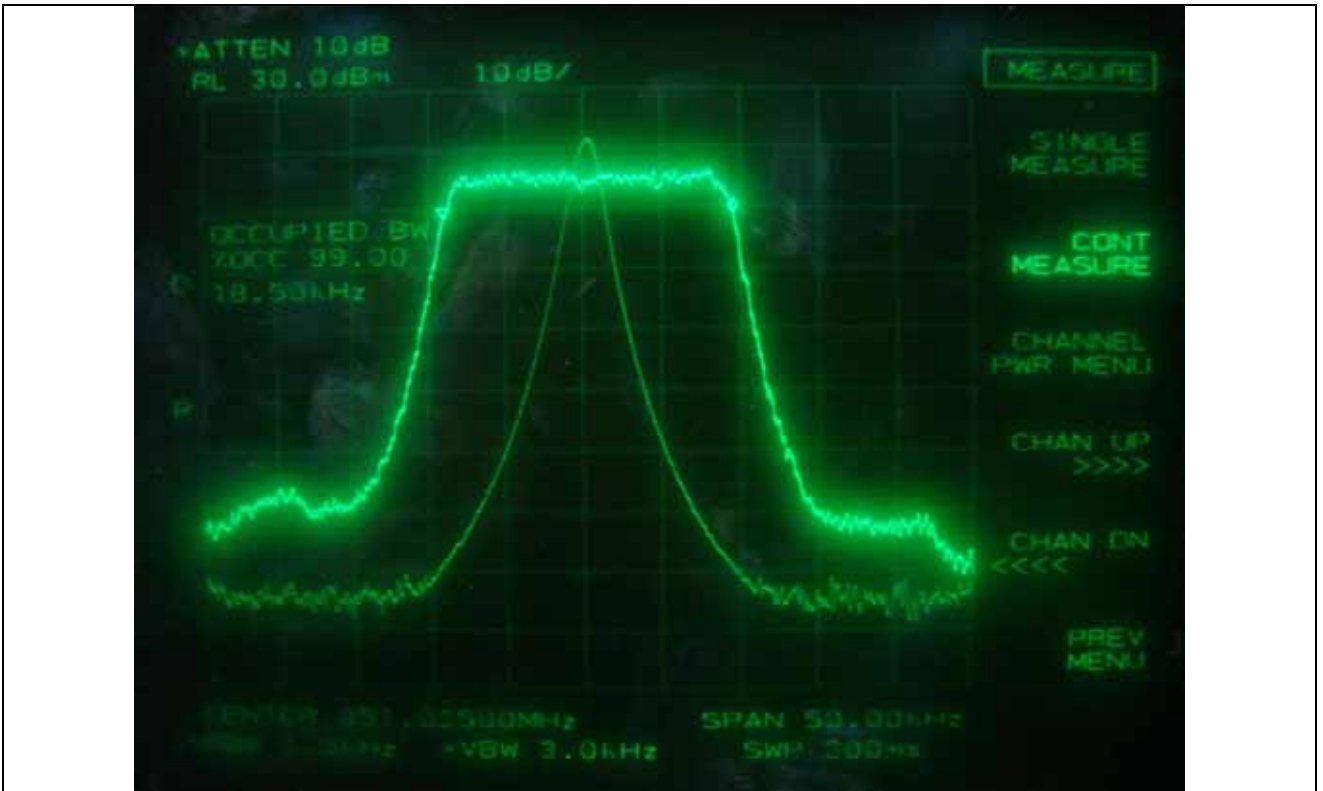


SMR – 26 dB Bandwidth (Low Channel)

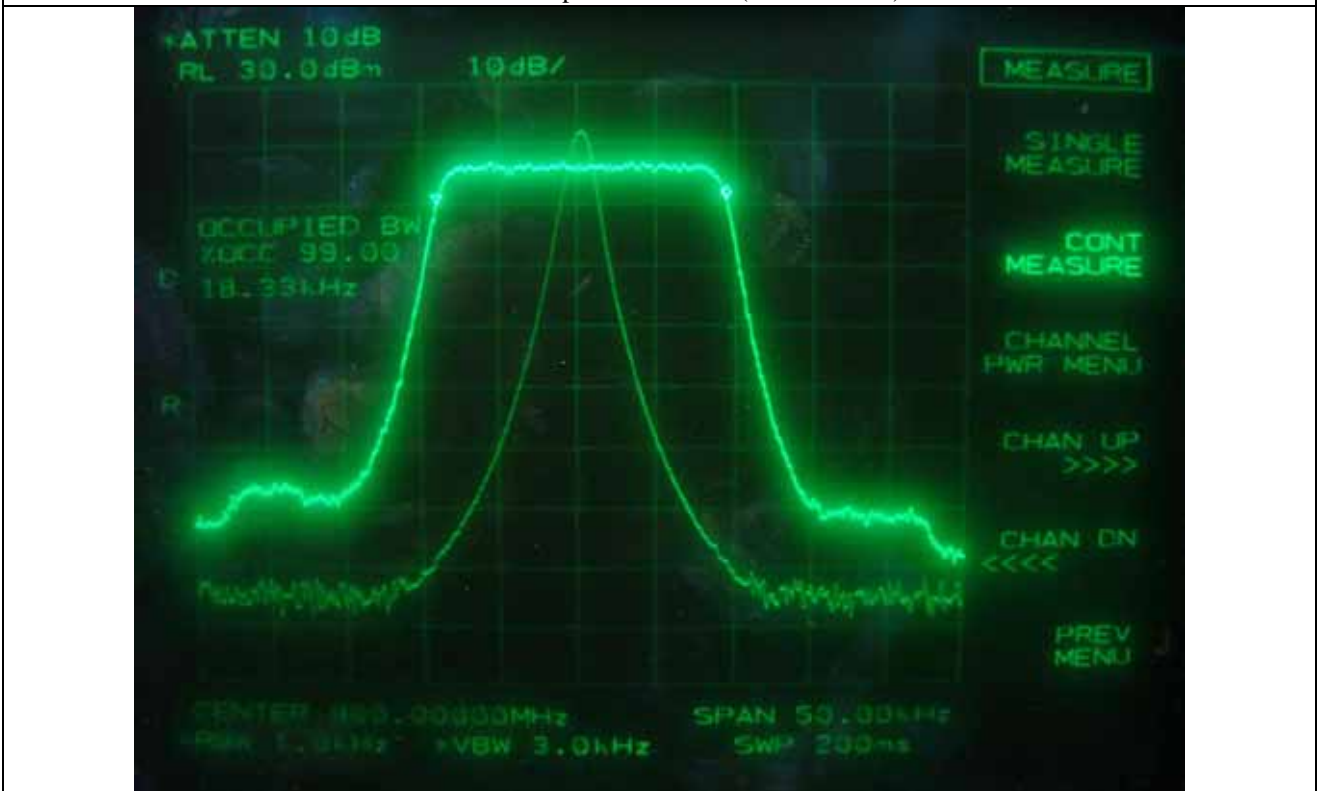


SMR – 26 dB Bandwidth (Middle Channel)

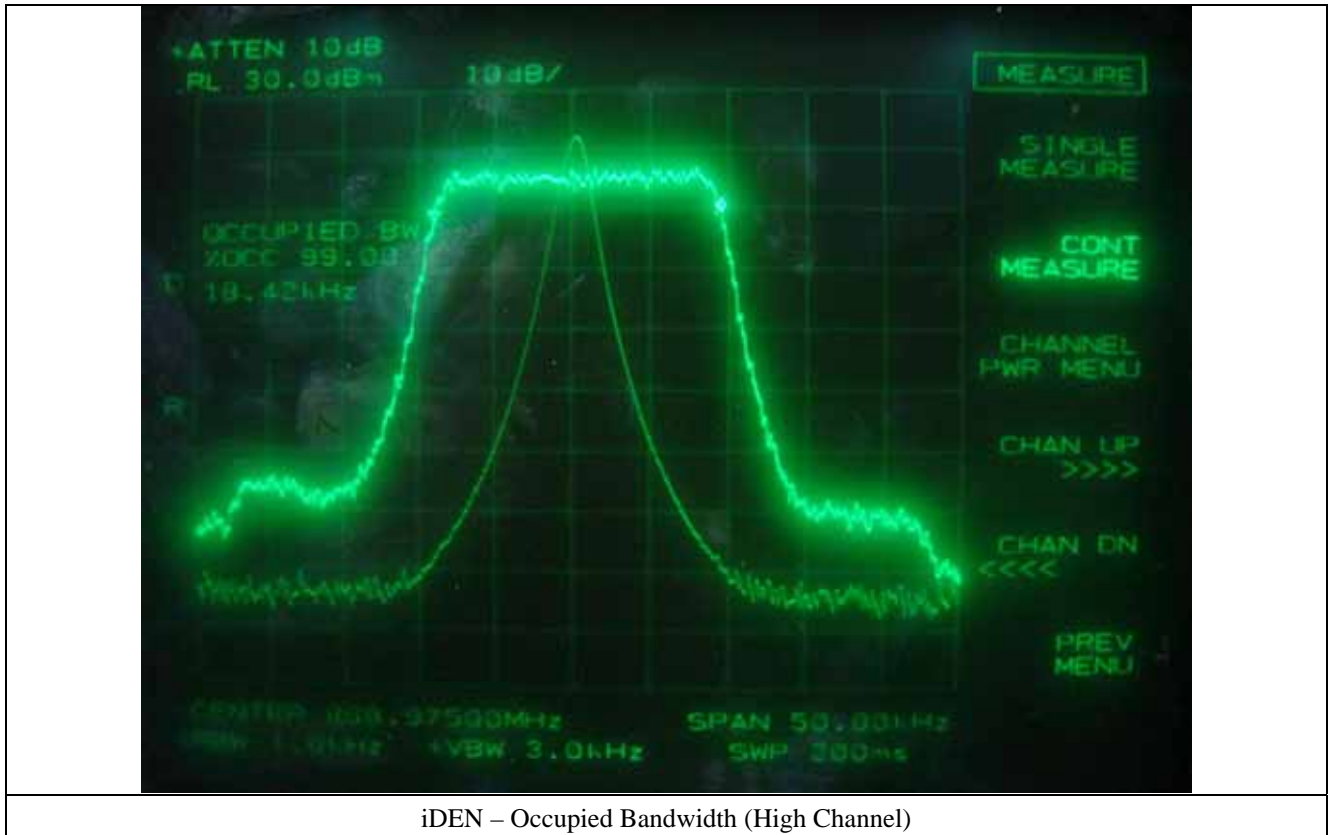




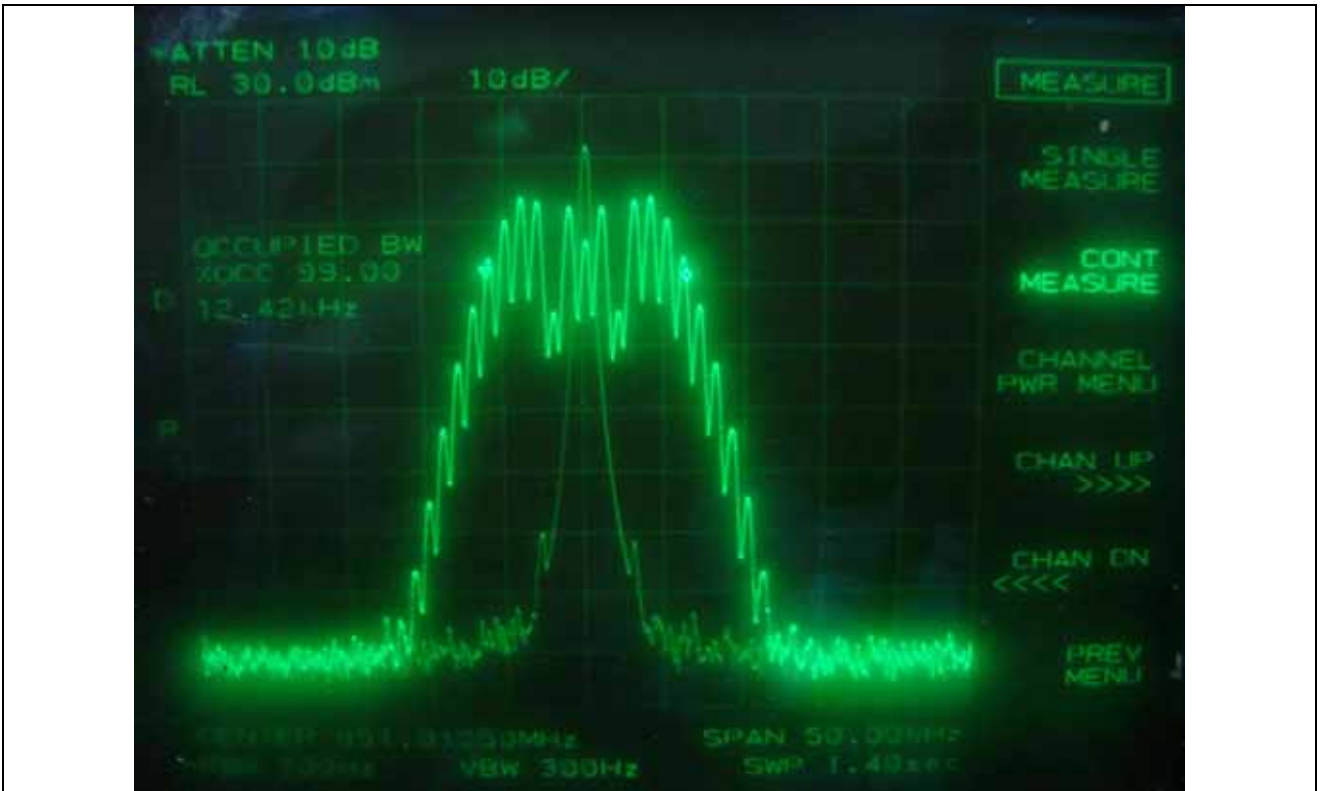
iDEN – Occupied Bandwidth (Low Channel)



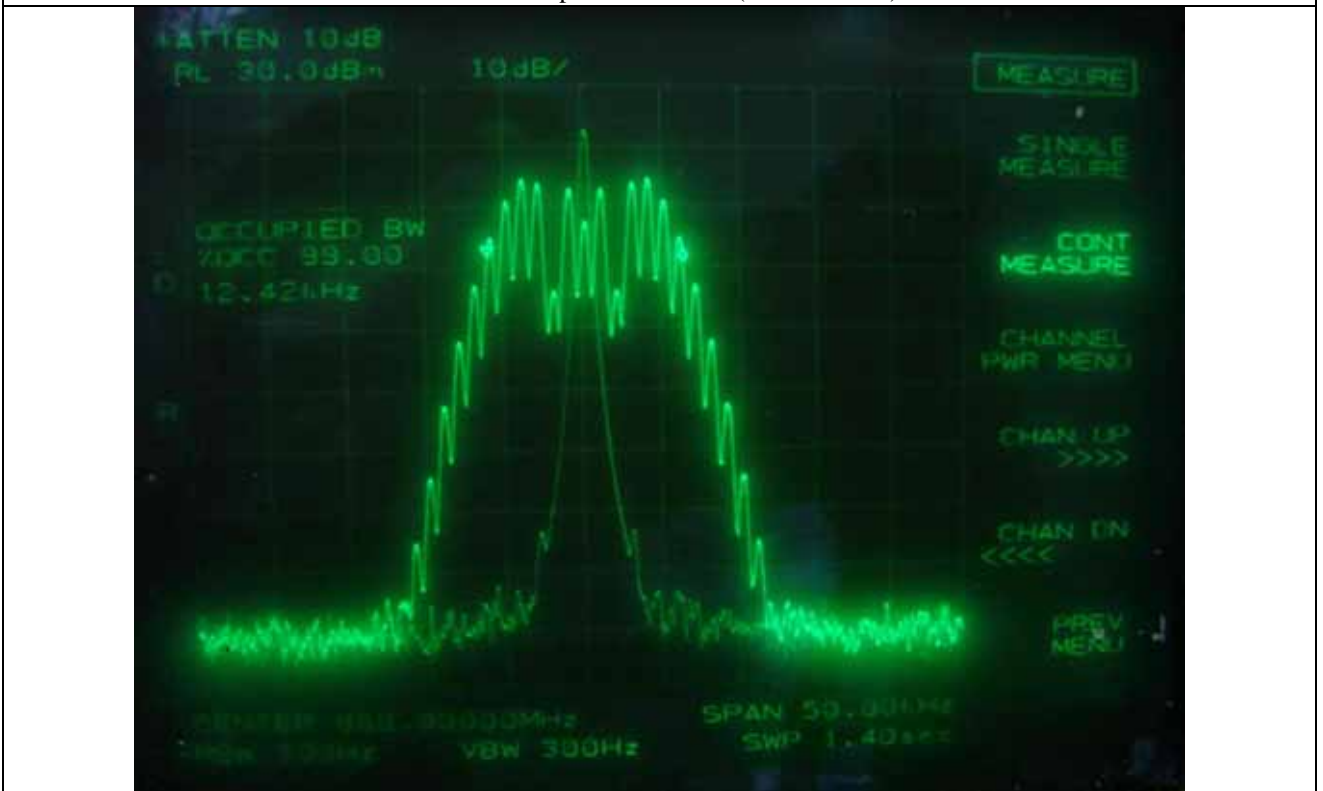
iDEN – Occupied Bandwidth (Middle Channel)



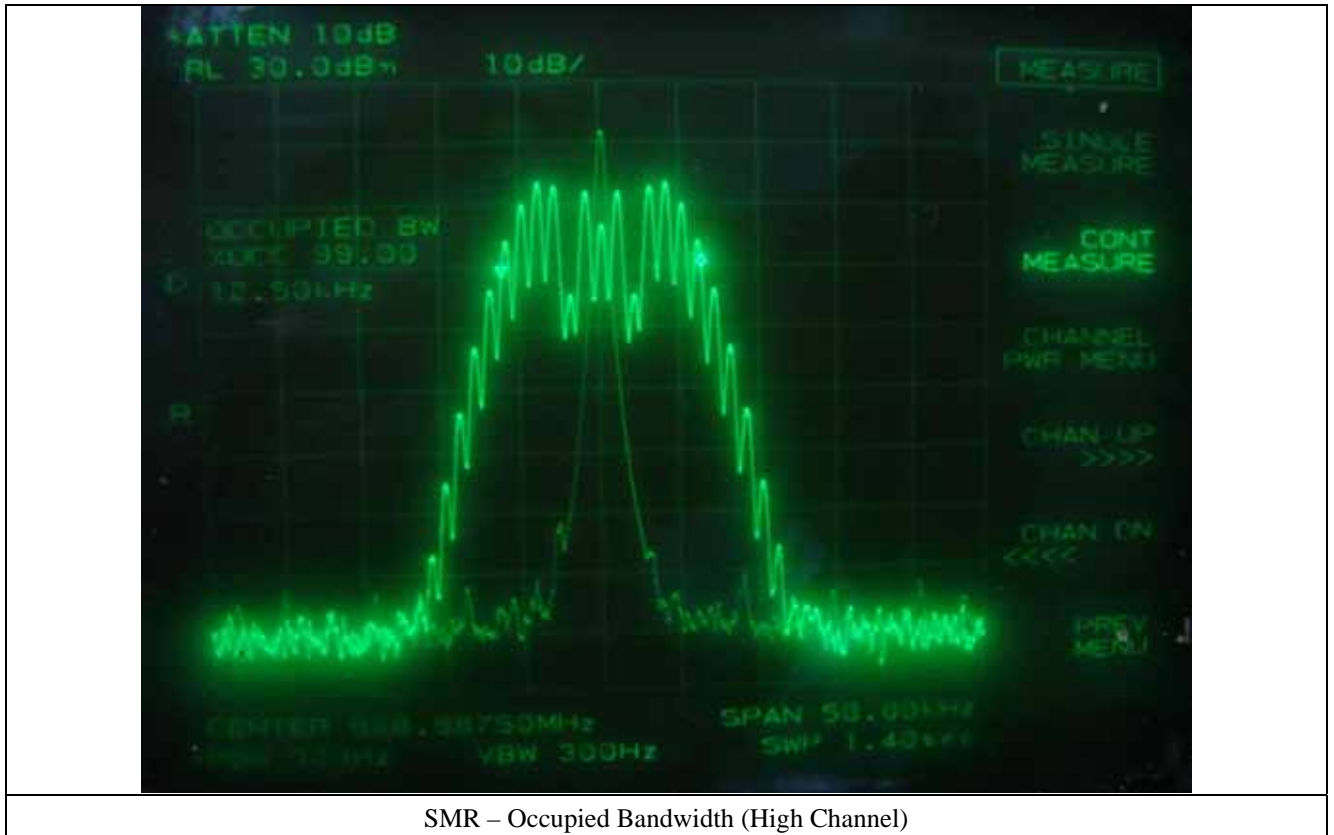
iDEN – Occupied Bandwidth (High Channel)

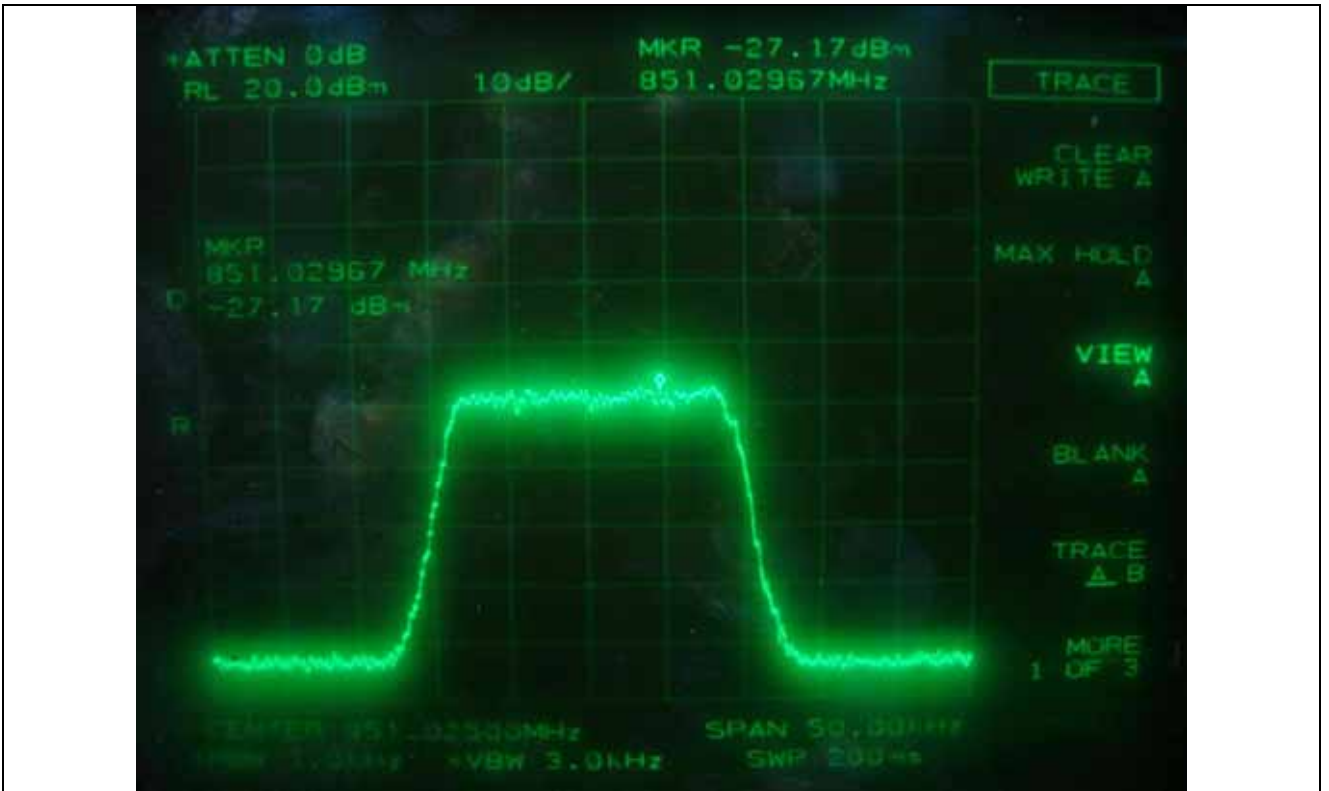


SMR – Occupied Bandwidth (Low Channel)

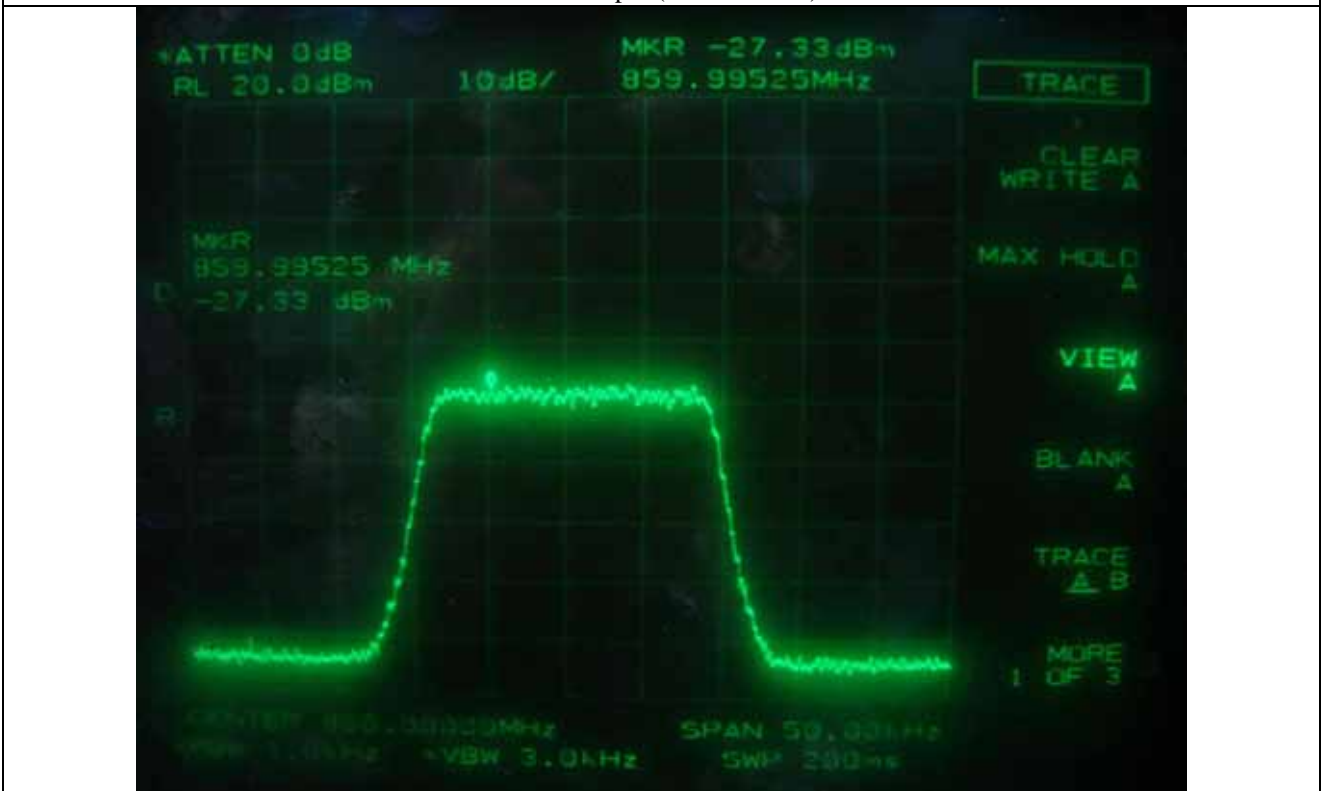


SMR – Occupied Bandwidth (Middle Channel)

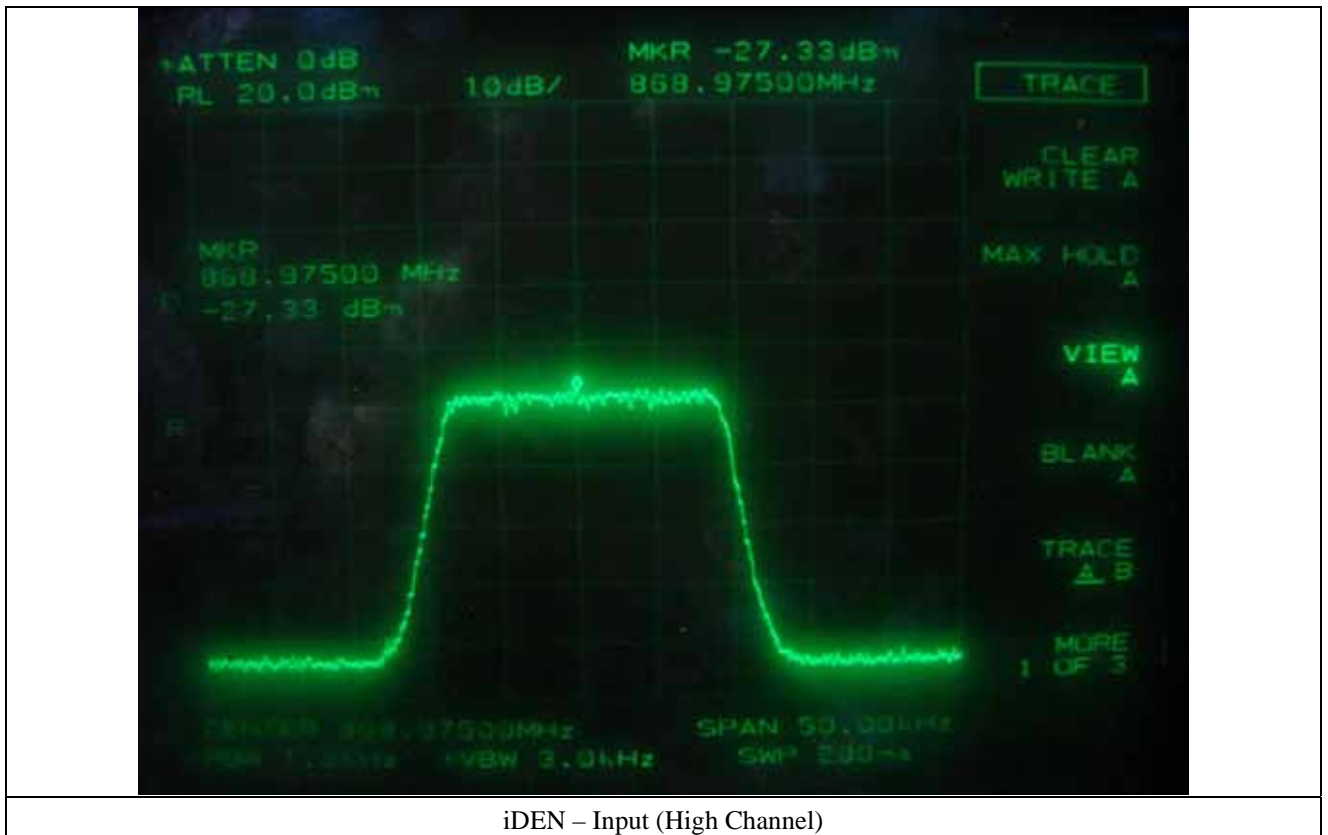




iDEN – Input (Low Channel)



iDEN – Input (Middle Channel)



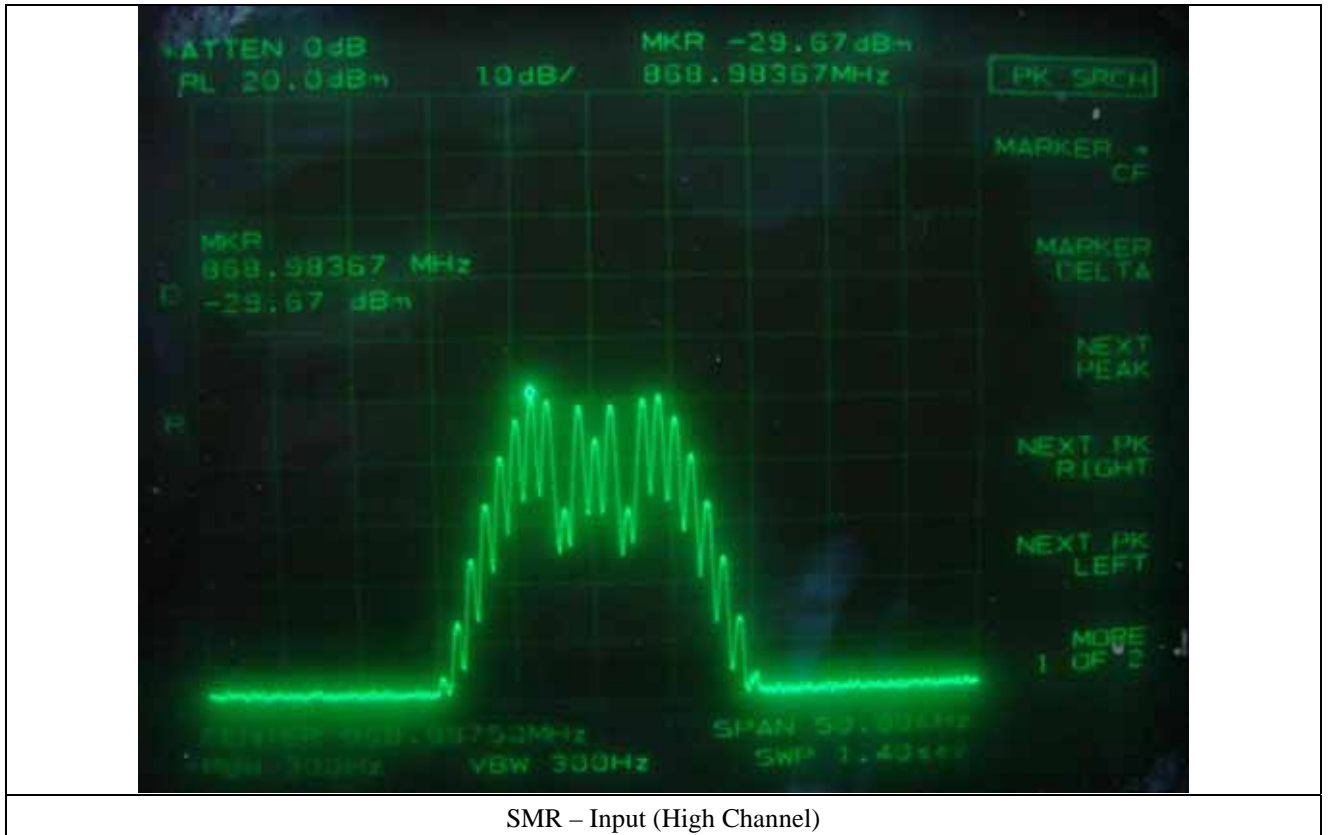
iDEN – Input (High Channel)



SMR – Input (Low Channel)



SMR – Input (Middle Channel)

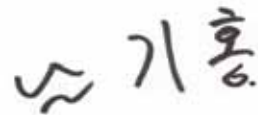


6.4.2 Test Result for 900I+PA (929 MHz ~ 930 MHz)

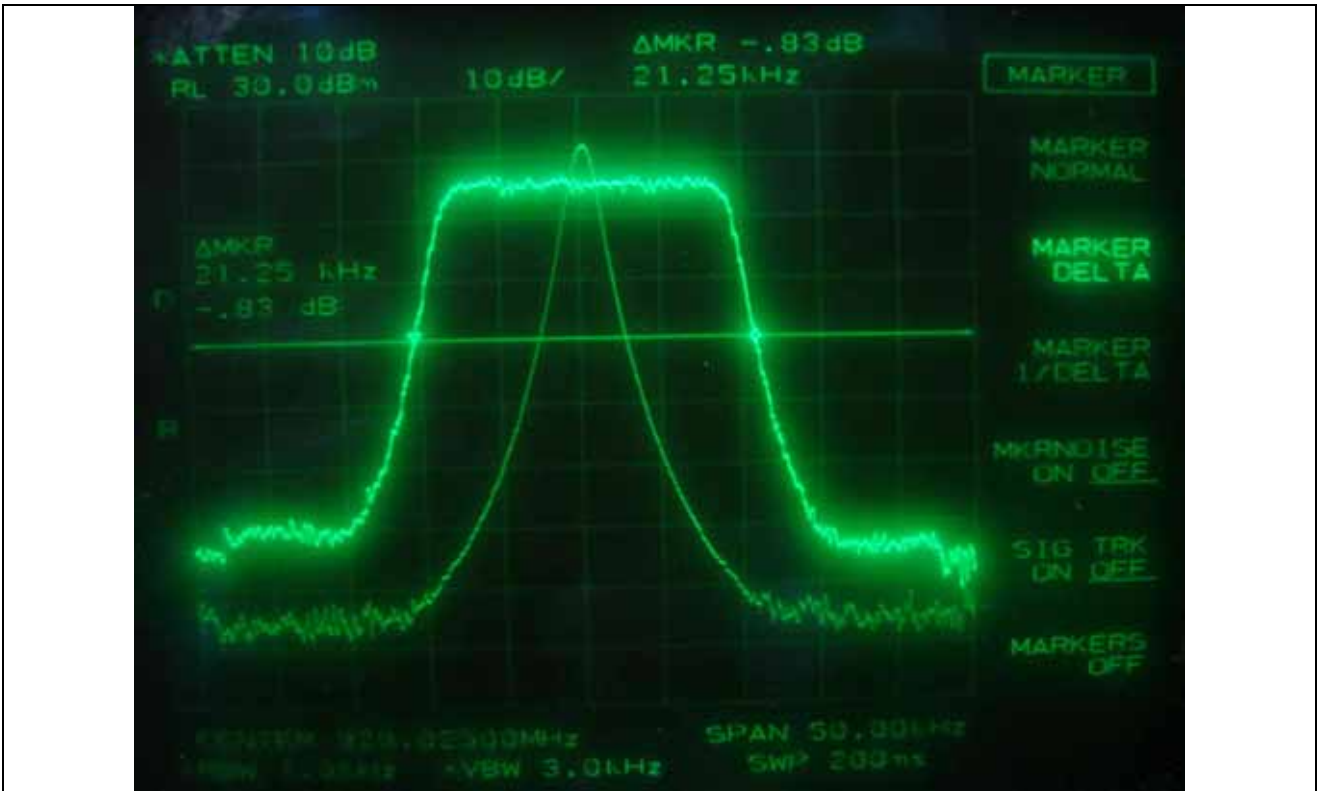
-. Test Date : March 10~11, 2009
-. Test Result : Pass

Modulation	Channel	26 dB Bandwidth (kHz)	99 % Occupied Bandwidth (kHz)
iDEN	Low	14.67	12.50
	Middle	14.67	12.50
	High	14.67	12.50
SMR	Low	21.25	18.33
	Middle	21.25	18.42
	High	21.25	18.42

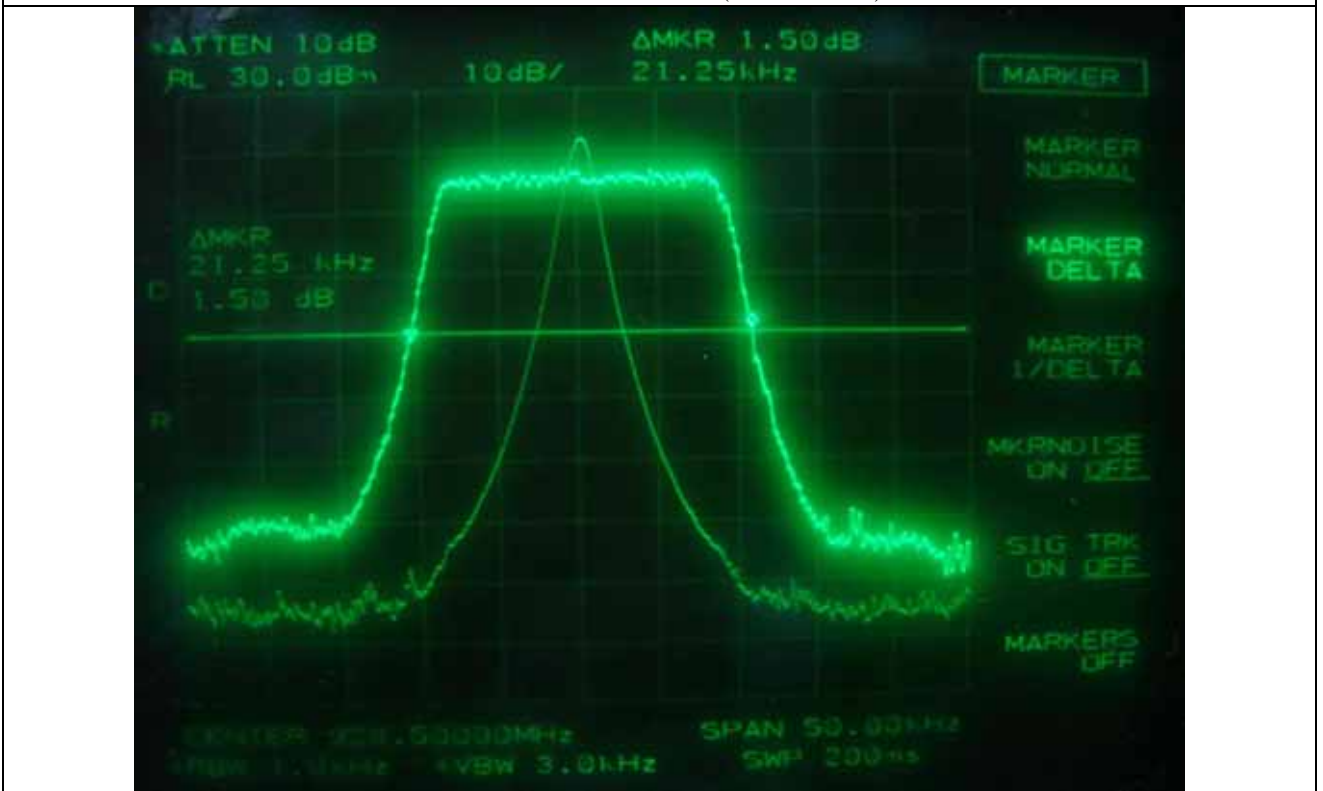
Remark: According to above result, the carrier frequency shall be within the frequency block edges.



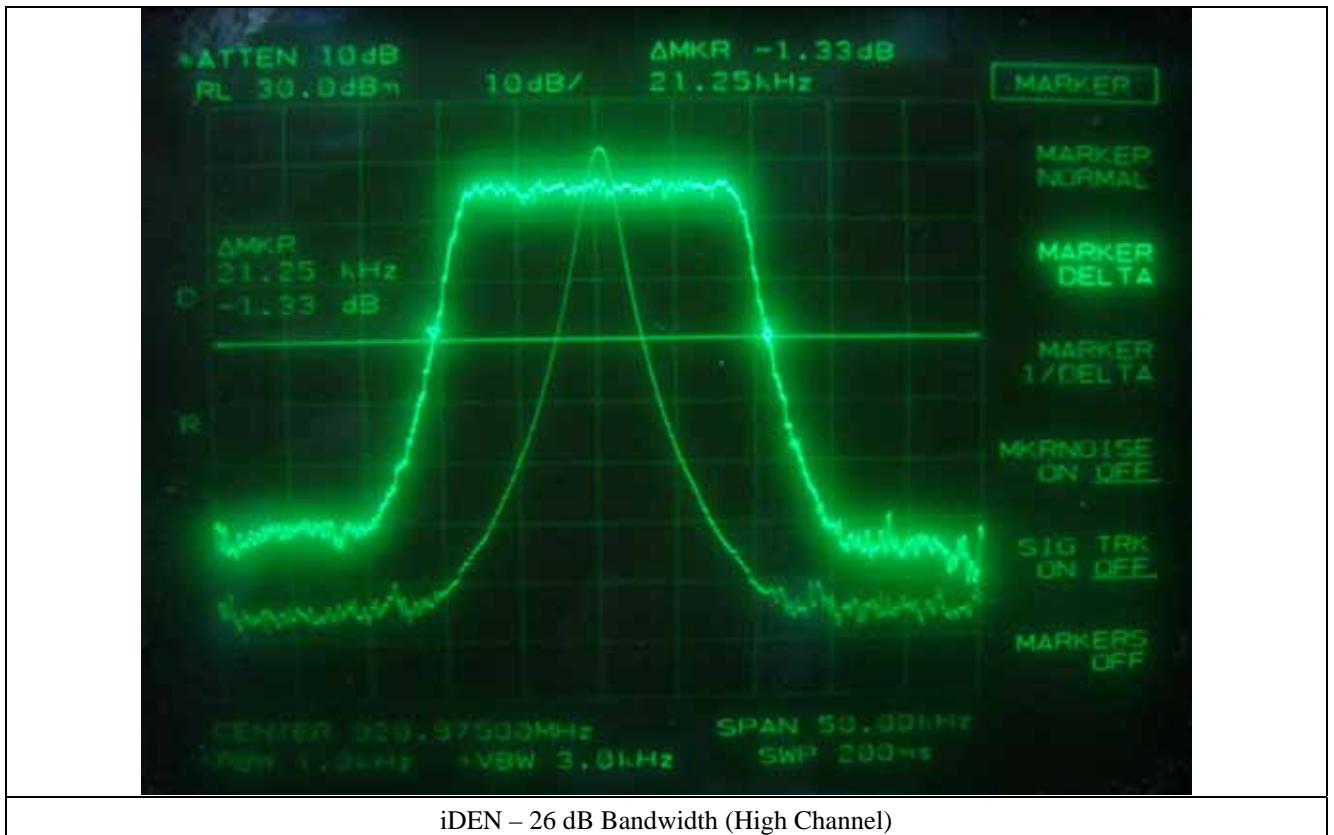
Tested by: Ki-Hong, Nam / Project Engineer

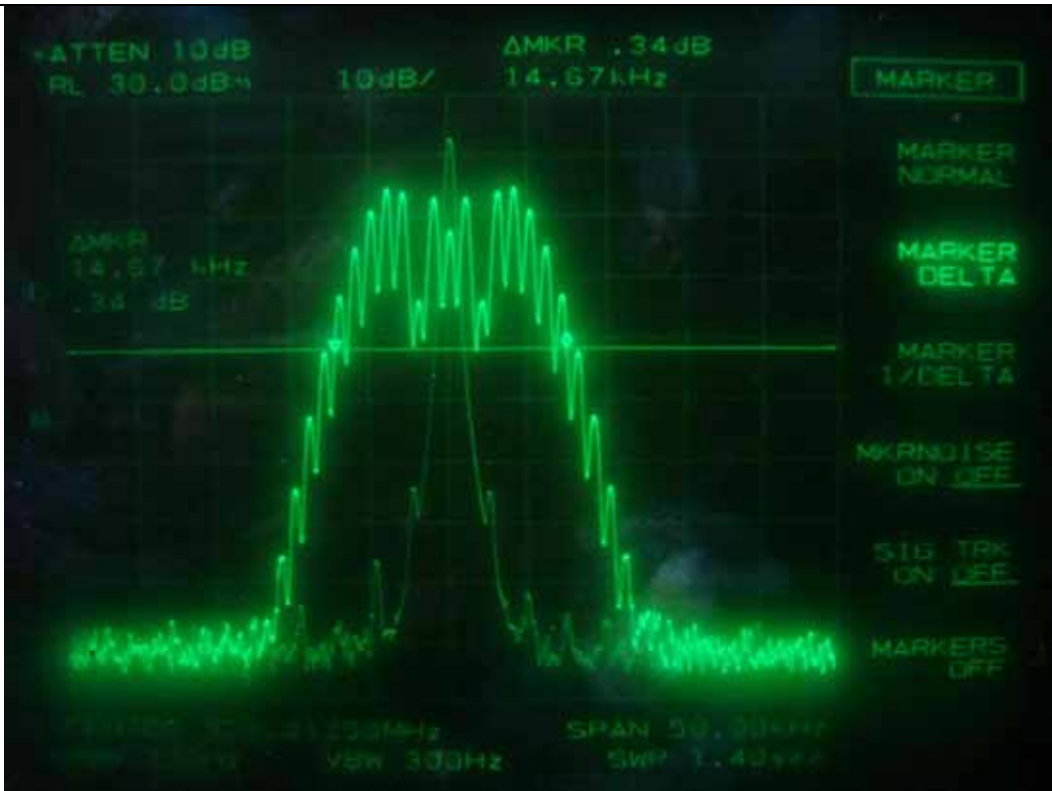


iDEN – 26 dB Bandwidth (Low Channel)

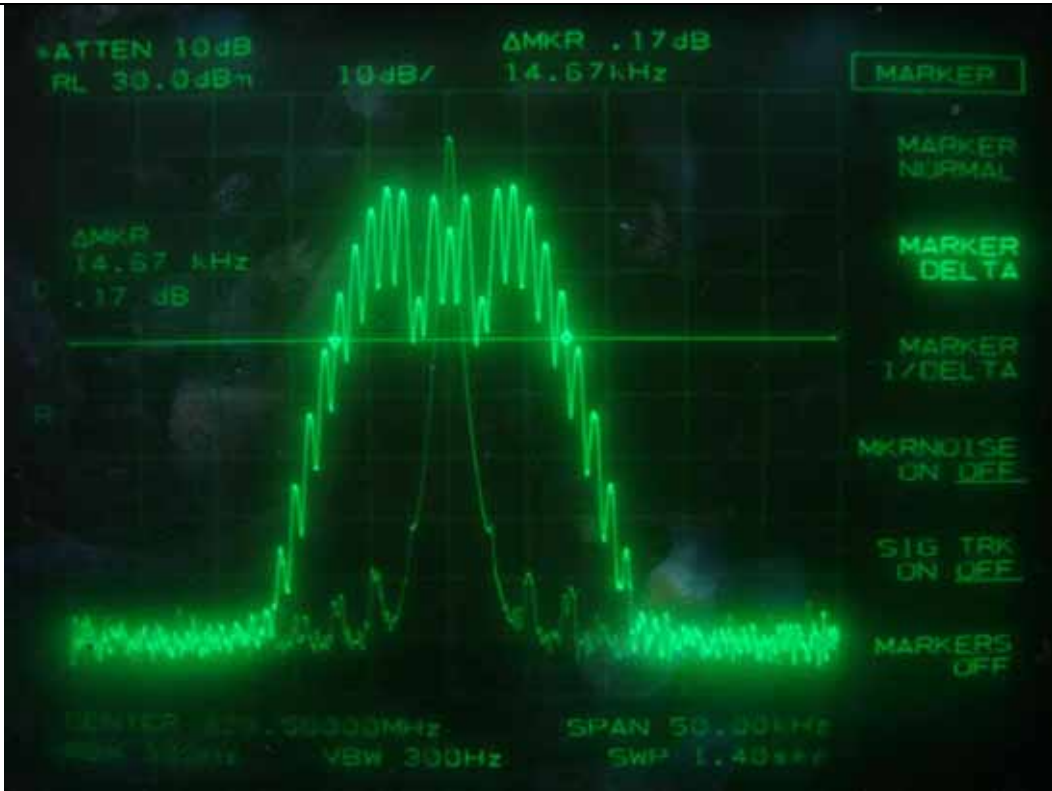


iDEN – 26 dB Bandwidth (Middle Channel)

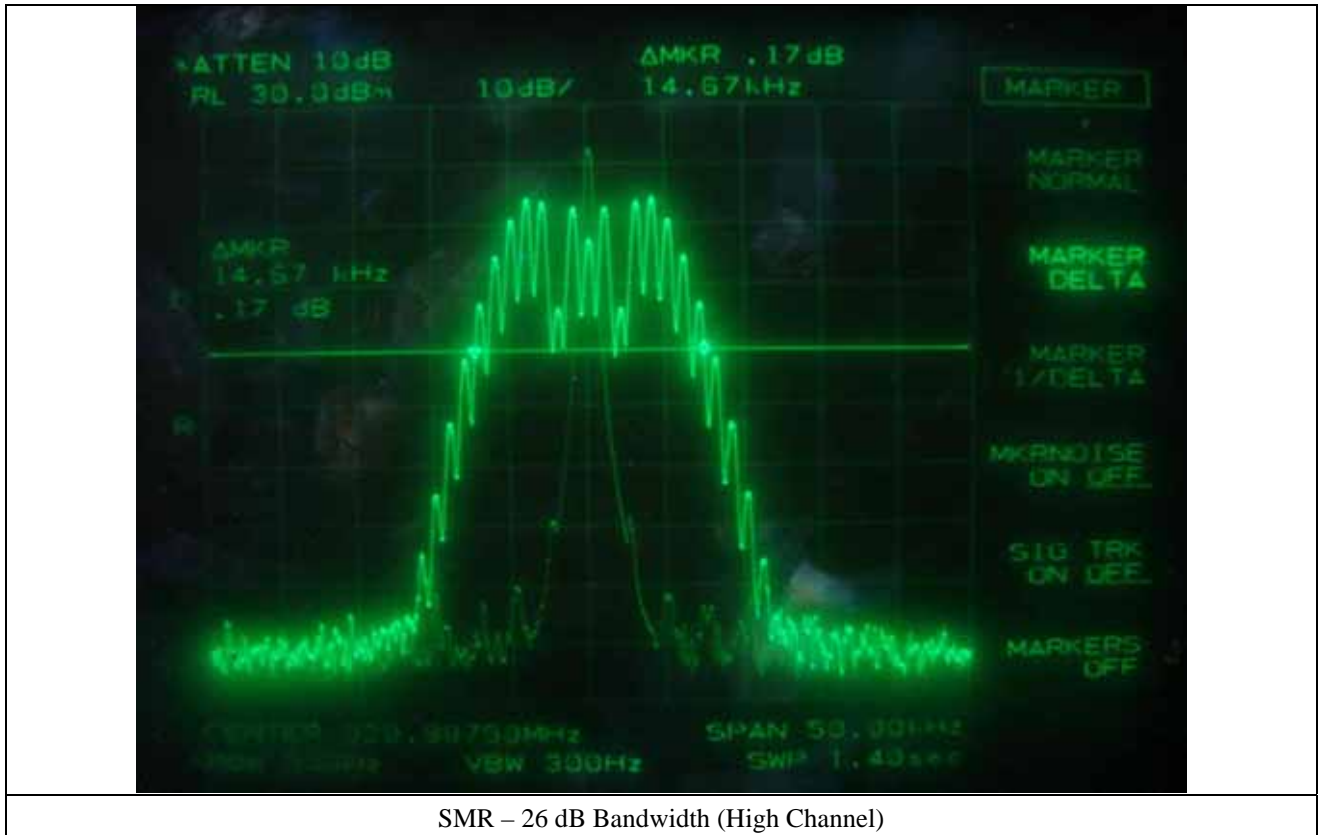


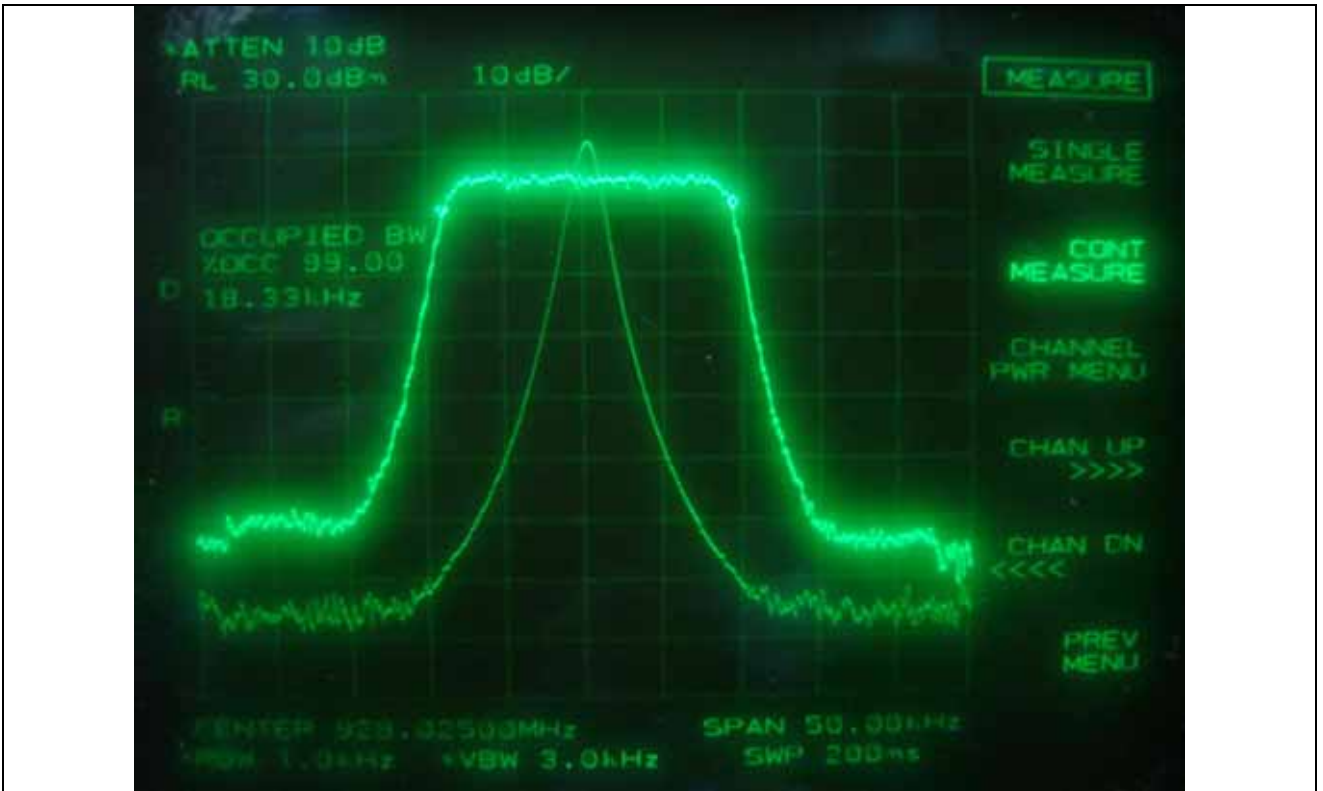


SMR – 26 dB Bandwidth (Low Channel)

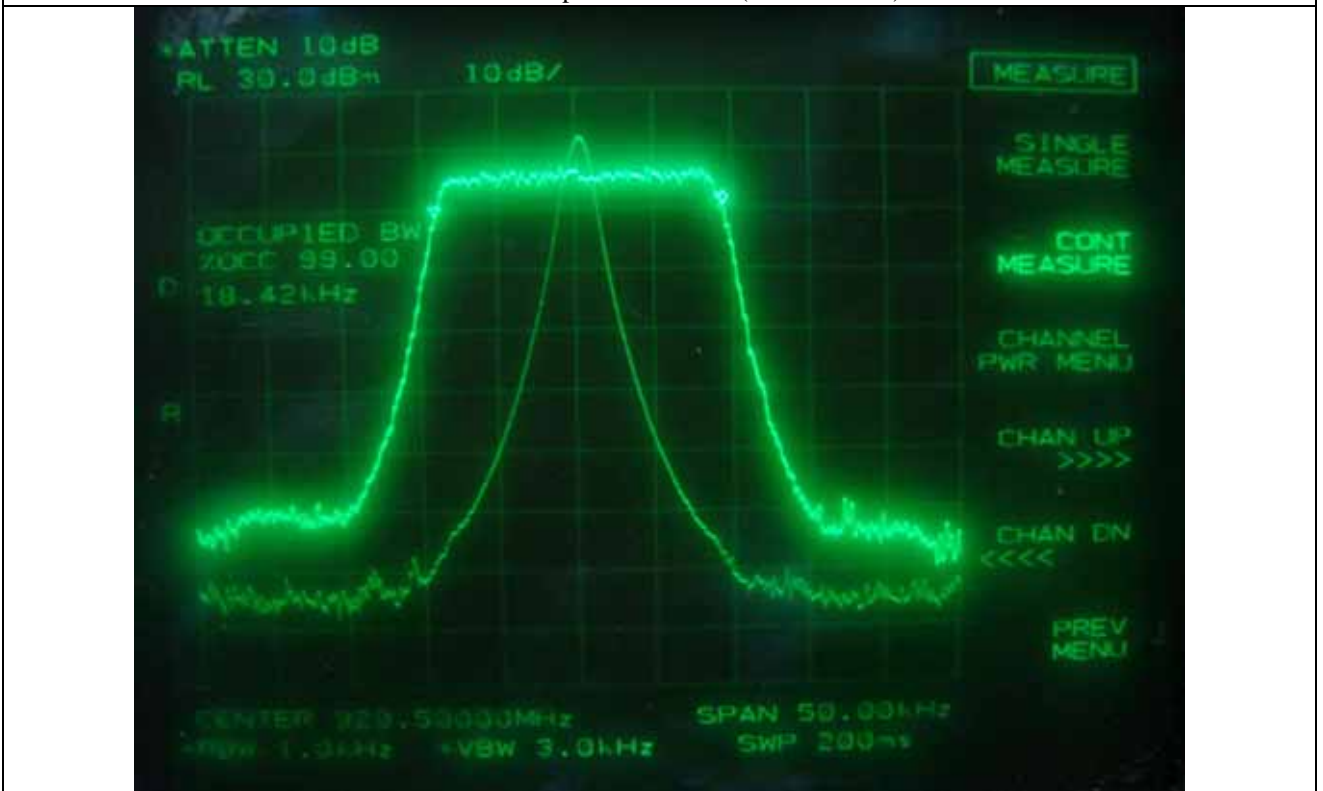


SMR – 26 dB Bandwidth (Middle Channel)

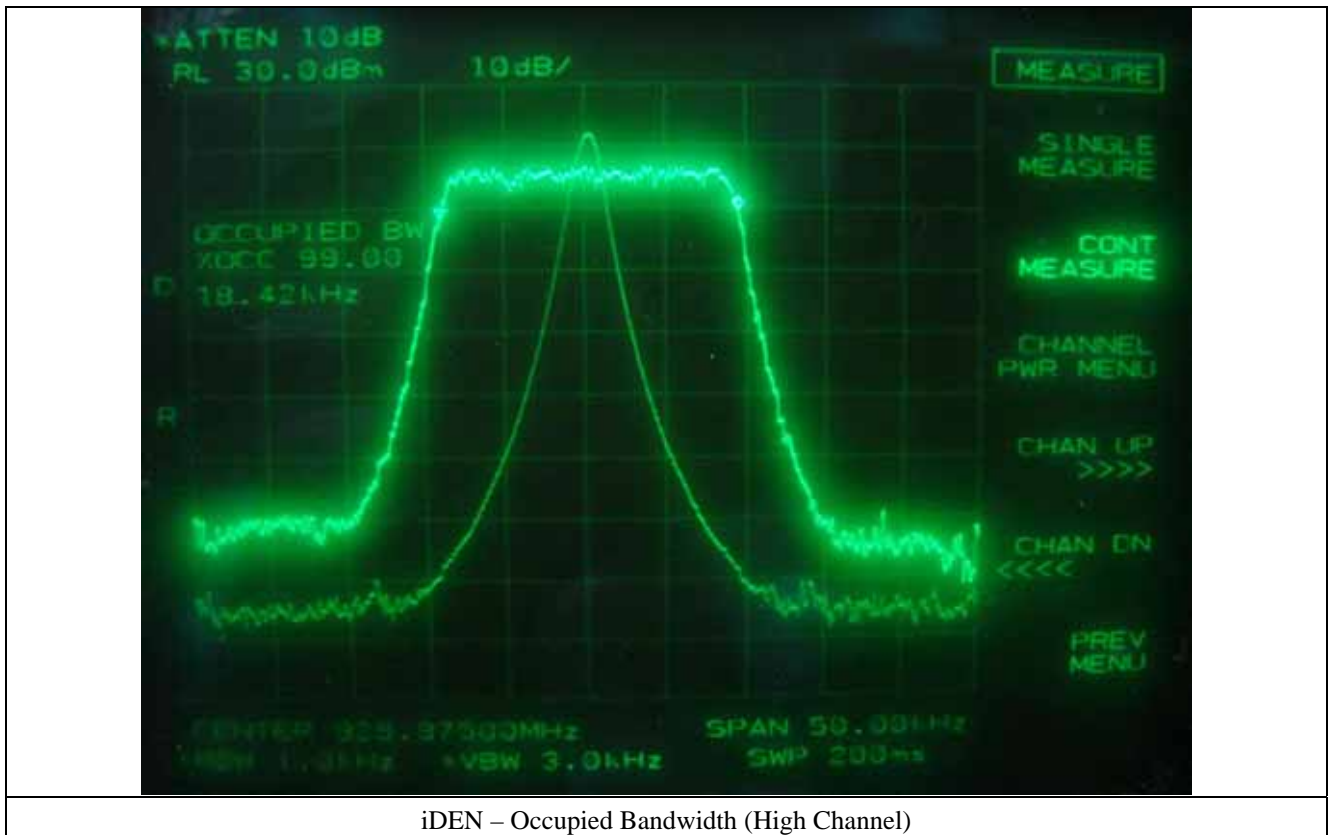


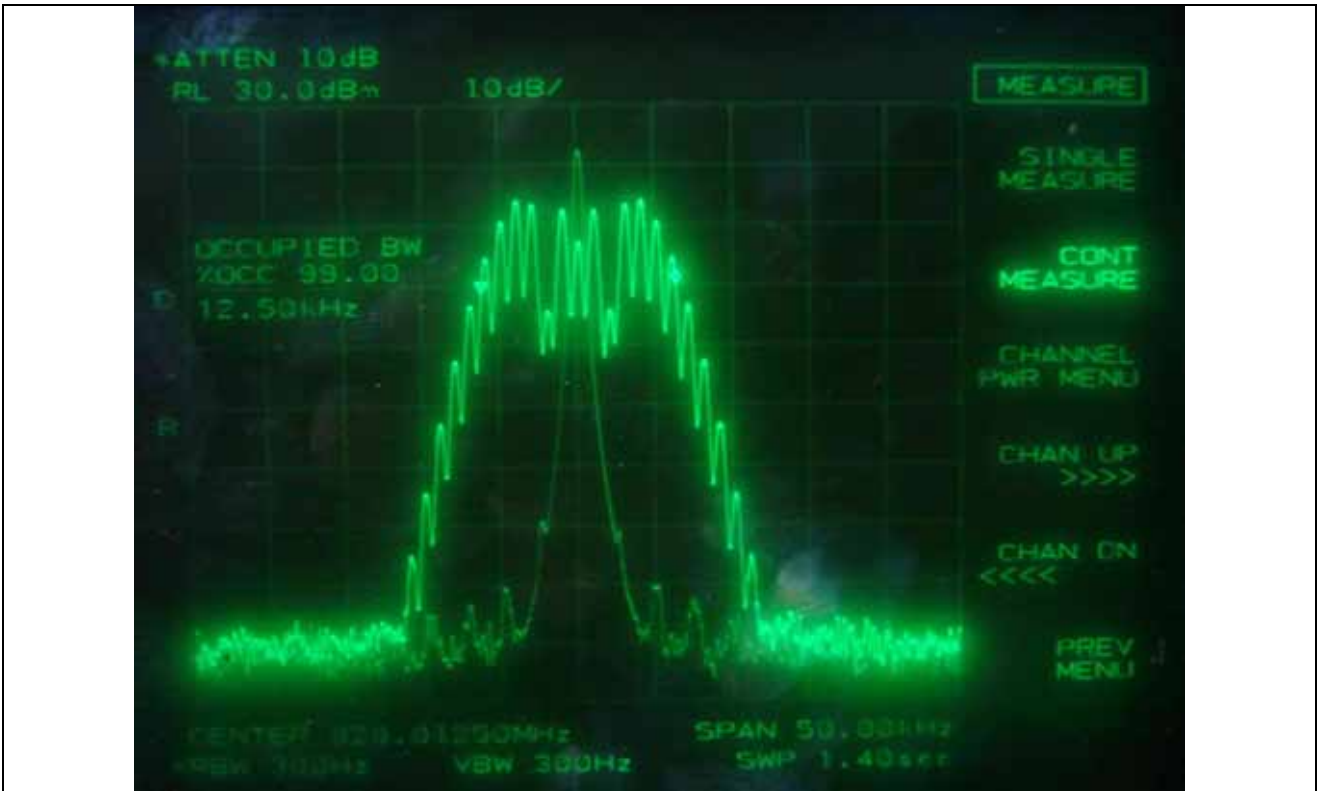


iDEN – Occupied Bandwidth (Low Channel)

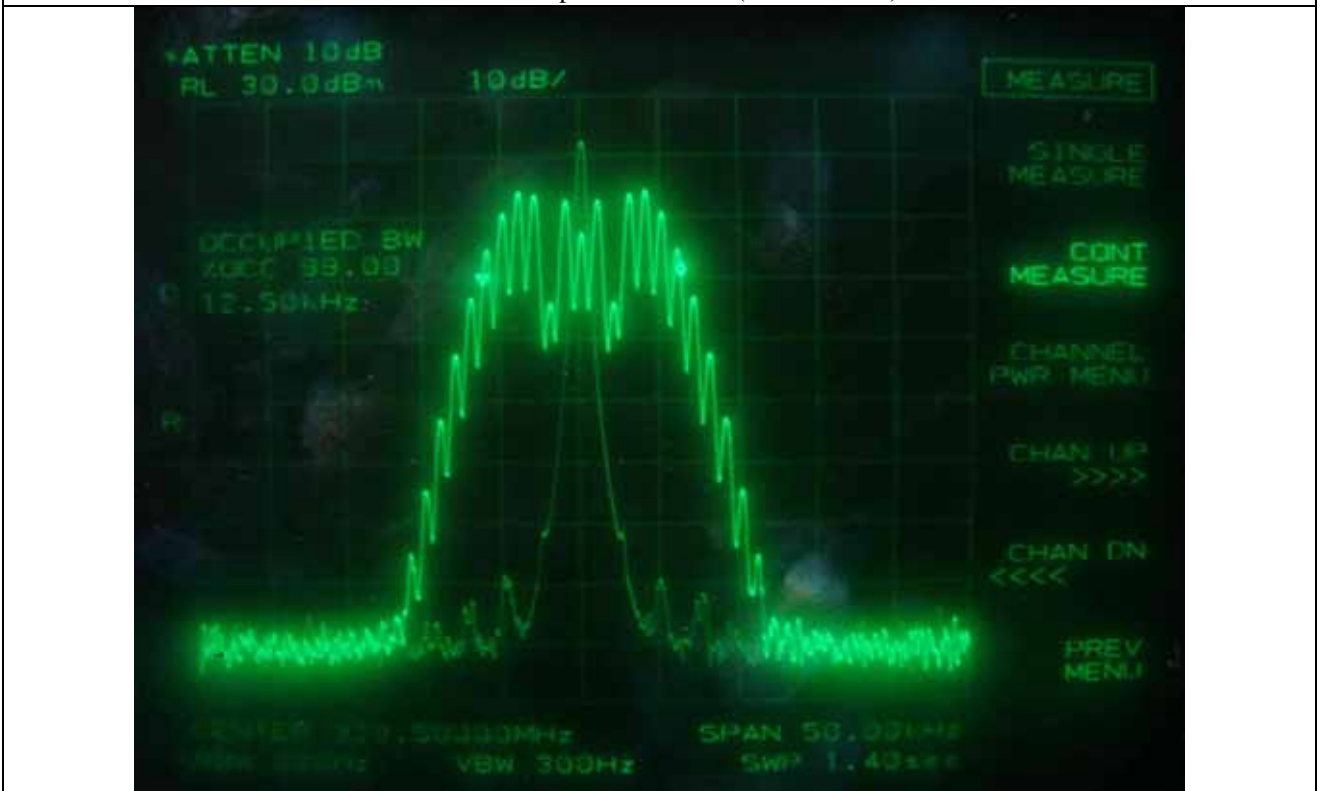


iDEN – Occupied Bandwidth (Middle Channel)

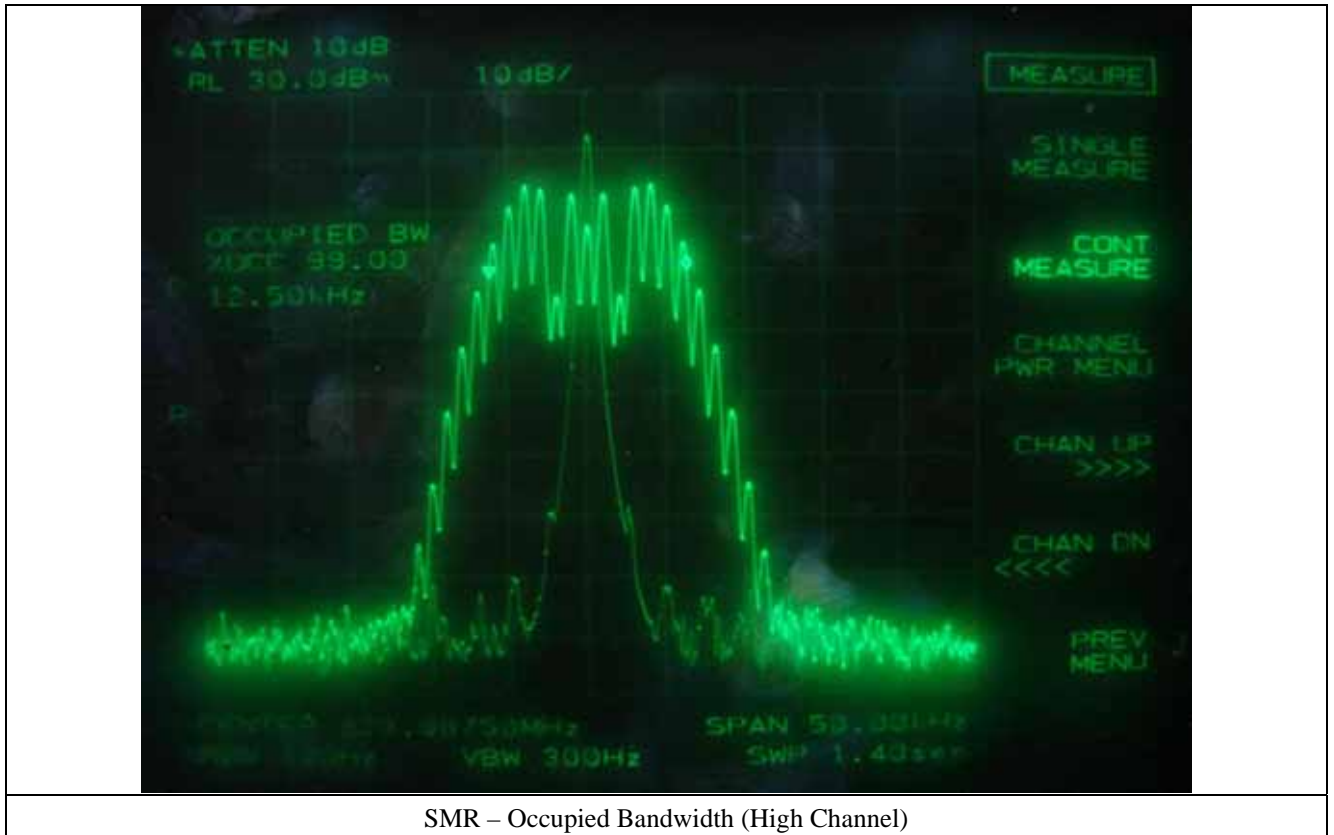


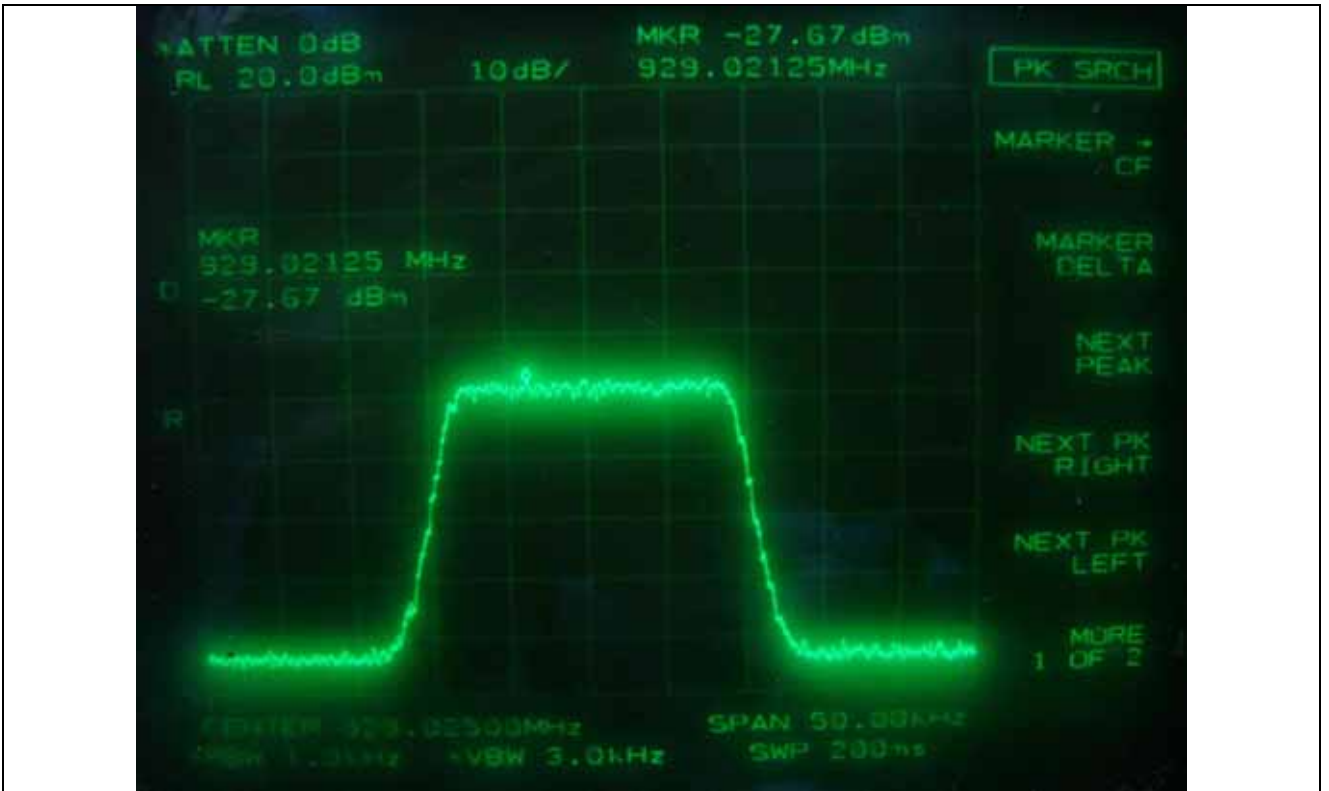


SMR – Occupied Bandwidth (Low Channel)

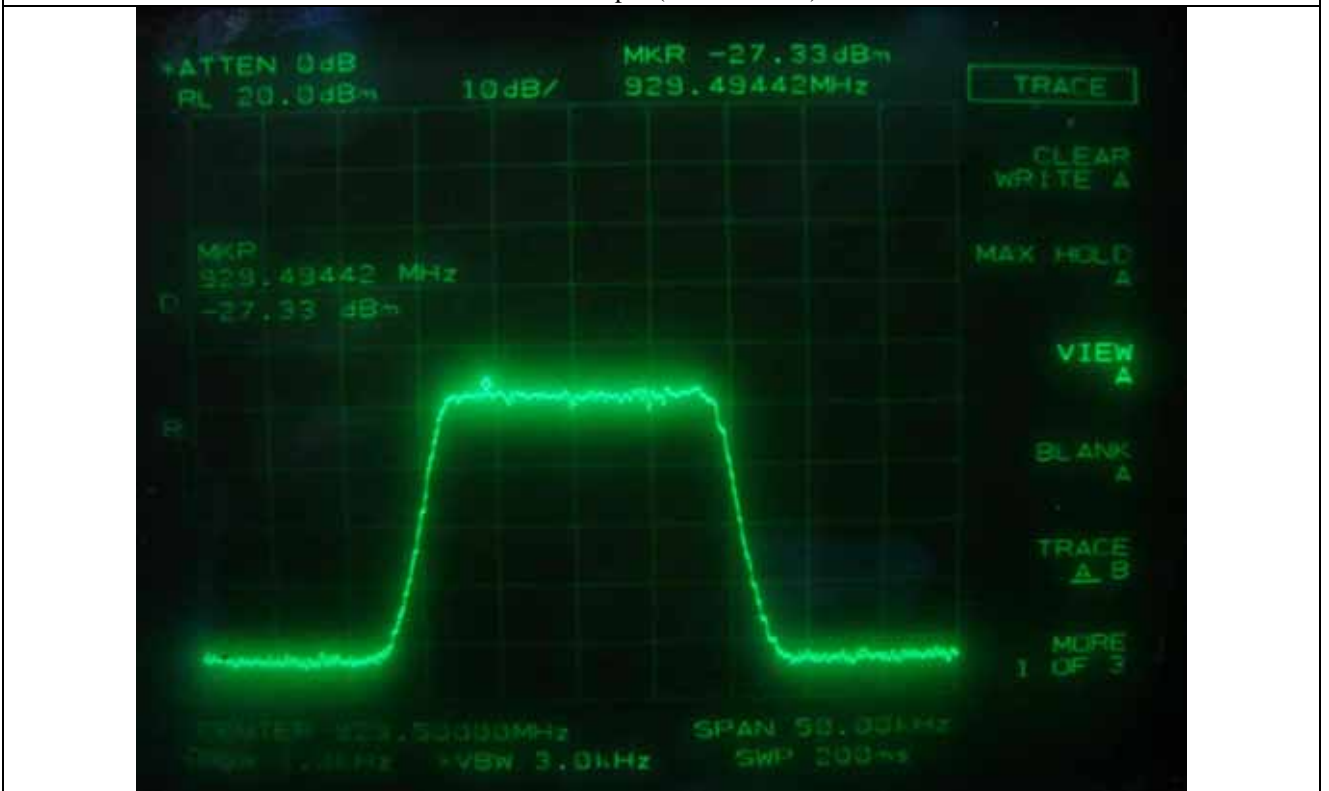


SMR – Occupied Bandwidth (Middle Channel)

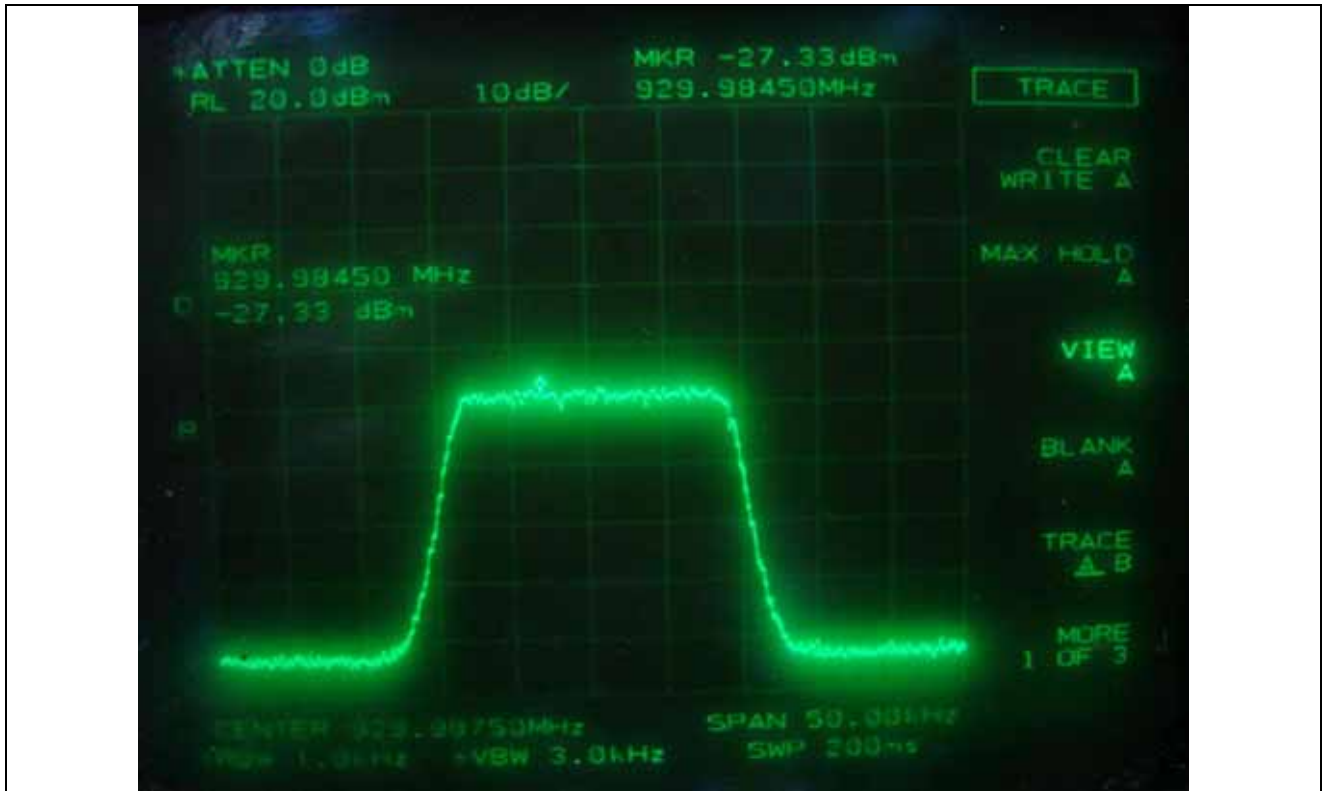




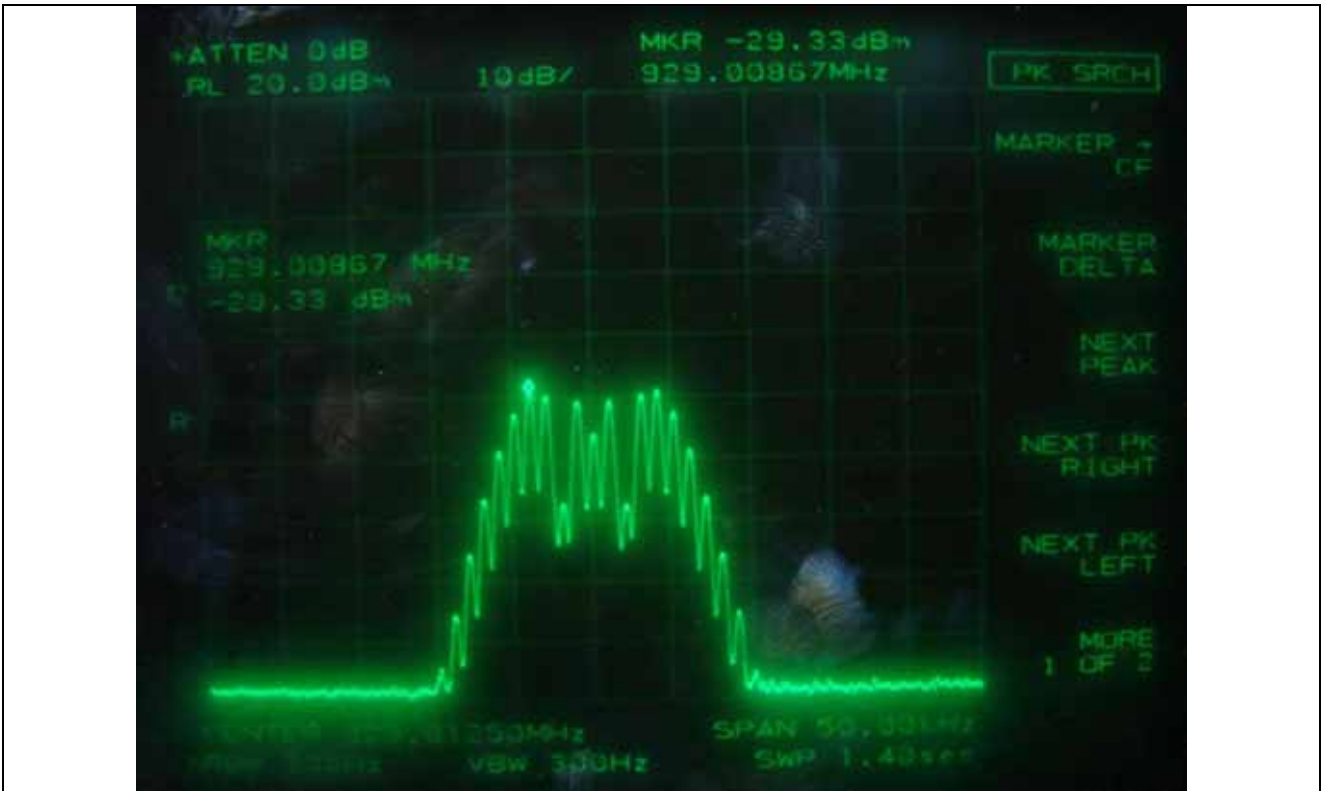
iDEN – Input (Low Channel)



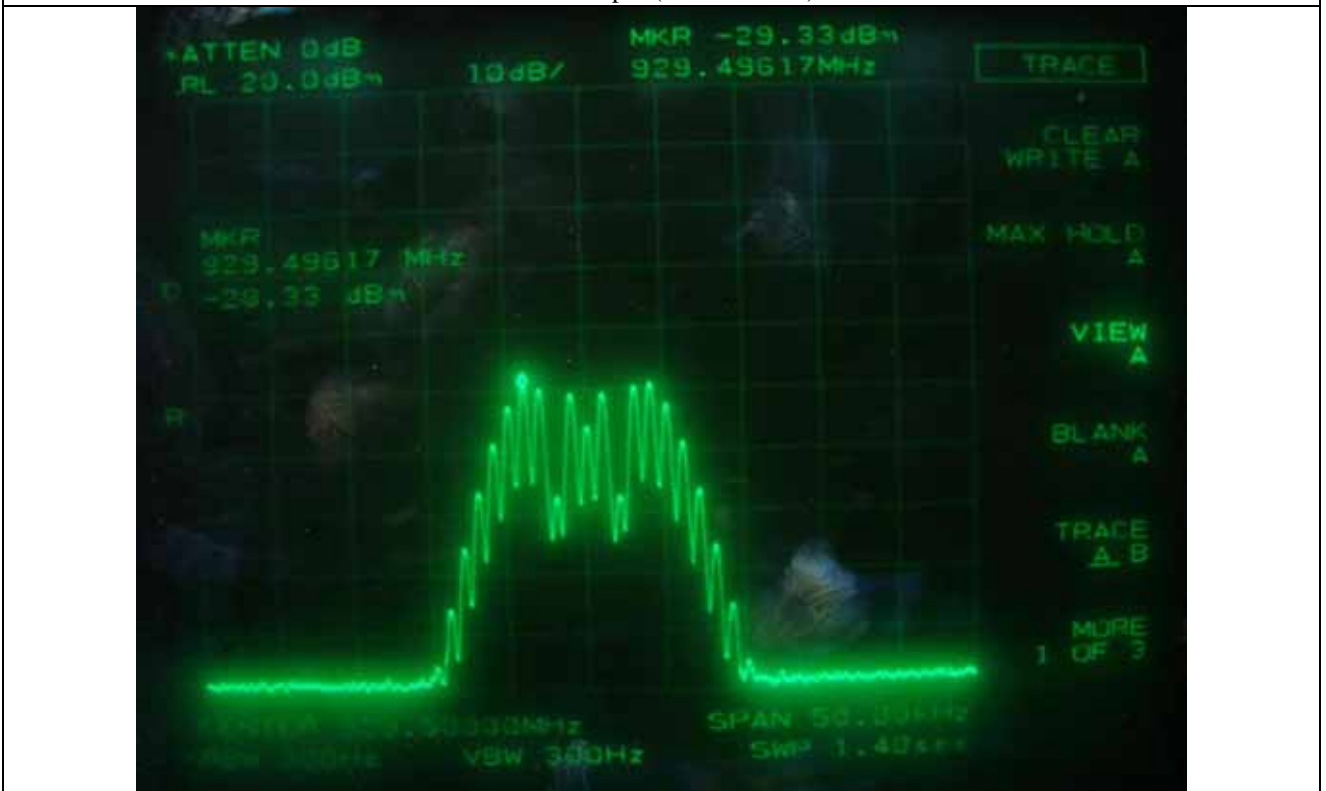
iDEN – Input (Middle Channel)



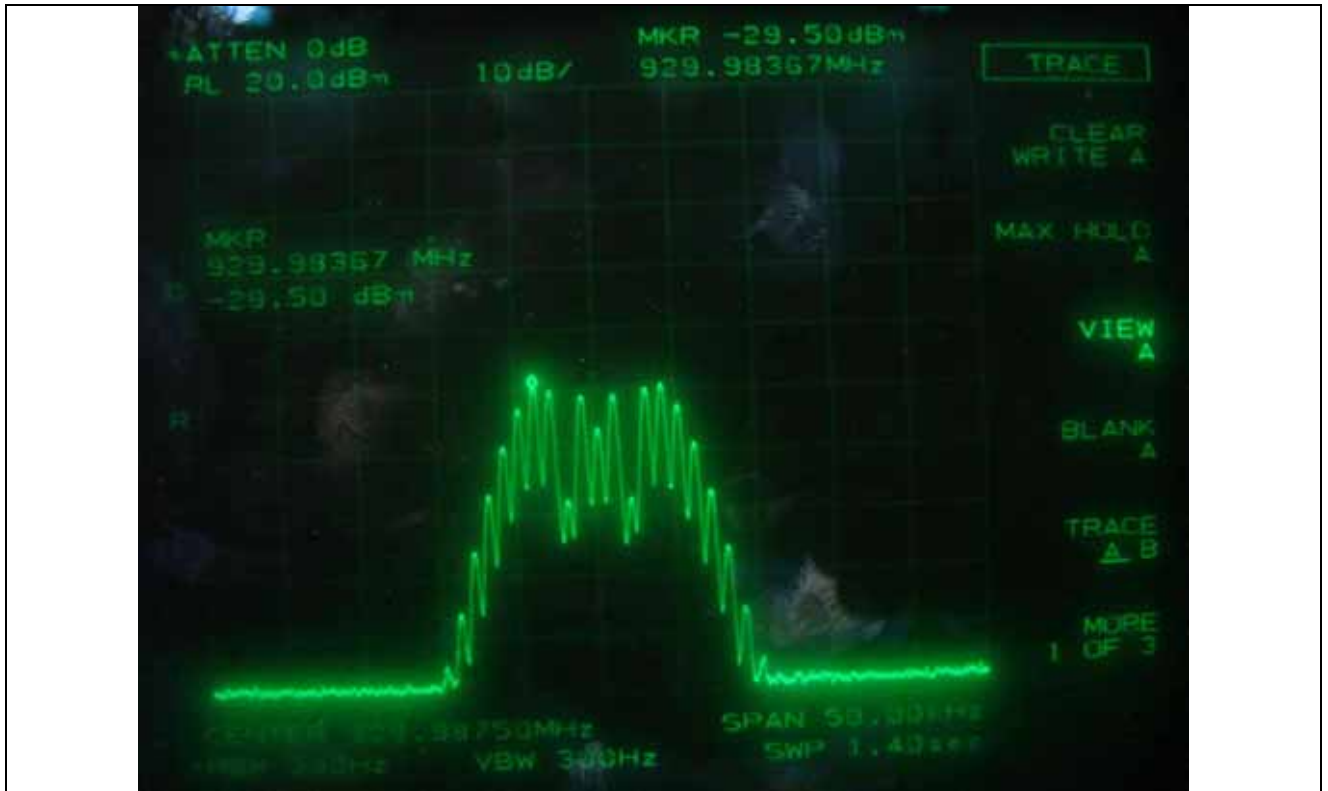
iDEN – Input (High Channel)



SMR – Input (Low Channel)



SMR – Input (Middle Channel)



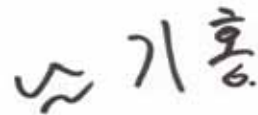
SMR – Input (High Channel)

6.4.3 Test Result for 900I+PA (935 MHz ~ 940 MHz)

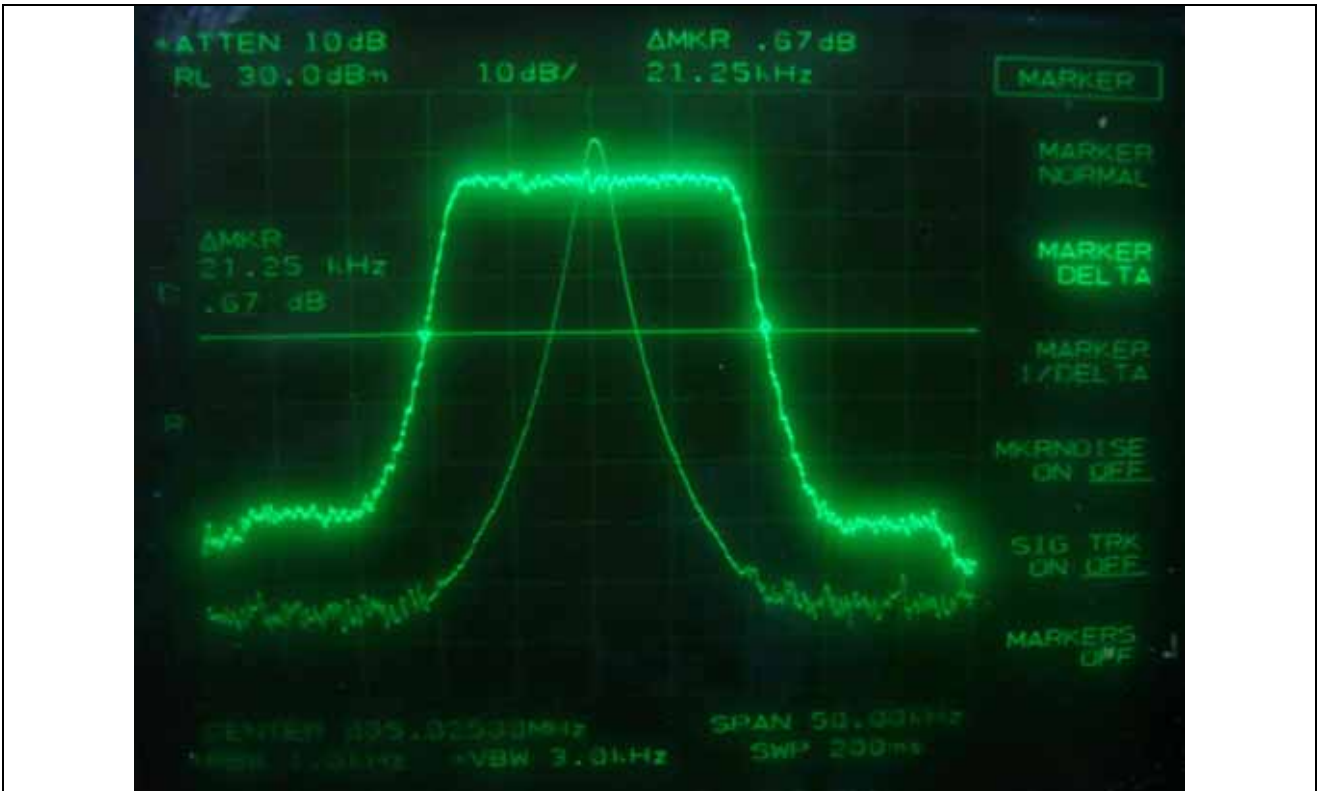
-. Test Date : March 10~11, 2009
-. Test Result : Pass

Modulation	Channel	26 dB Bandwidth (kHz)	99 % Occupied Bandwidth (kHz)
iDEN	Low	14.58	12.42
	Middle	14.67	12.42
	High	14.67	12.42
SMR	Low	21.25	18.33
	Middle	21.25	18.42
	High	21.33	18.42

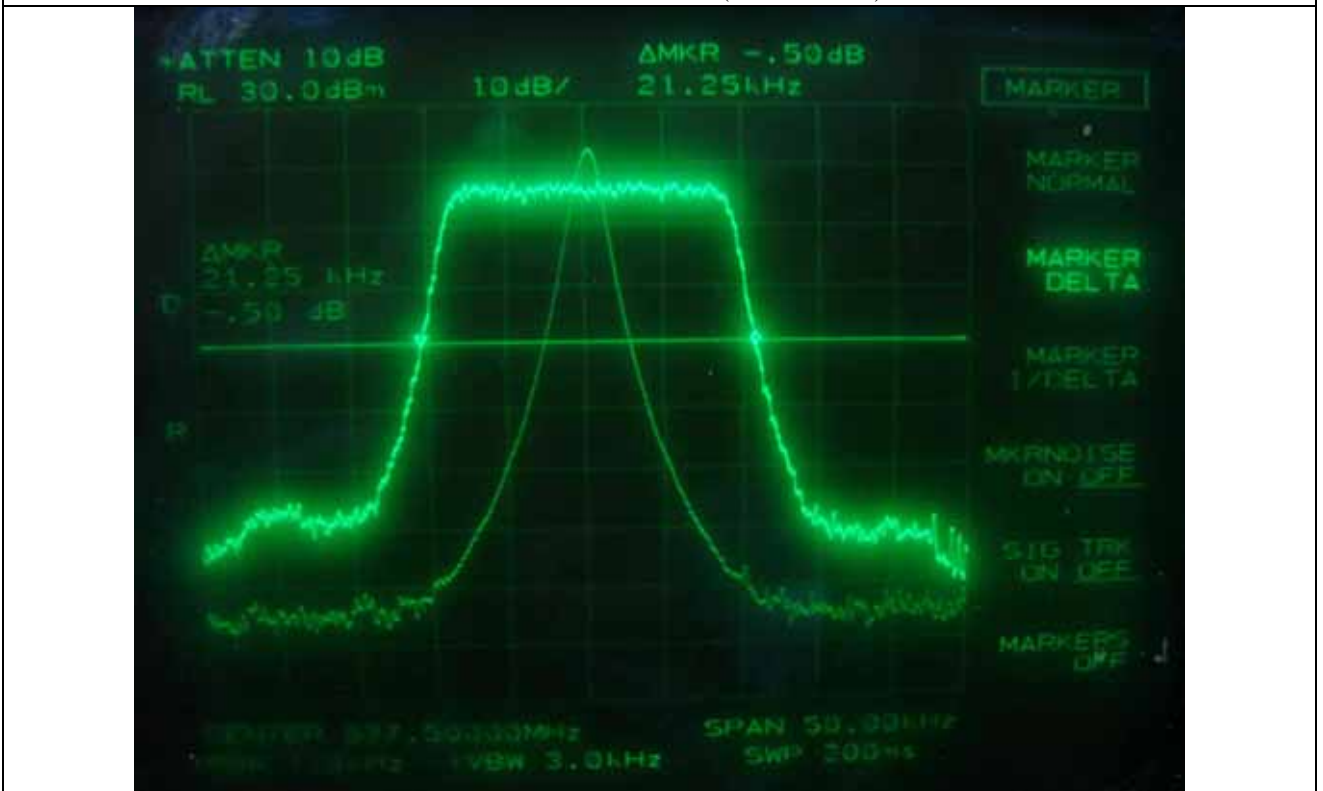
Remark: According to above result, the carrier frequency shall be within the frequency block edges.



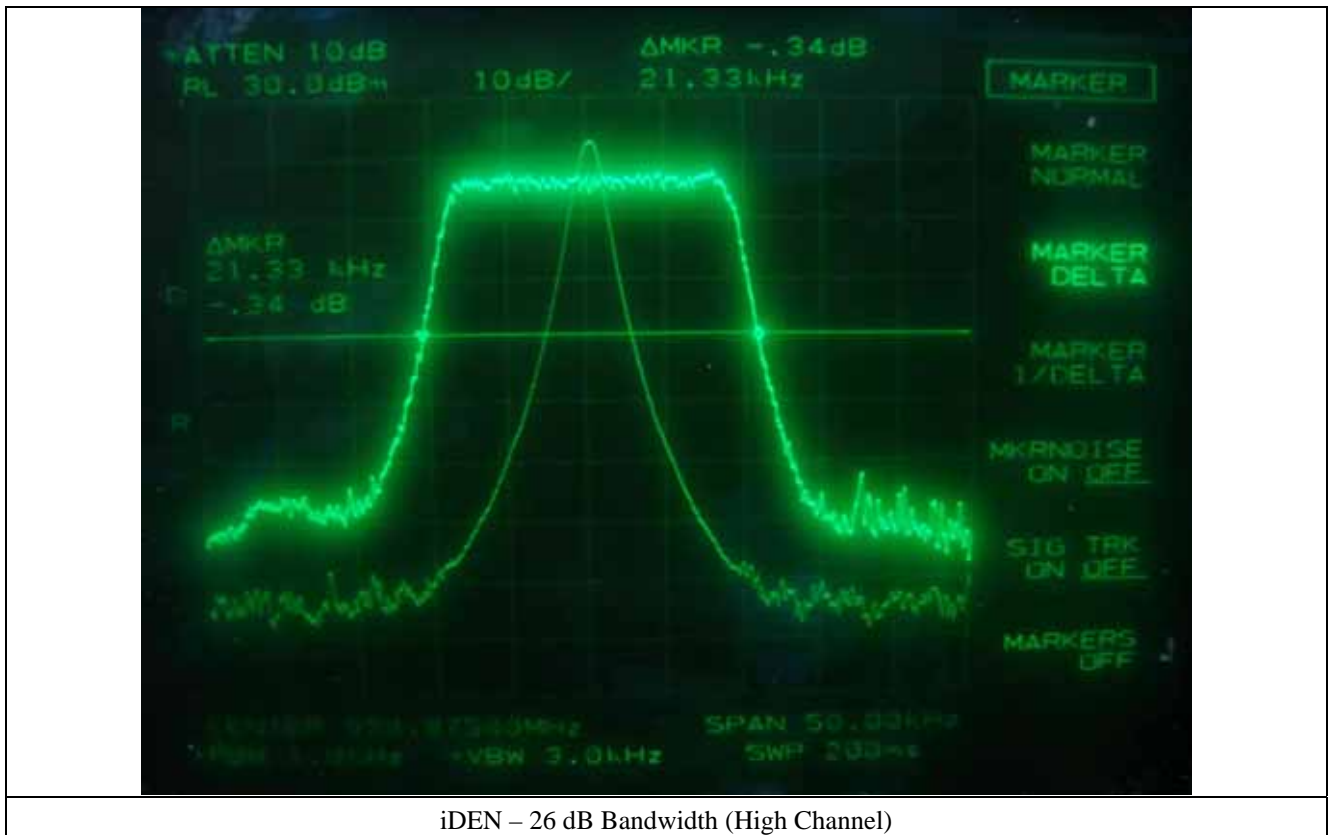
Tested by: Ki-Hong, Nam / Project Engineer

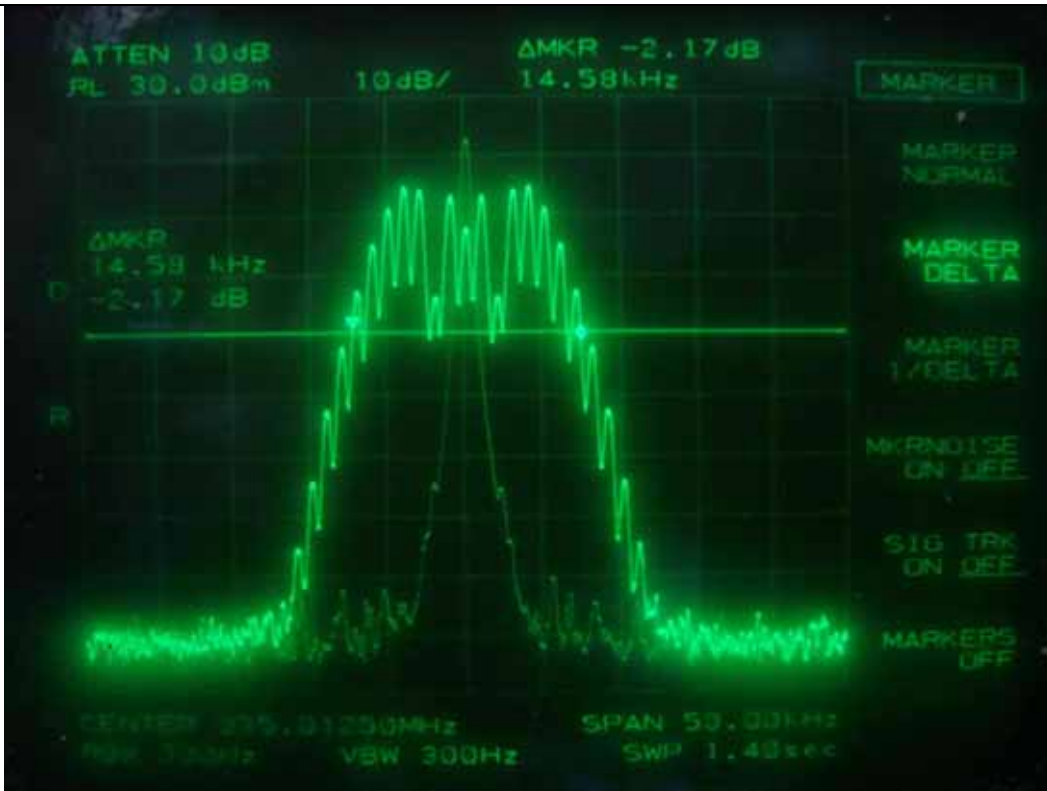


iDEN – 26 dB Bandwidth (Low Channel)

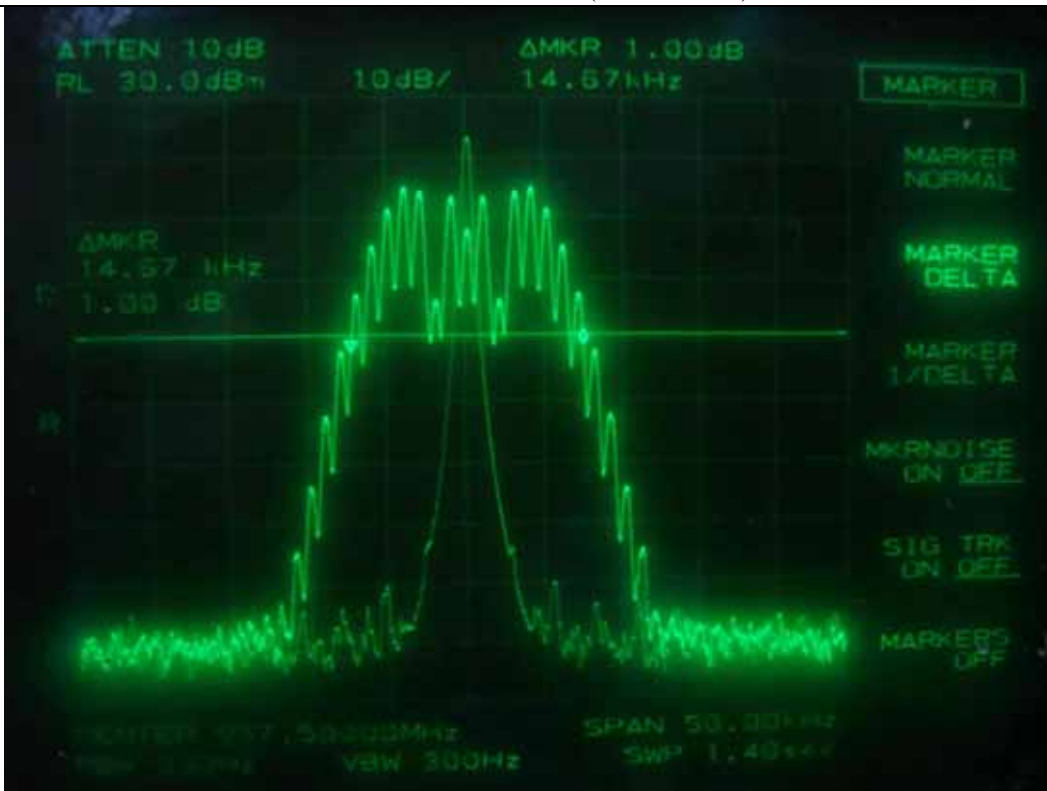


iDEN – 26 dB Bandwidth (Middle Channel)

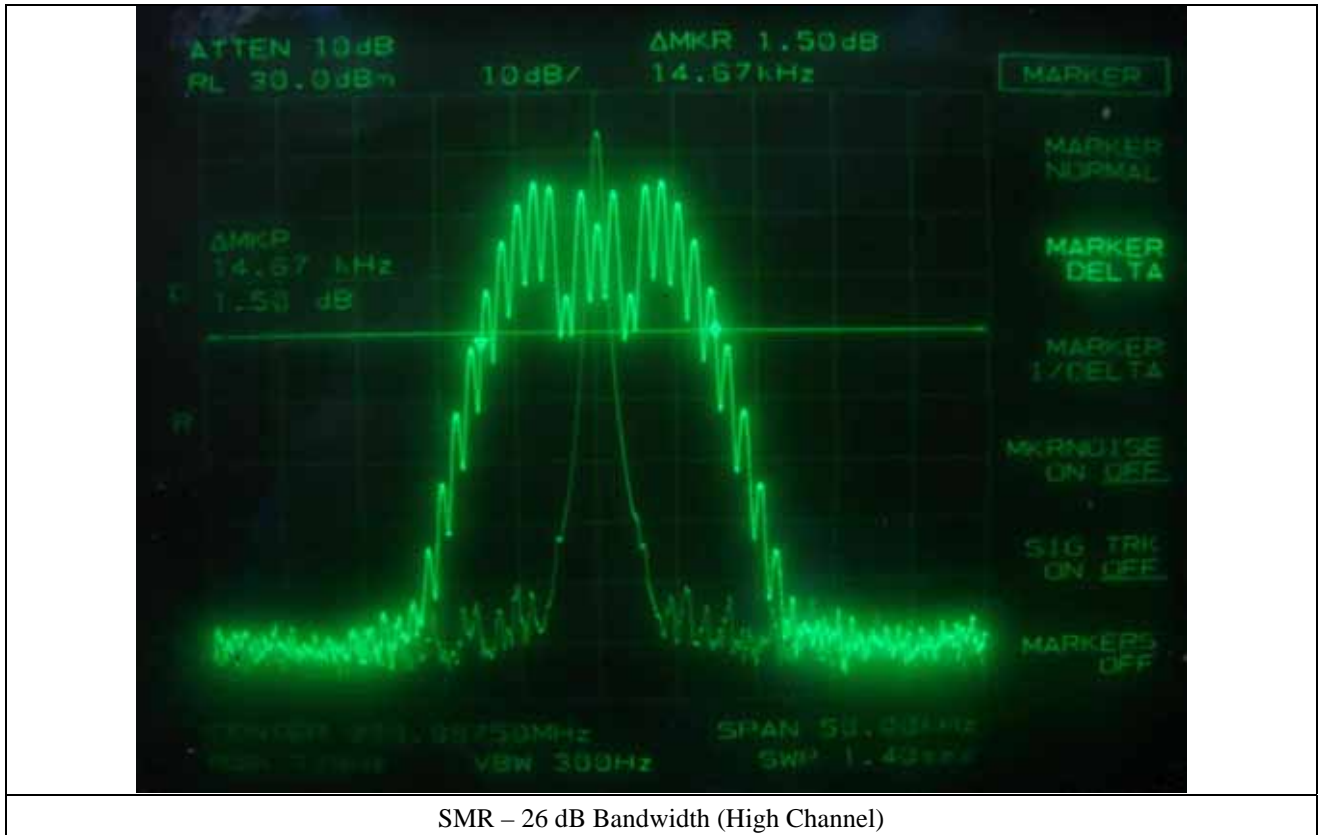


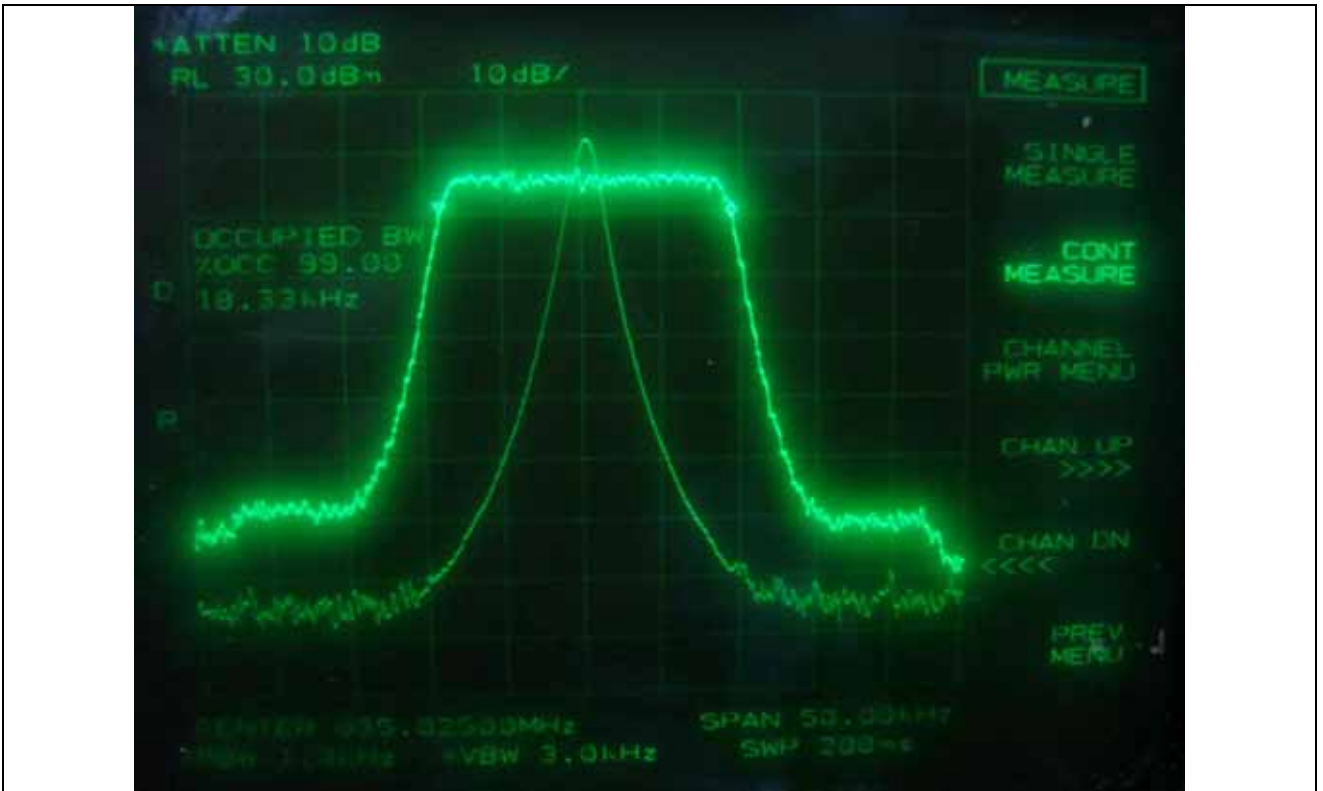


SMR – 26 dB Bandwidth (Low Channel)

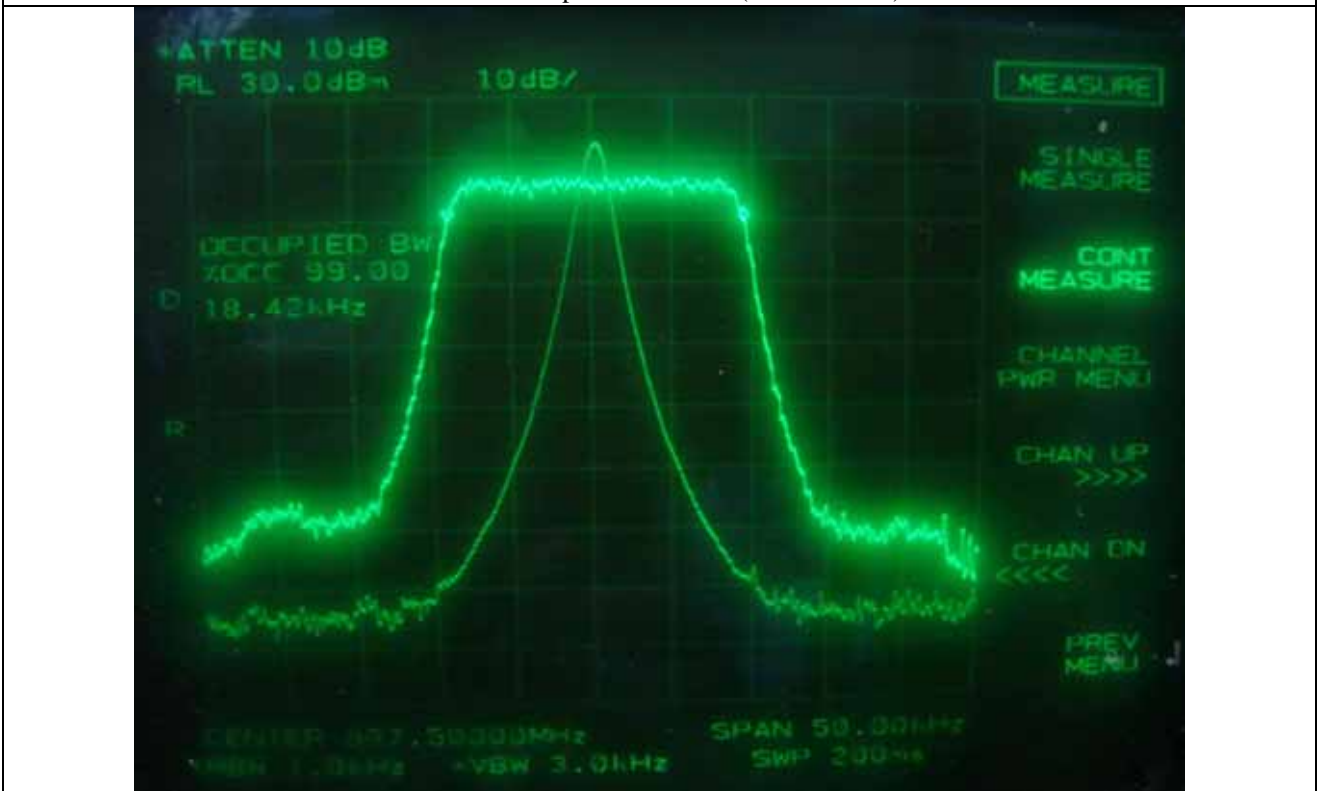


SMR – 26 dB Bandwidth (Middle Channel)

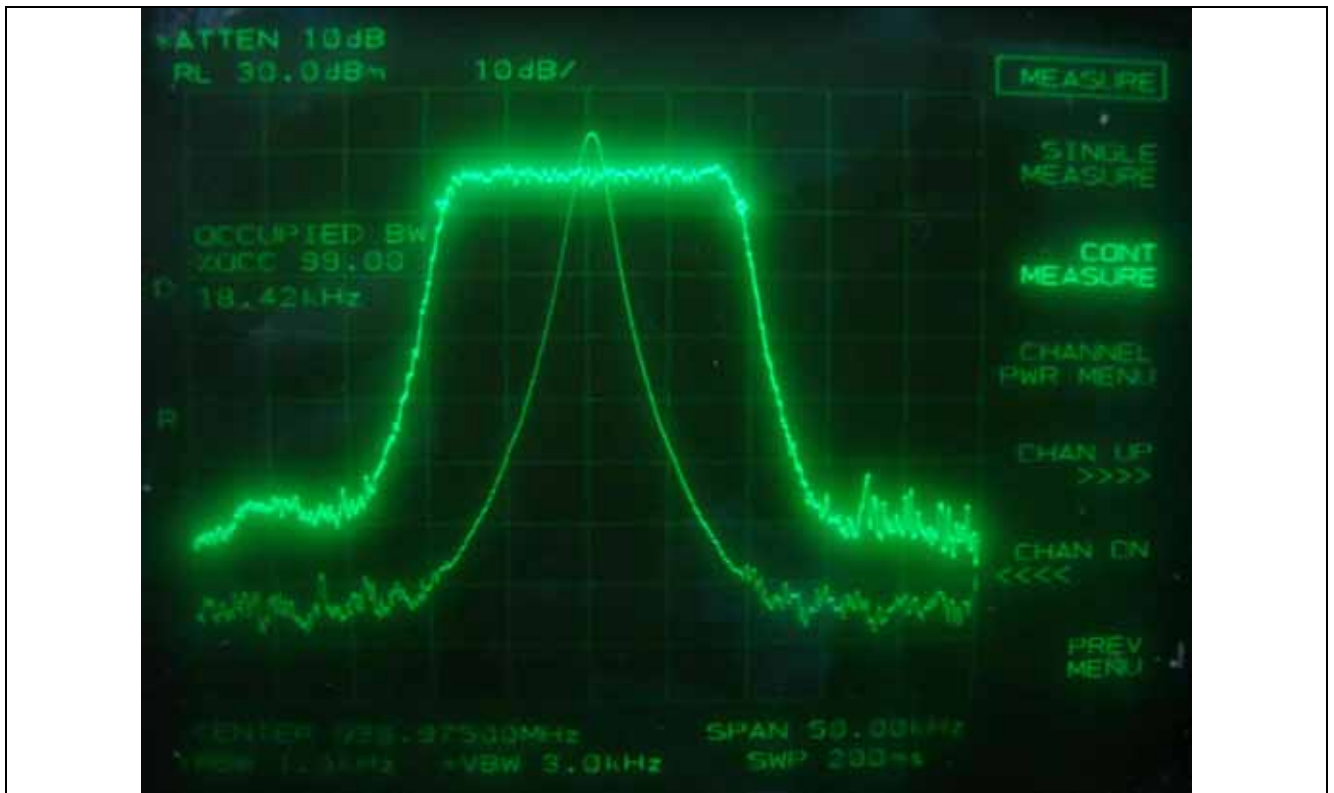




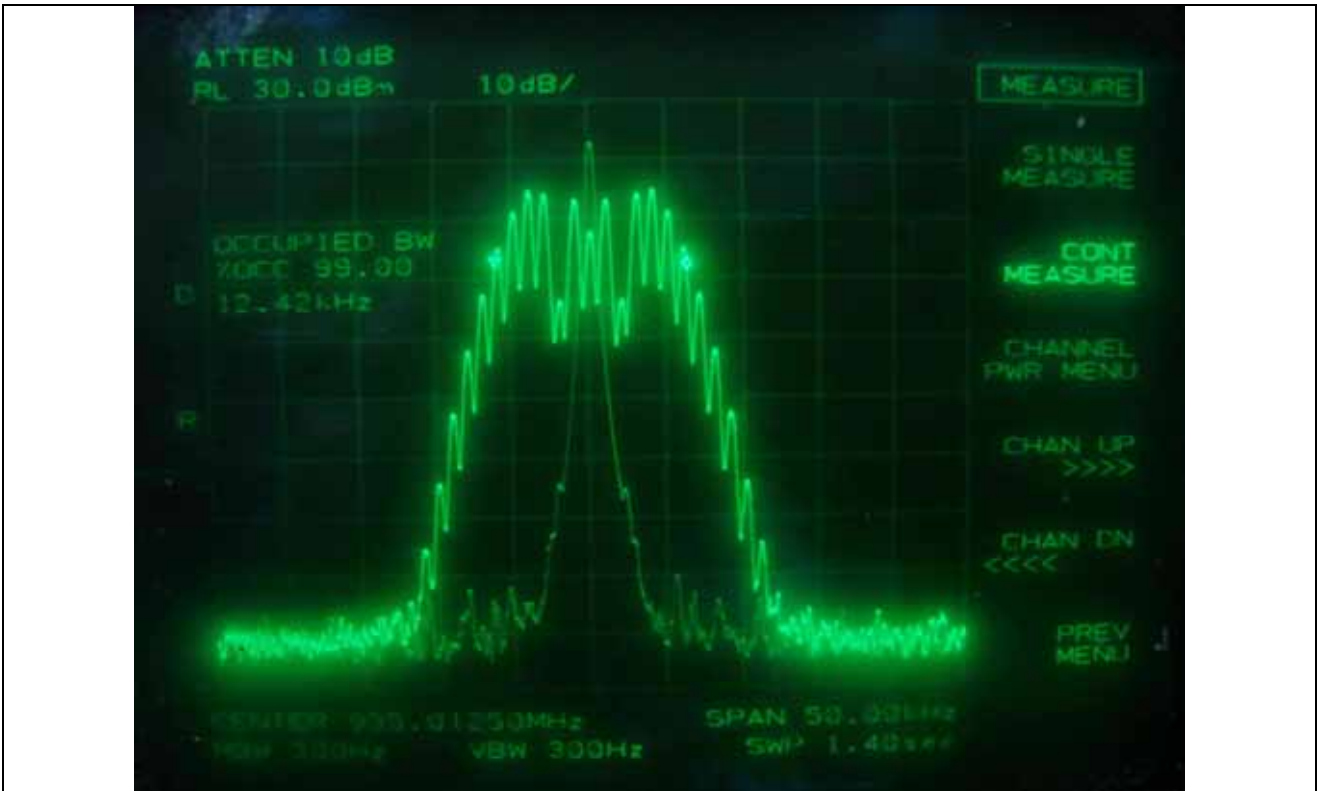
iDEN – Occupied Bandwidth (Low Channel)



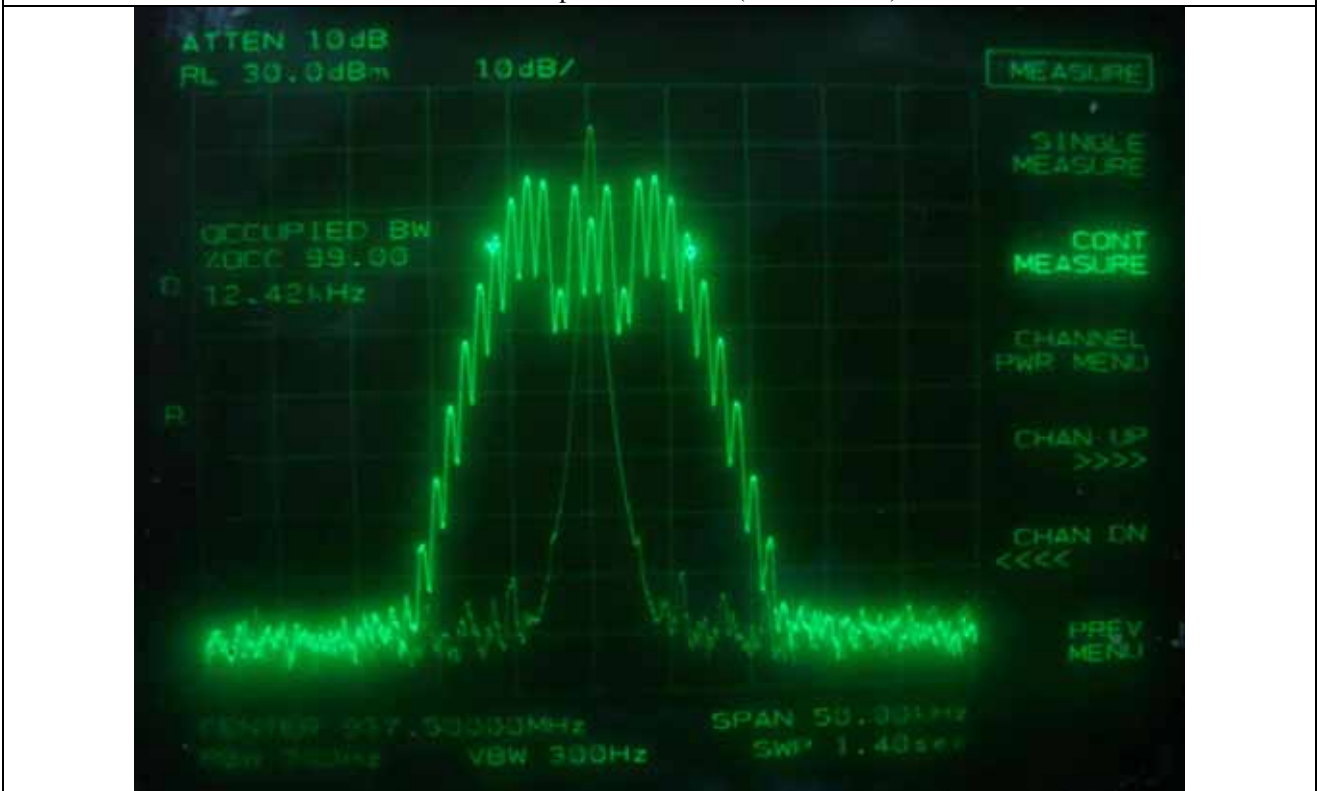
iDEN – Occupied Bandwidth (Middle Channel)



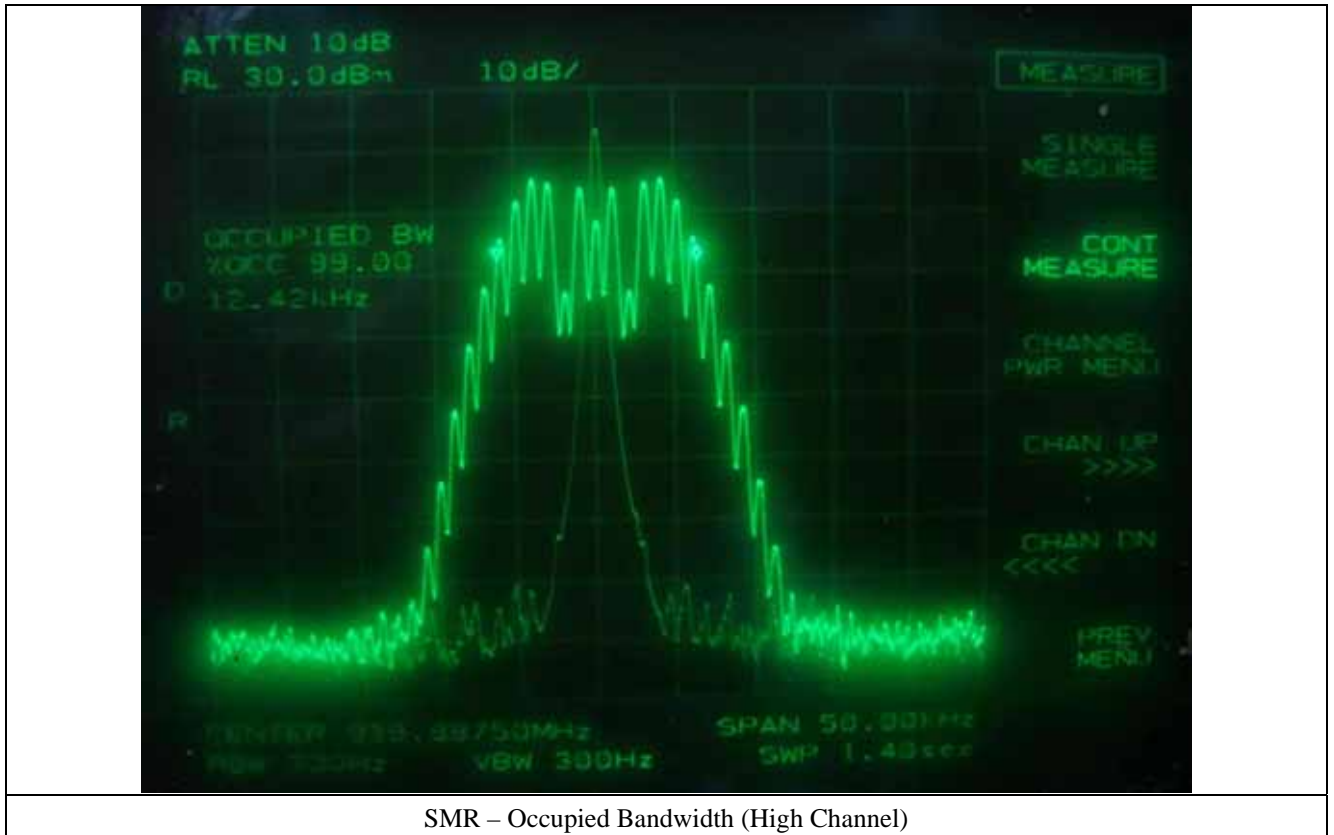
iDEN – Occupied Bandwidth (High Channel)

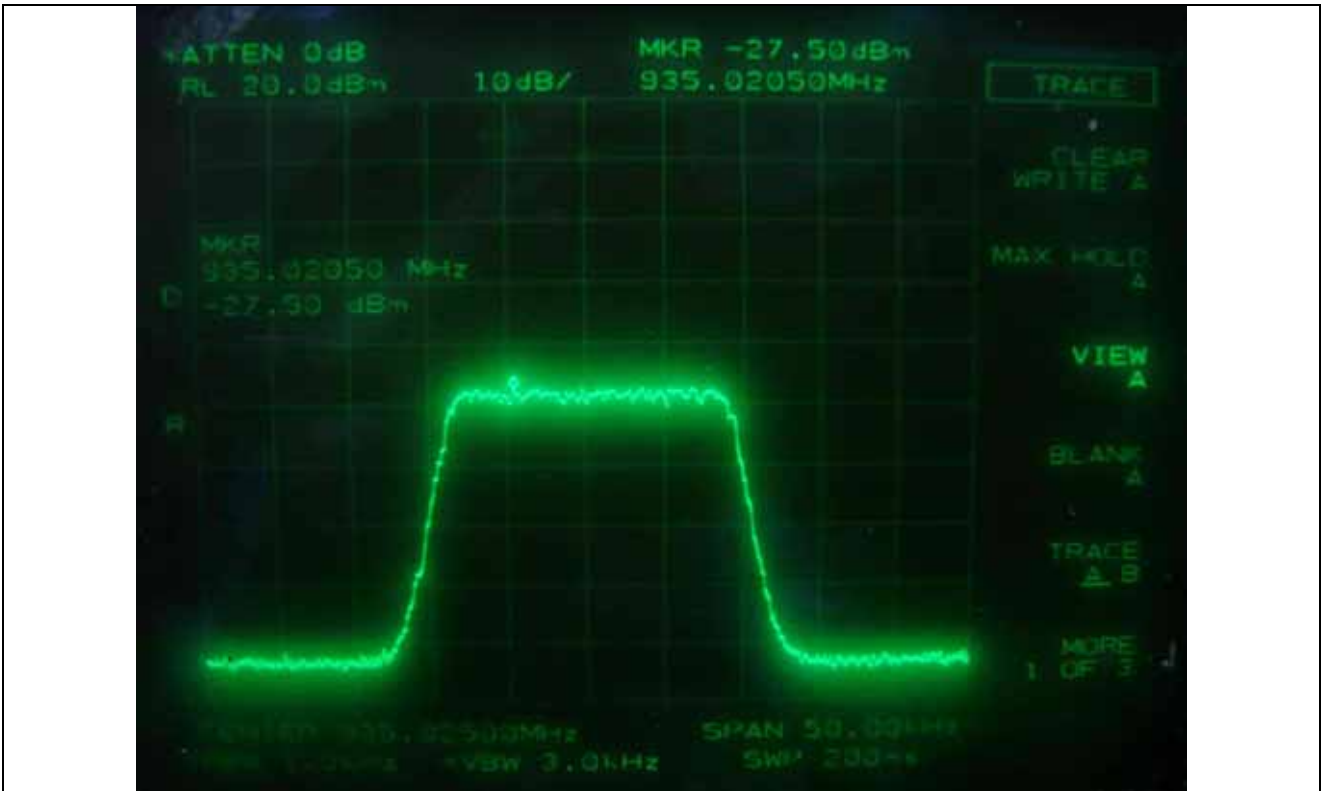


SMR – Occupied Bandwidth (Low Channel)

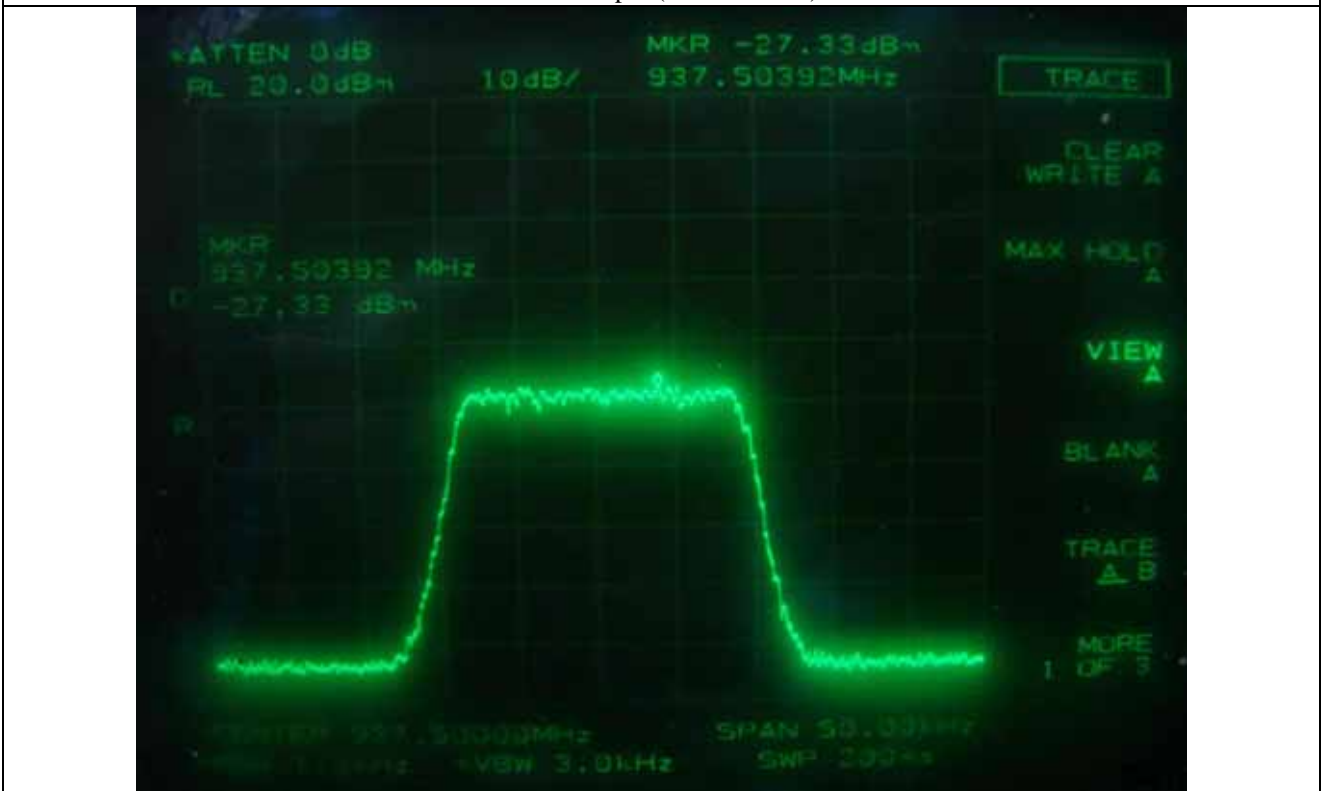


SMR – Occupied Bandwidth (Middle Channel)

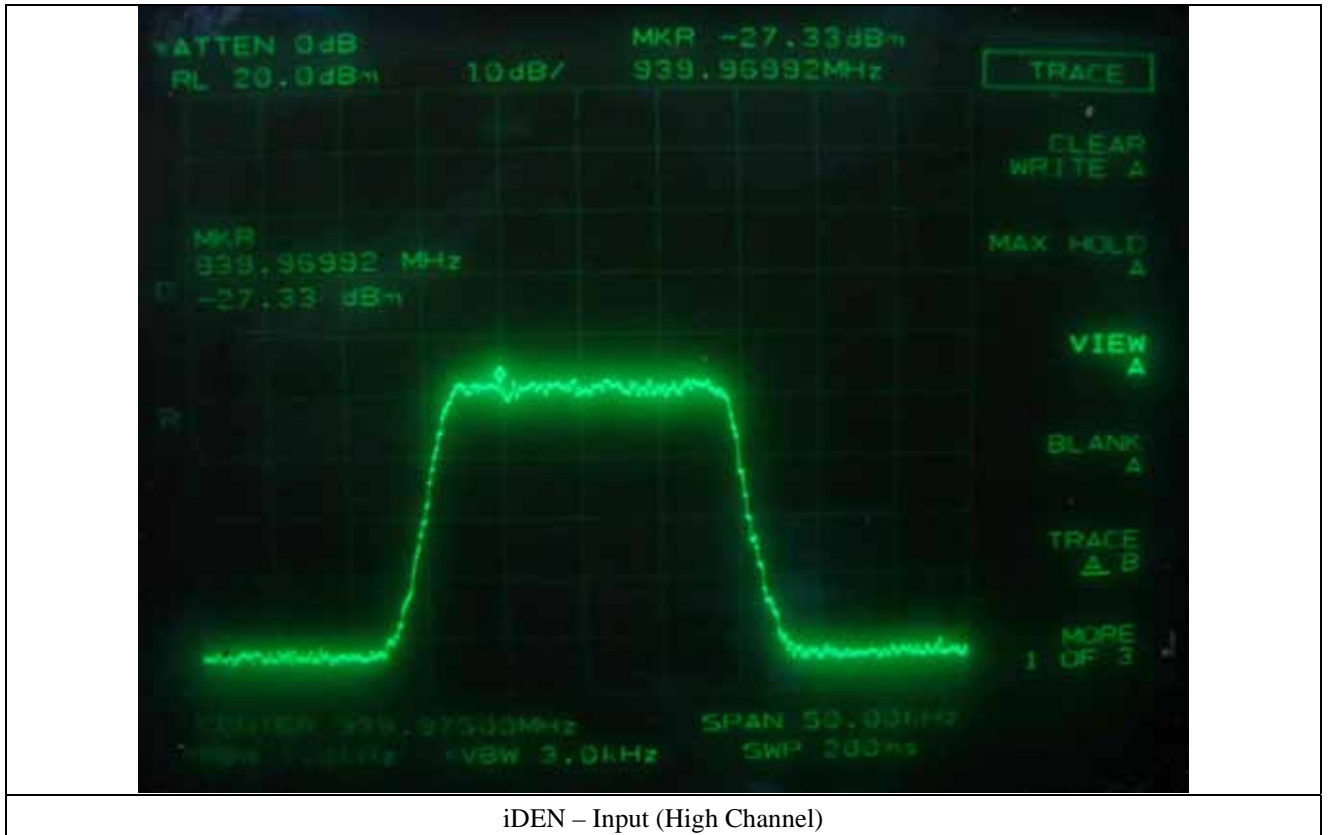




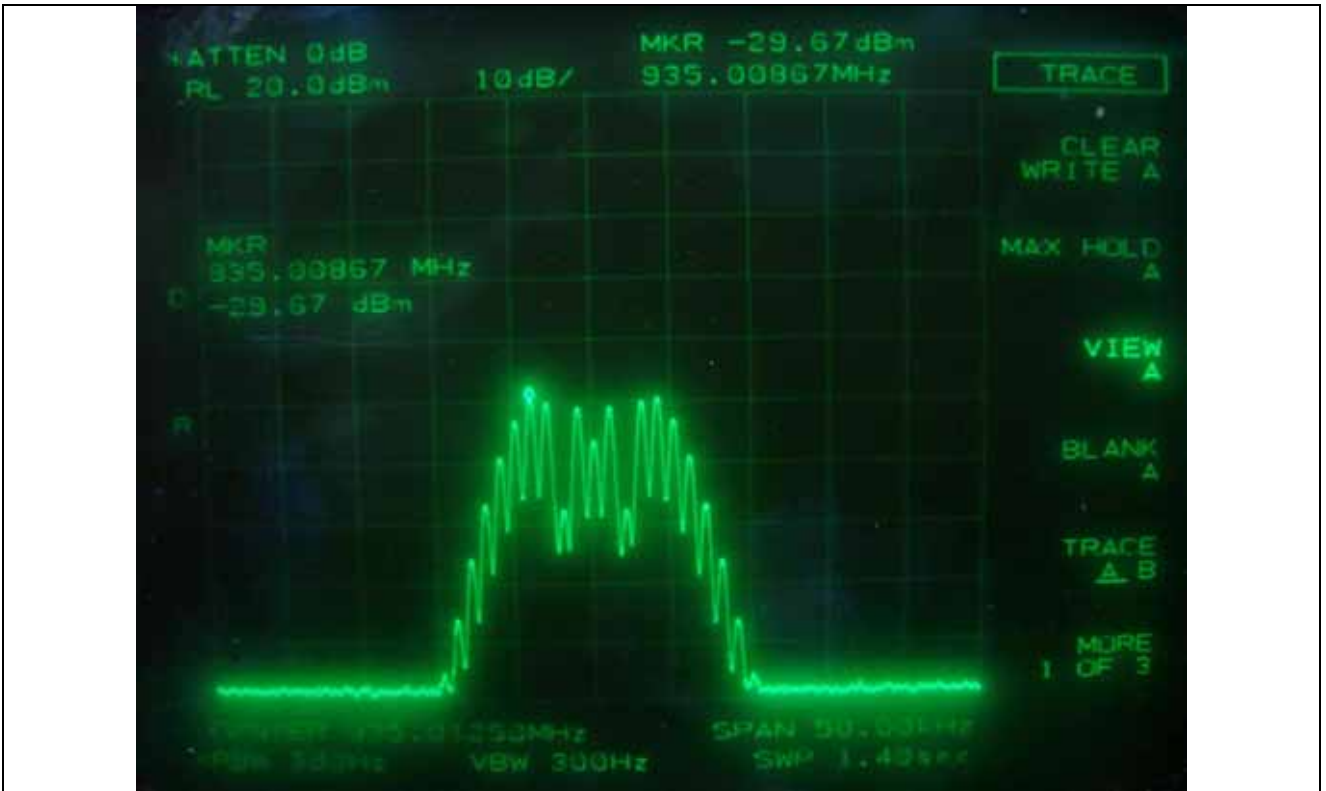
iDEN – Input (Low Channel)



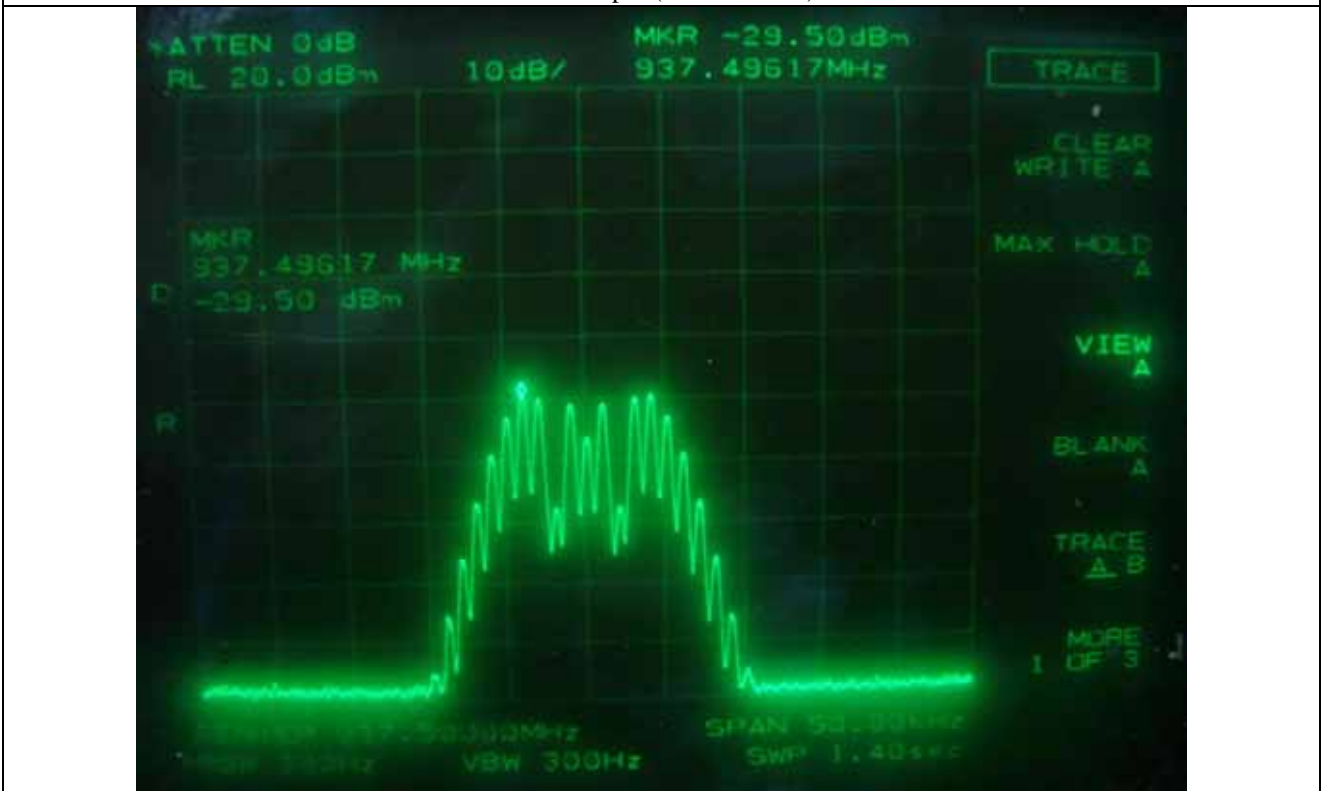
iDEN – Input (Middle Channel)



iDEN – Input (High Channel)



SMR – Input (Low Channel)



SMR – Input (Middle Channel)



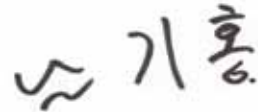
SMR - Input (High Channel)

6.4.4 Test Result for 900I+PA (940 MHz ~ 941 MHz)

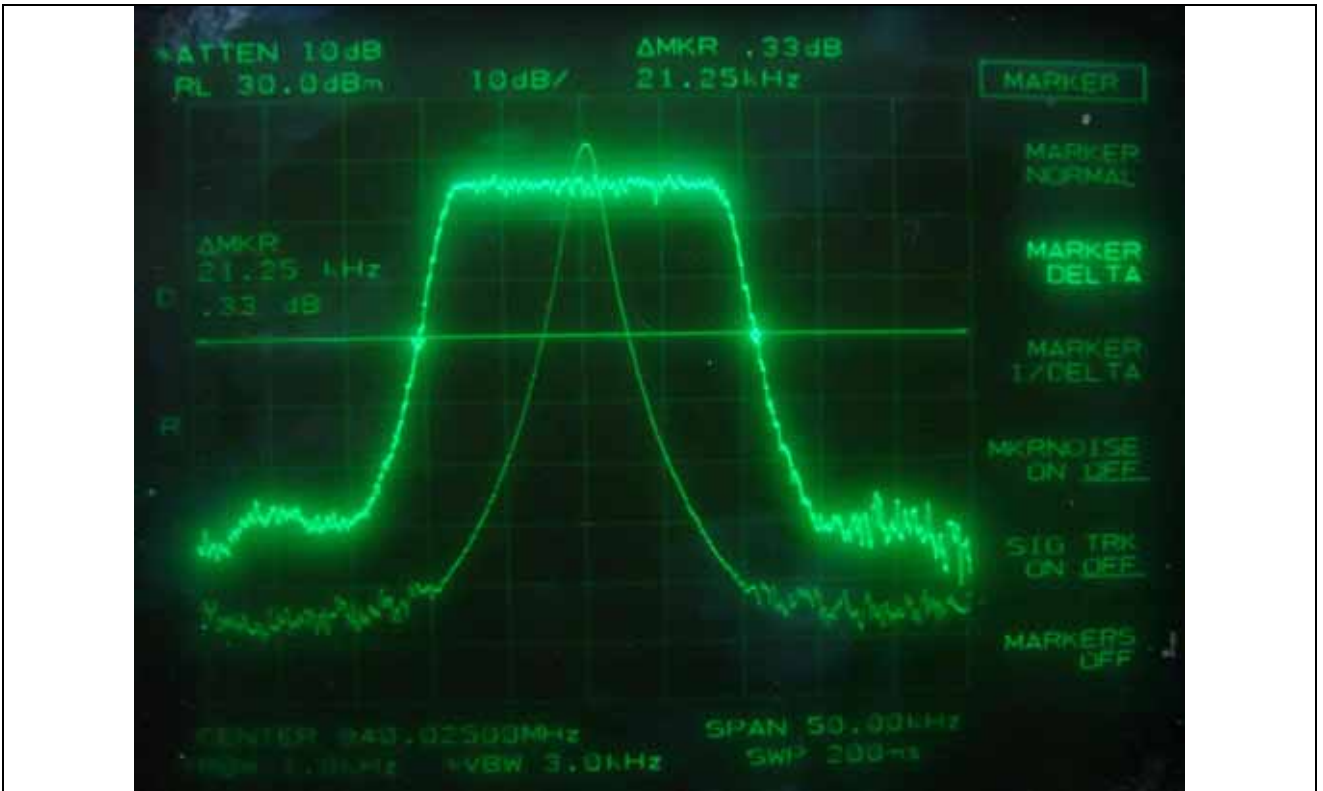
-. Test Date : March 10~11, 2009
-. Test Result : Pass

Modulation	Channel	26 dB Bandwidth (kHz)	99 % Occupied Bandwidth (kHz)
iDEN	Low	8.65	7.70
	Middle	8.65	7.70
	High	8.65	7.70
SMR	Low	21.25	18.33
	Middle	21.25	18.42
	High	21.25	18.25

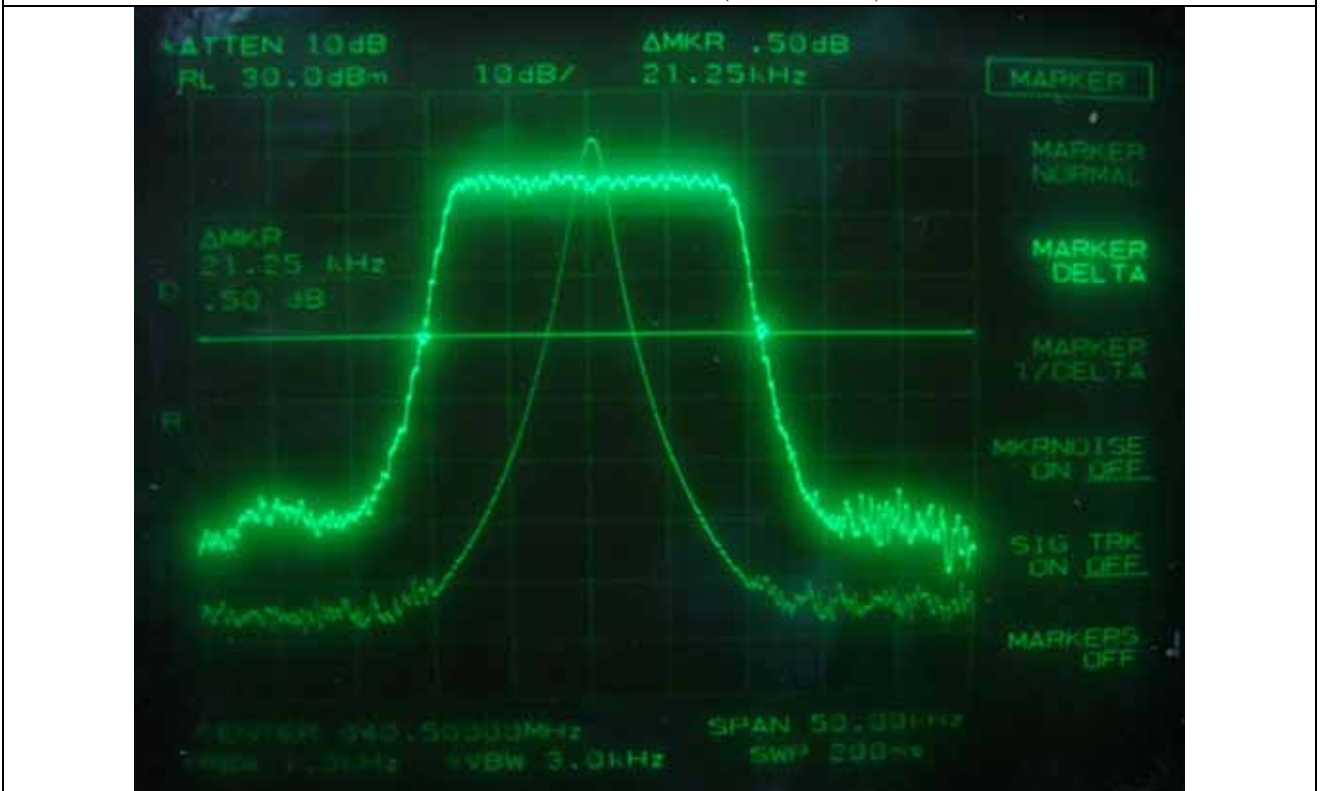
Remark: According to above result, the carrier frequency shall be within the frequency block edges.



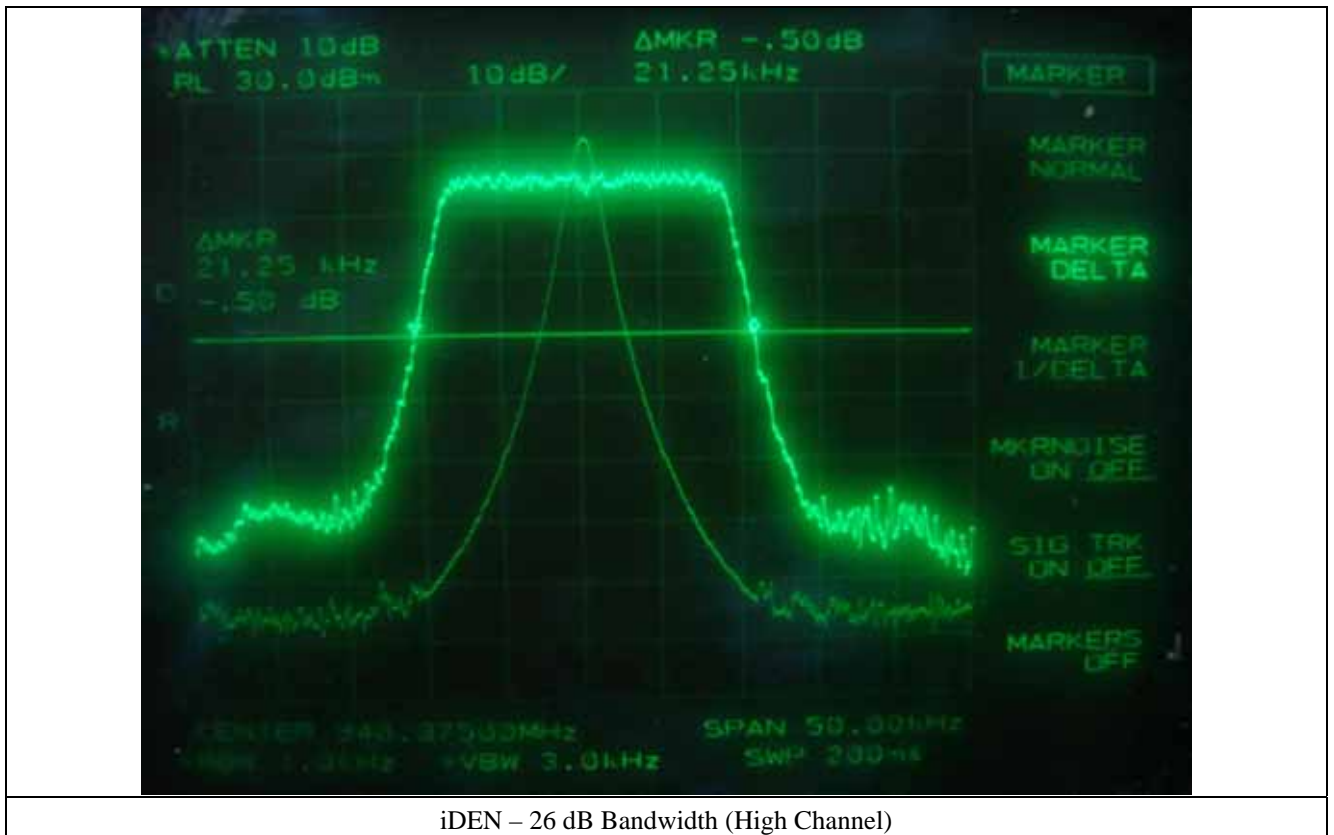
Tested by: Ki-Hong, Nam / Project Engineer

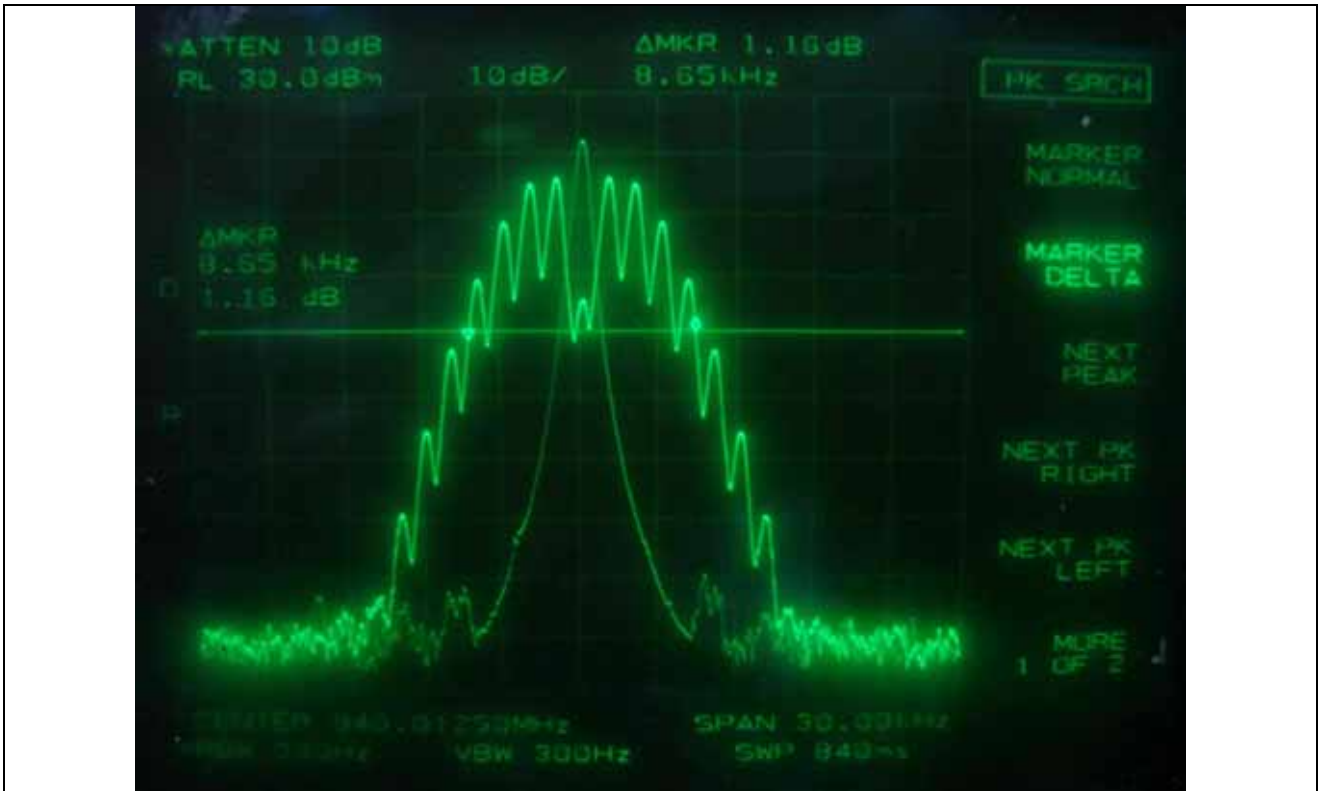


iDEN – 26 dB Bandwidth (Low Channel)

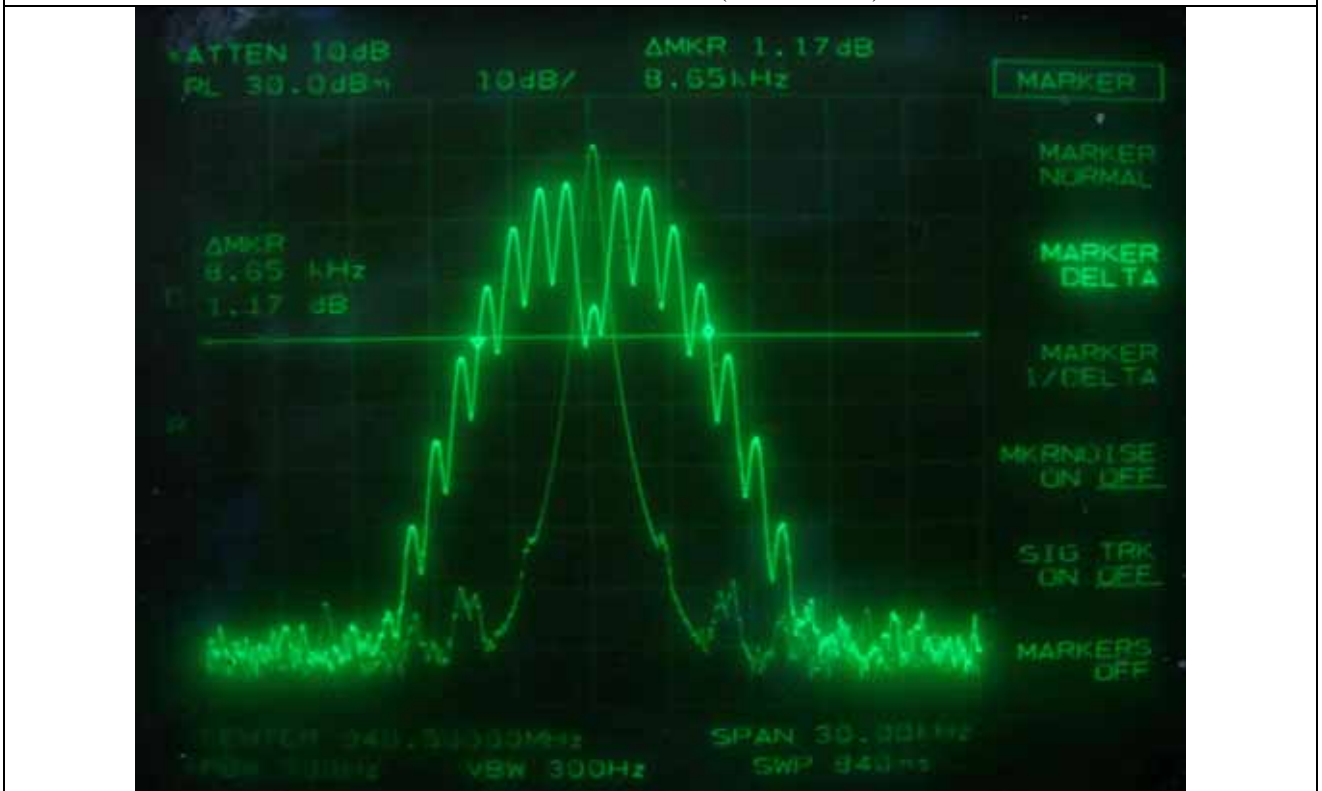


iDEN – 26 dB Bandwidth (Middle Channel)

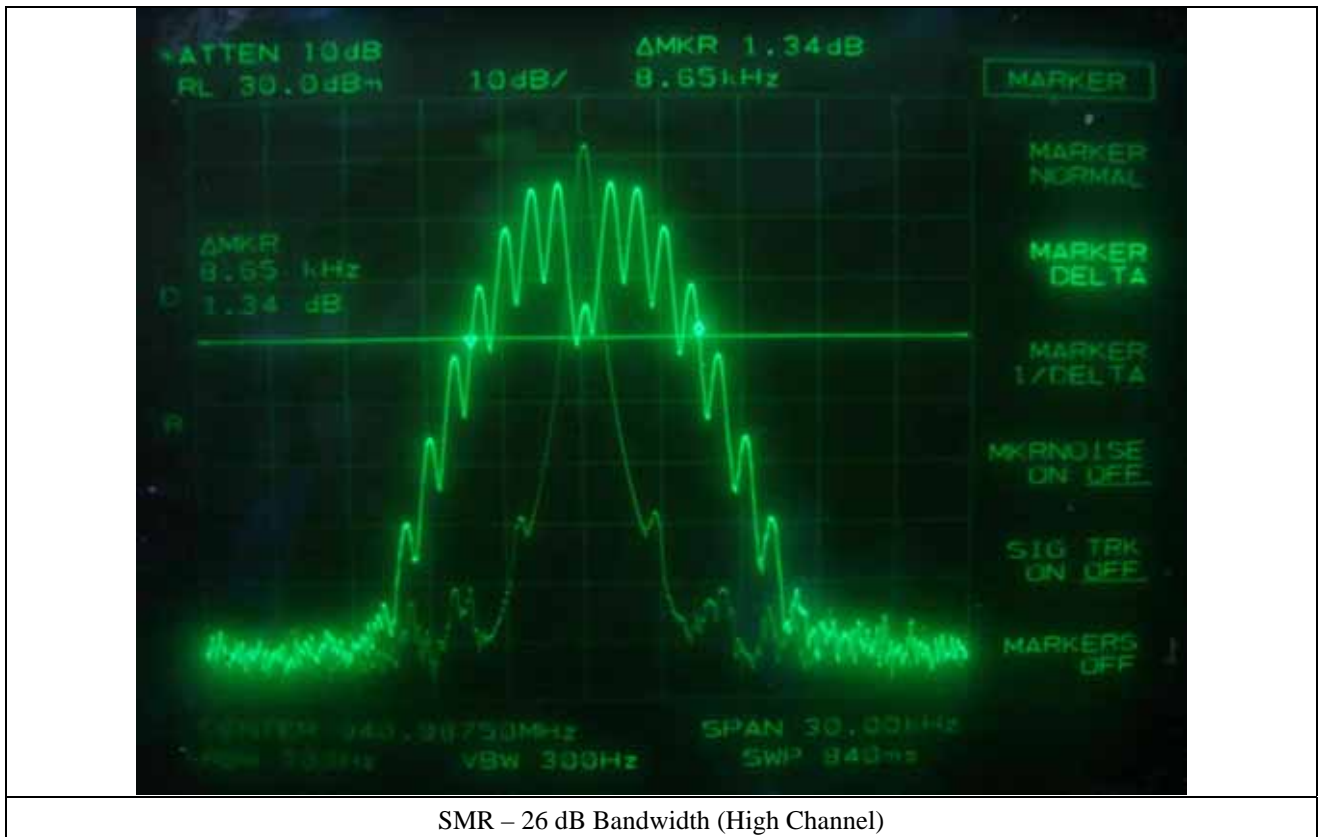


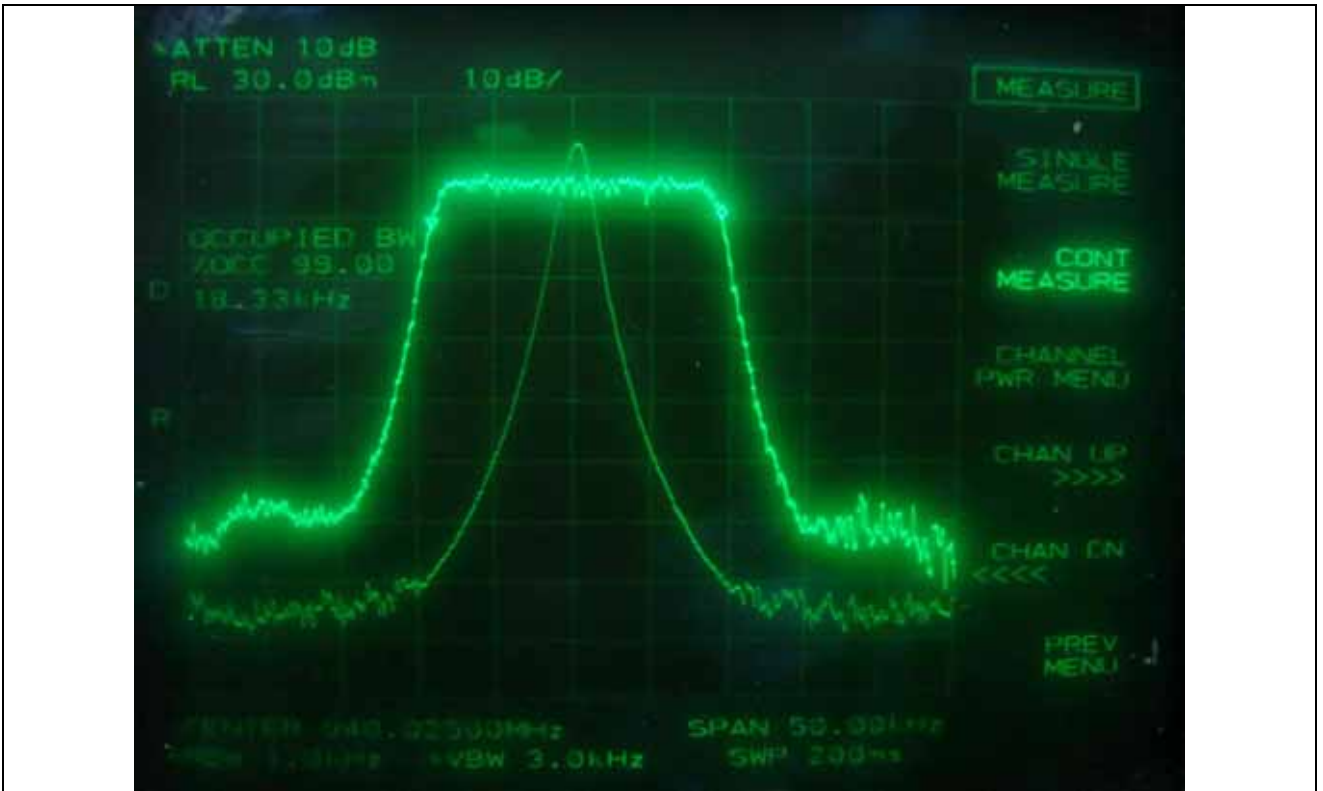


SMR – 26 dB Bandwidth (Low Channel)

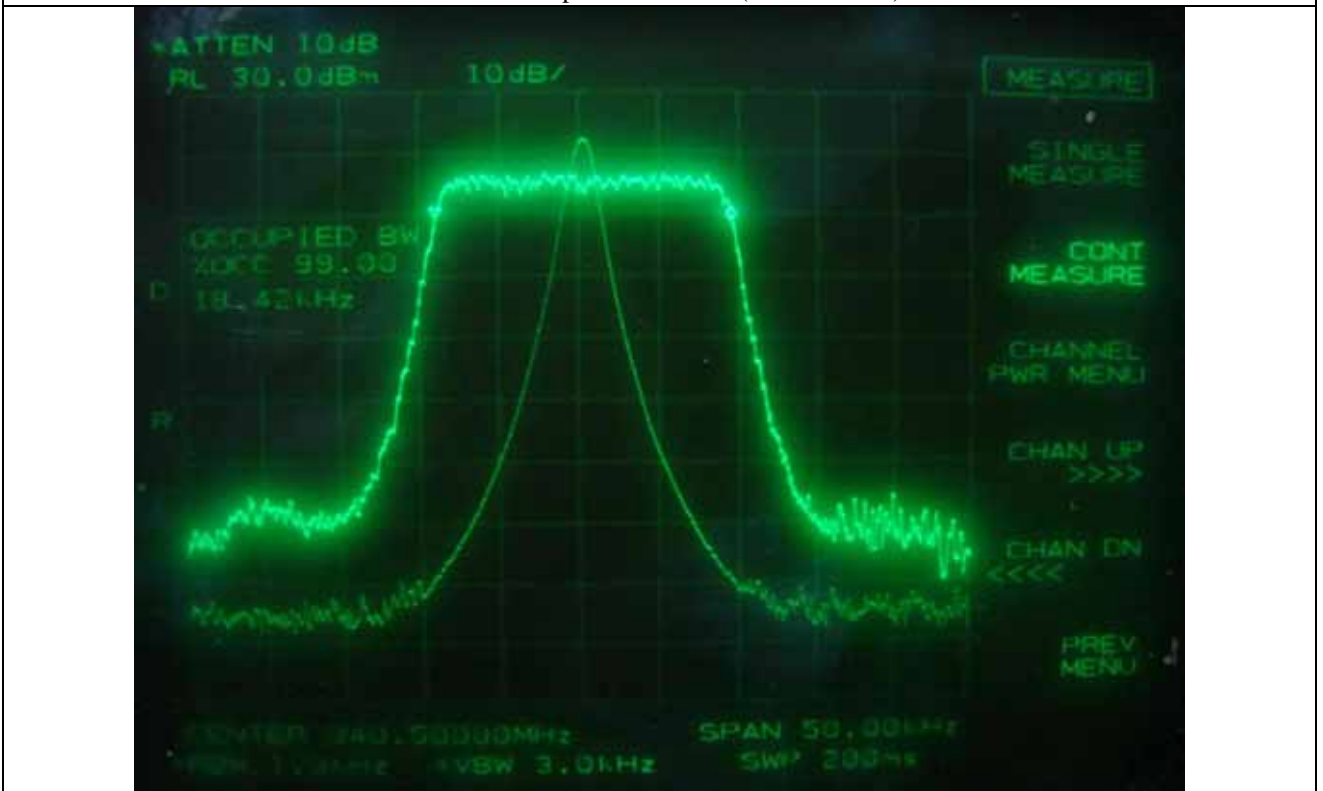


SMR – 26 dB Bandwidth (Middle Channel)

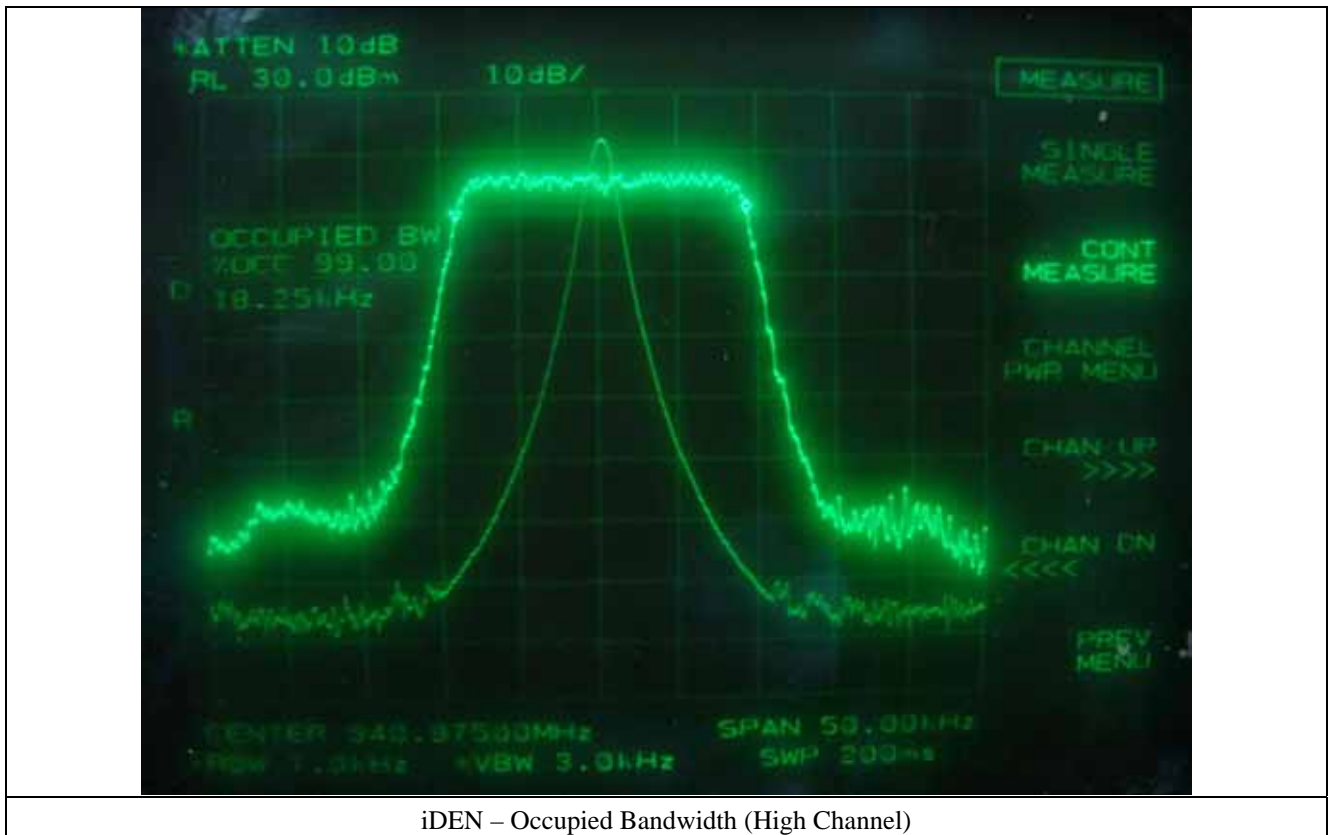




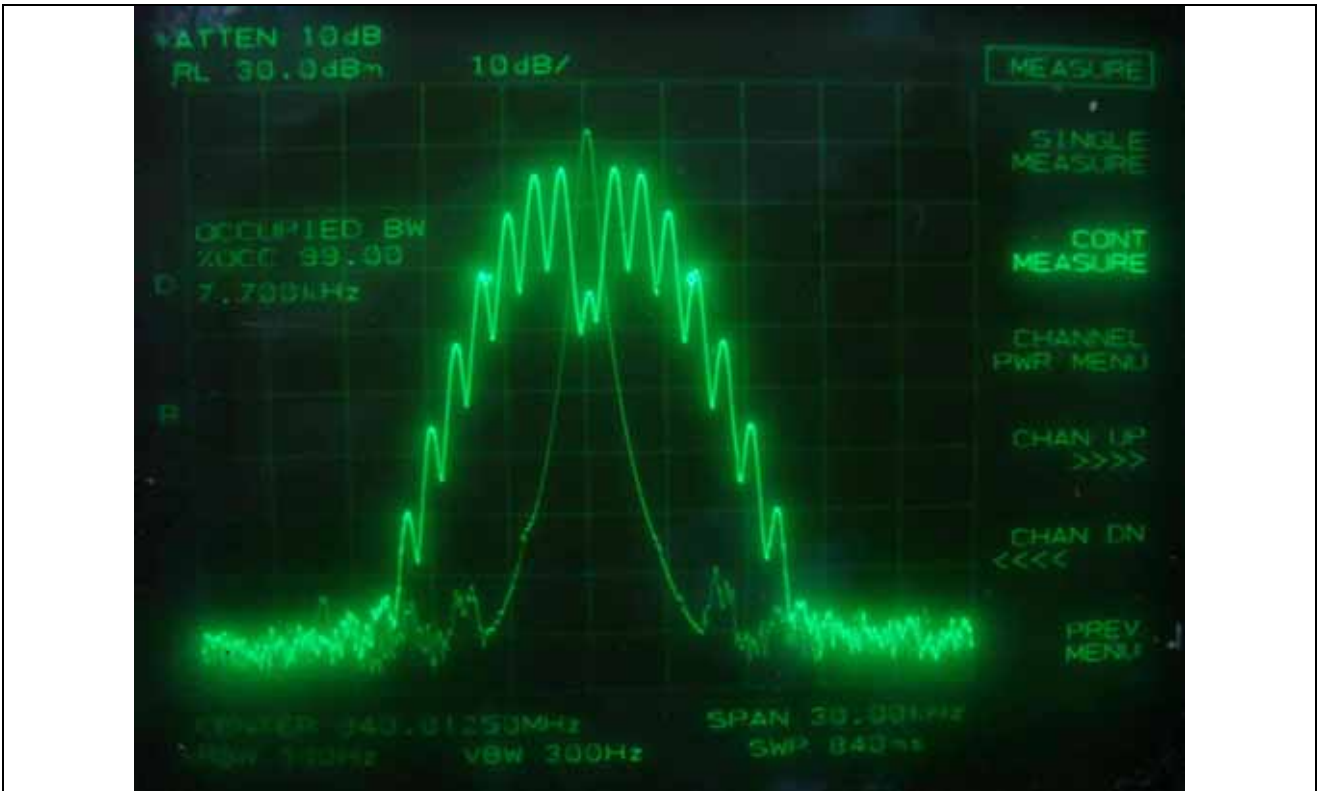
iDEN – Occupied Bandwidth (Low Channel)



iDEN – Occupied Bandwidth (Middle Channel)



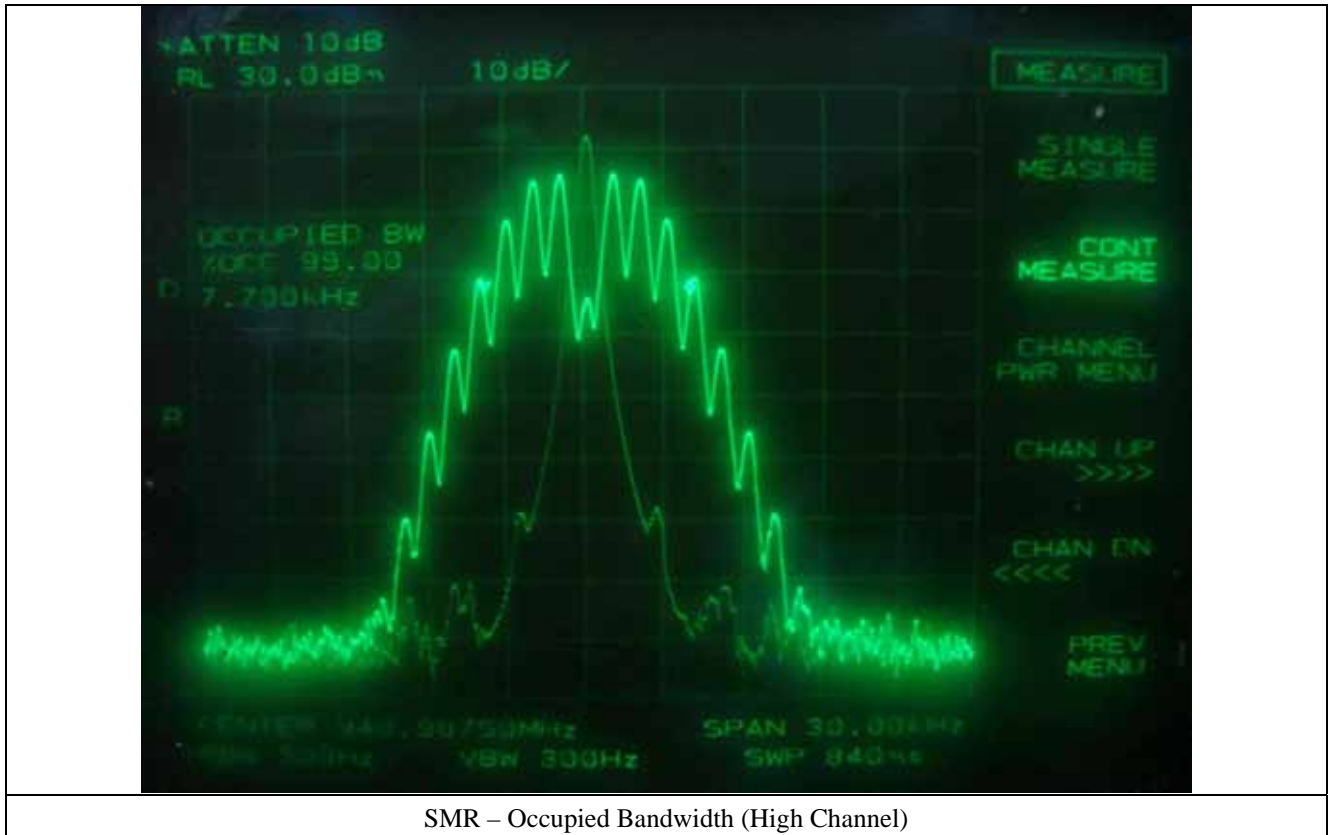
iDEN – Occupied Bandwidth (High Channel)

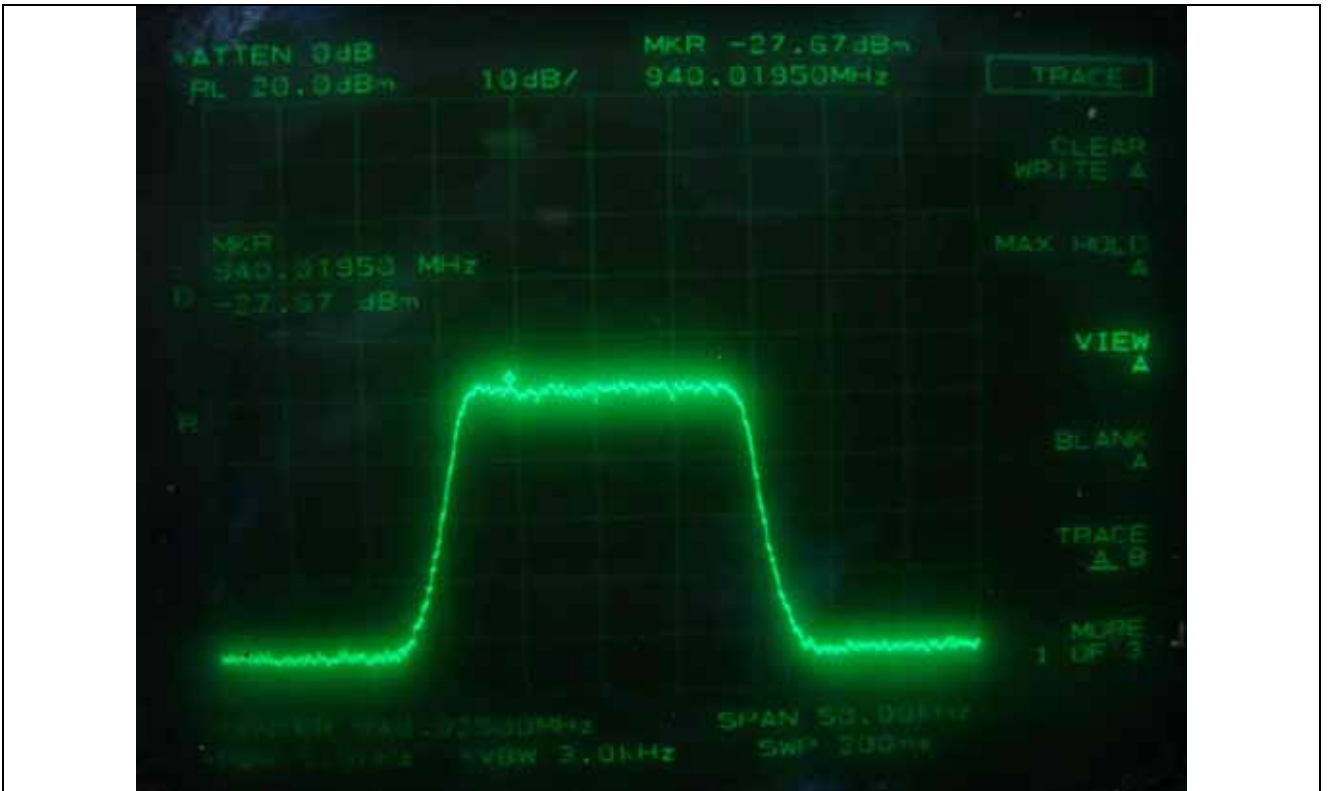


SMR – Occupied Bandwidth (Low Channel)

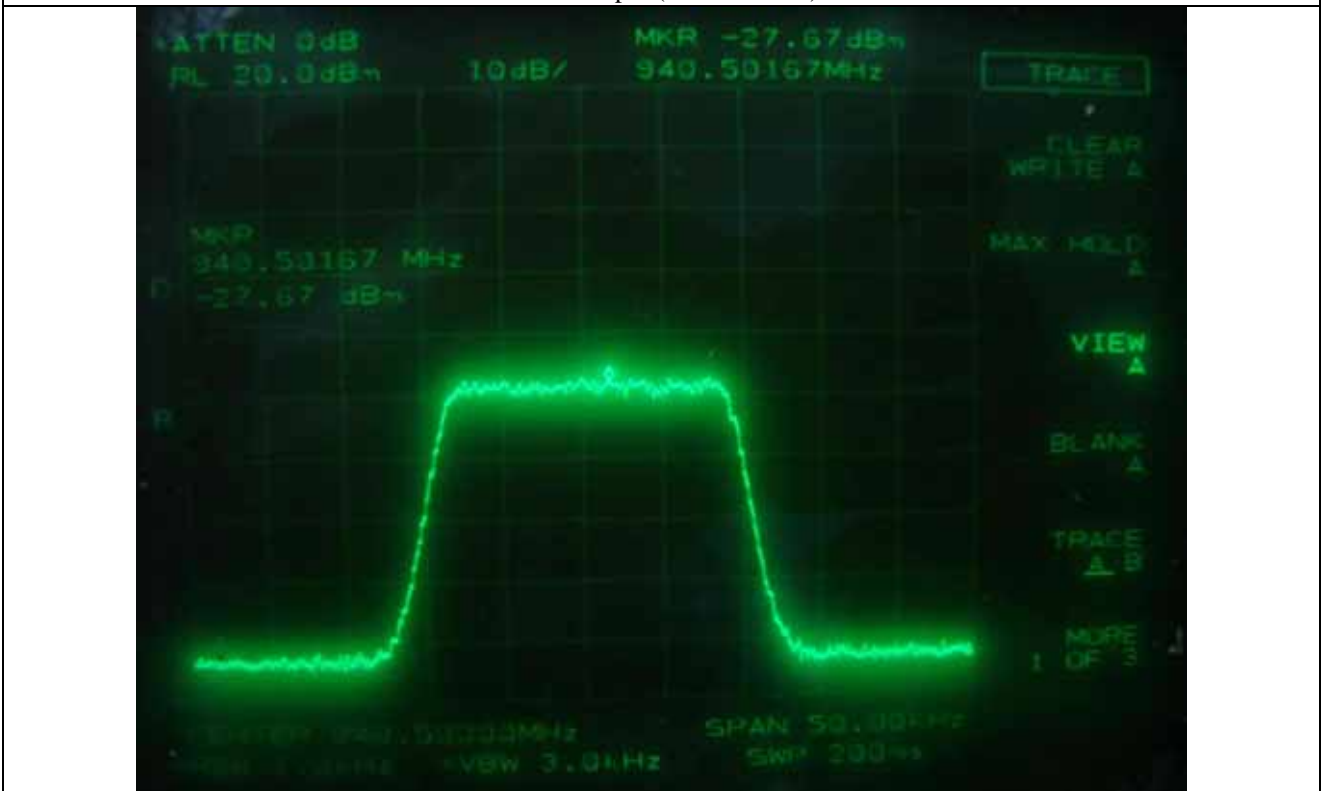


SMR – Occupied Bandwidth (Middle Channel)

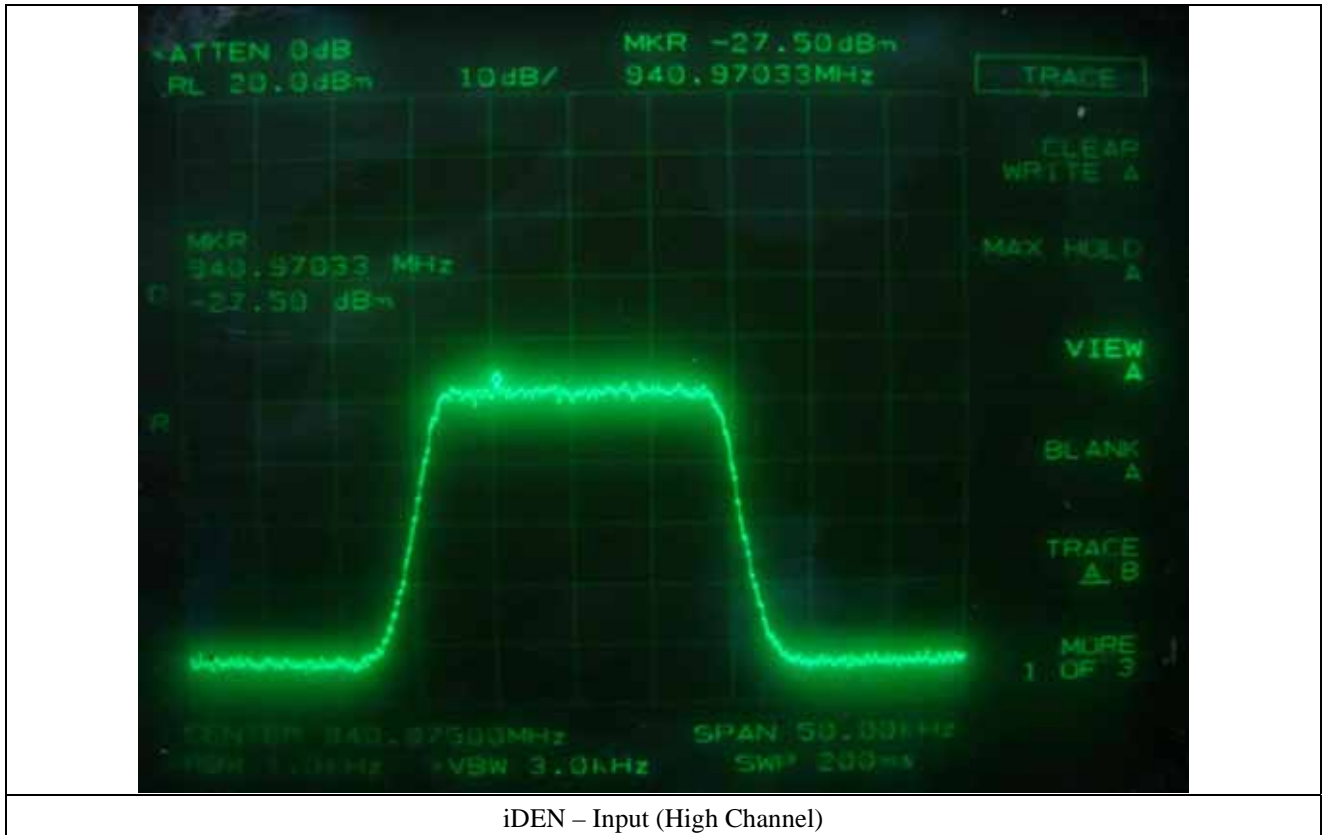




iDEN – Input (Low Channel)



iDEN – Input (Middle Channel)

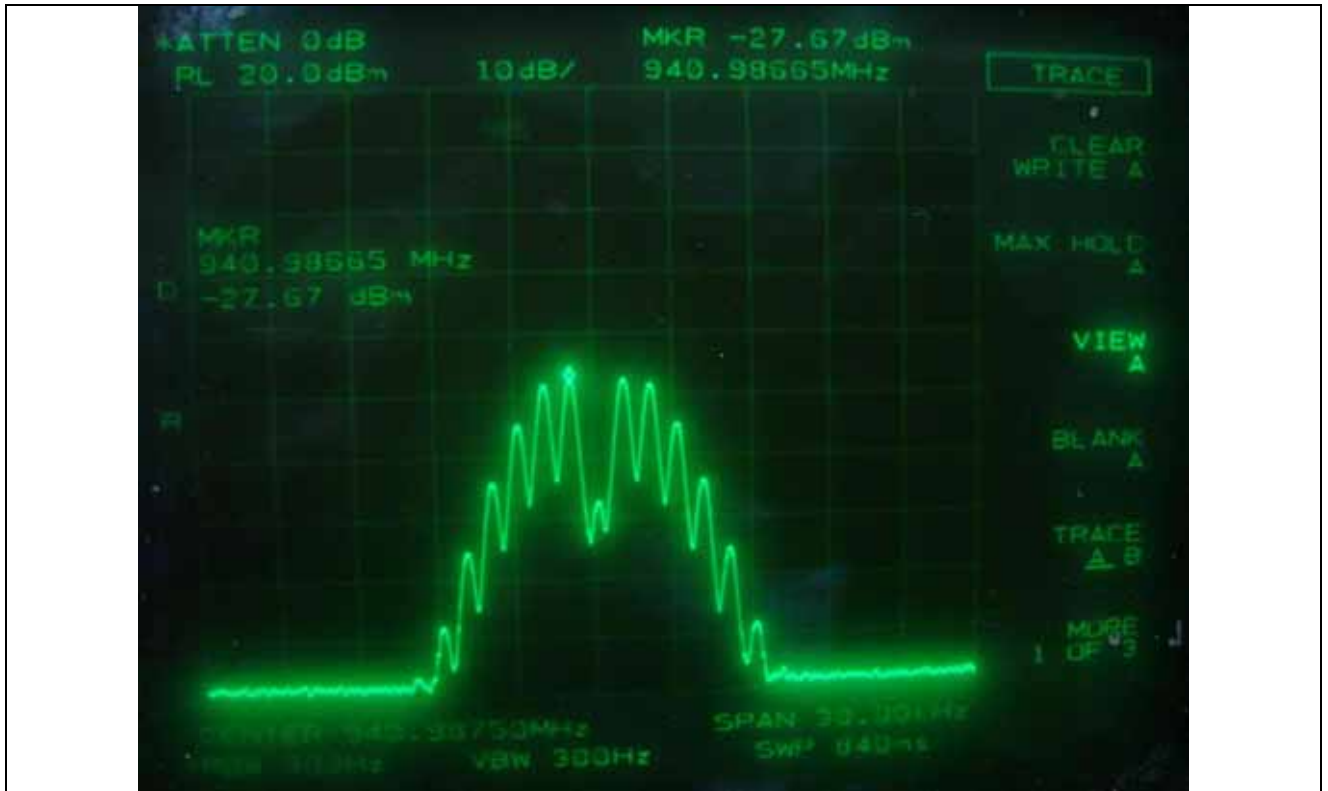




SMR – Input (Low Channel)



SMR – Input (Middle Channel)



SMR – Input (High Channel)

7. SPURIOUS EMISSION AT ANTENNA TERMINAL

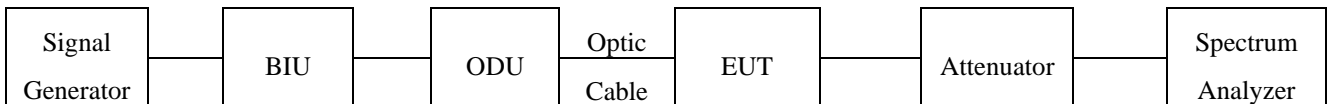
7.1 Operating environment

Temperature : 21.8 °C
Relative humidity : 47.4 %R.H.

7.2 Test set-up for conducted measurement

The RF signal from the signal generator(s) was injected to BIU (BTS Interface Unit) and then output signal from the BIU was injected to the input of ODU (Optic Distribution Unit) by coaxial cable and then the output port of the ODU was connected to the input of the EUT by optic cable. The amplified RF signal at the output of the EUT was connected to the spectrum analyzer. The test was performed at three frequencies (low, middle, and high channels) at each band using all applicable modulation.

The resolution bandwidth and video bandwidth of the spectrum analyzer was set at 1 MHz and sufficient scans were taken to show any out of band emissions up to 20 GHz.



7.3 Test equipment used

Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ - 8564E	HP	Spectrum Analyzer	3650A00756	June 16, 2008
■ - E4432B	HP	Signal Generator	US38440950	June 16, 2008
■ - SMJ100A	R/S	Vecter Signal Generator	100698	June 16, 2008
□ - FSP	R/S	Spectrum Analyzer	100017	Mar. 11, 2009

All test equipment used is calibrated on a regular basis.

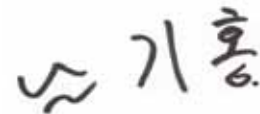
7.4 Test data

7.4.1 Test Result for 800PS

- . Test Date : March 10~11, 2009
- . Frequency range : 30 MHz ~ 20 GHz
- . Result : PASSED BY -14.49 dB at low channel of iDEN Mode

Modulation	Harmonic Frequency (MHz)	Measured Value (dBm)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)	
iDEN	Low	937.00	-37.50	0.50	-37.00	-13.00	-24.00
		2 110.00	-28.33	0.84	-27.49		-14.49
	Middle	940.20	-39.17	0.50	-38.67		-25.67
		2 110.00	-28.83	0.84	-27.99		-14.99
	High	933.70	-39.67	0.50	-39.17		-26.17
		2 110.00	-29.00	0.84	-28.16		-15.16
SMR	Low	930.50	-38.67	0.50	-38.17	-13.00	-25.17
		2 060.00	-29.00	0.84	-28.16		-15.16
	Middle	930.00	-39.83	0.50	-39.33		-26.33
		2 110.00	-29.33	0.84	-28.49		-15.49
	High	927.30	-39.50	0.50	-39.00		-26.00
		2 110.00	-29.83	0.84	-28.99		-15.99

According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0 dBm.



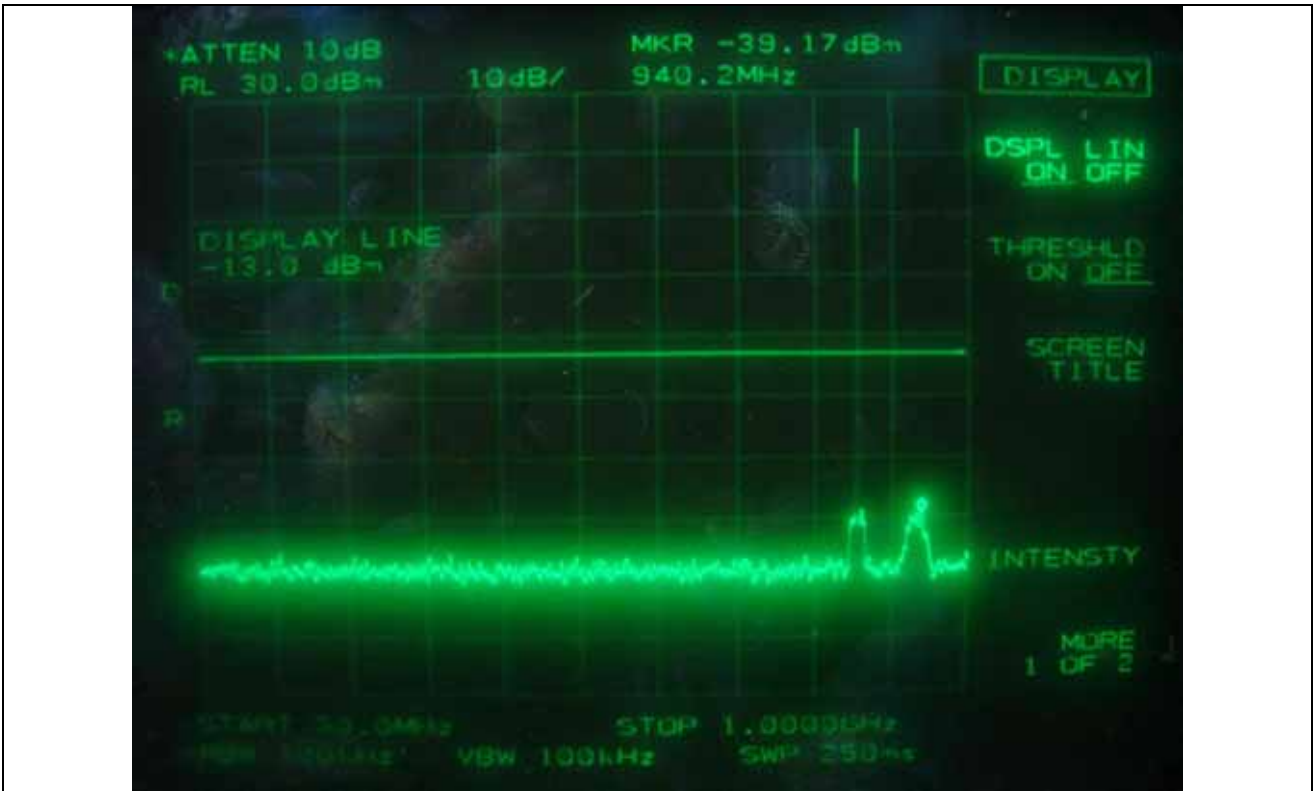
Tested by: Ki-Hong, Nam / Project Engineer



iDEN – Low Channel



iDEN – Low Channel



iDEN – Middle Channel



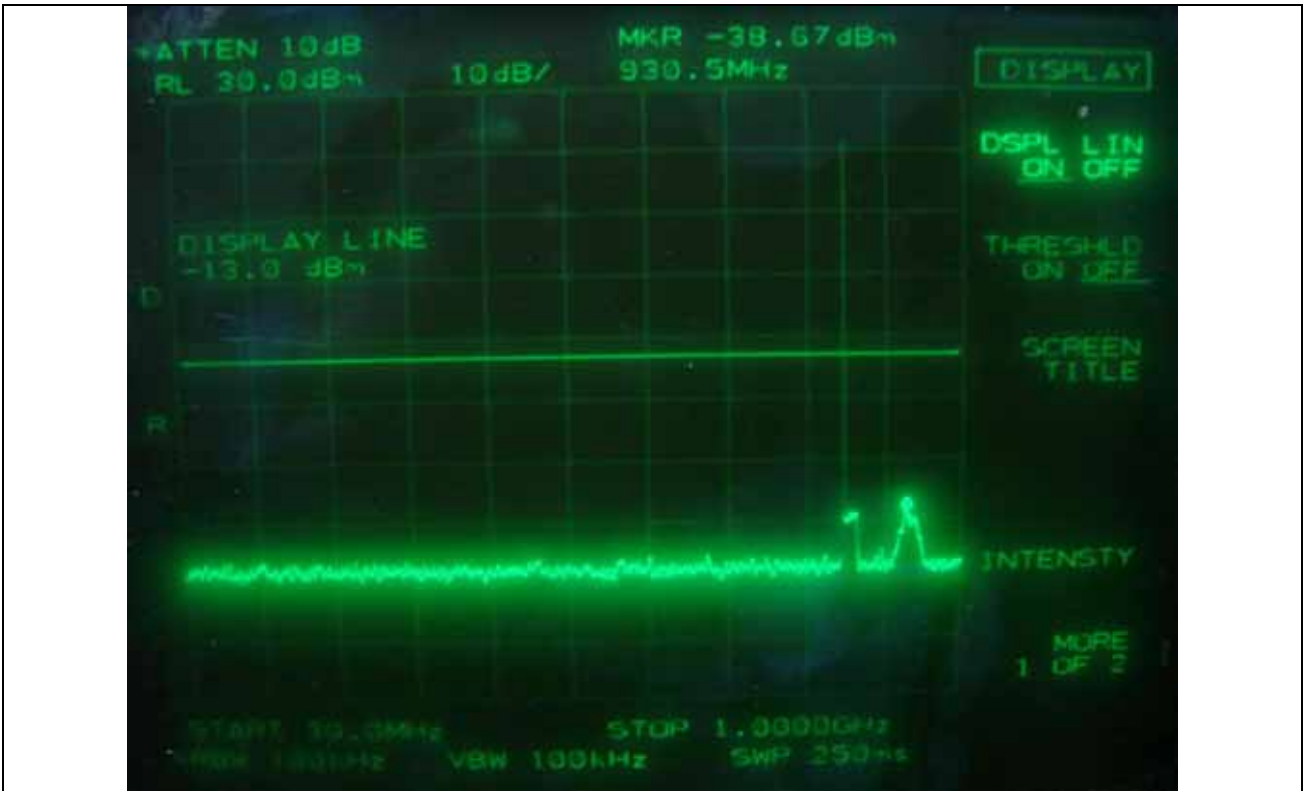
iDEN – Middle Channel



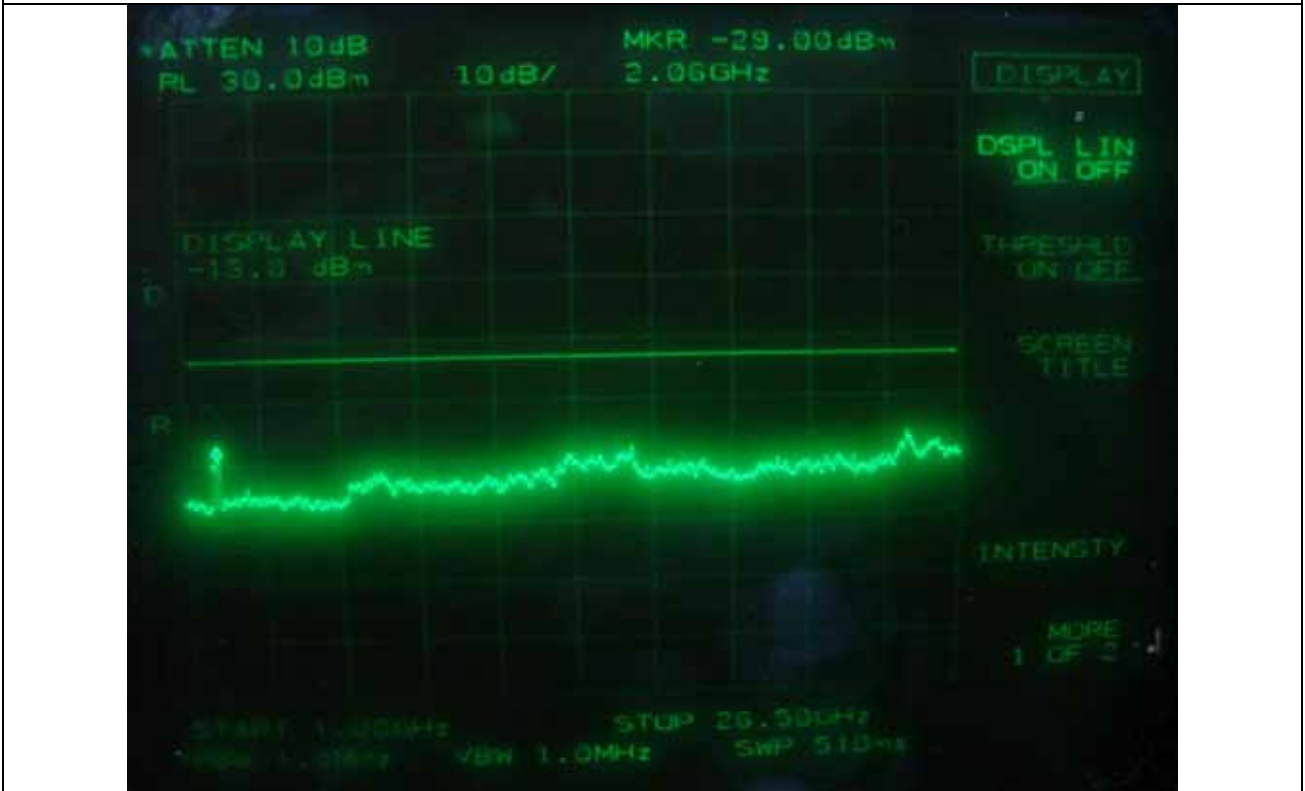
iDEN – High Channel



iDEN – High Channel



SMR – Low Channel



SMR – Low Channel



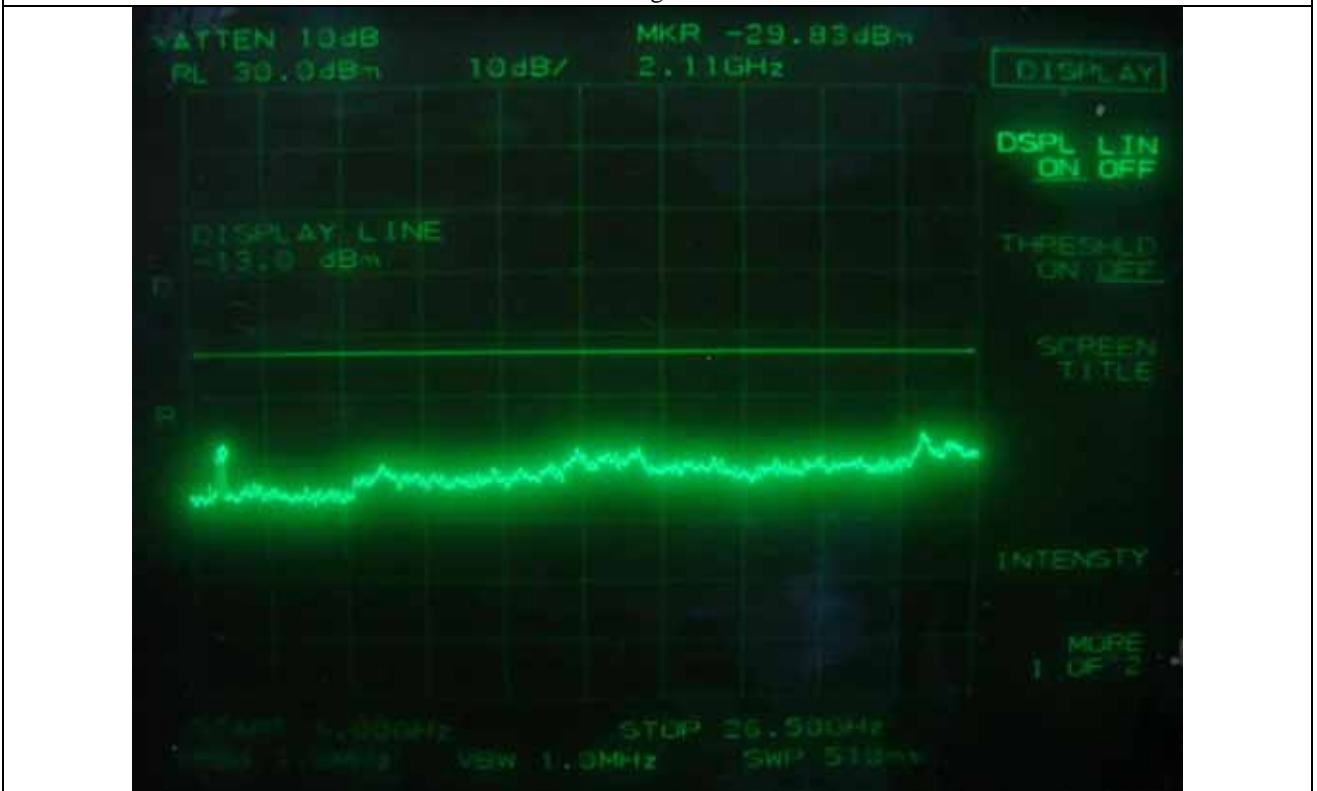
SMR – Middle Channel



SMR – Middle Channel



SMR – High Channel



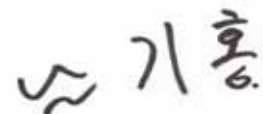
SMR – High Channel

7.4.2 Test Result for 900I+PA (929 MHz ~ 930 MHz)

- . Test Date : March 10~11, 2009
- . Frequency range : 30 MHz ~ 20 GHz
- . Result : PASSED BY -14.49 dB at low channel of iDEN Mode

Modulation	Harmonic Frequency (MHz)		Measured Value (dBm)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
iDEN	Low	851.30	-38.83	0.50	-38.33	-13.00	-25.33
		2 110.00	-29.33	0.84	-28.49		-15.49
	Middle	862.60	-38.17	0.50	-37.67		-24.67
		2 110.00	-29.67	0.84	-28.83		-15.83
	High	864.20	-38.67	0.50	-38.17		-25.17
		2 110.00	-29.83	0.84	-28.99		-15.99
SMR	Low	867.40	-38.00	0.50	-37.50	-13.00	-24.50
		2 110.00	-29.83	0.84	-28.99		-15.99
	Middle	865.80	-39.17	0.50	-38.67		-25.67
		2 110.00	-29.67	0.84	-28.83		-15.83
	High	856.10	-38.50	0.50	-38.00		-25.00
		2 060.00	-29.33	0.84	-28.49		-15.49

According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0 dBm.



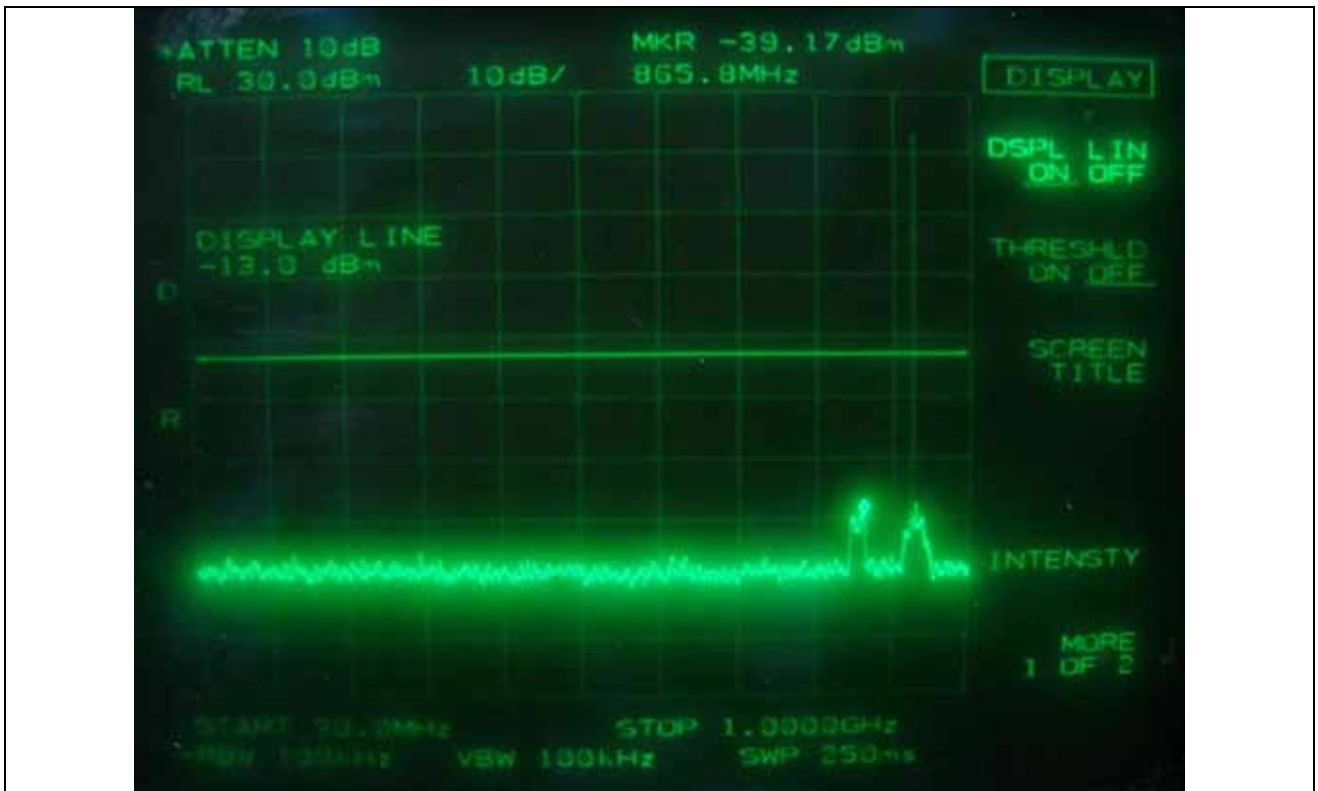
Tested by: **Ki-Hong, Nam / Project Engineer**



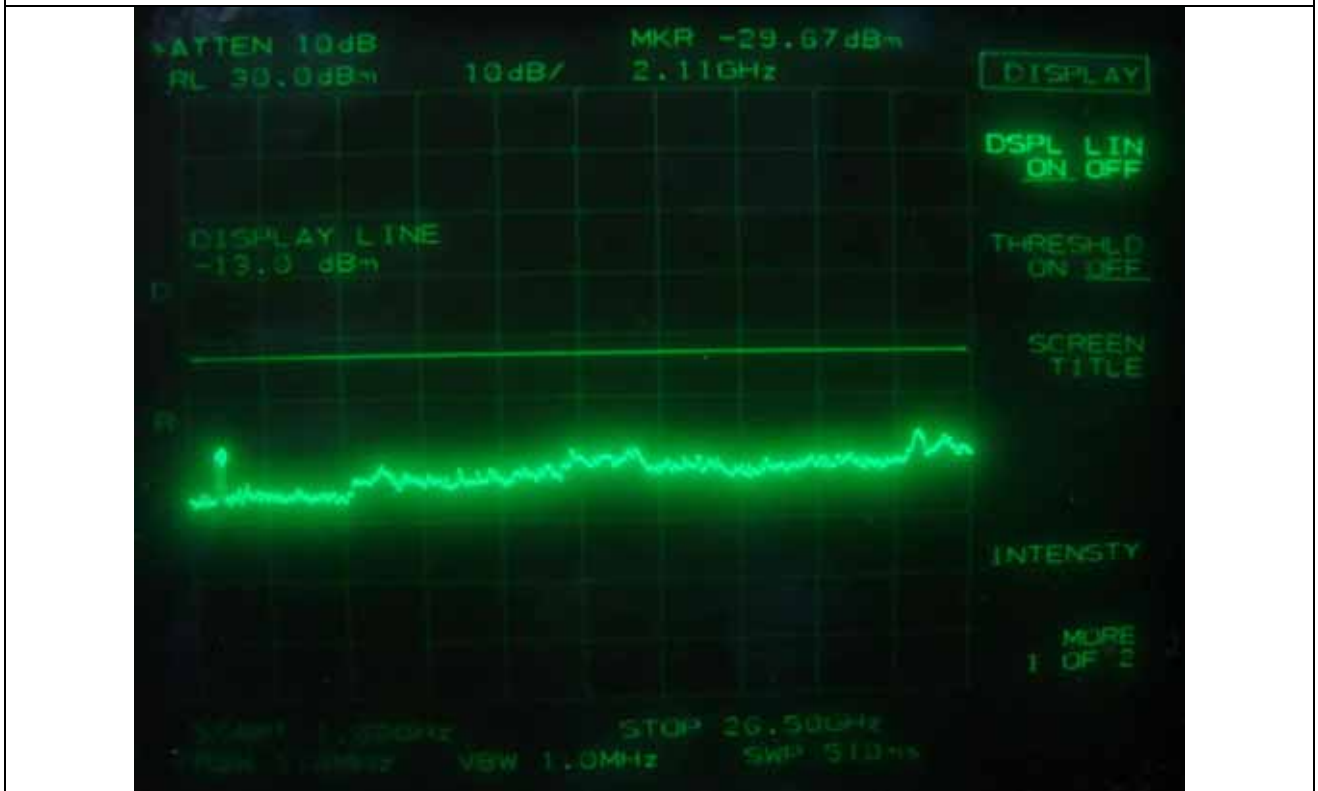
iDEN - Low Channel



iDEN - Low Channel



iDEN – Middle Channel



iDEN – Middle Channel



iDEN – High Channel



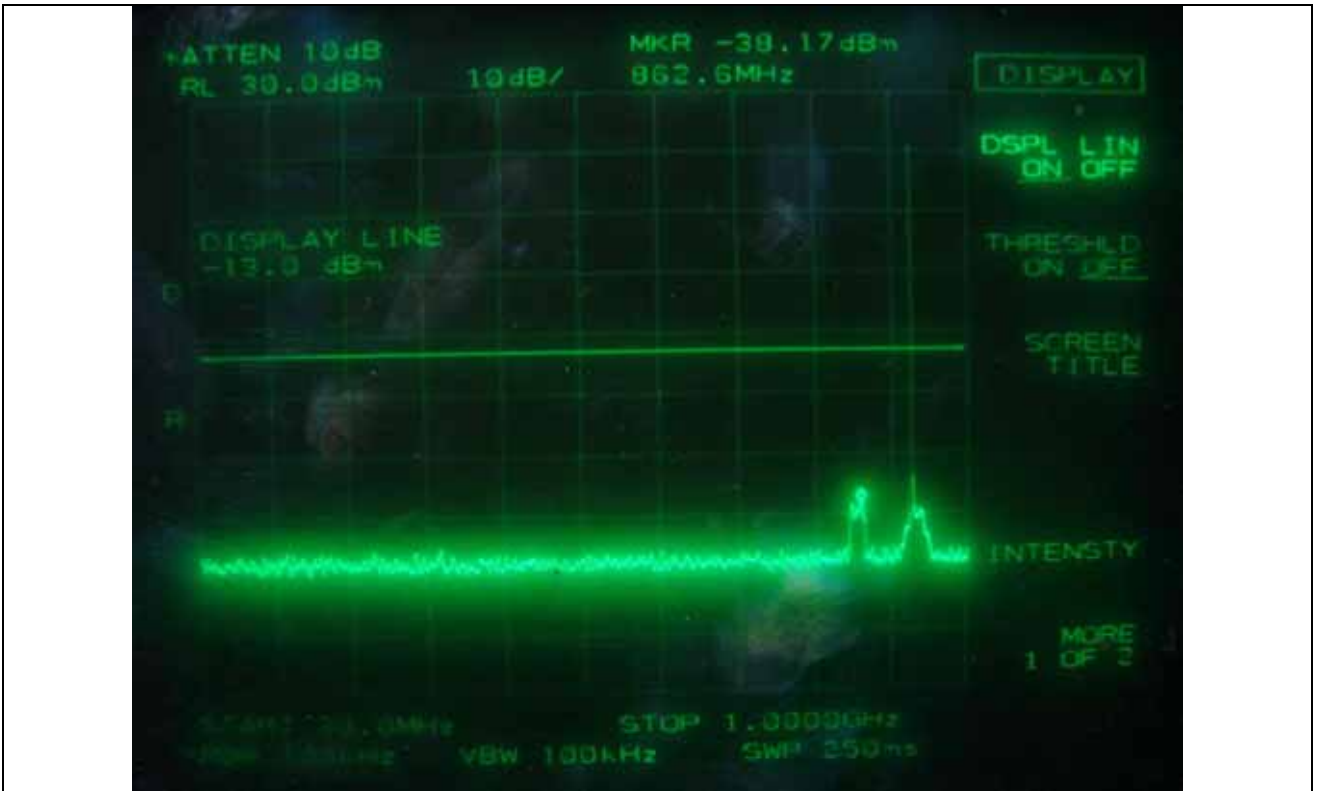
iDEN – High Channel



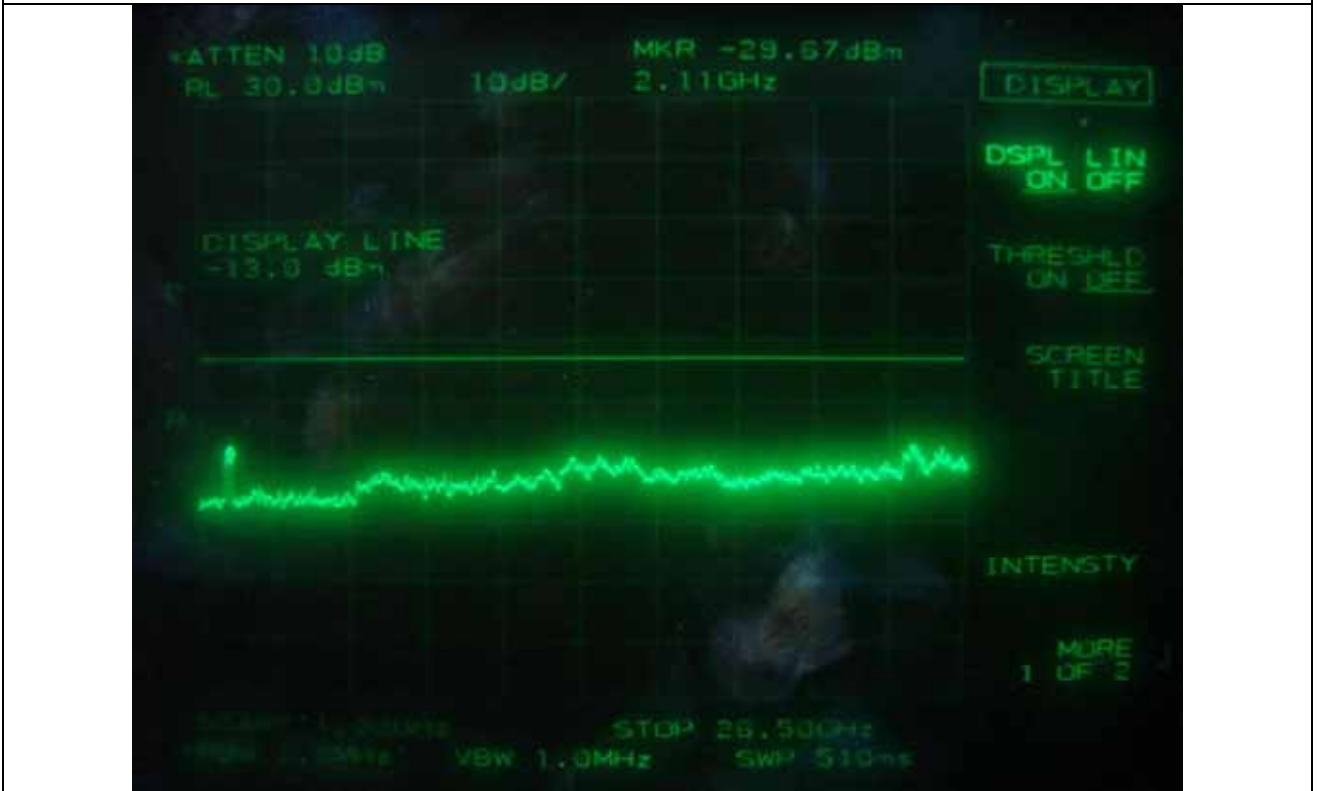
SMR – Low Channel



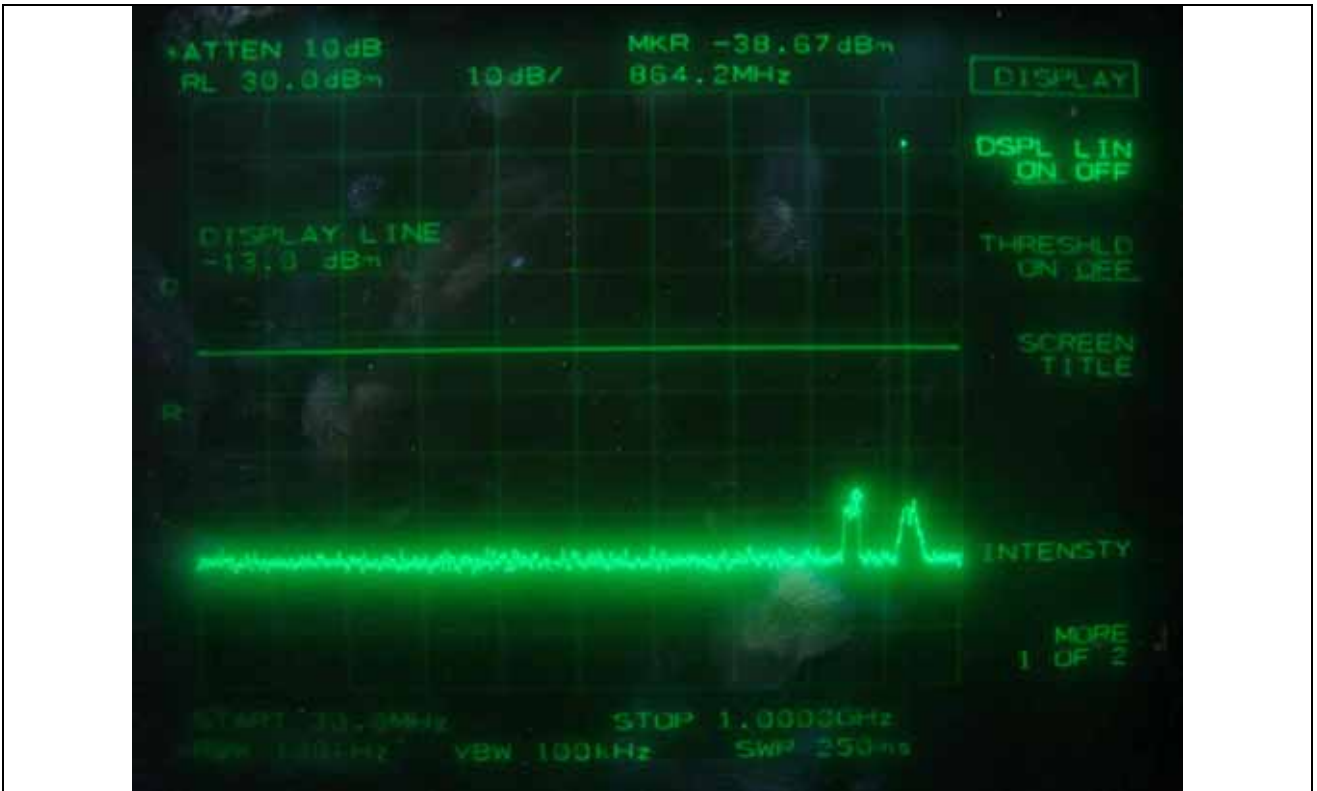
SMR – Low Channel



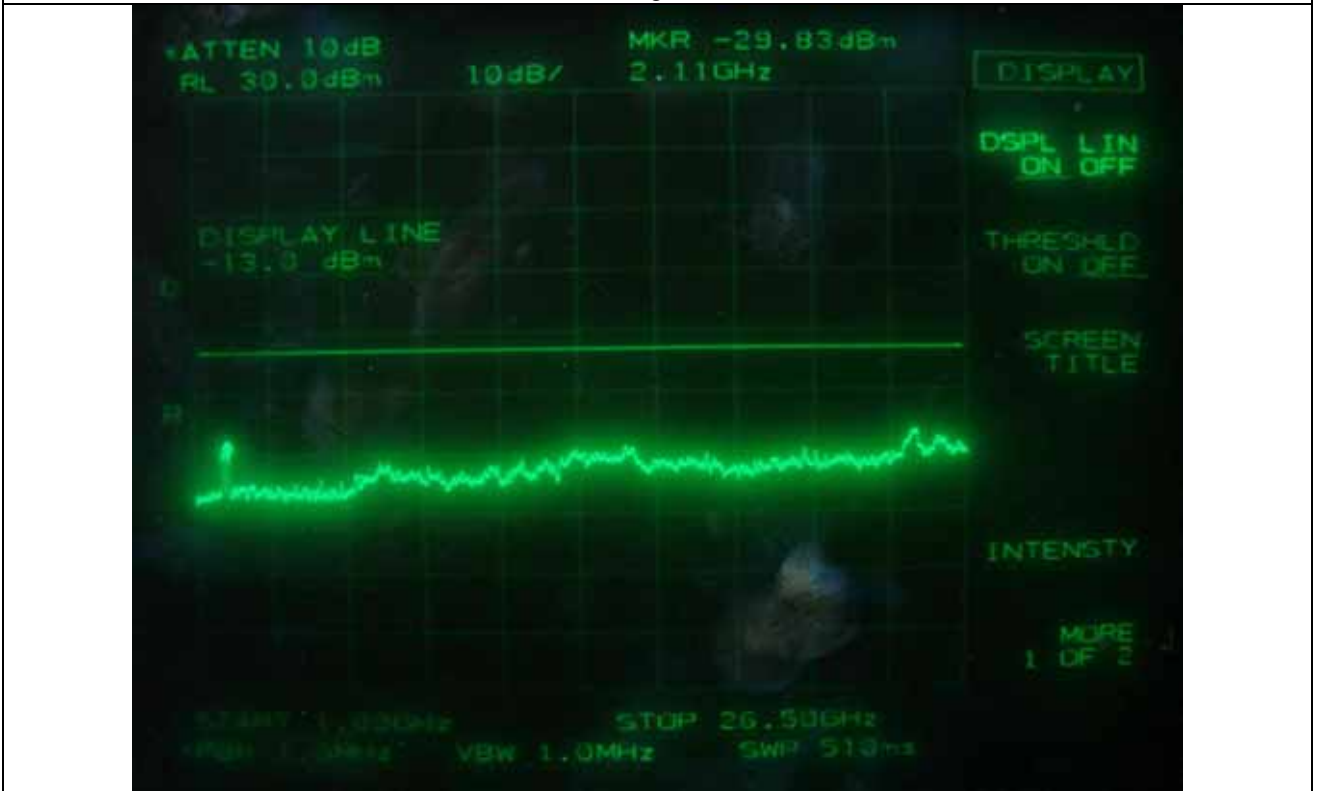
SMR – Middle Channel



SMR – Middle Channel



SMR – High Channel



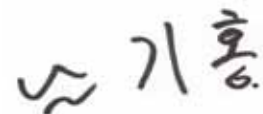
SMR – High Channel

7.4.3 Test Result for 900I+PA (935 MHz ~ 940 MHz)

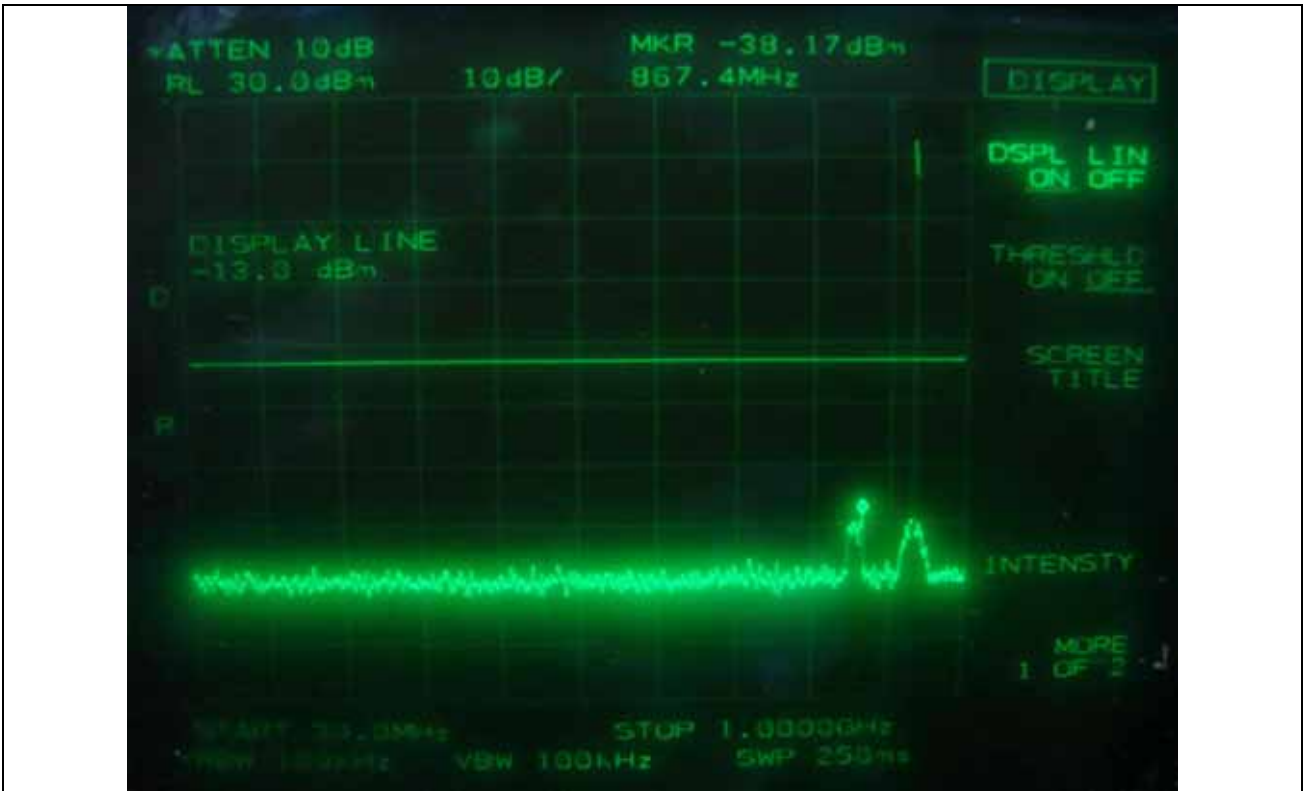
- . Test Date : March 10~11, 2009
- . Frequency range : 30 MHz ~ 20 GHz
- . Result : PASSED BY -14.49 dB at low channel of iDEN Mode

Modulation	Harmonic Frequency (MHz)		Measured Value (dBm)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
iDEN	Low	862.60	-38.67	0.50	-38.17	-13.00	-25.17
		2 110.00	-28.50	0.84	-27.66		-14.66
	Middle	864.20	-38.17	0.50	-37.67		-24.67
		2 110.00	-28.67	0.84	-27.83		-14.83
	High	864.20	-38.50	0.50	-38.00		-25.00
		2 110.00	-28.33	0.84	-27.49		-14.49
SMR	Low	867.40	-38.17	0.50	-37.67	-13.00	-24.67
		2 110.00	-28.17	0.84	-27.33		-14.33
	Middle	852.90	-38.33	0.50	-37.83		-24.83
		2 060.00	-28.83	0.84	-27.99		-14.99
	High	861.00	-38.50	0.50	-38.00		-25.00
		2 110.00	-28.67	0.84	-27.83		-14.83

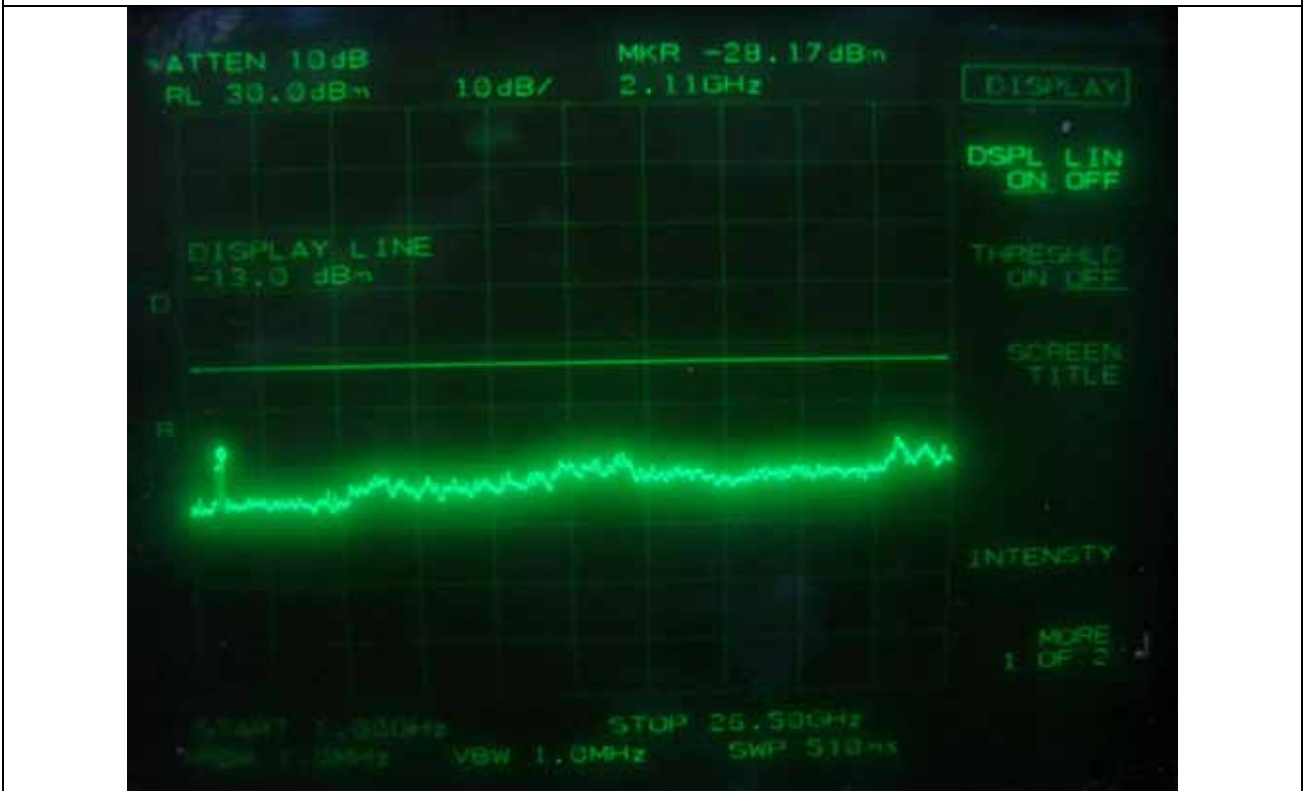
According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0 dBm.



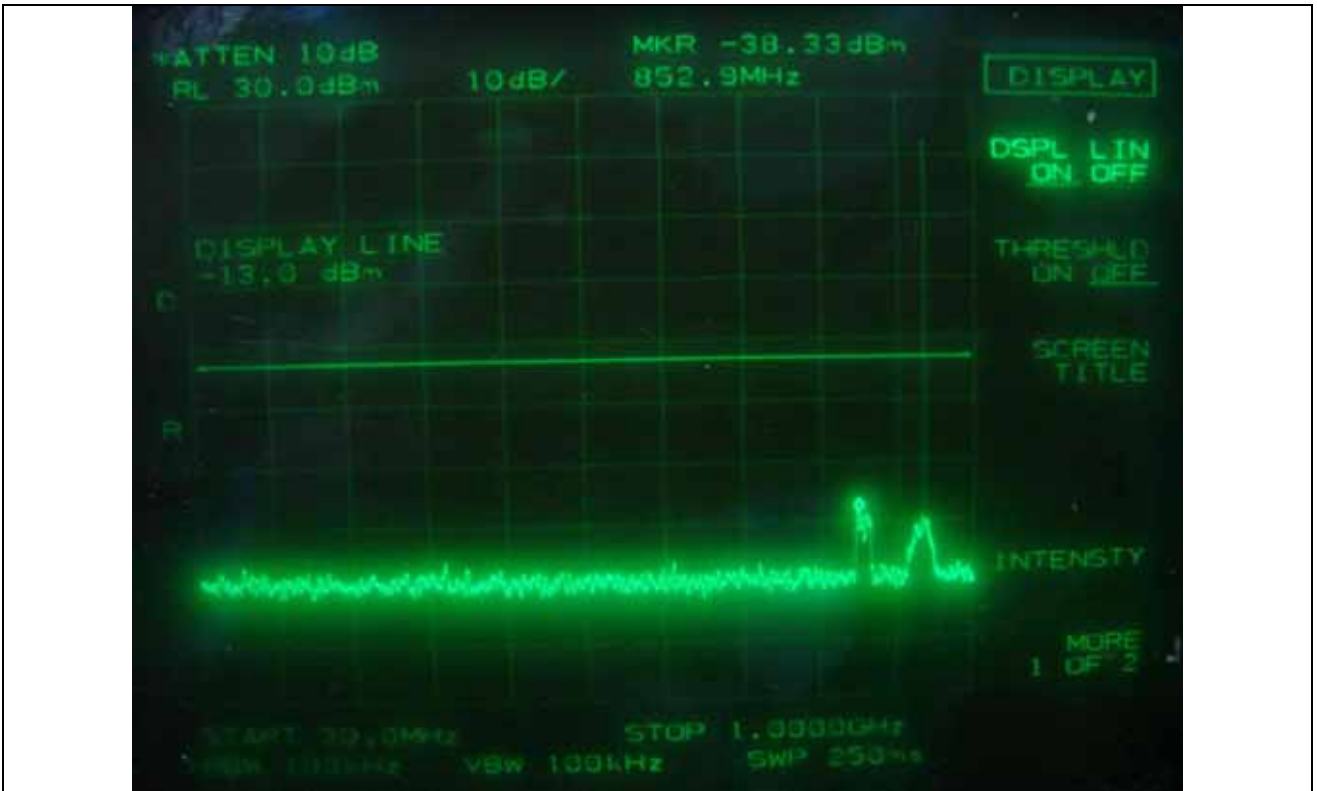
Tested by: **Ki-Hong, Nam / Project Engineer**



iDEN - Low Channel



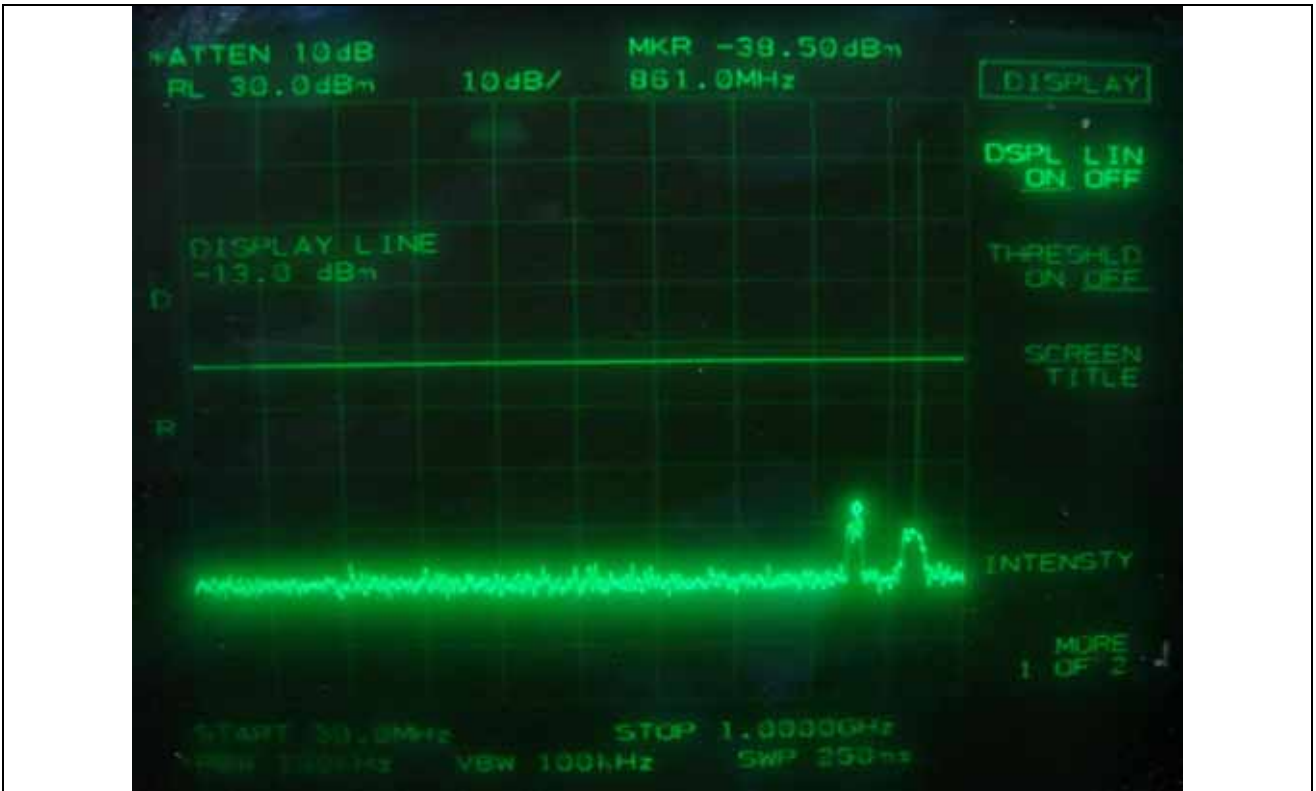
iDEN - Low Channel



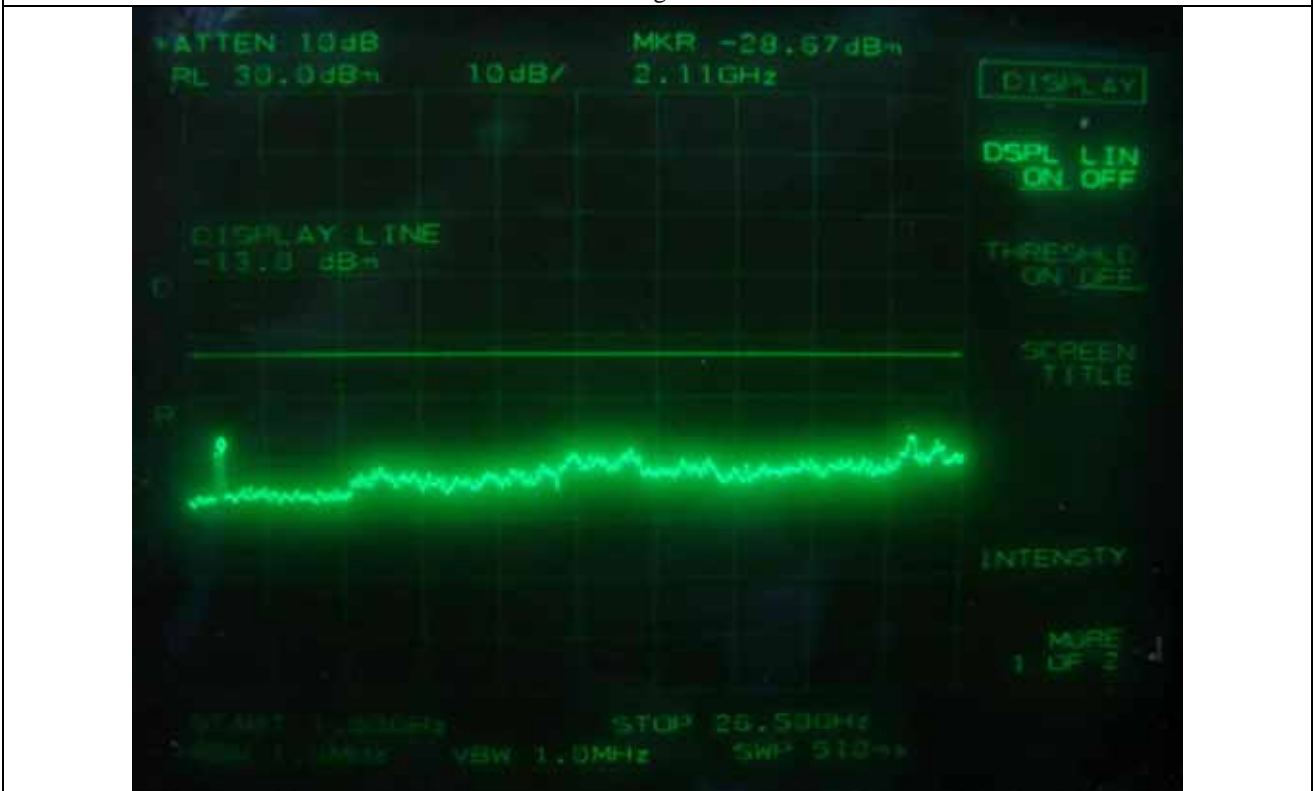
iDEN – Middle Channel



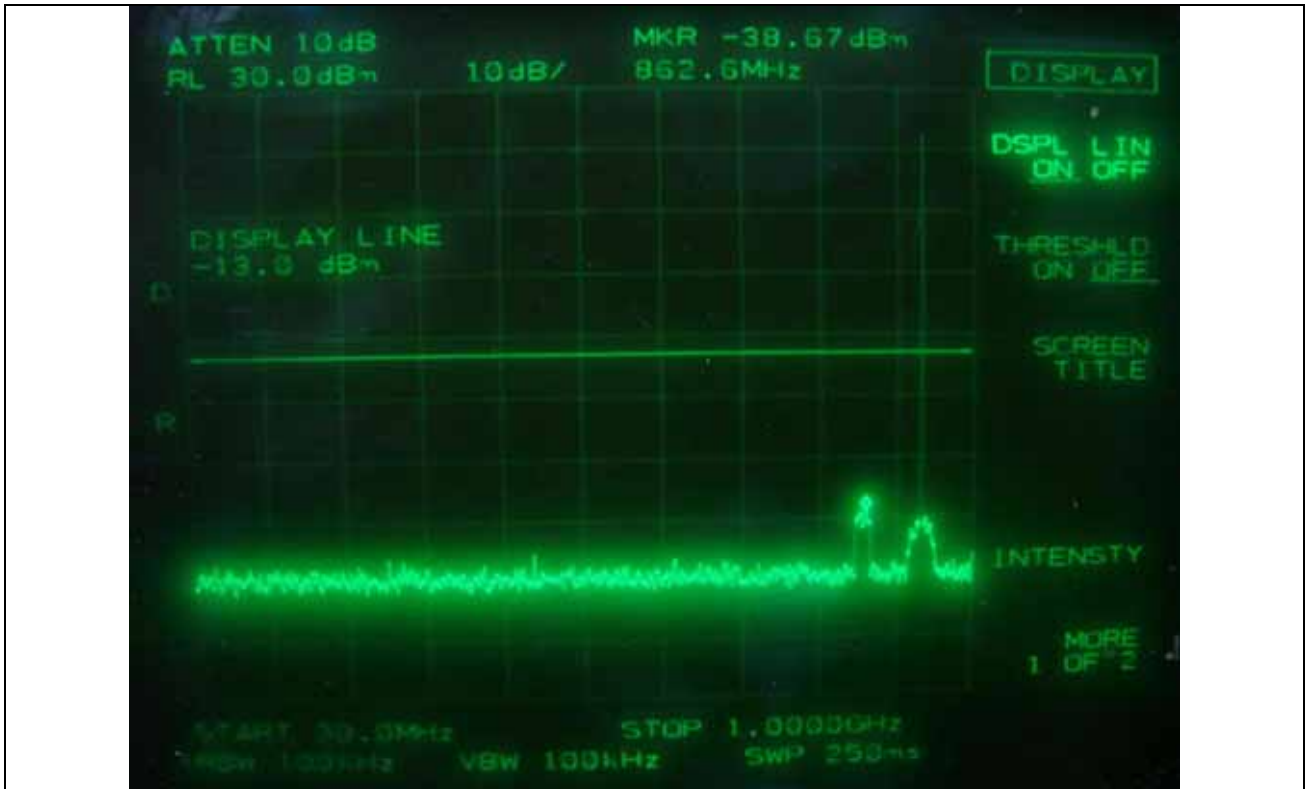
iDEN – Middle Channel



iDEN – High Channel



iDEN – High Channel



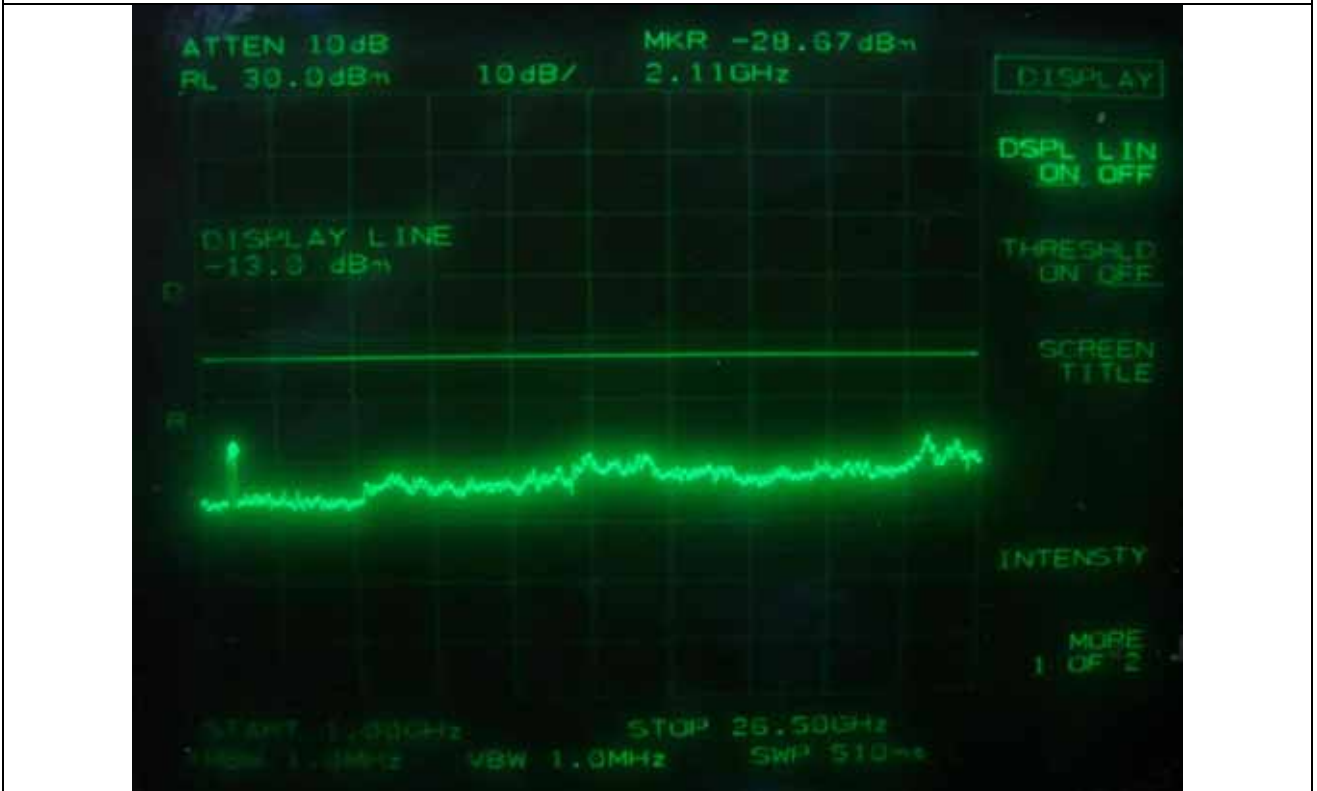
SMR – Low Channel



SMR – Low Channel



SMR – Middle Channel



SMR – Middle Channel



SMR – High Channel



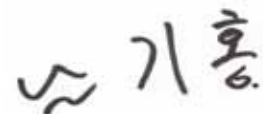
SMR – High Channel

7.4.4 Test Result for 900I+PA (940 MHz ~ 941 MHz)

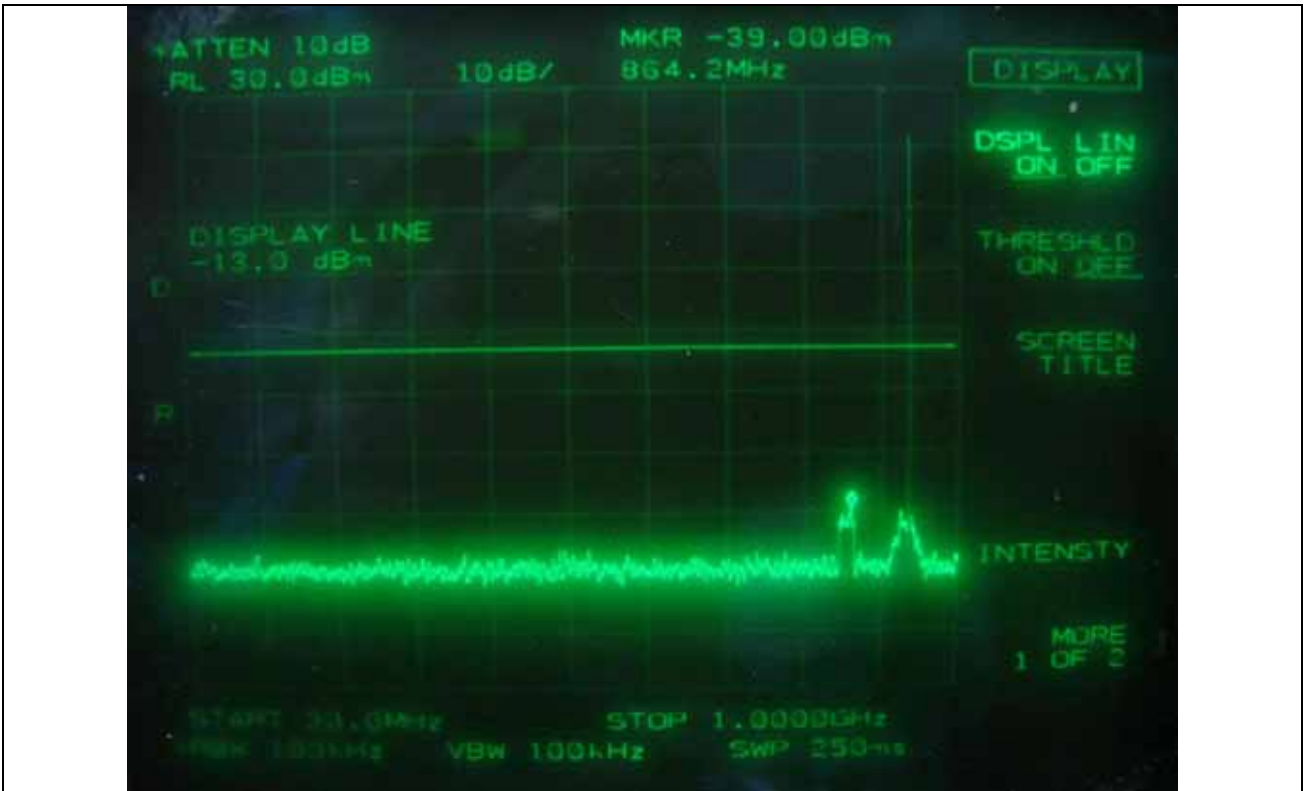
- . Test Date : March 10~11, 2009
- . Frequency range : 30 MHz ~ 20 GHz
- . Result : PASSED BY -14.49 dB at low channel of iDEN Mode

Modulation	Harmonic Frequency (MHz)		Measured Value (dBm)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
iDEN	Low	862.60	-39.00	0.50	-38.50	-13.00	-25.50
		2 110.00	-29.17	0.84	-28.33		-15.33
	Middle	849.70	-39.33	0.50	-38.83		-25.83
		2 060.00	-28.83	0.84	-27.99		-14.99
	High	859.40	-39.17	0.50	-38.67		-25.67
		2 110.00	-29.17	0.84	-28.33		-15.33
SMR	Low	864.20	-39.00	0.50	-38.50	-13.00	-25.50
		2 060.00	-29.50	0.84	-28.66		-15.66
	Middle	851.30	-39.17	0.50	-38.67		-25.67
		2 110.00	-29.50	0.84	-28.66		-15.66
	High	852.90	-38.50	0.50	-38.00		-25.00
		2 060.00	-29.33	0.84	-28.49		-15.49

According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0 dBm.



Tested by: **Ki-Hong, Nam / Project Engineer**



iDEN – Low Channel



iDEN – Low Channel



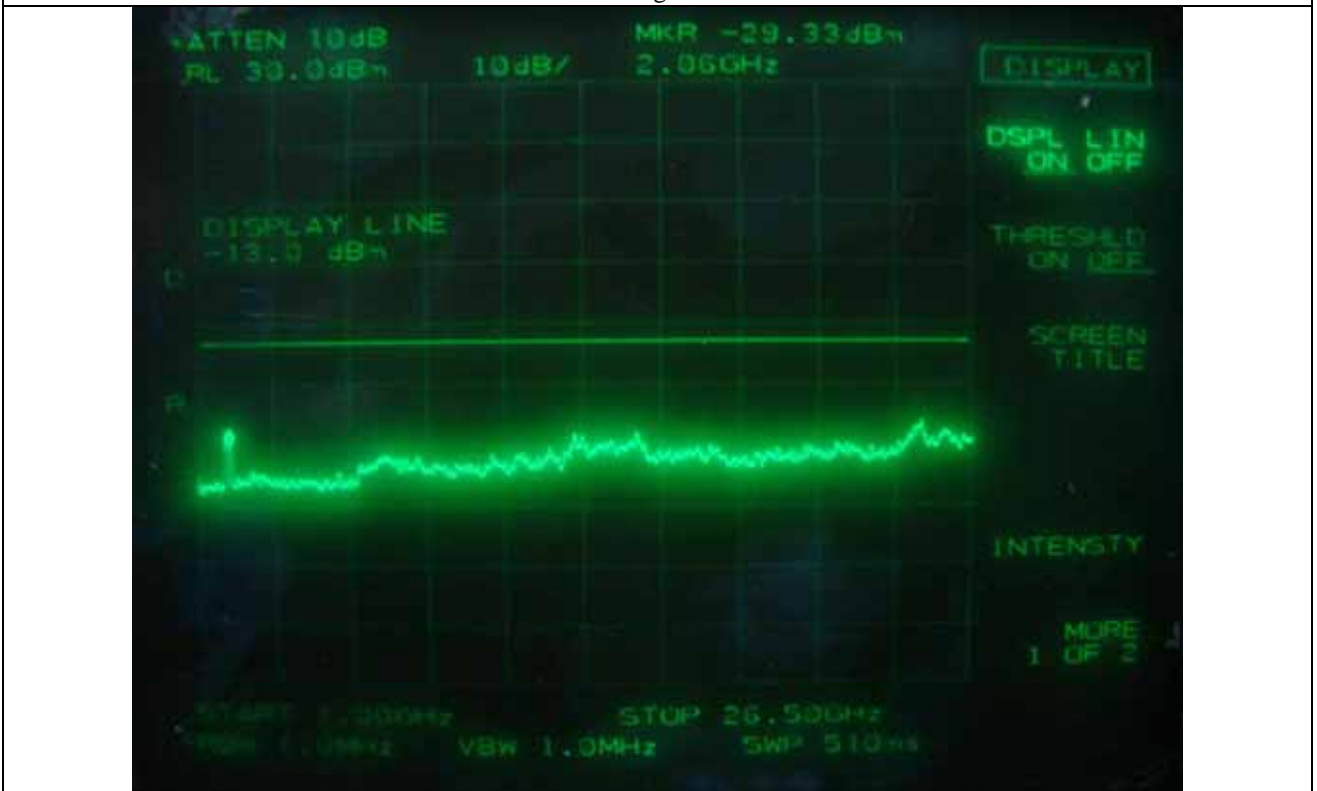
iDEN – Middle Channel



iDEN – Middle Channel



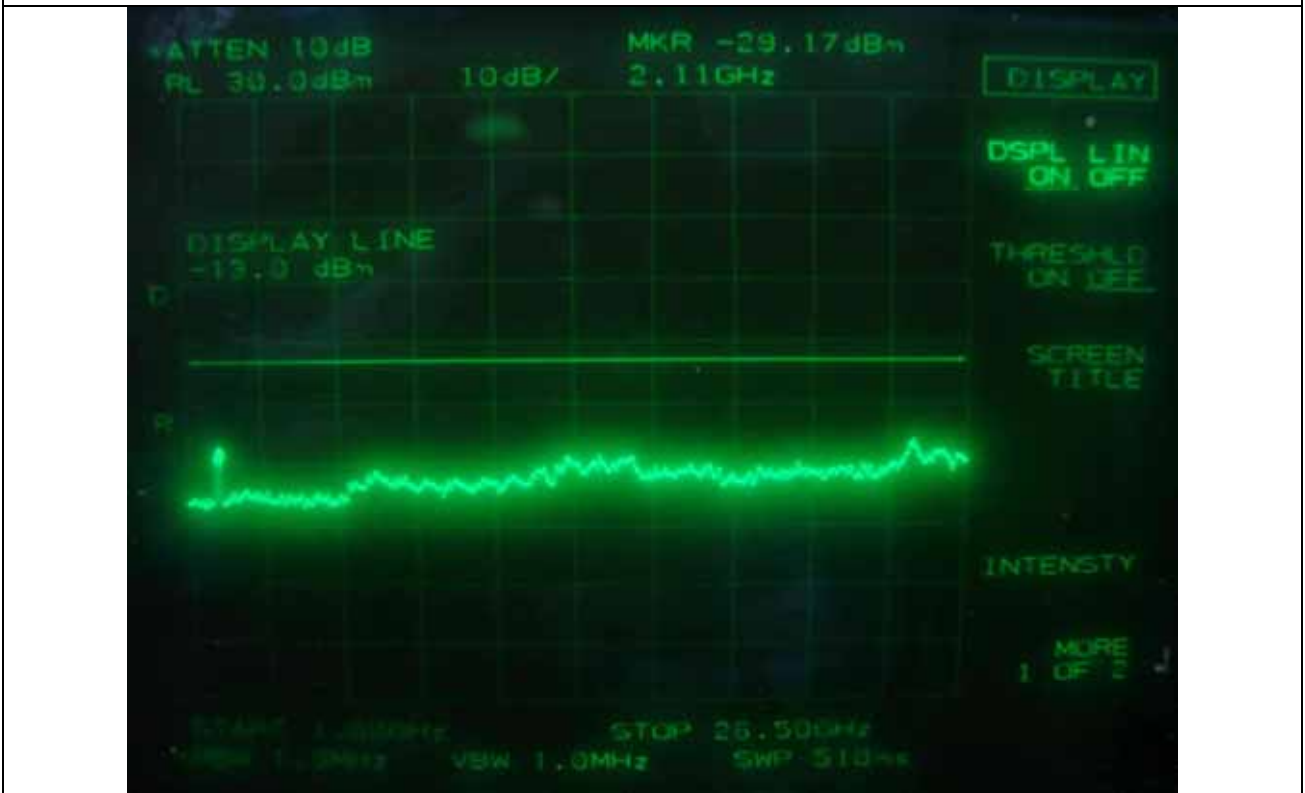
iDEN – High Channel



iDEN – High Channel



SMR – Low Channel



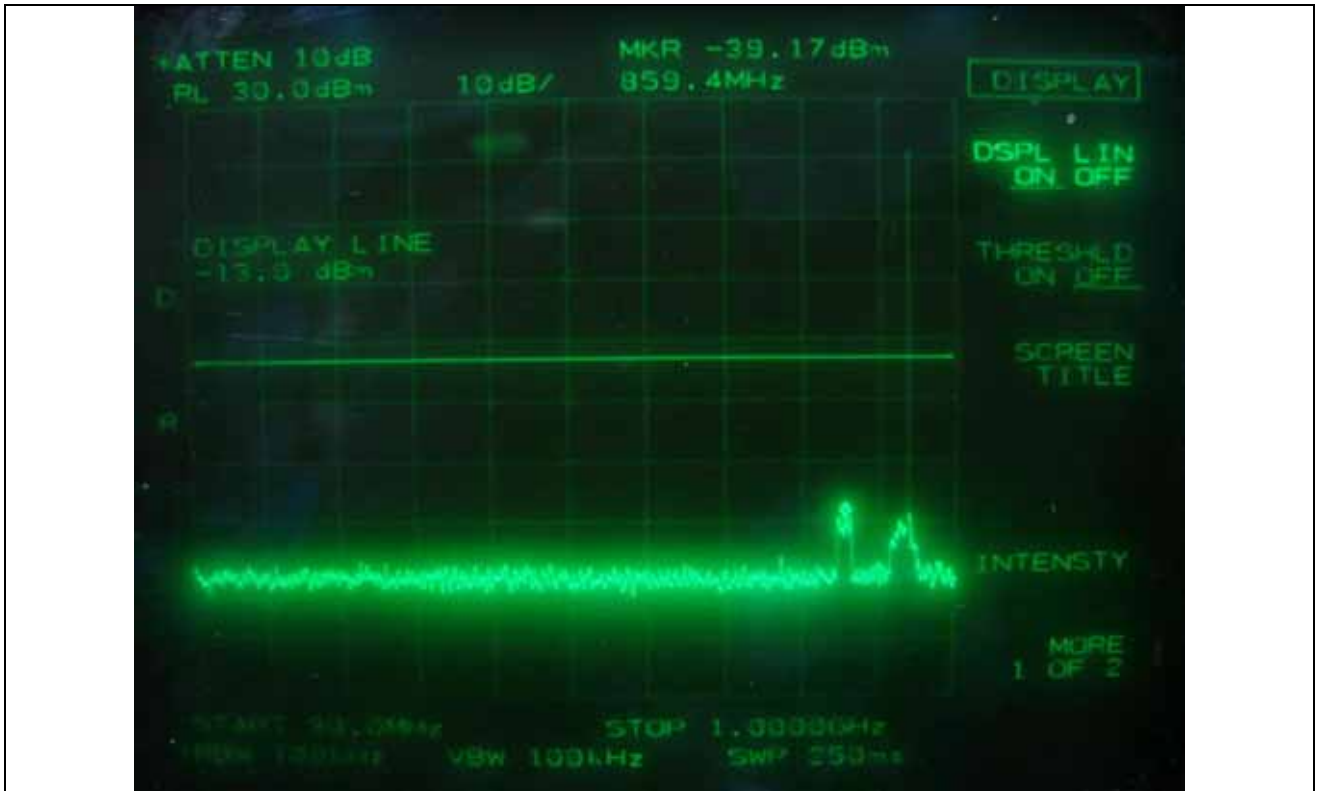
SMR – Low Channel



SMR – Middle Channel



SMR – Middle Channel



SMR – High Channel



SMR – High Channel

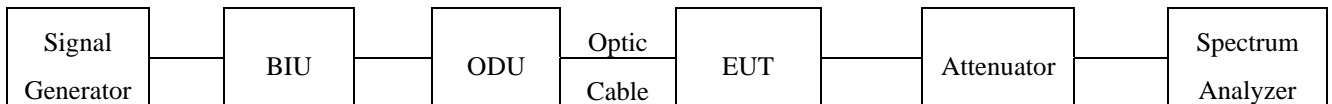
8. SPURIOUS EMISSION AT ANTENNA TERMINAL AT BLOCK EDGES \pm 1 MHz

8.1 Operating environment

Temperature : 21.8 °C
Relative humidity : 47.4 %R.H.

8.2 Test set-up for conducted measurement

The RF signal from the signal generator(s) was injected to BIU (BTS Interface Unit) and then output signal from the BIU was injected to the input of ODU (Optic Distribution Unit) by coaxial cable and then the output port of the ODU was connected to the input of the EUT by optic cable. The amplified RF signal at the output of the EUT was connected to the spectrum analyzer. The test was performed at three frequencies (low, middle, and high channels) at each band using all applicable modulation.



8.3 Test equipment used

Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ - FSP	R/S	Spectrum Analyzer	100017	Mar. 11, 2009
■ - E4432B	HP	Signal Generator	US38440950	June 16, 2008

All test equipment used is calibrated on a regular basis.

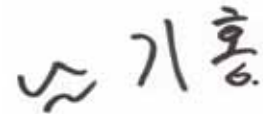
8.4 Test data

8.4.1 Test Result for 800PS

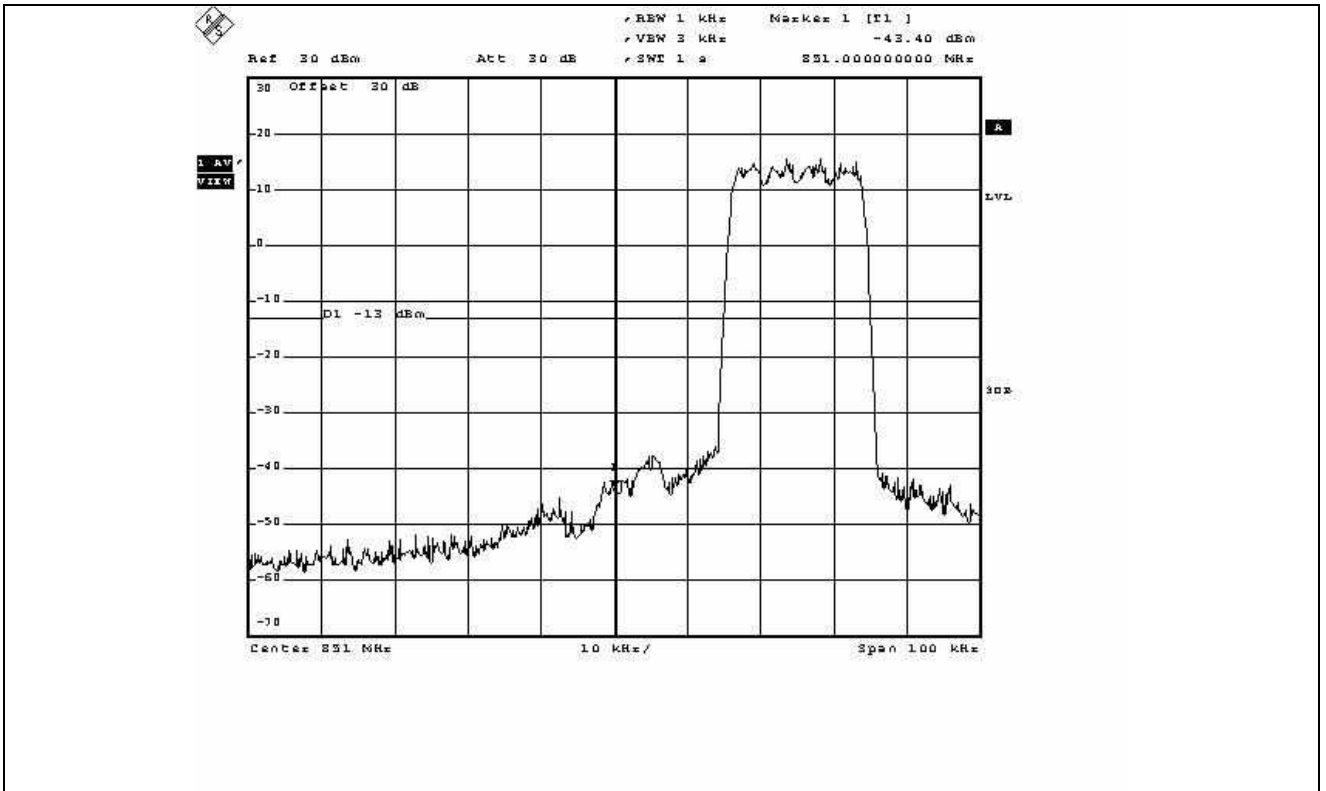
- . Test Date : March 10~11, 2009
- . Result : PASSED BY -30.40 dB at low channel of iDEN Mode

Modulation	Channel	Measured Frequency (MHz)	Max. Measured Value (dBm)	Limit (dBm)
iDEN	Low	851.00	-43.40	-13.00
	High	869.00	-51.80	
SMR	Low	850.99	-57.64	
	High	869.00	-55.18	

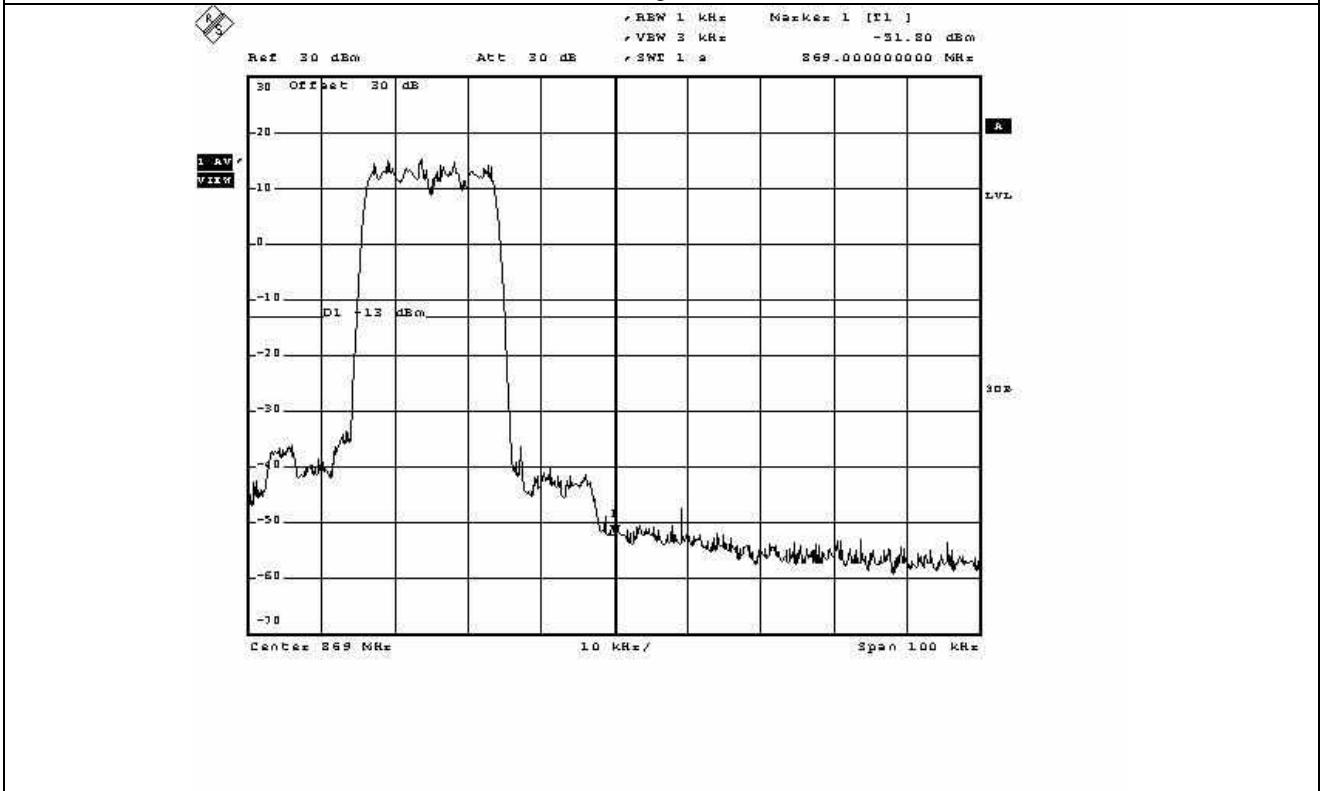
According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0dBm.



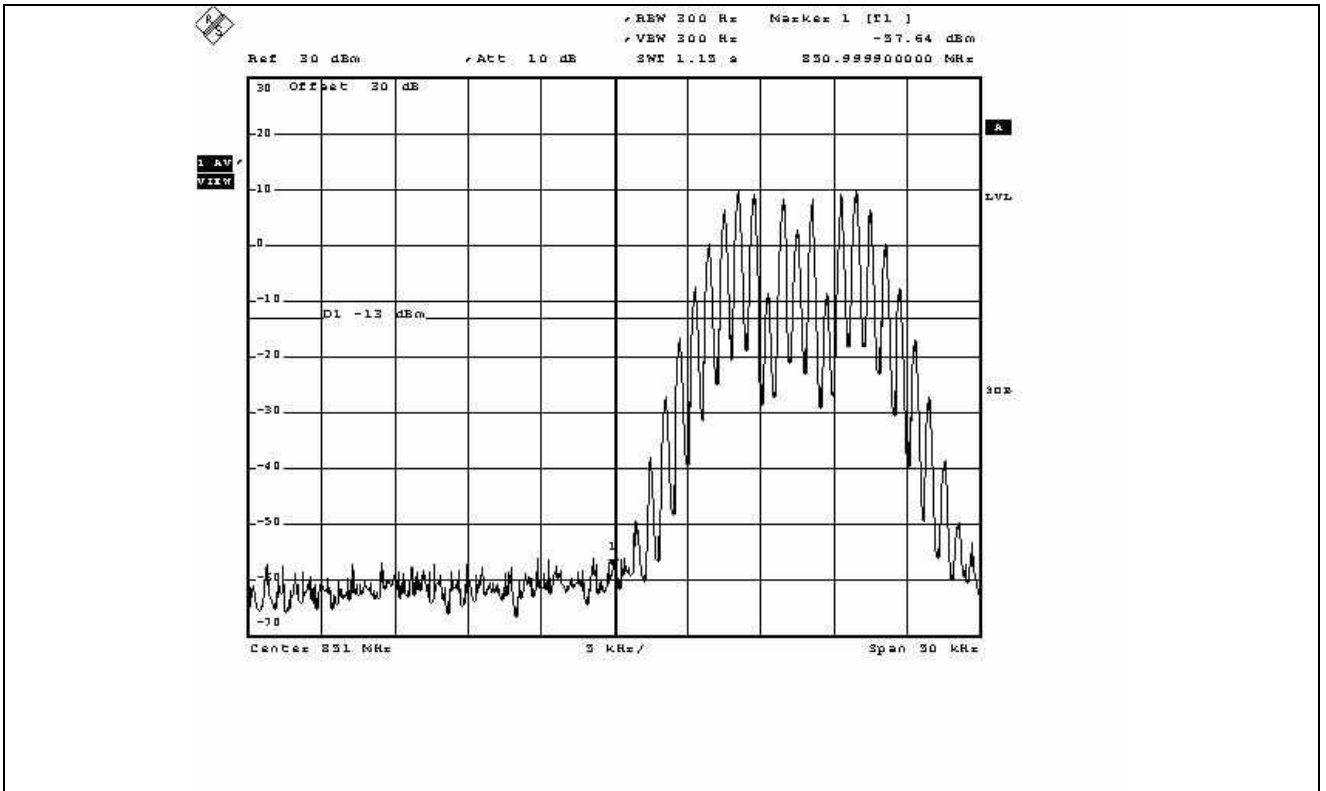
Tested by: Ki-Hong, Nam / Project Engineer



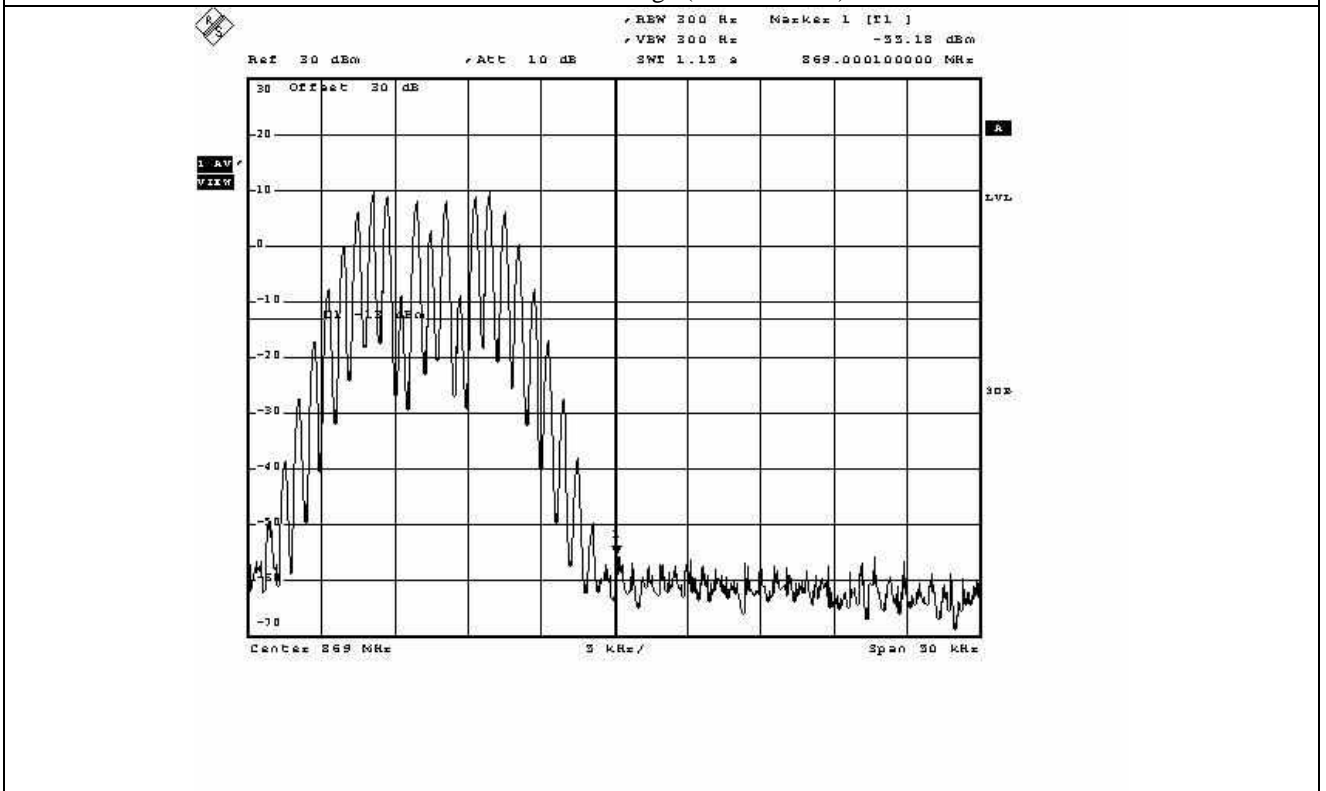
iDEN – Band Edge (Low Channel)



iDEN – Band Edge (High Channel)



SMR – Band Edge (Low Channel)



SMR – Band Edge (High Channel)

8.4.2 Test Result for 900I+PA (929 MHz ~ 930 MHz)

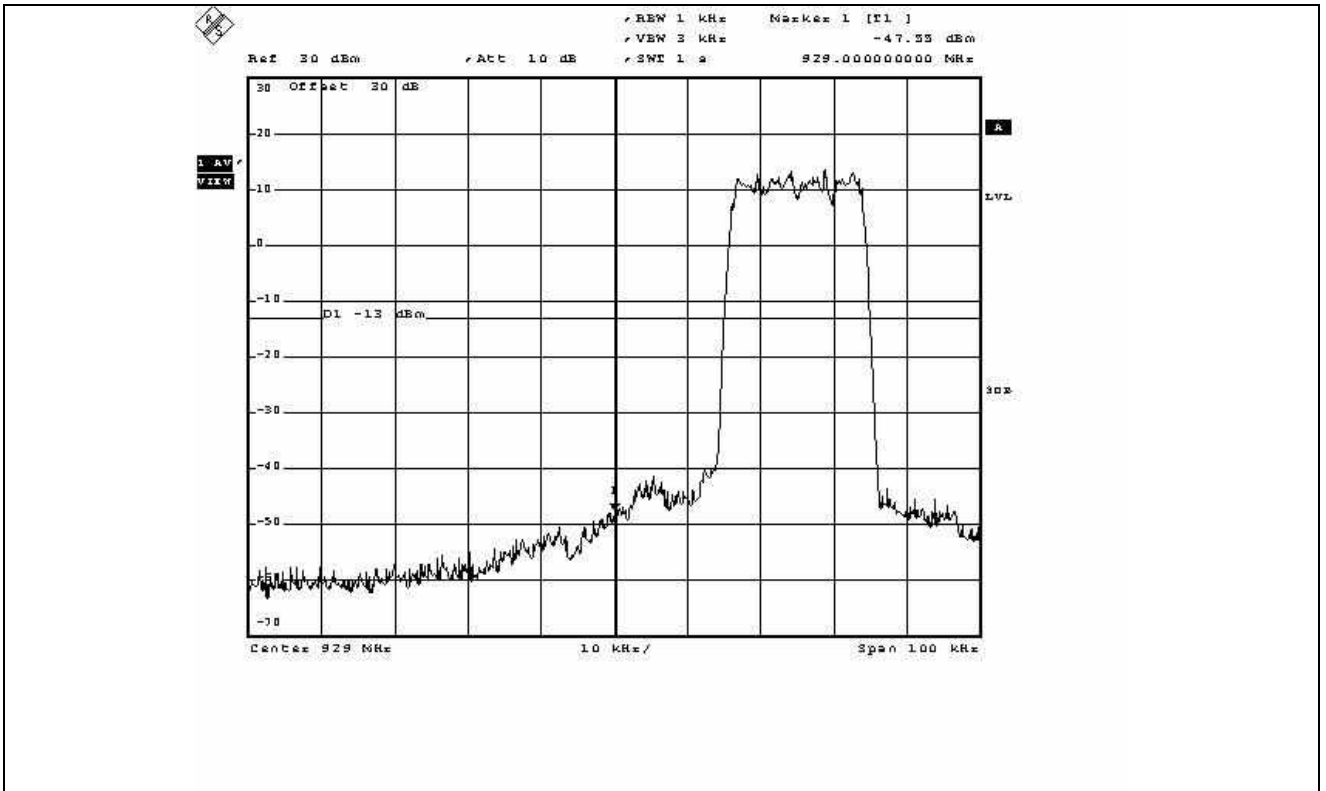
- Test Date : March 10~11, 2009
- Result : PASSED BY -34.55 dB at low channel of iDEN Mode

Modulation	Channel	Measured Frequency (MHz)	Max. Measured Value (dBm)	Limit (dBm)
iDEN	Low	929.00	-47.55	-13.00
	High	930.00	-50.52	
SMR	Low	828.99	-57.28	
	High	930.00	-55.88	

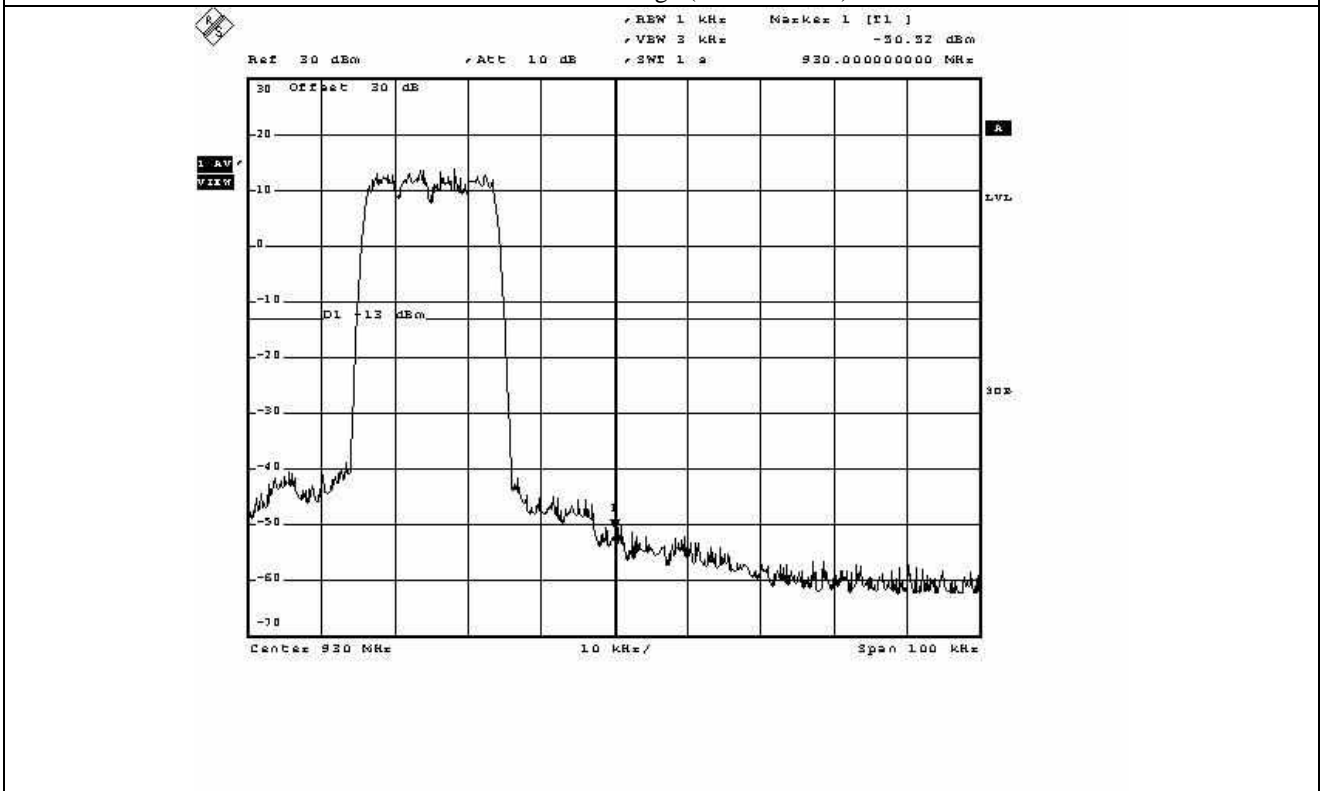
According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0dBm.

~ 기홍

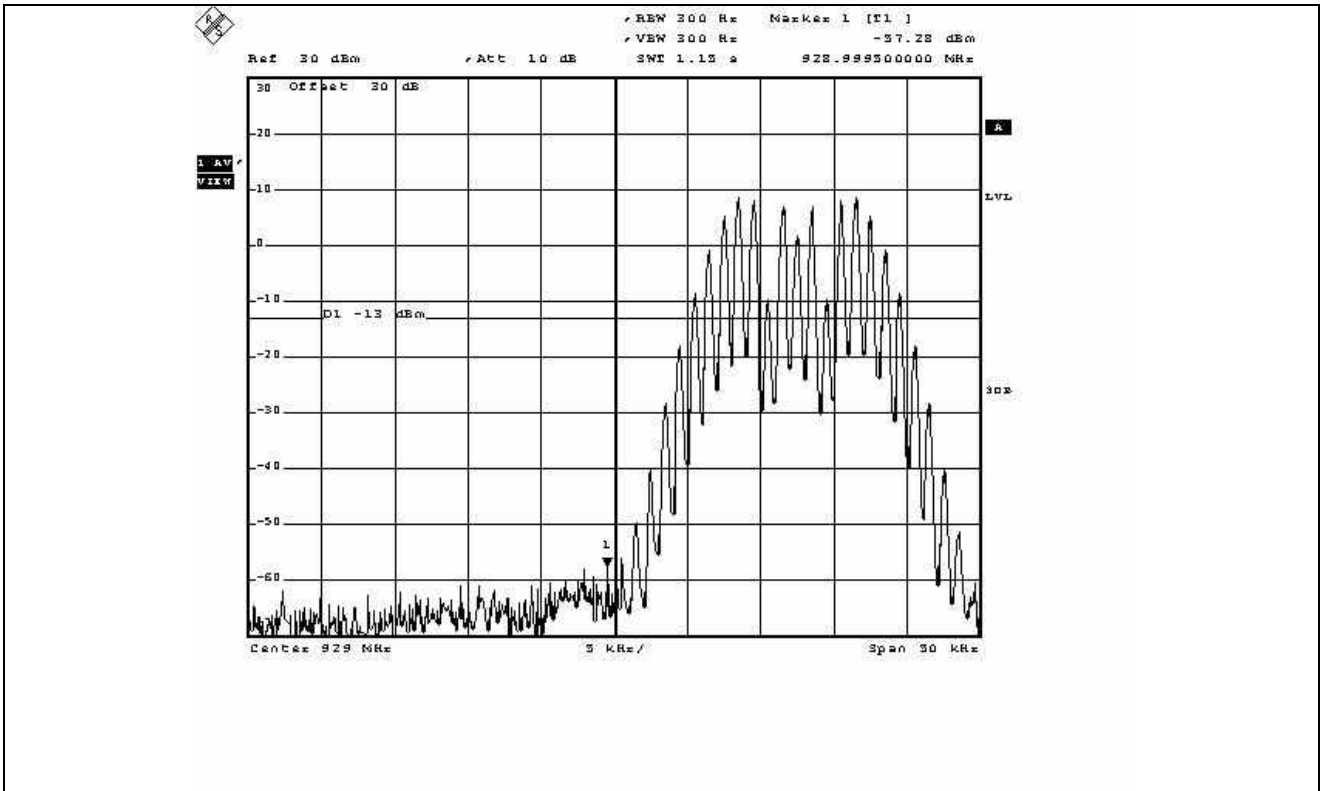
Tested by: Ki-Hong, Nam / Project Engineer



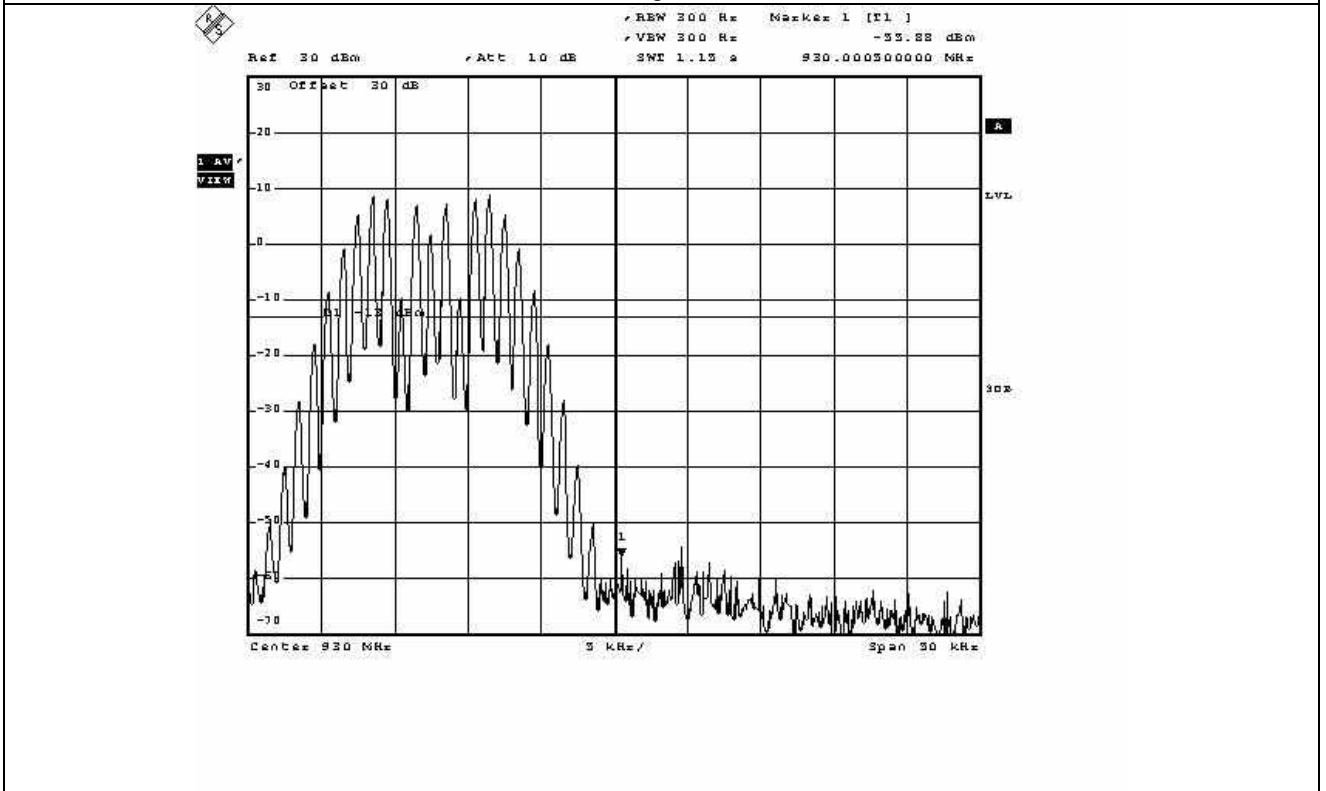
iDEN – Band Edge (Low Channel)



iDEN – Band Edge (High Channel)



SMR – Band Edge (Low Channel)



SMR – Band Edge (High Channel)

8.4.3 Test Result for 900I+PA (935 MHz ~ 940 MHz)

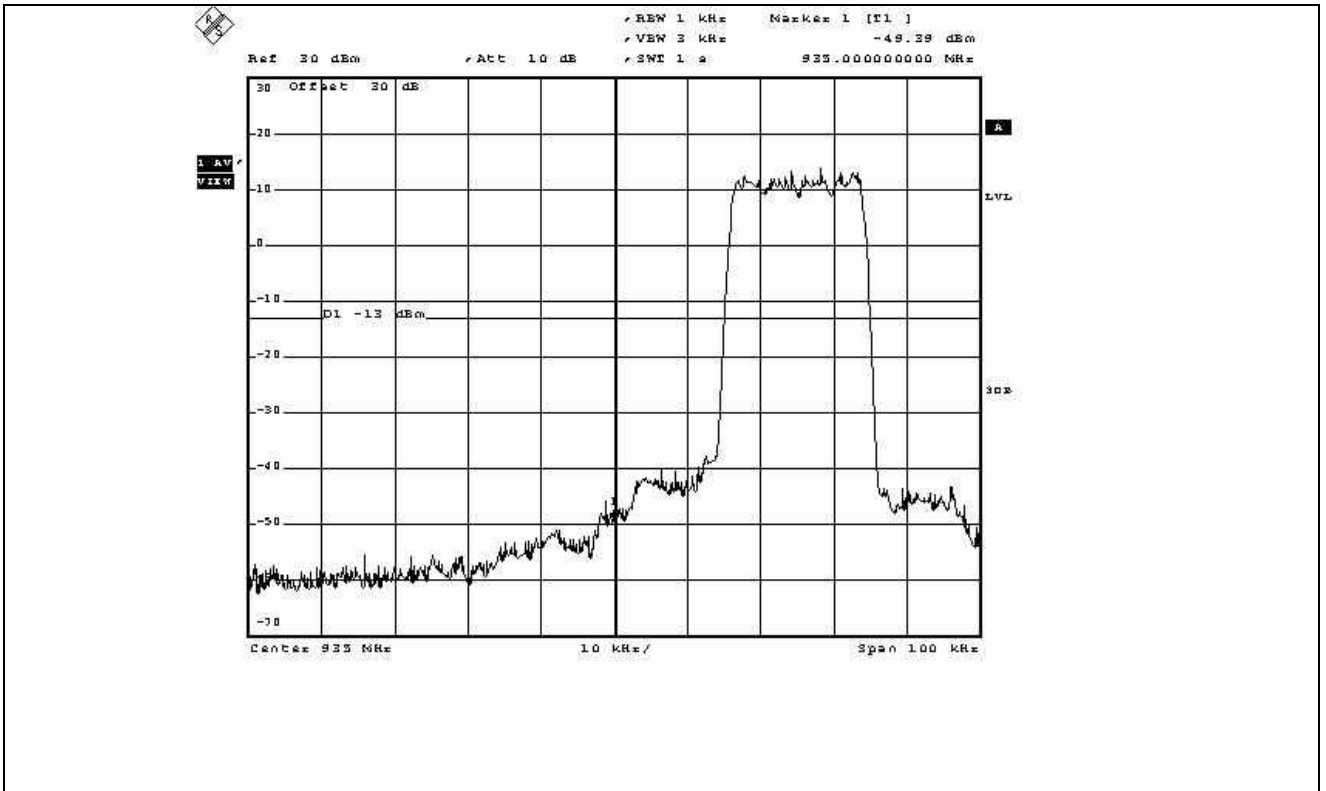
- . Test Date : March 10~11, 2009
- . Result : PASSED BY -36.39 dB at low channel of iDEN Mode

Modulation	Channel	Measured Frequency (MHz)	Max. Measured Value (dBm)	Limit (dBm)
iDEN	Low	935.00	-49.39	-13.00
	High	940.00	-51.14	
SMR	Low	935.00	-57.06	
	High	940.00	-61.67	

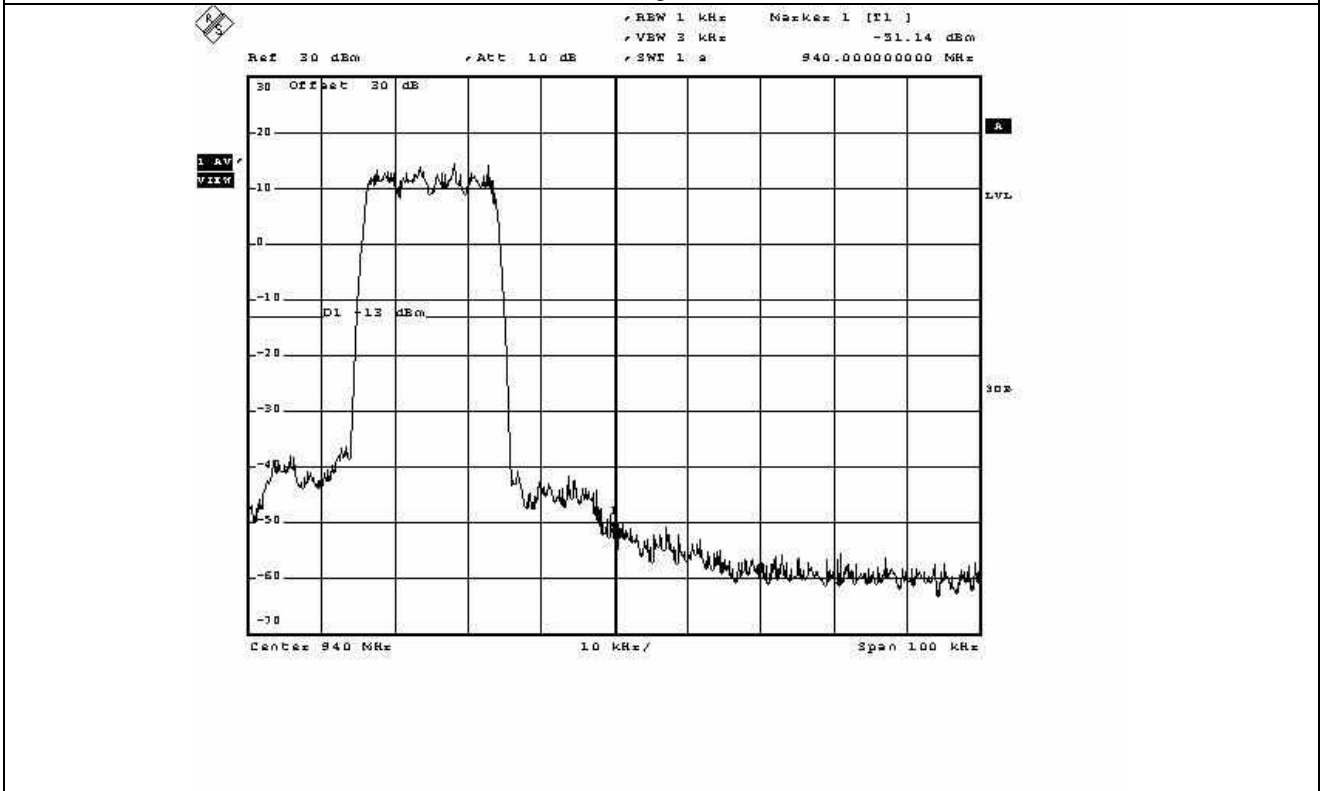
According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0dBm.

~ 기홍

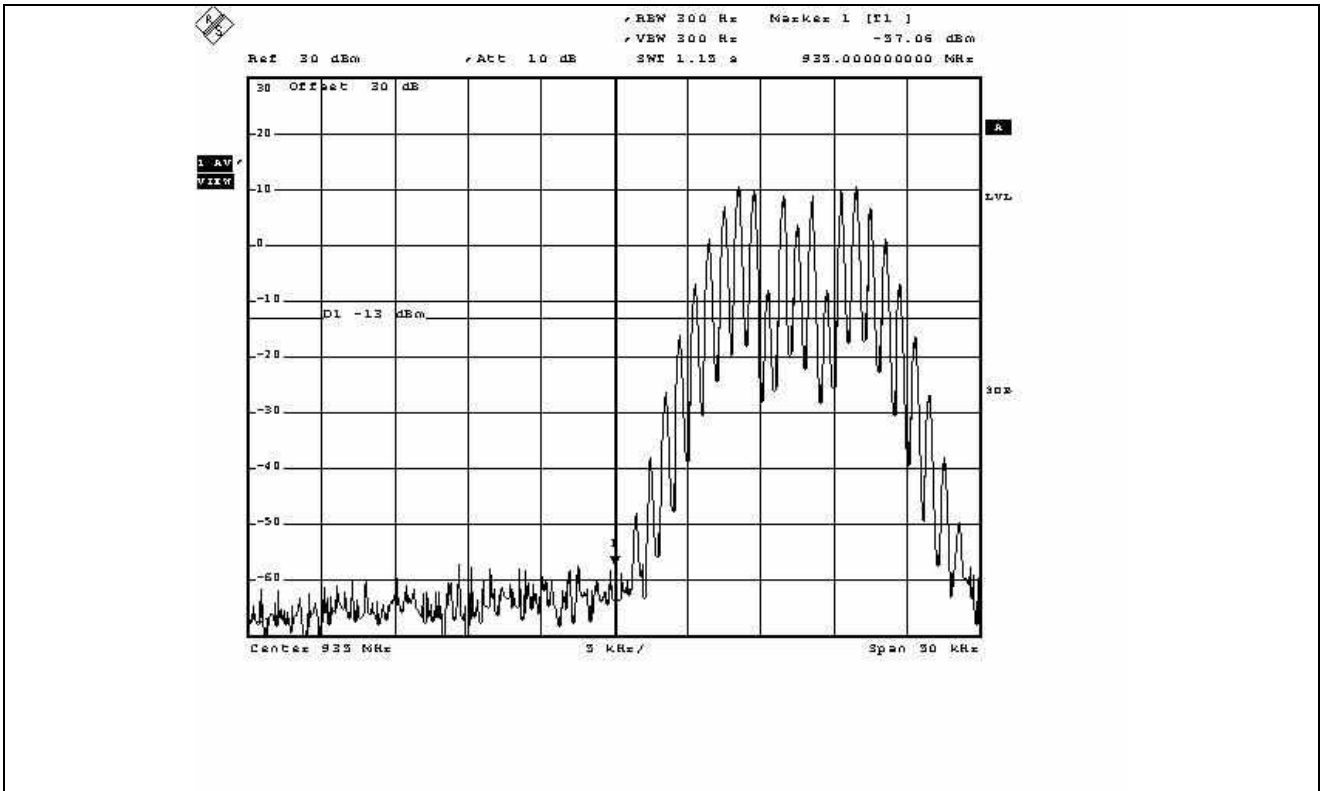
Tested by: Ki-Hong, Nam / Project Engineer



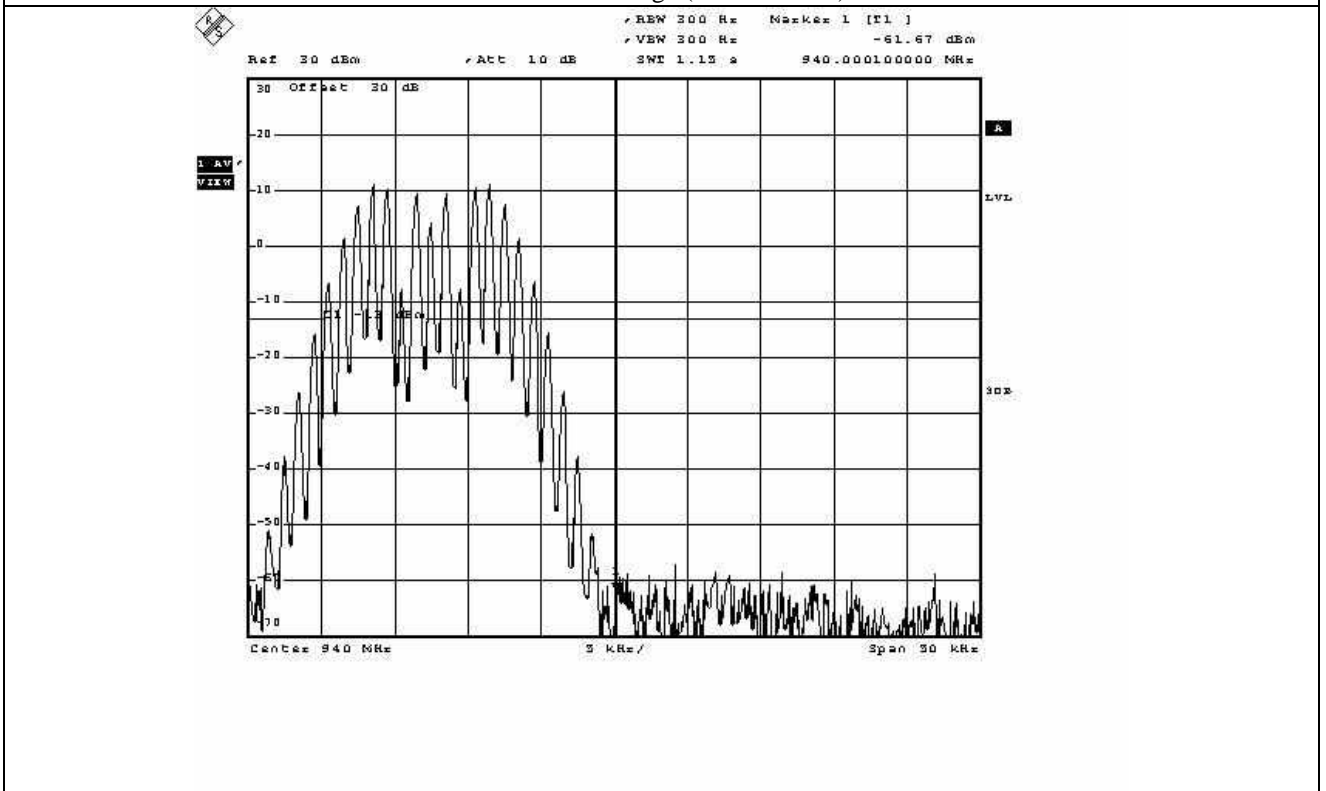
iDEN – Band Edge (Low Channel)



iDEN – Band Edge (High Channel)



SMR – Band Edge (Low Channel)



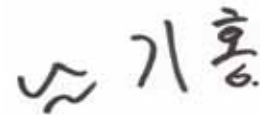
SMR – Band Edge (High Channel)

8.4.4 Test Result for 900I+PA (940 MHz ~ 941 MHz)

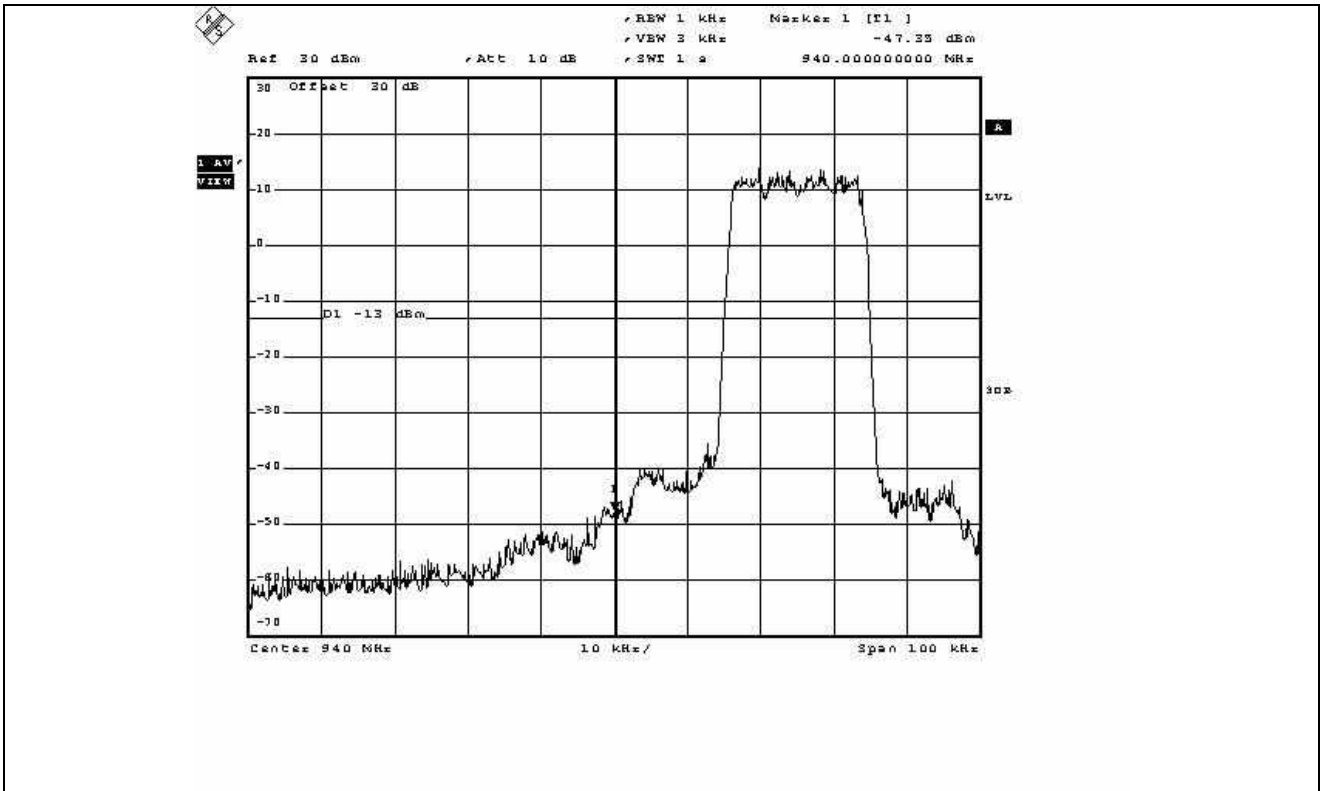
- Test Date : March 10~11, 2009
- Result : PASSED BY -36.35 dB at low channel of iDEN Mode

Modulation	Channel	Measured Frequency (MHz)	Max. Measured Value (dBm)	Limit (dBm)
iDEN	Low	940.00	-47.35	-13.00
	High	941.00	-47.37	
SMR	Low	940.00	-59.74	
	High	941.00	-58.76	

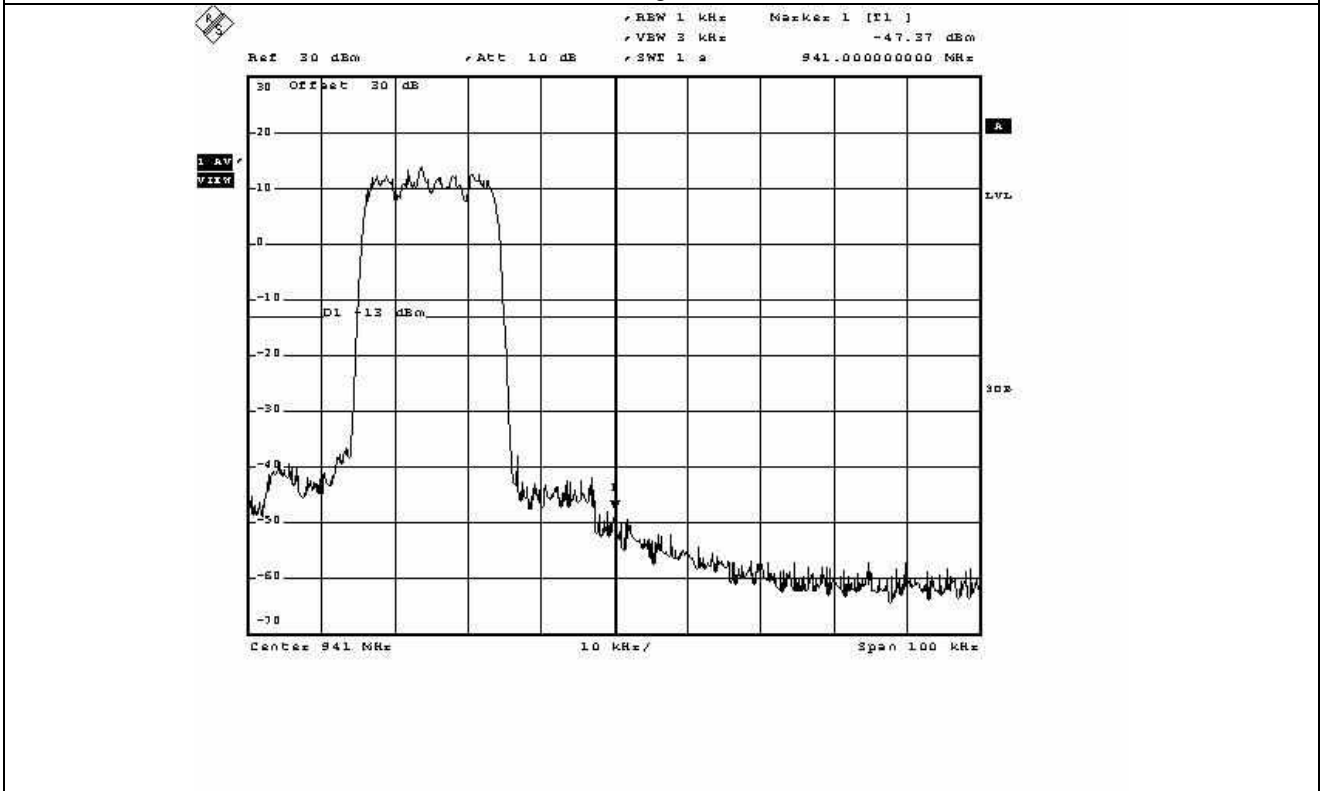
According to Part 90I, out of band emission shall be attenuated by $43 + 10 \log (P)$ dBc, equates to -13.0dBm.



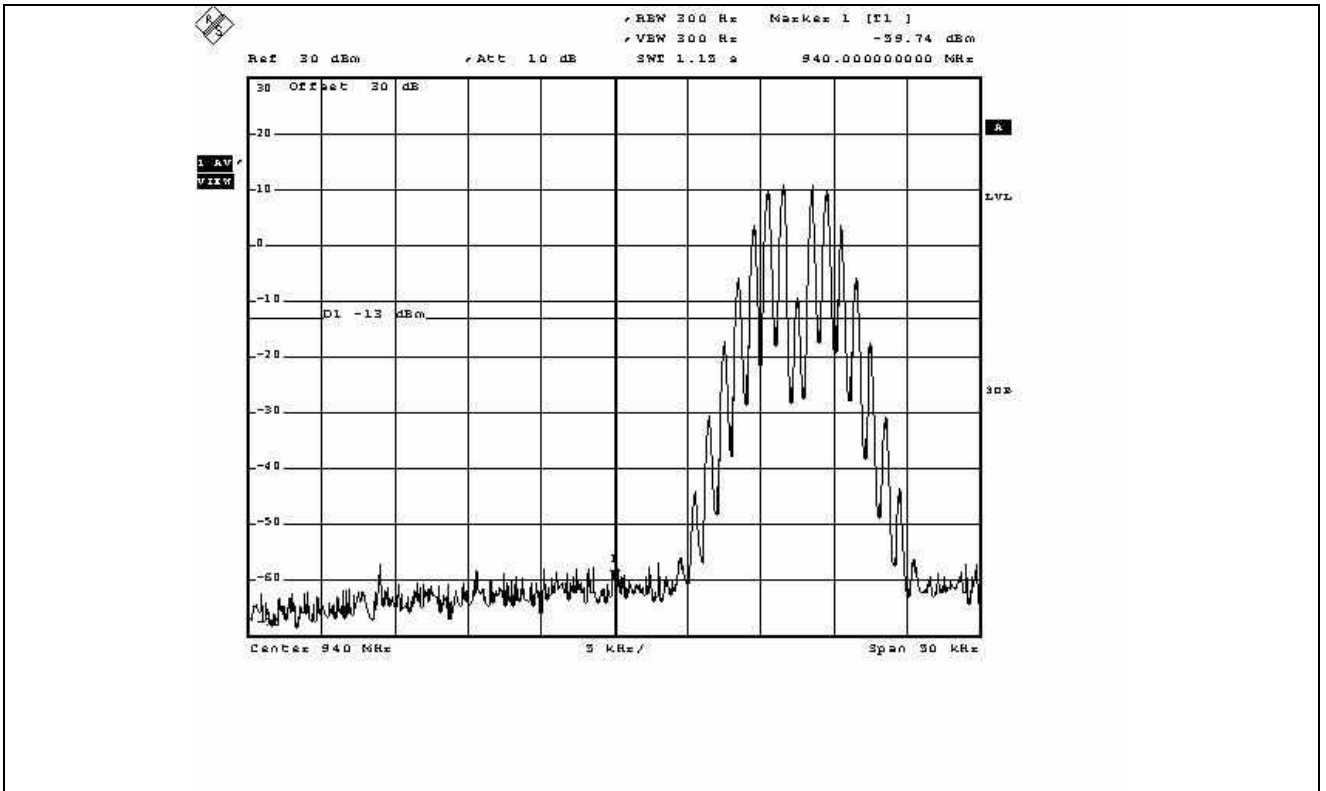
Tested by: Ki-Hong, Nam / Project Engineer



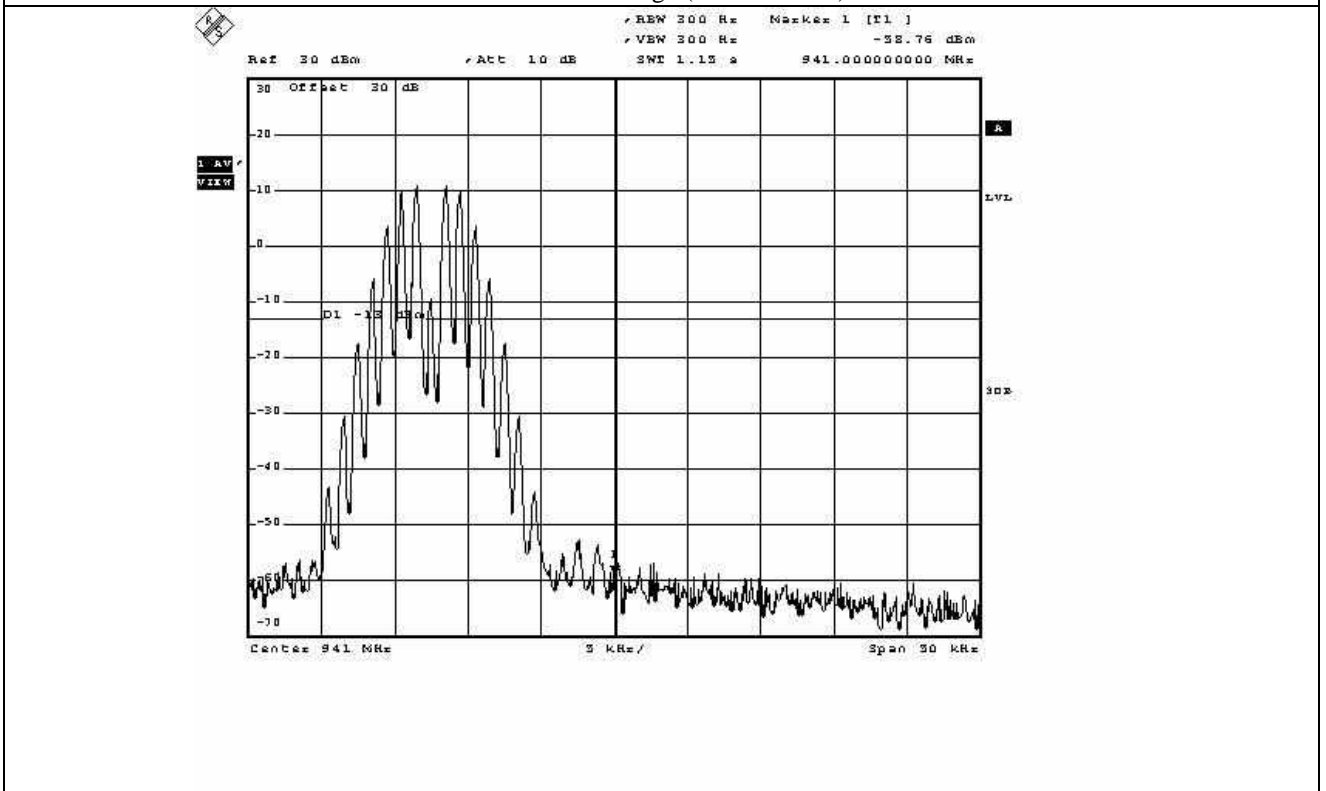
iDEN – Band Edge (Low Channel)



iDEN – Band Edge (High Channel)



SMR – Band Edge (Low Channel)



SMR – Band Edge (High Channel)

9. INTERMODULATION TEST

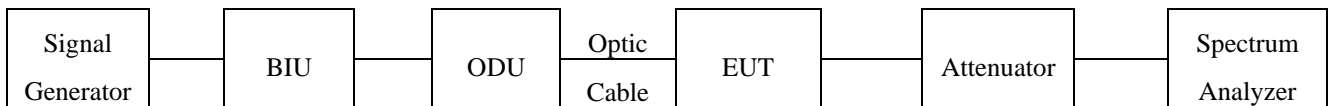
9.1 Operating environment

Temperature : 21.8 °C
Relative humidity : 47.4 %R.H.

9.2 Test set-up

The RF signal from the signal generator(s) was injected to BIU (BTS Interface Unit) and then output signal from the BIU was injected to the input of ODU (Optic Distribution Unit) by coaxial cable and then the output port of the ODU was connected to the input of the EUT by optic cable. The amplified RF signal at the output of the EUT was connected to the spectrum analyzer. The test was performed at three frequencies (low, middle, and high channels) at each band using all applicable modulation.

Two input signals are equal in level and were sent to the input of the EUT.



9.3 Test equipment used

	Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ -	8564E	HP	Spectrum Analyzer	3650A00756	June 16, 2008
■ -	E4432B	HP	Signal Generator	US38440950	June 16, 2008
■ -	SMJ100A	R/S	Vecter Signal Generator	100698	June 16, 2008
■ -	FSP	R/S	Spectrum Analyzer	100017	Mar. 11, 2008

All test equipment used is calibrated on a regular basis.

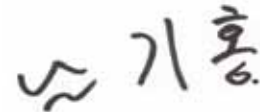
9.4 Test data

9.4.1 Test Result for 800PS

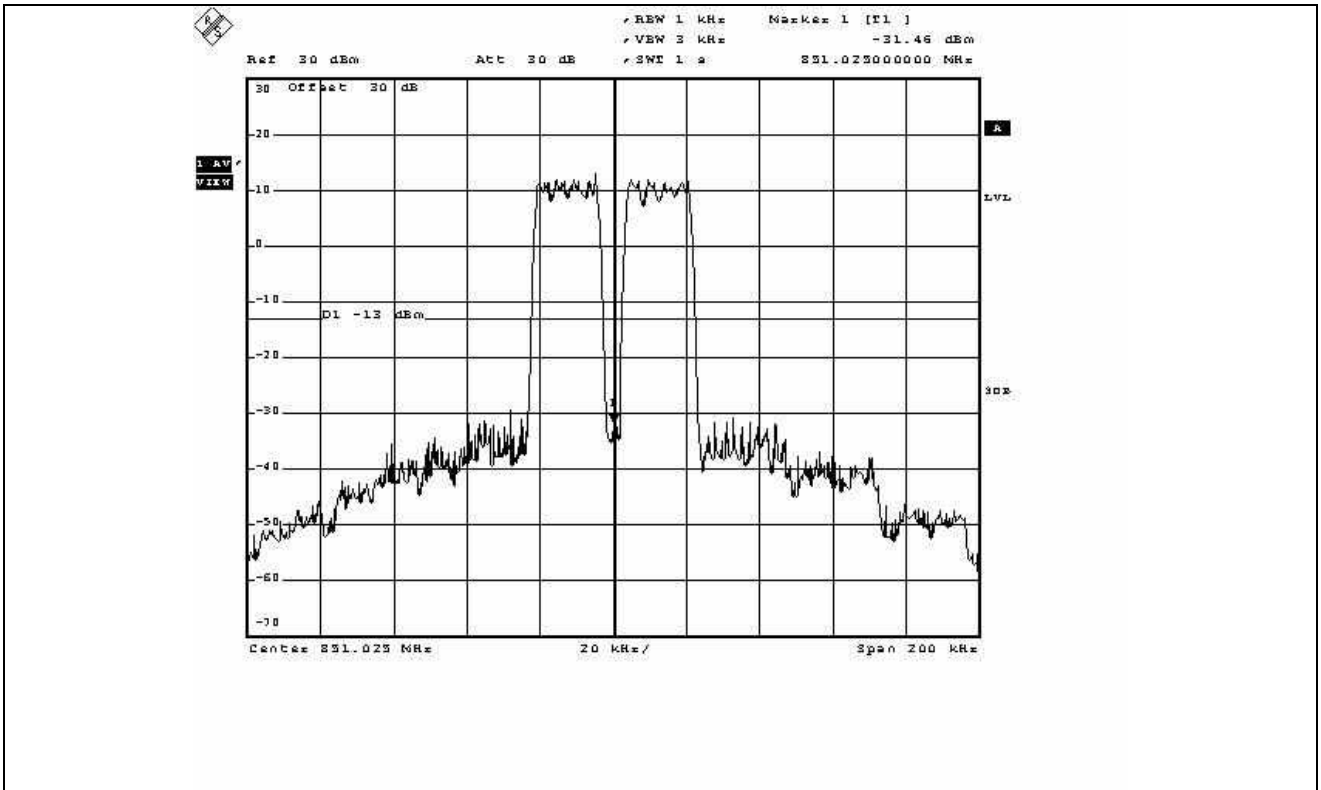
-. Test Date : March 09, 2009
 -. Test Result : Pass

Modulation	Channel	Measured
iDEN	Low	< -13 dBm
	High	< -13 dBm
SMR	Low	< -13 dBm
	High	< -13 dBm

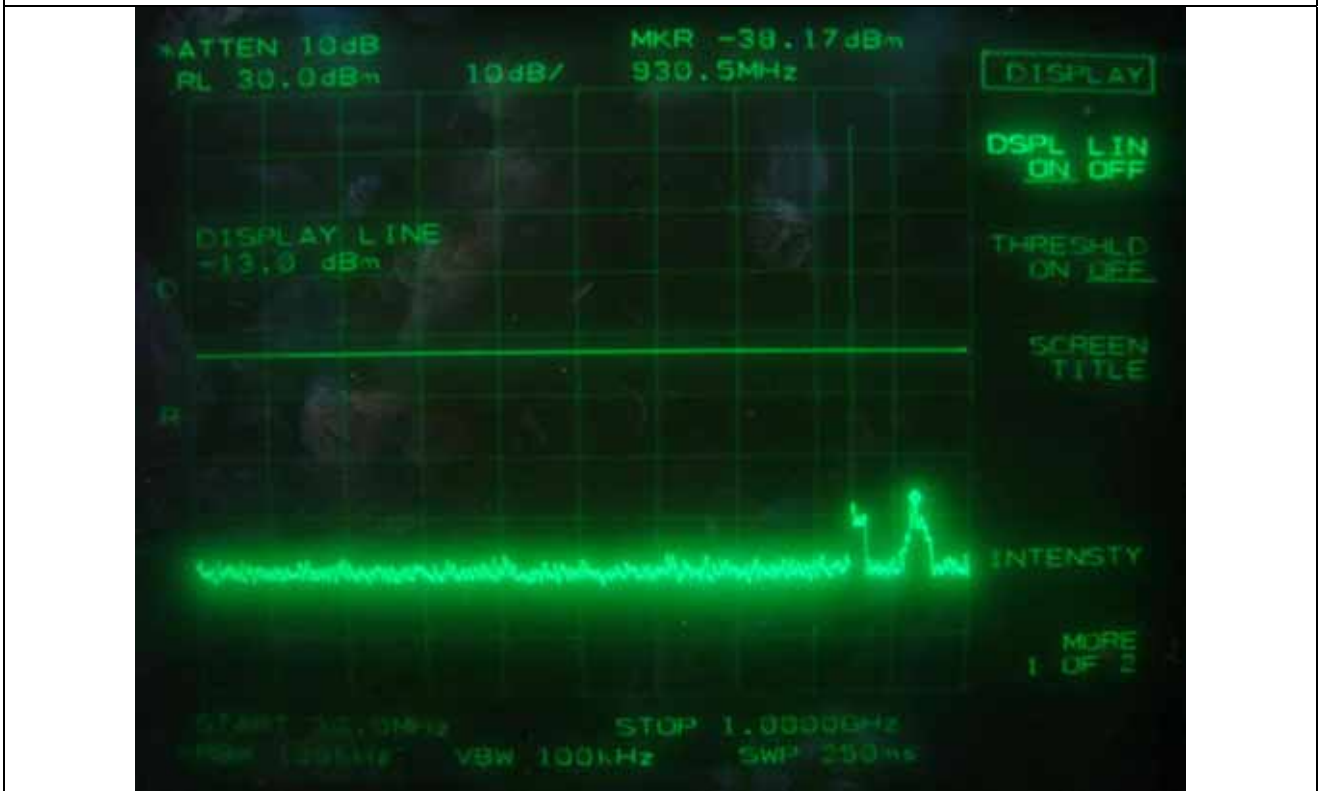
Remark: Intermodulation products must be attenuated below the rated power of the EUT at least $43 + 10\log(P_w)$, equivalent to -13dBm. Please refer to test data hereinafter.



Tested by: Ki-Hong, Nam / Project Engineer



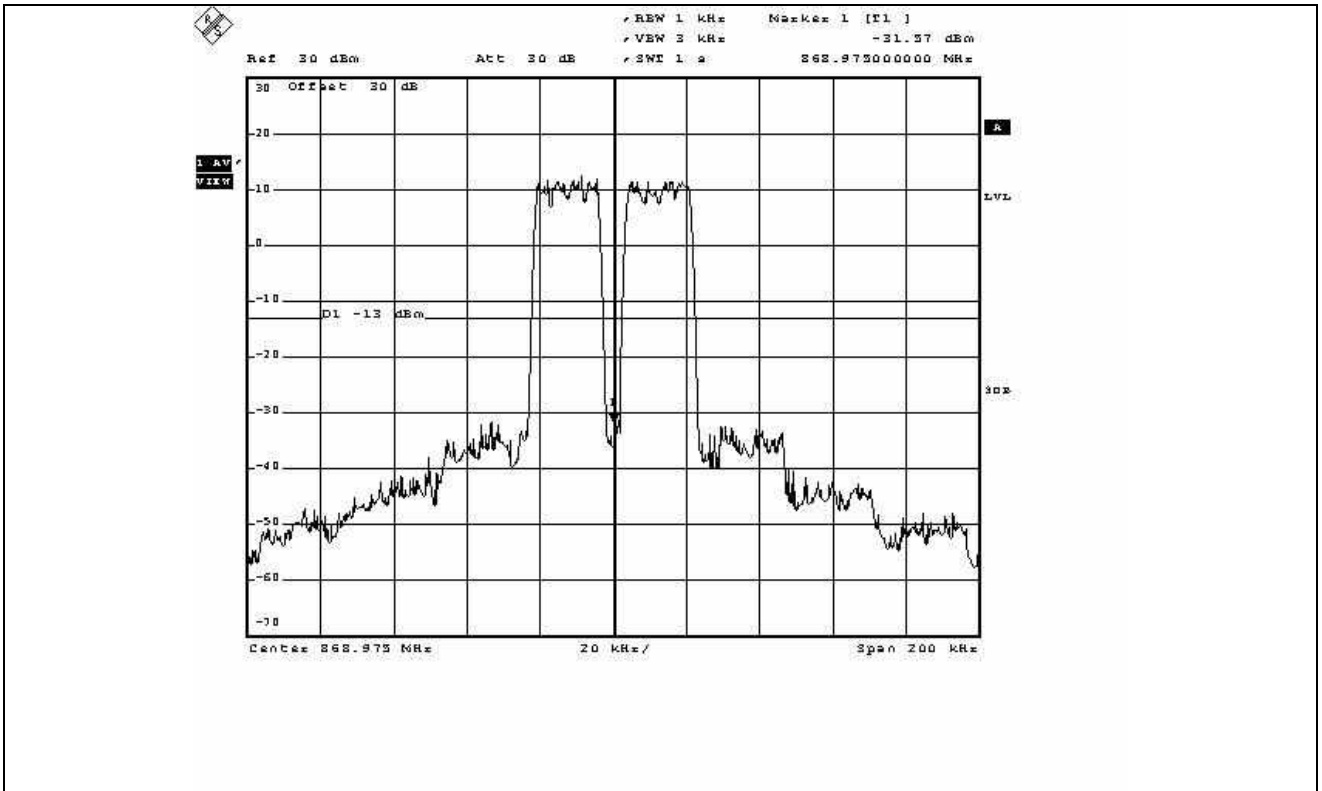
iDEN – Low Channel



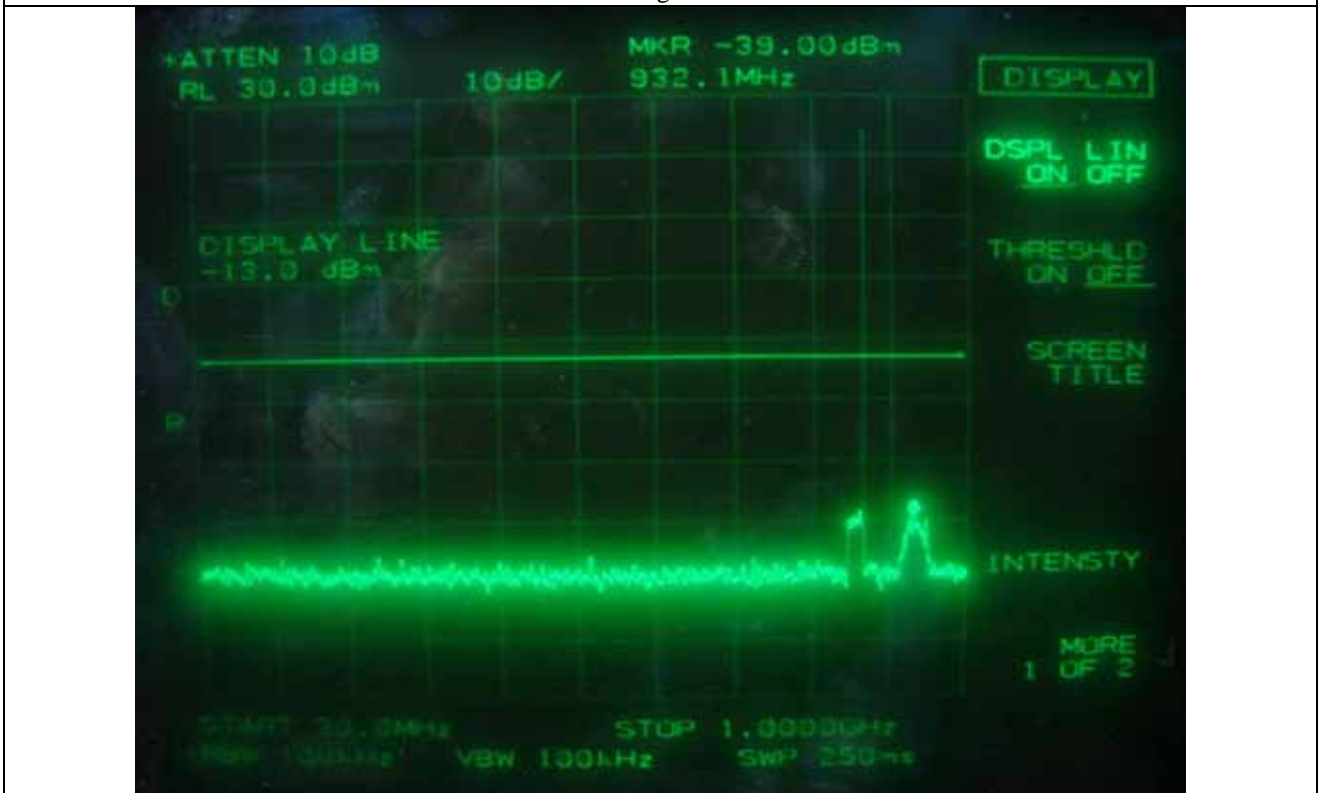
iDEN – Low Channel



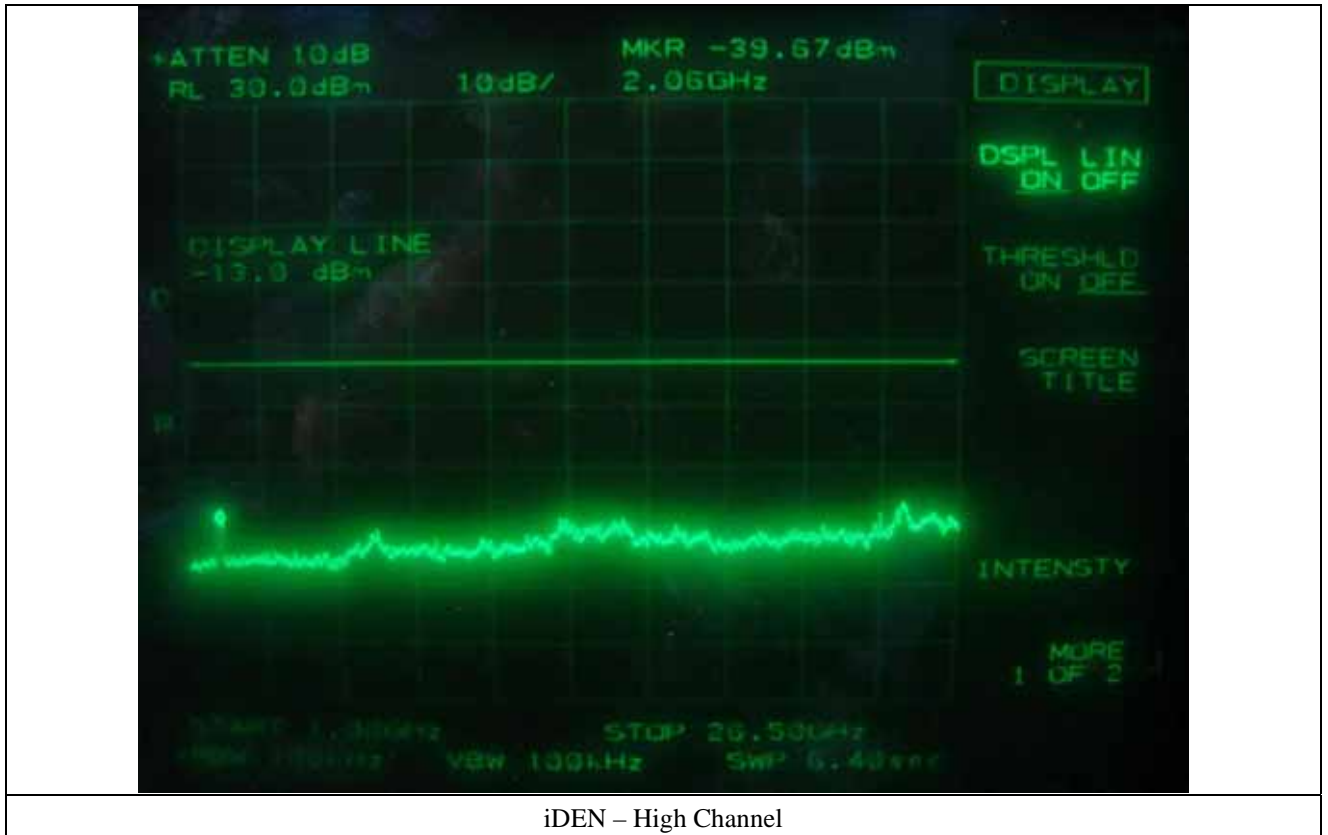
iDEN - Low Channel



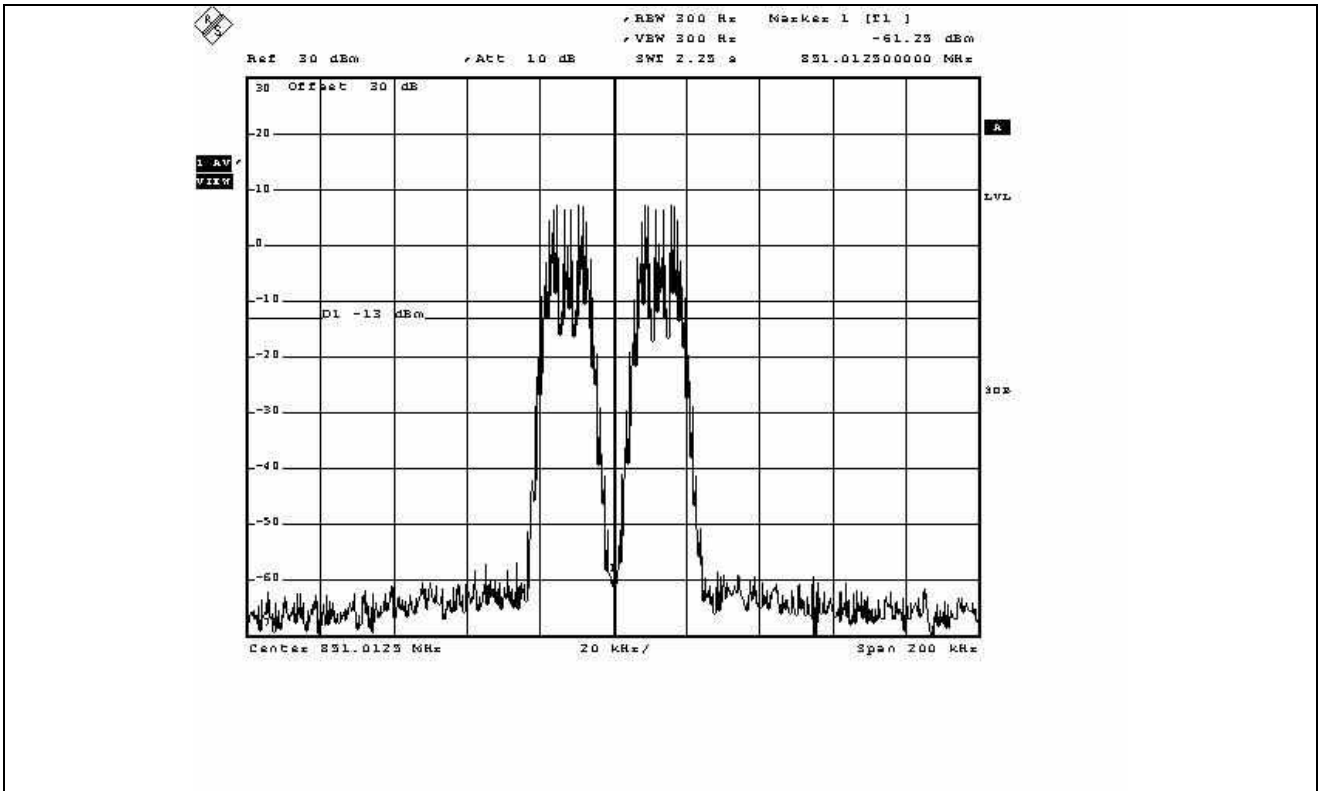
iDEN – High Channel



iDEN – High Channel



iDEN – High Channel



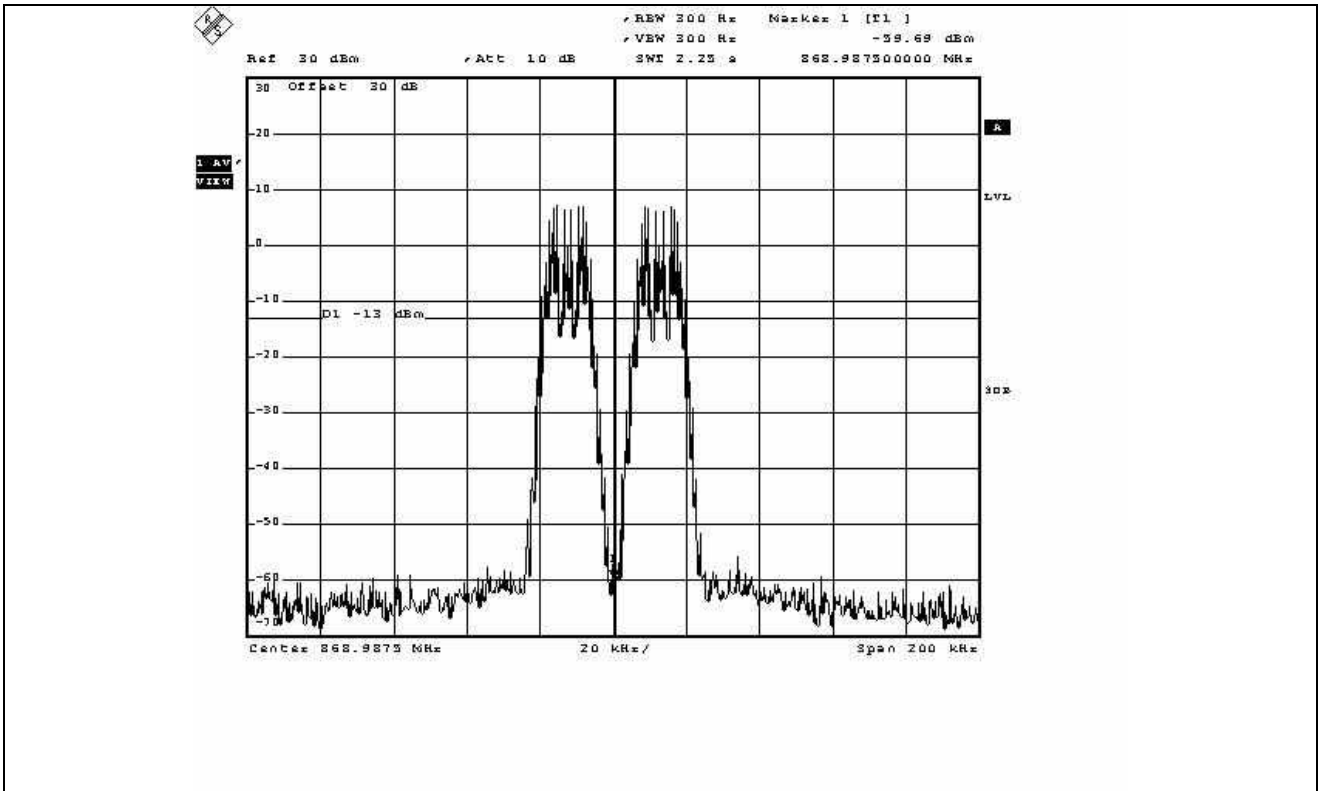
SMR – Low Channel



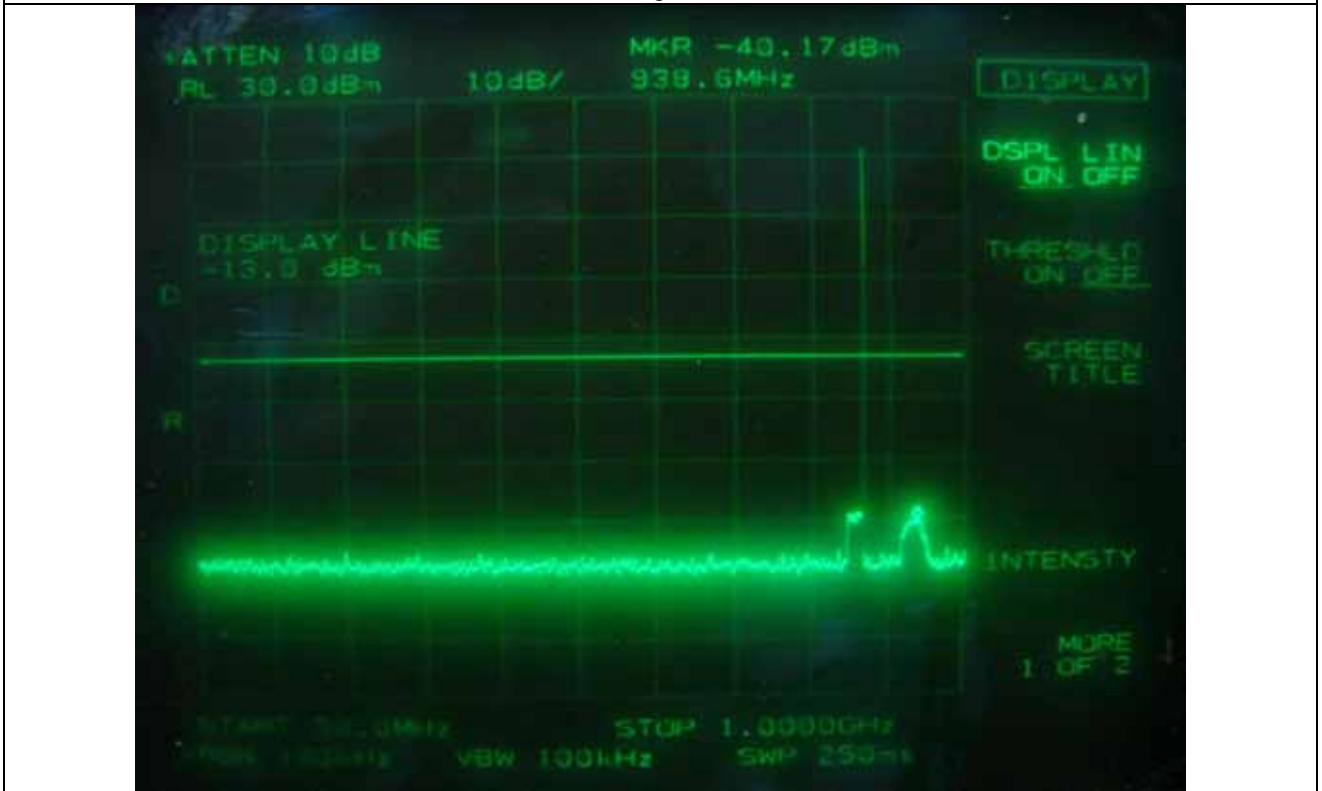
SMR – Low Channel



SMR – Low Channel



SMR – High Channel



SMR – High Channel



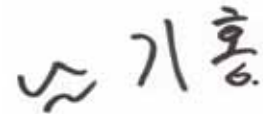
SMR – High Channel

9.4.2 Test Result for 900I+PA (929 MHz ~ 930 MHz)

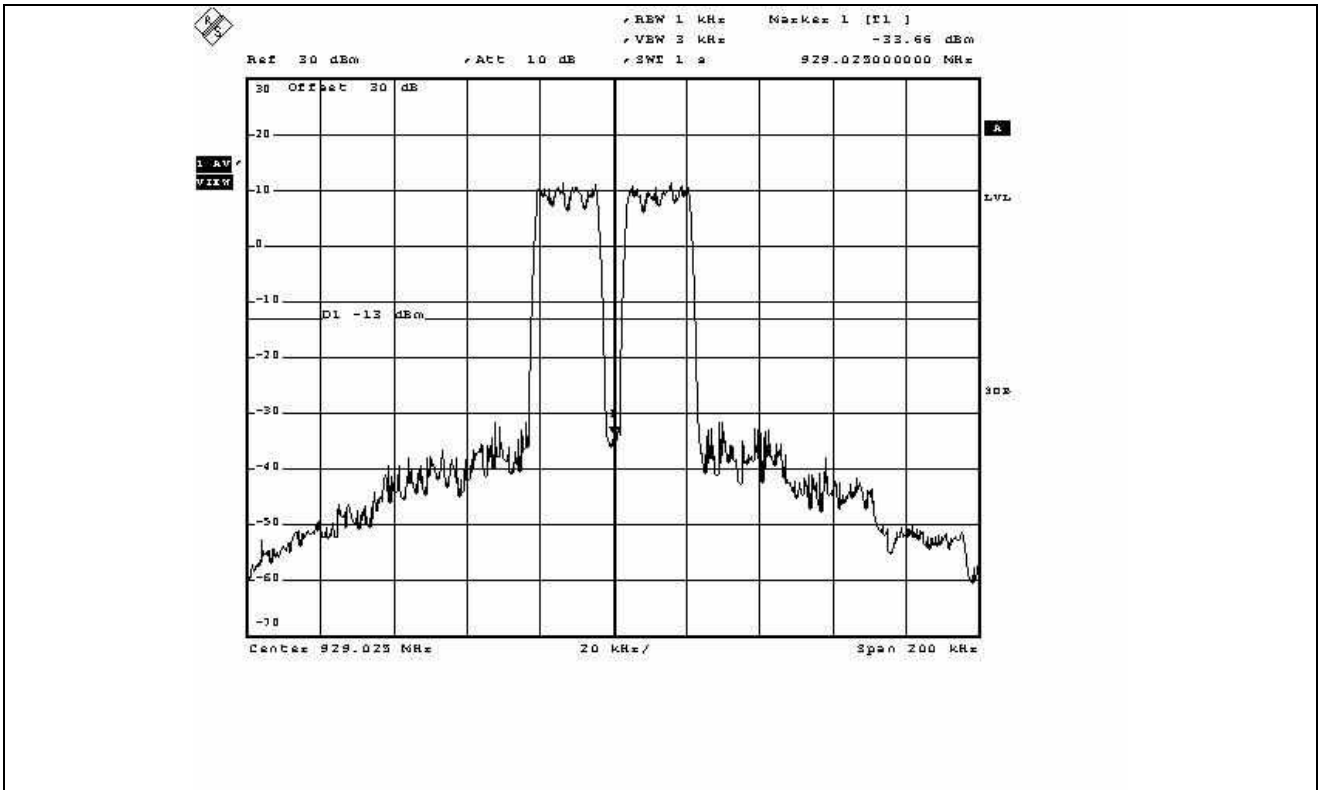
-. Test Date : March 09, 2009
-. Test Result : Pass

Modulation	Channel	Measured
iDEN	Low	< -13 dBm
	High	< -13 dBm
SMR	Low	< -13 dBm
	High	< -13 dBm

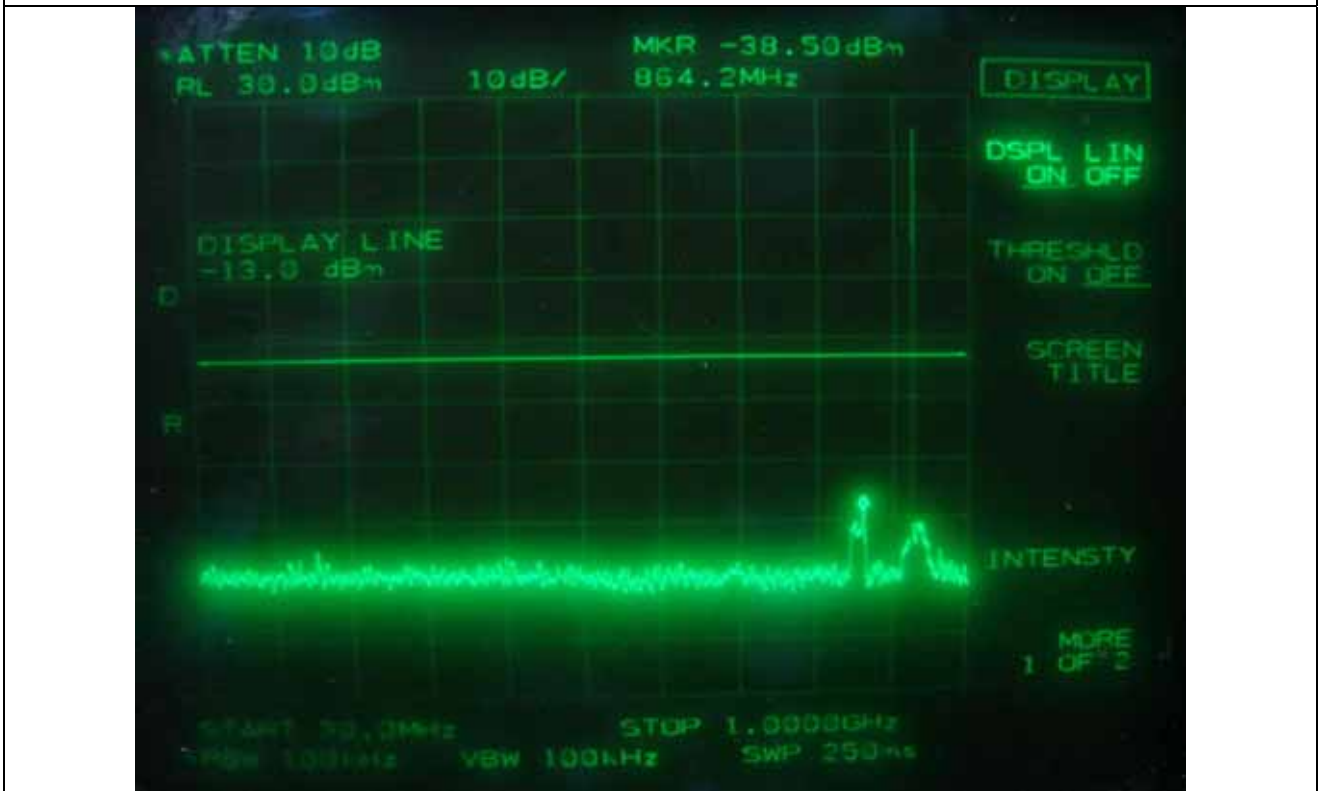
Remark: Intermodulation products must be attenuated below the rated power of the EUT at least $43 + 10\log(P_w)$, equivalent to -13dBm. Please refer to test data hereinafter.



Tested by: Ki-Hong, Nam / Project Engineer

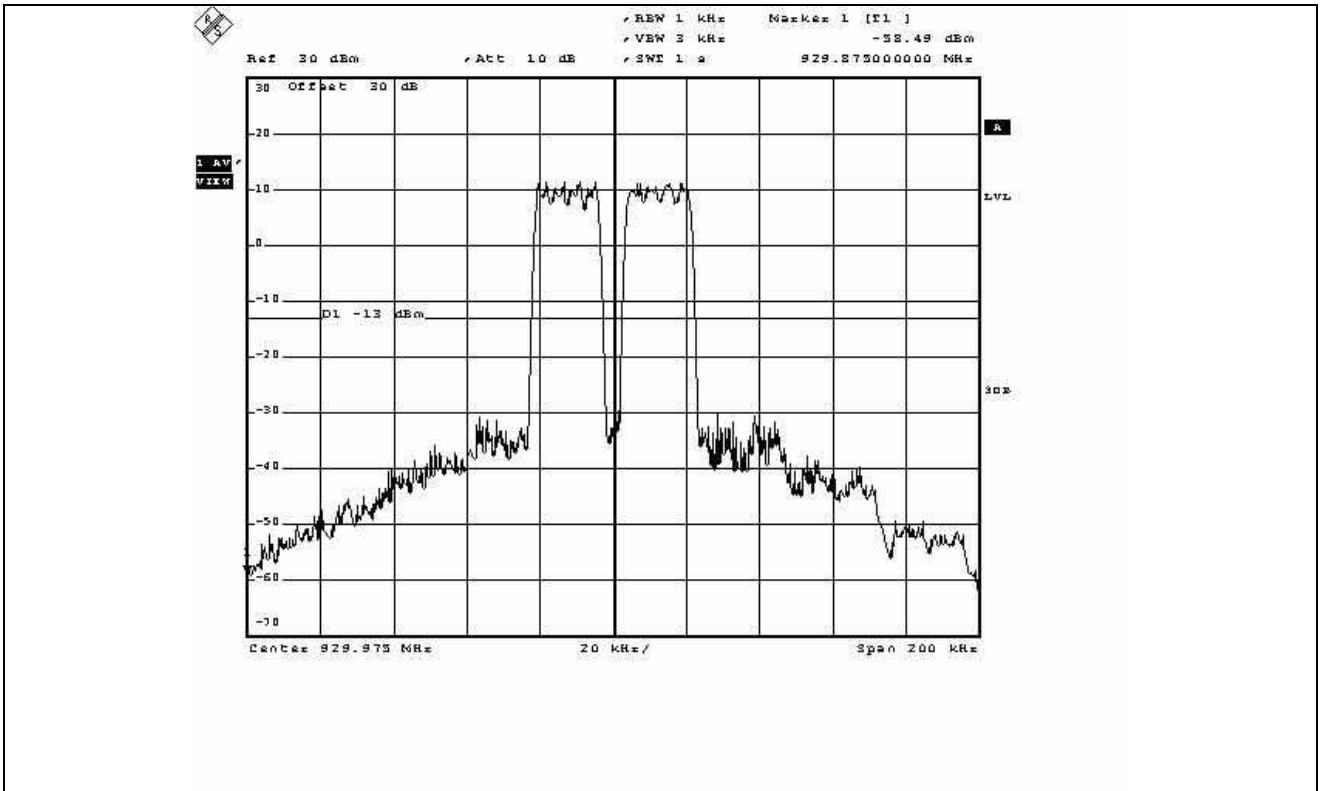


iDEN – Low Channel



iDEN – Low Channel



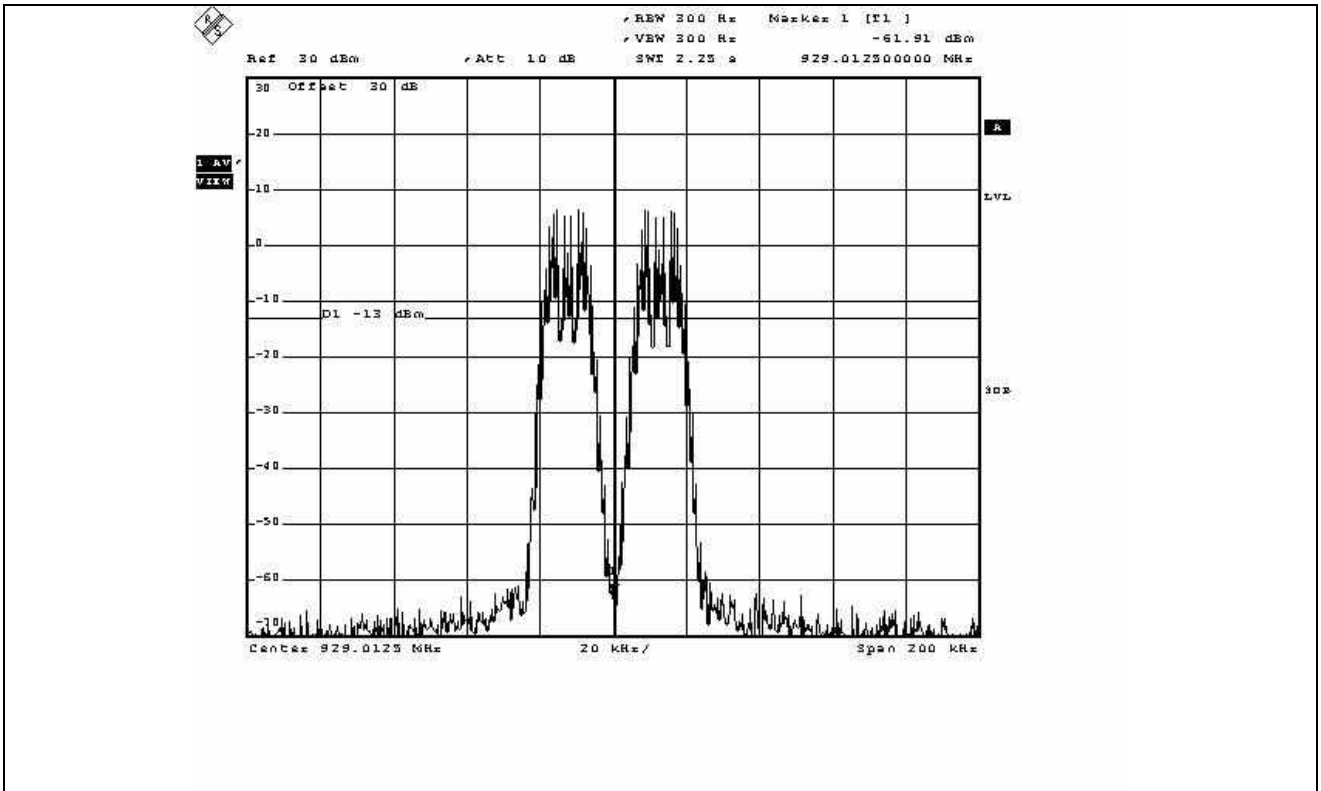


iDEN – High Channel

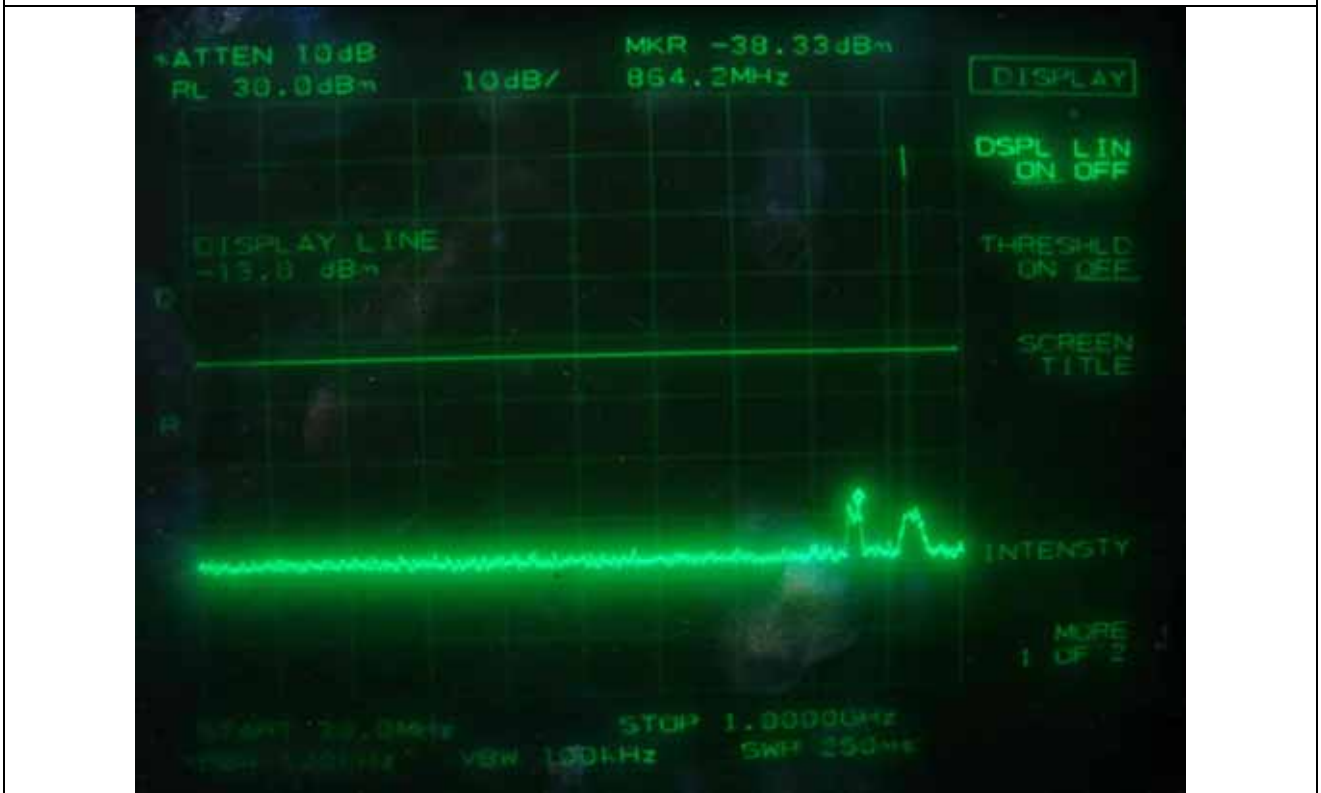


iDEN – High Channel





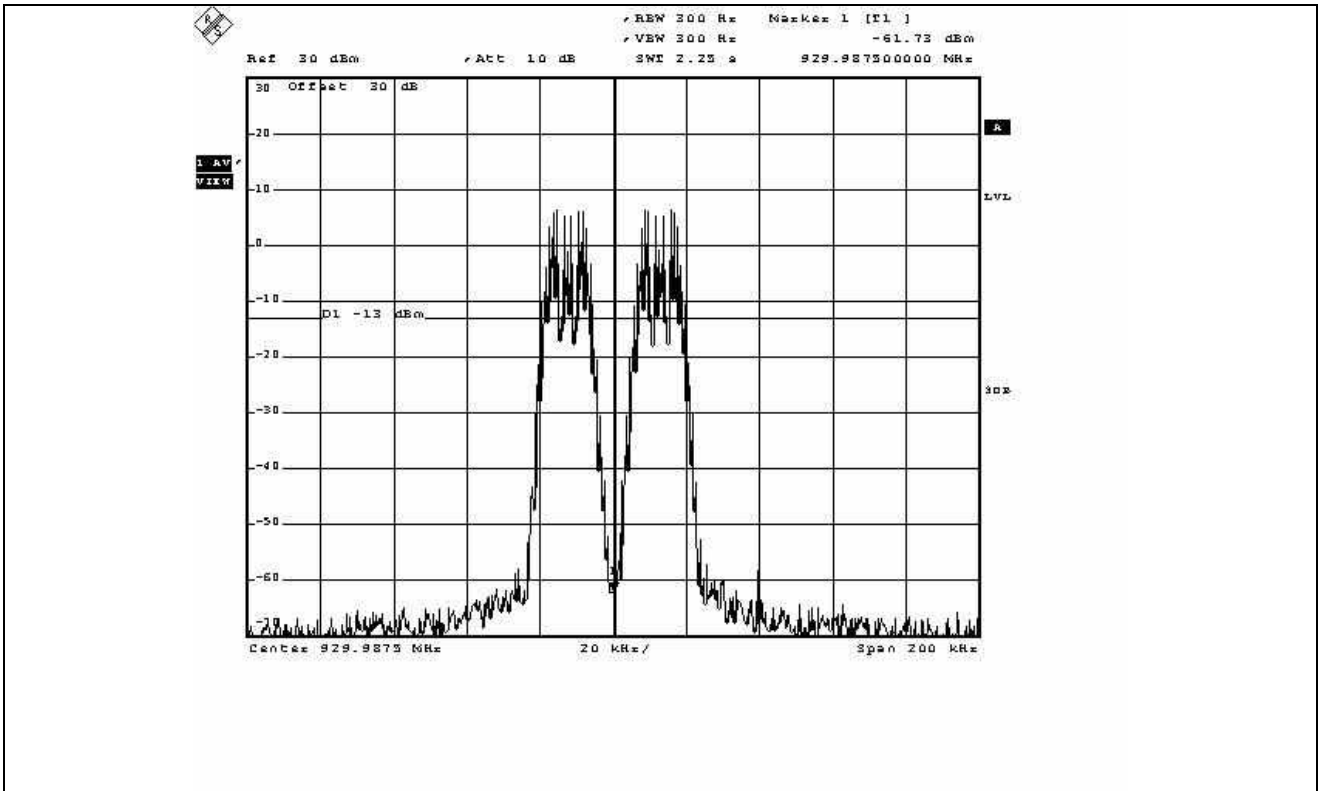
SMR – Low Channel



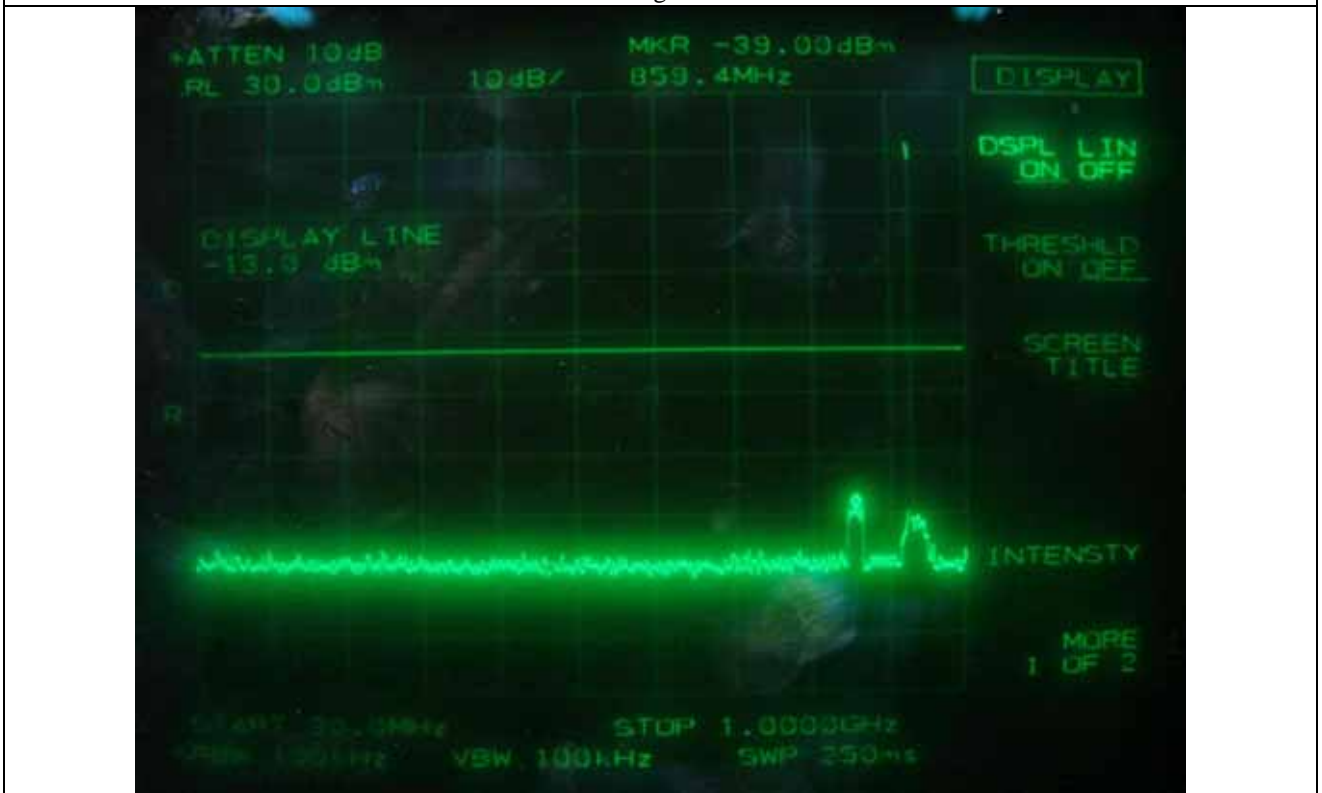
SMR – Low Channel



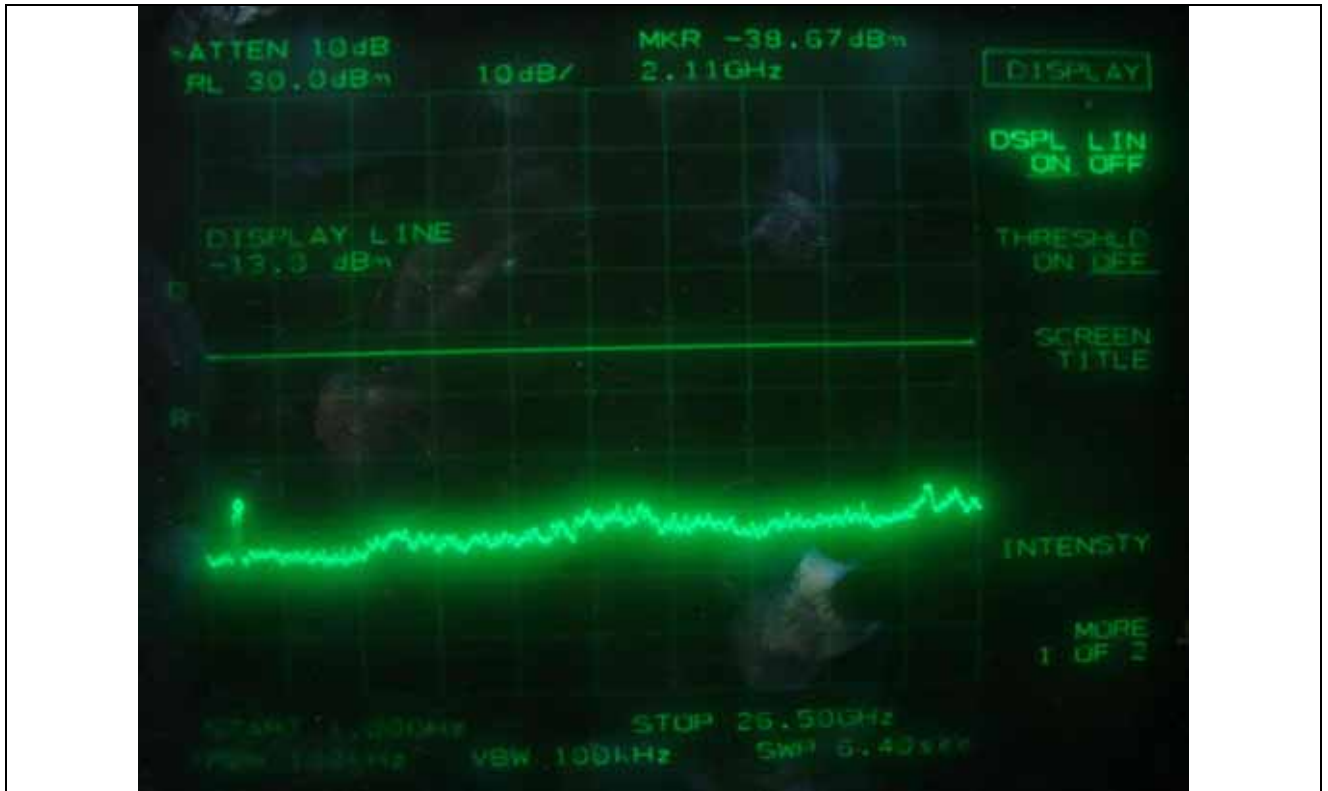
SMR – Low Channel



SMR – High Channel



SMR – High Channel



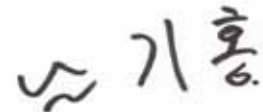
SMR – High Channel

9.4.3 Test Result for 900I+PA (935 MHz ~ 940 MHz)

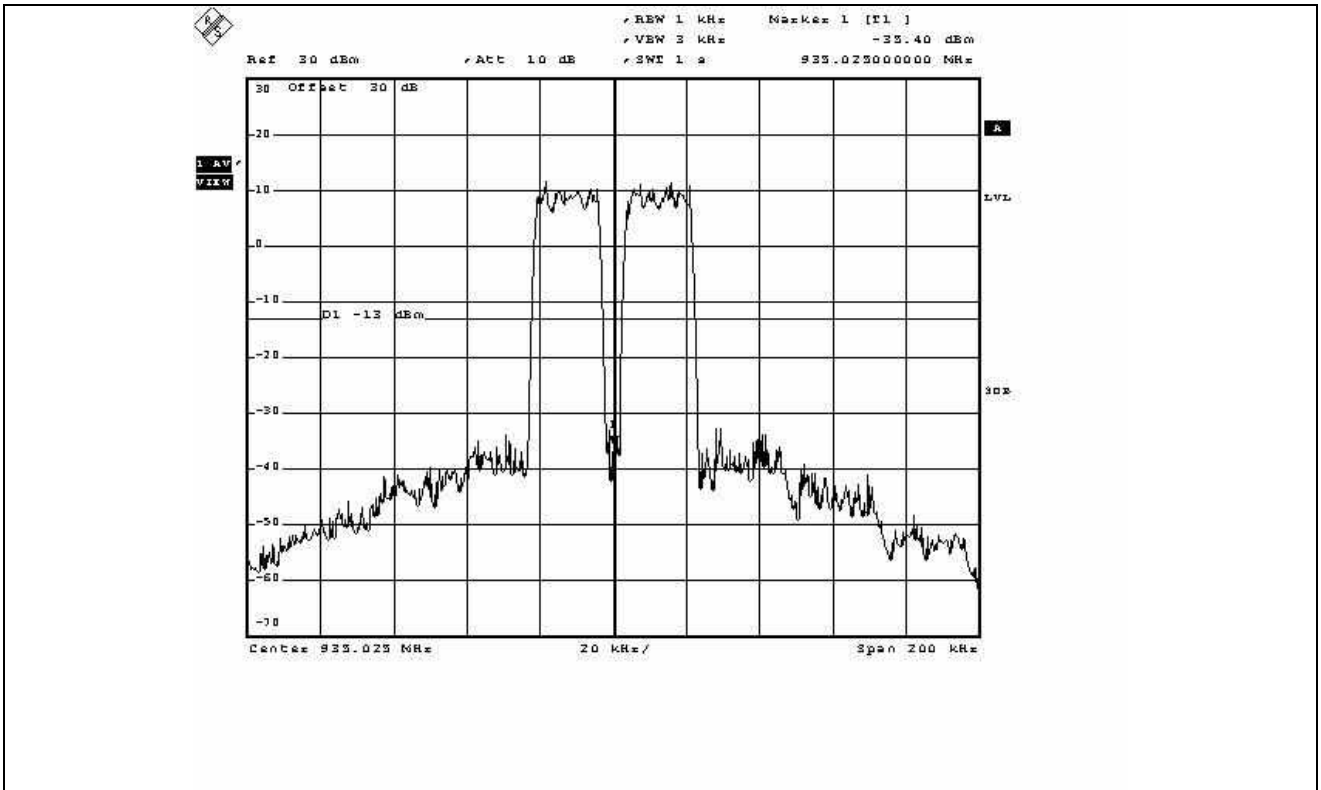
-. Test Date : March 09, 2009
-. Test Result : Pass

Modulation	Channel	Measured
iDEN	Low	< -13 dBm
	High	< -13 dBm
SMR	Low	< -13 dBm
	High	< -13 dBm

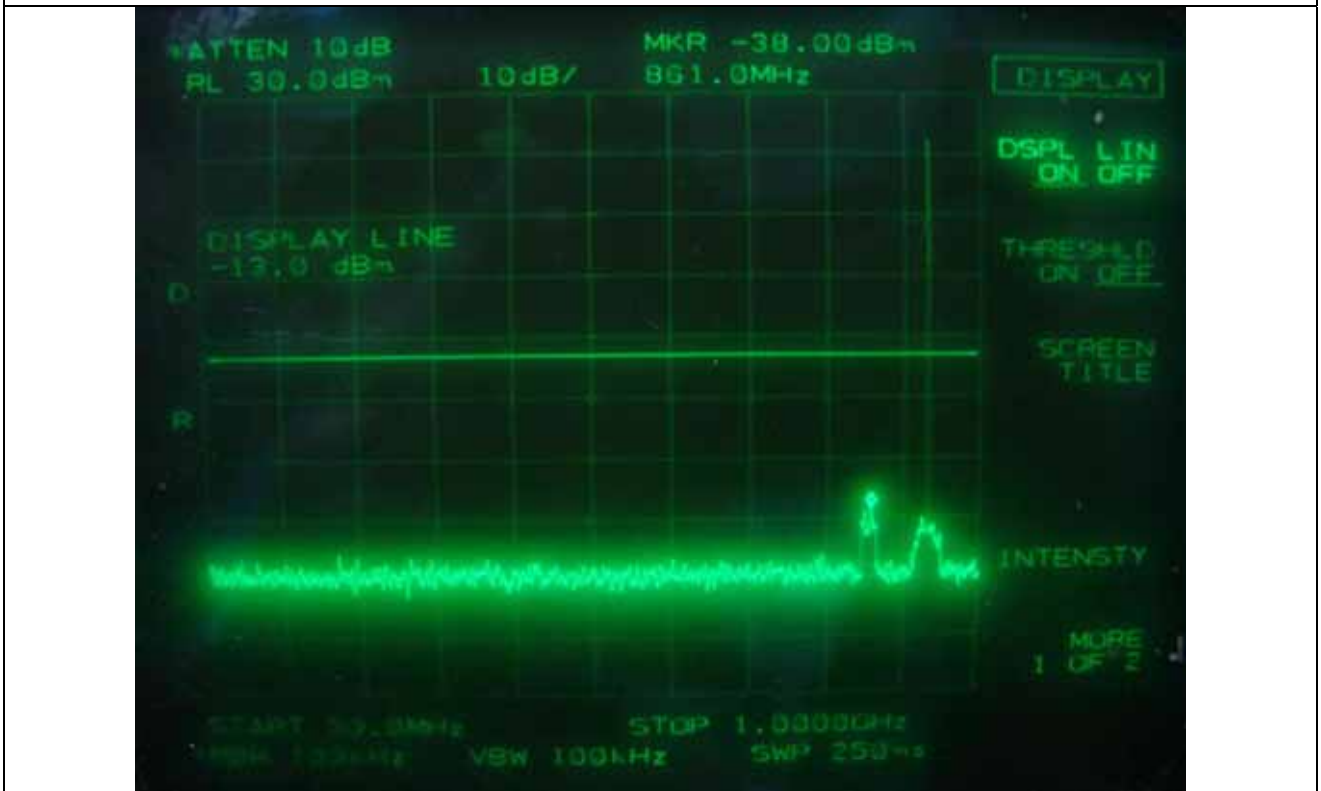
Remark: Intermodulation products must be attenuated below the rated power of the EUT at least $43 + 10\log(P_w)$, equivalent to -13dBm. Please refer to test data hereinafter.



Tested by: Ki-Hong, Nam / Project Engineer



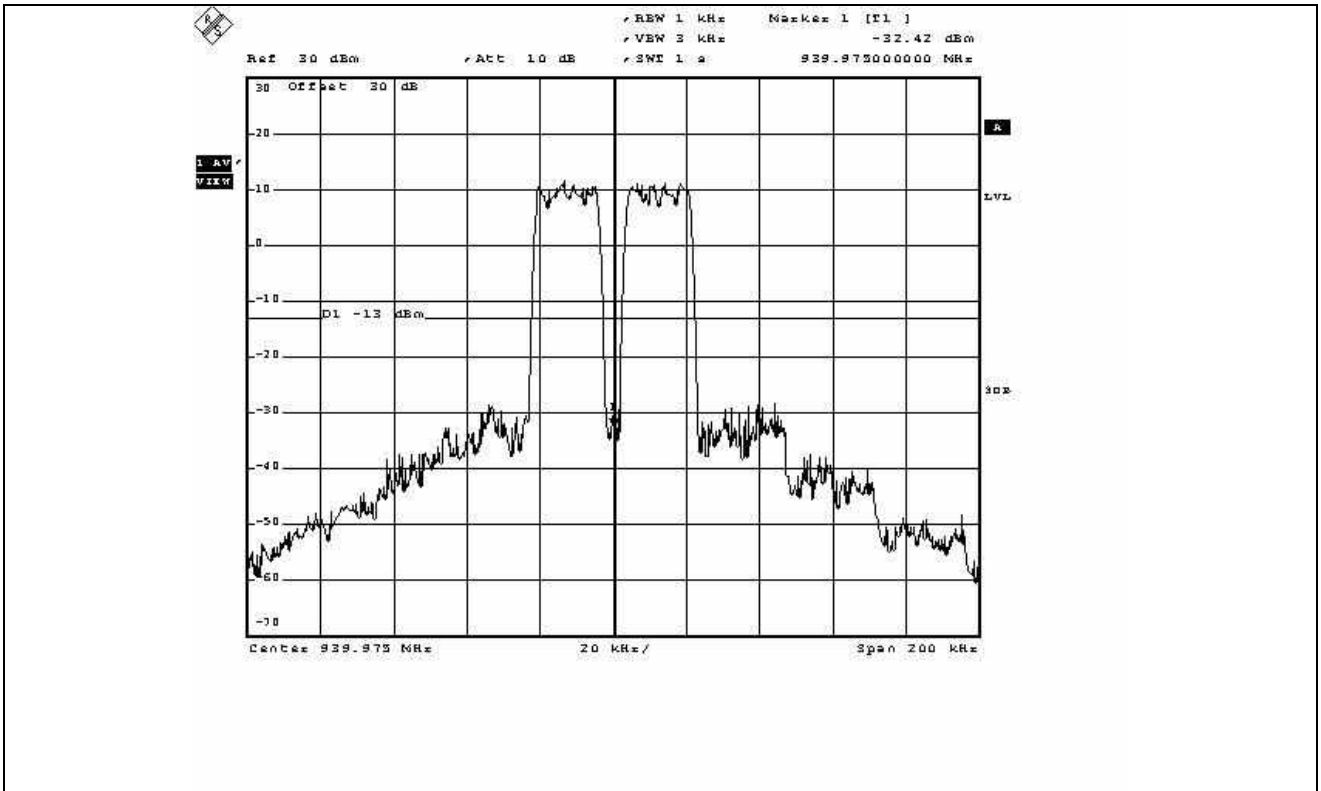
iDEN – Low Channel



iDEN – Low Channel



iDEN – Low Channel



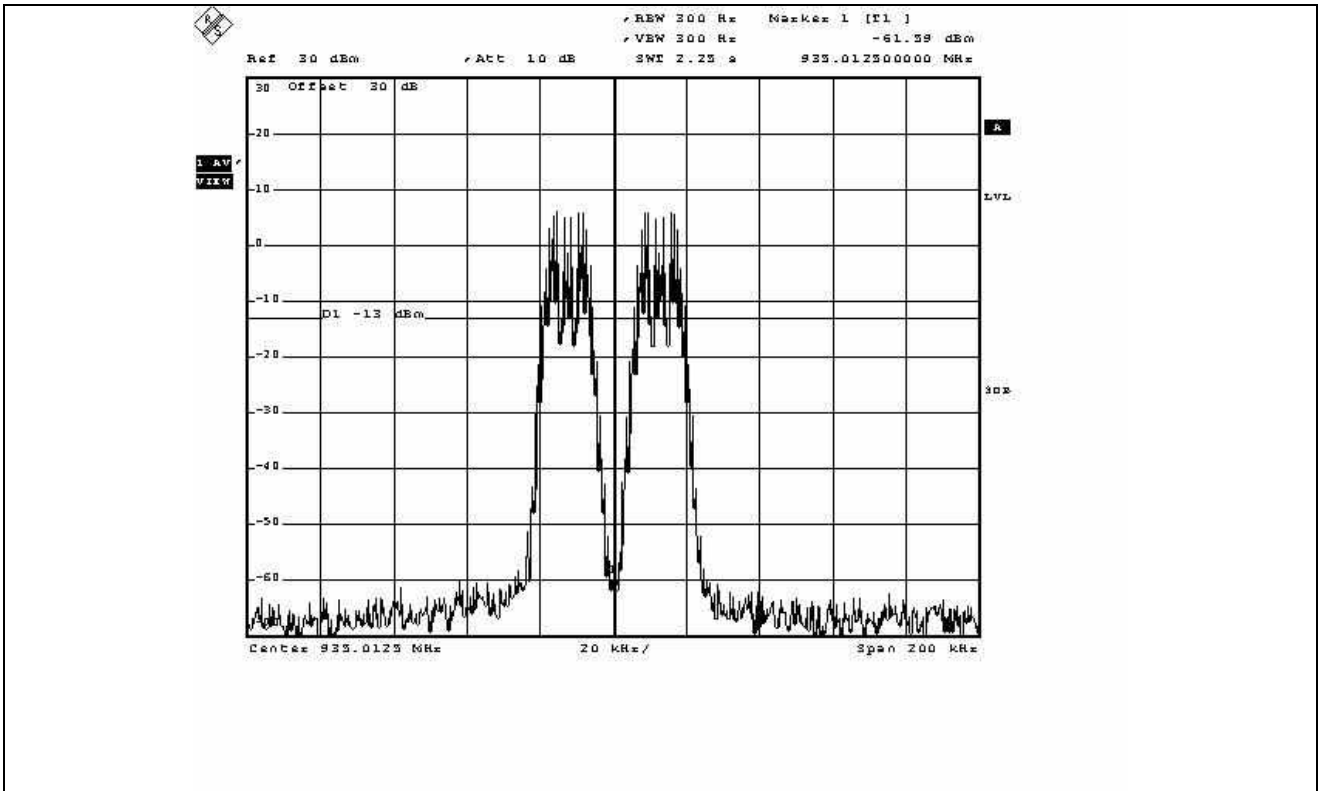
iDEN – High Channel



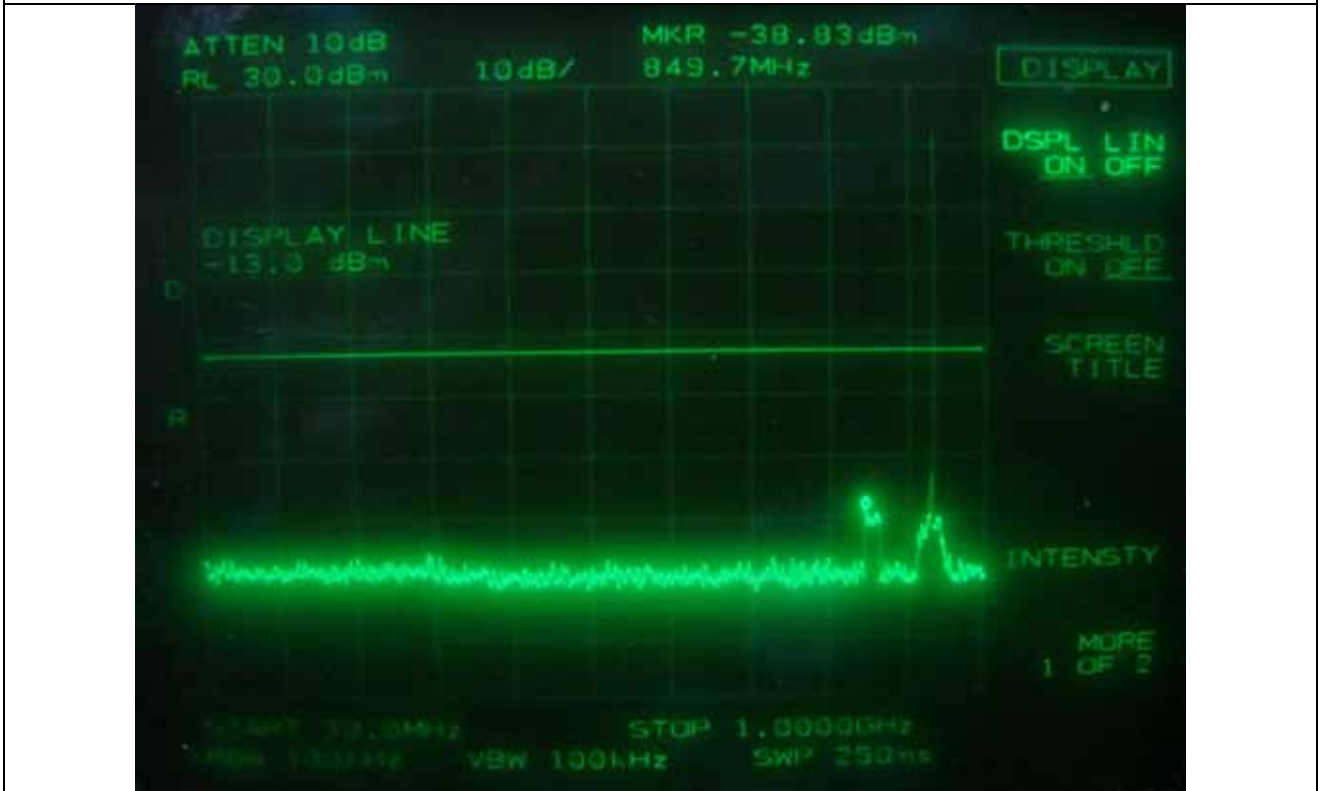
iDEN – High Channel



iDEN – High Channel

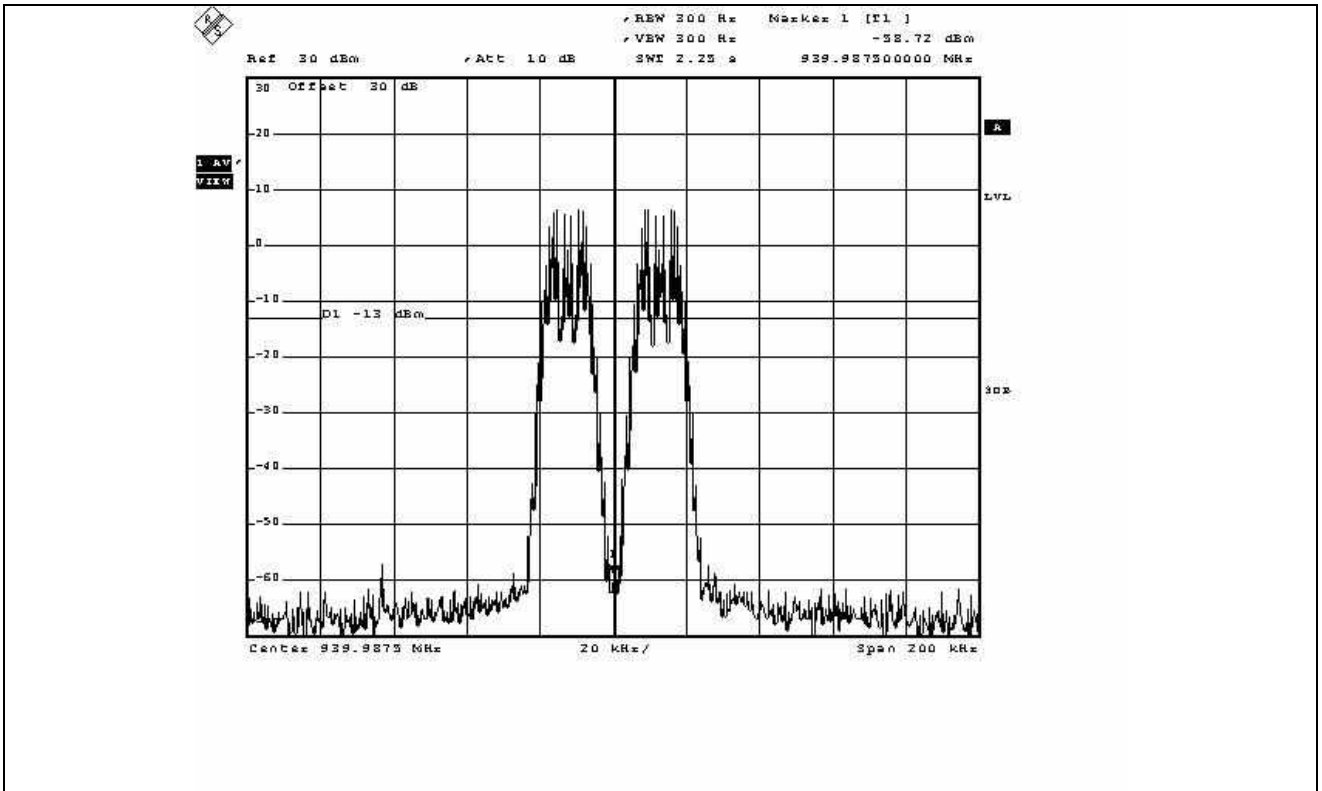


SMR – Low Channel

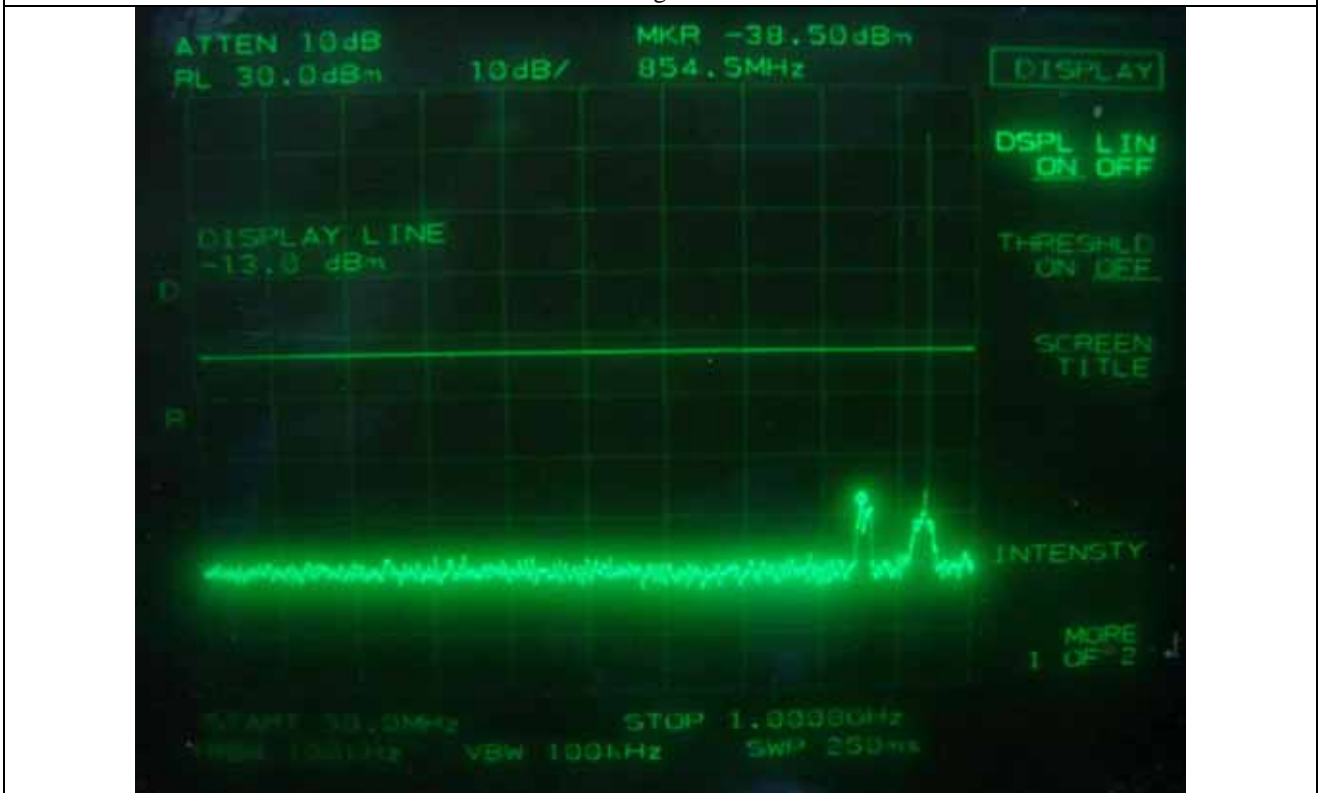


SMR – Low Channel

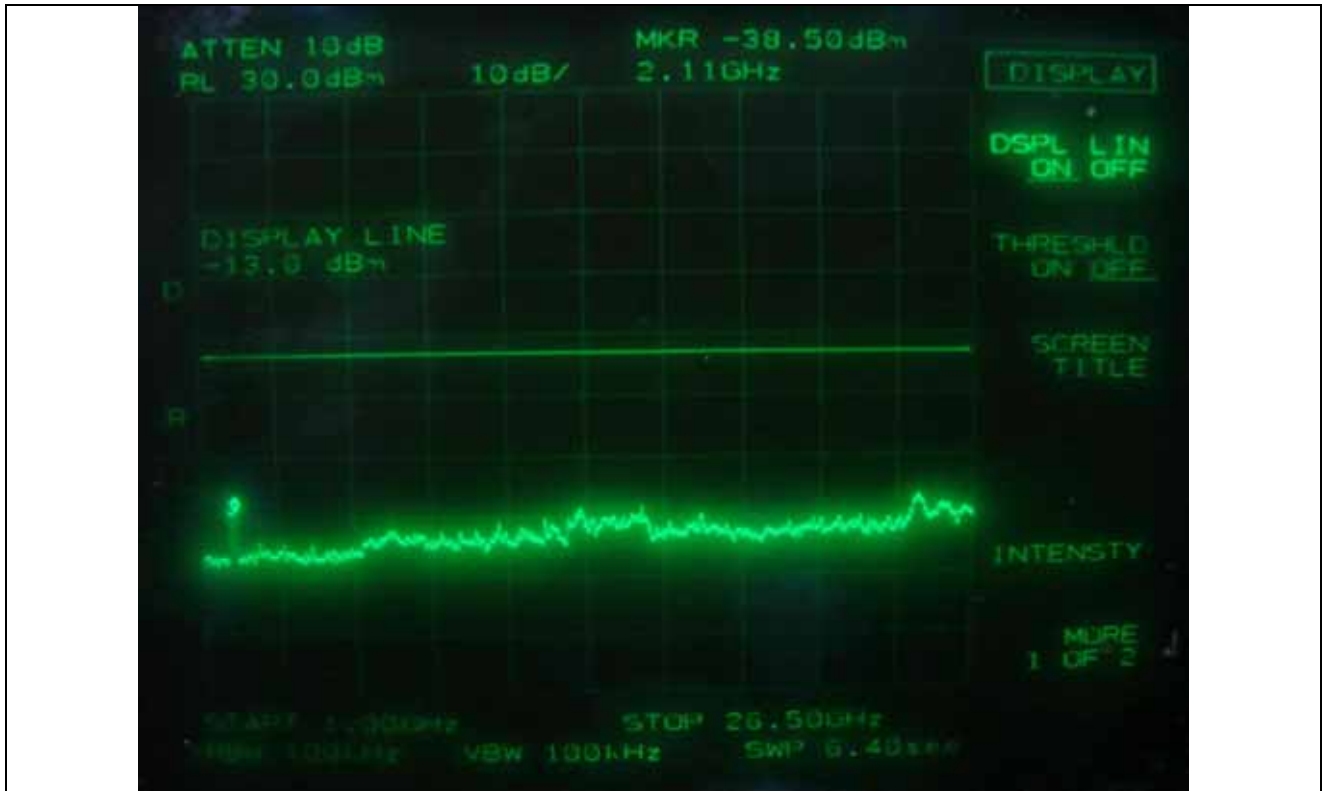




SMR – High Channel



SMR – High Channel



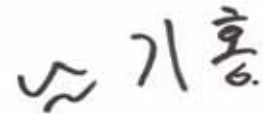
SMR – High Channel

9.4.4 Test Result for 900I+PA (940 MHz ~ 941 MHz)

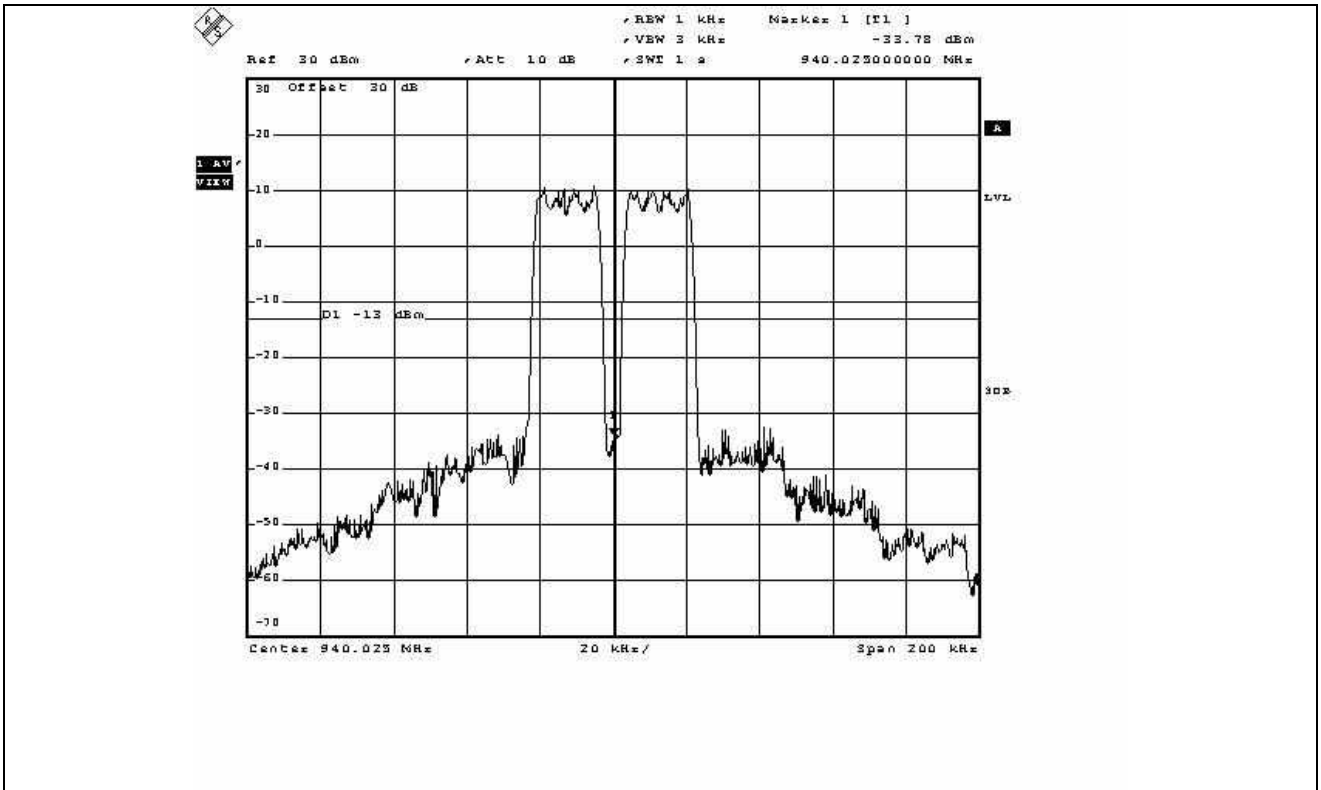
-. Test Date : March 09, 2009
-. Test Result : Pass

Modulation	Channel	Measured
iDEN	Low	< -13 dBm
	High	< -13 dBm
SMR	Low	< -13 dBm
	High	< -13 dBm

Remark: Intermodulation products must be attenuated below the rated power of the EUT at least $43 + 10\log(P_w)$, equivalent to -13dBm. Please refer to test data hereinafter.



Tested by: Ki-Hong, Nam / Project Engineer

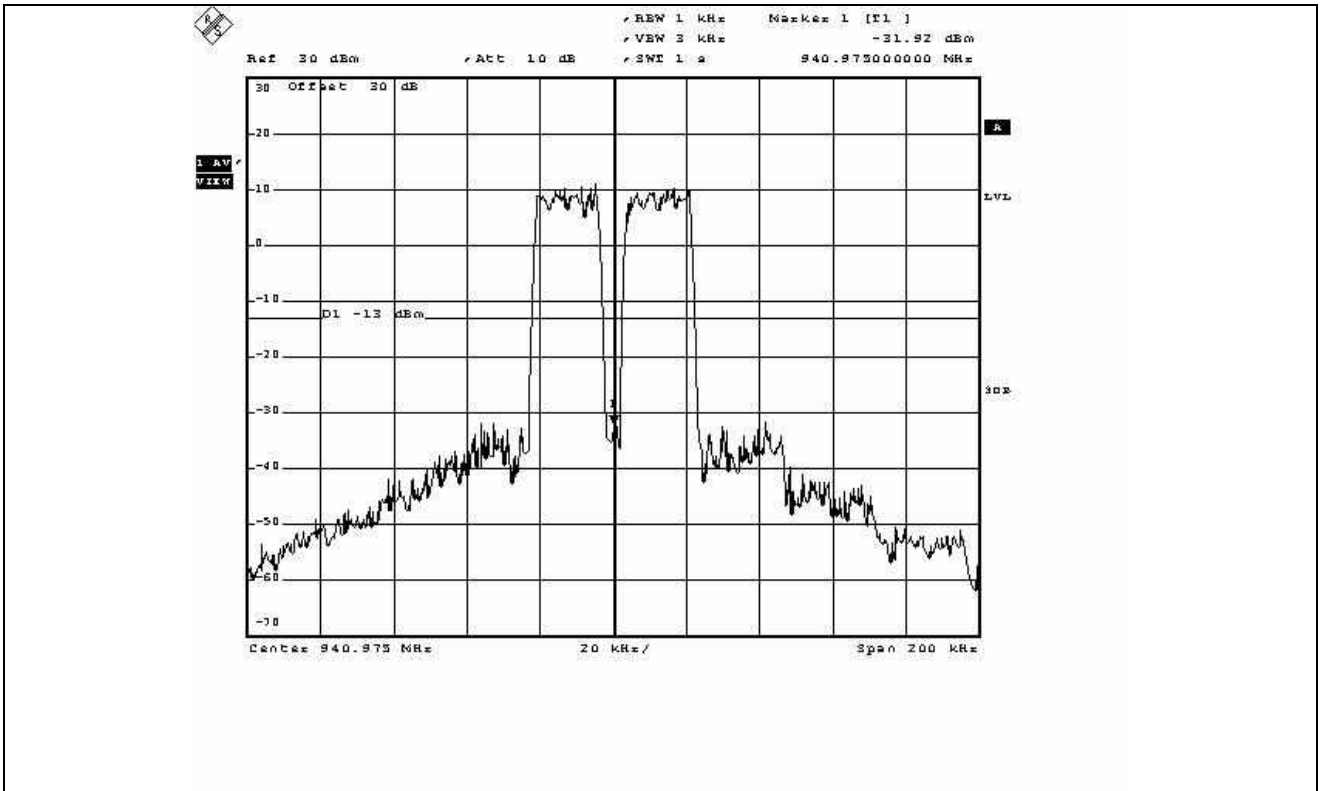


iDEN – Low Channel



iDEN – Low Channel





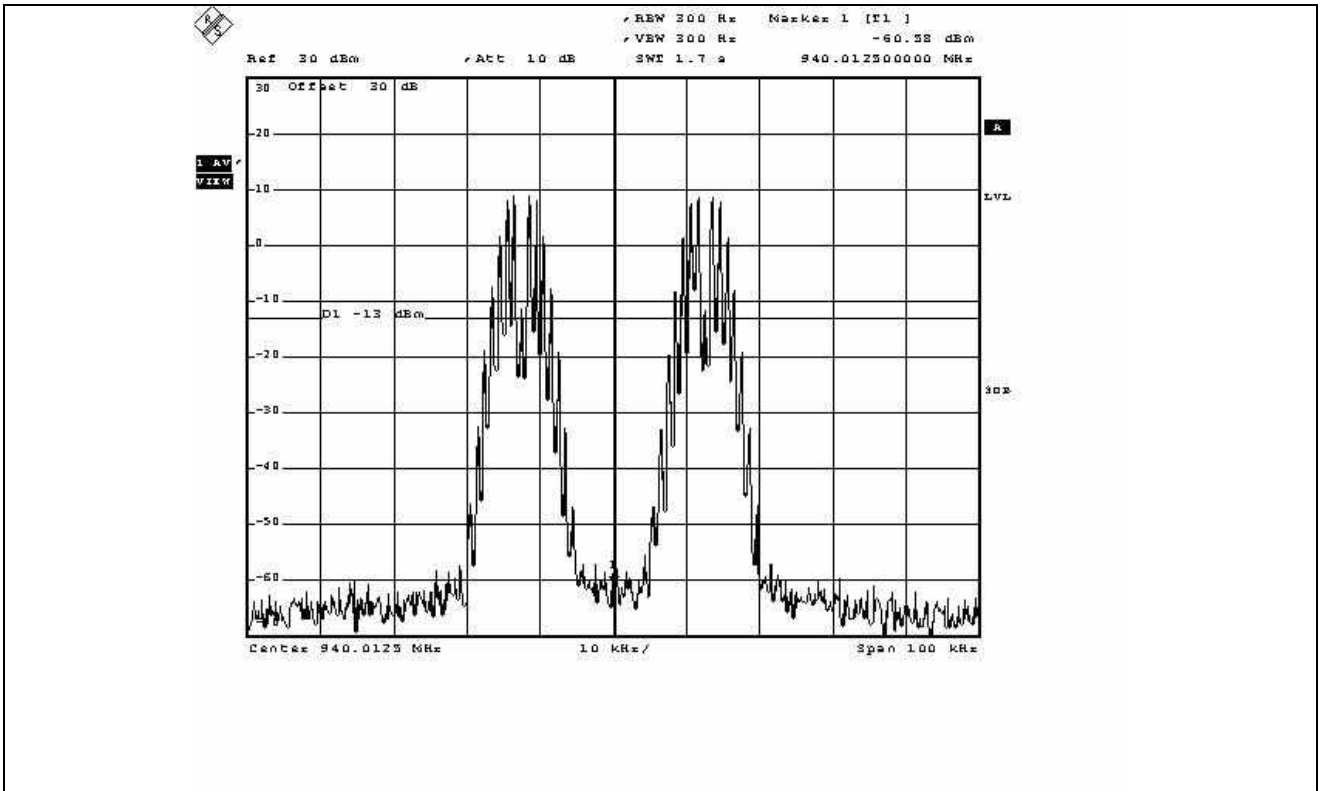
iDEN – High Channel



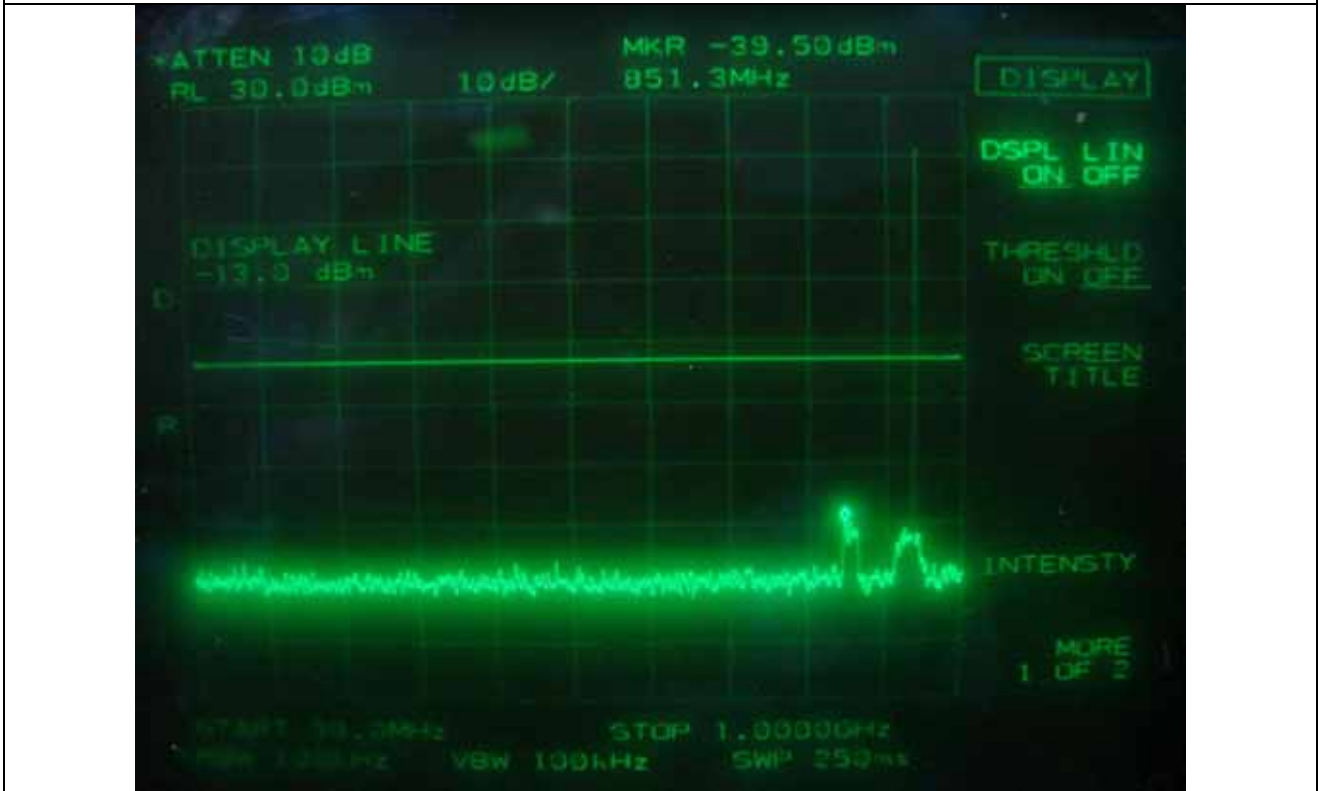
iDEN – High Channel



iDEN – High Channel



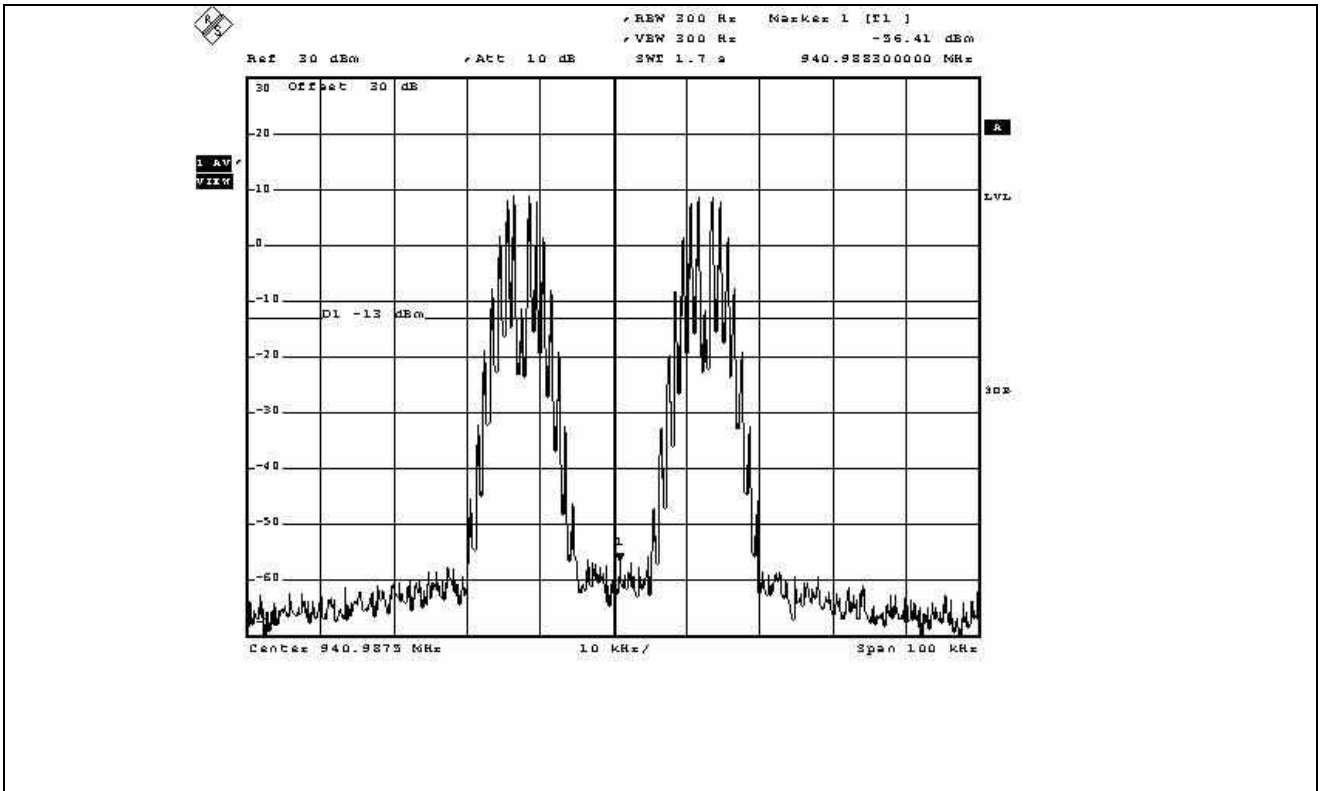
SMR – Low Channel



SMR – Low Channel



SMR – Low Channel



SMR – High Channel



SMR – High Channel



10. FIELD STRENGTH OF SPURIOUS RADIATION

10.1 Operating environment

Temperature : 11.8 °C
Relative humidity : 40.5 %R.H.

10.2 Test set-up

The radiated emissions measurements were on the 3 meters, open-field test site. The EUT and other support equipment were placed on a non-conductive turntable above the ground plane. The interconnecting cables from outside test site were inserted into ferrite clamps at the point where the cables reach the turntable.

The frequency spectrum from 30 MHz to up to 10th harmonic of the fundamental frequency was scanned and emission levels maximized at each frequency recorded. The system was rotated 360°, and the antenna was varied in height between 1.0 and 4.0 meters in order to determine the maximum emission levels. The test was performed by placing the EUT on 3-orthogonal axis. This procedure was performed for both horizontal and vertical polarization of the receiving antenna.

The maximum radiated emission was recorded and used as reference for the effective radiated power measurement. The EUT was then replaced by a tuned dipole antenna or Horn antenna and was oriented for vertical polarization and then the length was adjusted to correspond to the frequency of the transmitter. The substitution antenna was connected to a signal generator with a coaxial cable. The receiving antenna height was raised and lowered again through the specified range of height until maximum signal level is detected by the measuring receiver. The signal to the substitution antenna was adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the EUT radiated power measured, corrected for the change of input attenuation setting of the measuring receiver. The signal generator level was recorded and corrected by the power loss in the cable between the signal generator and substitution antenna and further corrected for the gain of the dipole antenna or horn antenna used relative to an ideal tuned dipole antenna. The measurement was repeated with the test antenna and the substitution antenna oriented for horizontal polarization. The measure of the effective radiated power is the larger of the two levels recorded.

10.3 Test equipment used

	Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ -	ESVD	Rohde & Schwarz	EMI Test Receiver	838453/018	Nov. 06, 2008
■ -	8564E	Hewlett-Packard	Spectrum Analyzer	3650A00756	June 16, 2008
■ -	83051A	Agilent	Preamplifier	3950M00201	June 16, 2008
■ -	E4432B	Hewlett-Packard	Signal Generator	US38440950	June 16, 2008
■ -	83650L	Hewlett-Packard	Signal Generator	3844A00415	June 16, 2008
■ -	BBHA9120D	Schwarzbeck	Horn Antenna	BBHA9120D294	July 03, 2006(3Y)
■ -	BBHA9120D	Schwarzbeck	Horn Antenna	BBHA9120D295	July 04, 2006(3Y)
■ -	SMJ100A	R/S	Vecter Signal Generator	100698	June 16, 2008
■ -	FSP	R/S	Spectrum Analyzer	100017	Mar. 11, 2009

All test equipment used is calibrated on a regular basis.

10.4 Test data for radiated emission

10.4.1 Test Result for 800PS

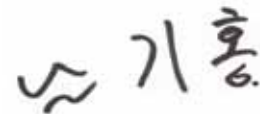
10.4.1.1 Modulated Input Signal: iDEN (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.49 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
851.025 0	61.67	-4.21	0.07	H	1.59	-5.73	-	-
	62.15	-2.70		V		-4.22	-	-
Test Data for Middle Channel								
860.000 0	61.72	-3.95	0.01	H	1.60	-5.54	-	-
	62.33	-2.50		V		-4.09	-	-
Test Data for High Channel								
868.975 0	61.50	-4.08	-0.18	H	1.62	-5.88	-	-
	62.20	-2.44		V		-4.24	-	-
100.100 0	26.72	-58.76	1.60	V	0.33	-57.49	-13.00	-44.49
110.400 0	24.65	-61.18	1.55	H	0.33	-59.30	-13.00	-46.30
262.200 0	22.33	-62.60	1.66	H	0.50	-60.44	-13.00	-47.44
858.100 0	23.78	-63.09	0.03	V	0.67	-62.39	-13.00	-49.39

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

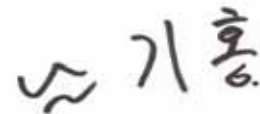
10.4.1.2 Modulated Input Signal: SMR (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.65 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
851.012 5	61.81	-4.07	0.07	H	1.59	-5.59	-	-
	62.50	-2.35		V		-3.87	-	-
Test Data for Middle Channel								
860.000 0	61.78	-3.89	0.01	H	1.60	-5.48	-	-
	62.41	-2.42		V		-4.01	-	-
Test Data for High Channel								
868.987 5	61.45	-4.13	-0.18	H	1.62	-5.93	-	-
	62.27	-2.37		V		-4.17	-	-
100.100 0	26.56	-58.92	1.60	V	0.33	-57.65	-13.00	-44.65
110.400 0	24.71	-61.12	1.55	H	0.33	-59.24	-13.00	-46.24
262.200 0	22.83	-62.10	1.66	H	0.50	-59.94	-13.00	-46.94
858.100 0	23.17	-63.70	0.03	V	0.67	-63.00	-13.00	-50.00

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

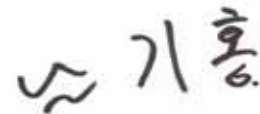
10.4.1.3 Modulated Input Signal: iDEN (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.29dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
851.025 0	61.50	-4.38	0.07	H	1.59	-5.90	-	-
	62.25	-2.60		V		-4.12	-	-
Test Data for Middle Channel								
860.000 0	61.83	-3.84	0.01	H	1.60	-5.43	-	-
	62.50	-2.33		V		-3.92	-	-
Test Data for High Channel								
868.975 0	61.72	-3.86	-0.18	H	1.62	-5.66	-	-
	62.42	-2.22		V		-4.02	-	-
100.100 0	26.92	-58.56	1.60	V	0.33	-57.29	-13.00	-44.29
110.400 0	24.48	-61.35	1.55	H	0.33	-60.13	-13.00	-47.13
262.200 0	22.57	-62.36	1.66	H	0.50	-61.20	-13.00	-48.20
858.100 0	23.50	-63.37	0.03	V	0.67	-64.01	-13.00	-51.01

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

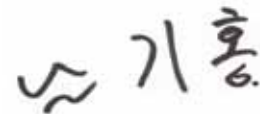
10.4.1.4 Modulated Input Signal: SMR (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.88 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
851.012 5	61.72	-4.16	0.07	H	1.59	-5.68	-	-
	62.48	-2.37		V		-3.89	-	-
Test Data for Middle Channel								
860.000 0	61.33	-4.34	0.01	H	1.60	-5.93	-	-
	62.27	-2.56		V		-4.15	-	-
Test Data for High Channel								
868.987 5	61.67	-3.91	-0.18	H	1.62	-5.71	-	-
	62.33	-2.31		V		-4.11	-	-
100.100 0	26.33	-59.15	1.60	V	0.33	-57.88	-13.00	-44.88
110.400 0	24.83	-61.00	1.55	H	0.33	-59.78	-13.00	-46.78
262.200 0	22.78	-62.15	1.66	H	0.50	-60.99	-13.00	-47.99
858.100 0	23.50	-63.37	0.03	V	0.67	-64.01	-13.00	-51.01

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

10.4.2 Test Result for 900I+PA (929 MHz ~ 930 MHz)

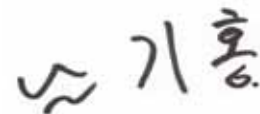
10.4.2.1 Modulated Input Signal: iDEN (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.86 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
929.025 0	60.25	-5.80	-0.52	H	1.67	-7.99	-	-
	59.67	-4.41		V		-6.60	-	-
Test Data for Middle Channel								
929.500 0	60.42	-6.19	-0.52	H	1.67	-8.38	-	-
	59.50	-4.80		V		-6.99	-	-
Test Data for High Channel								
929.987 5	60.83	-5.42	-0.50	H	1.67	-7.59	-	-
	59.78	-4.39		V		-6.56	-	-
100.100 0	26.35	-59.13	1.60	V	0.33	-57.86	-13.00	-44.86
110.400 0	24.72	-61.11	1.55	H	0.33	-59.89	-13.00	-46.89
262.200 0	22.65	-62.28	1.66	H	0.50	-61.12	-13.00	-48.12
858.100 0	23.17	-63.70	0.03	V	0.67	-64.34	-13.00	-51.34

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

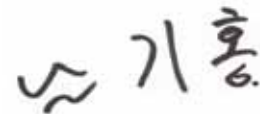
10.4.2.2 Modulated Input Signal: SMR (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.30 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
929.025 0	60.38	-5.67	-0.52	H	1.67	-7.86	-	-
	59.83	-4.25		V		-6.44	-	-
Test Data for Middle Channel								
929.500 0	60.78	-5.83	-0.52	H	1.67	-8.02	-	-
	60.00	-4.30		V		-6.49	-	-
Test Data for High Channel								
929.987 5	60.55	-5.70	-0.50	H	1.67	-7.87	-	-
	59.90	-4.27		V		-6.44	-	-
100.100 0	26.91	-58.57	1.60	V	0.33	-57.30	-13.00	-44.30
110.400 0	24.50	-61.33	1.55	H	0.33	-59.45	-13.00	-46.45
262.200 0	22.83	-62.10	1.66	H	0.50	-59.94	-13.00	-46.94
858.100 0	23.78	-63.09	0.03	V	0.67	-62.39	-13.00	-49.39

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

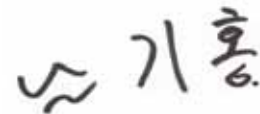
10.4.2.3 Modulated Input Signal: iDEN (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.29dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
929.025 0	60.60	-5.45	-0.52	H	1.67	-7.64	-	-
	59.92	-4.16		V		-6.35	-	-
Test Data for Middle Channel								
929.500 0	60.33	-6.28	-0.52	H	1.67	-8.47	-	-
	59.42	-4.88		V		-7.07	-	-
Test Data for High Channel								
929.987 5	60.78	-5.47	-0.50	H	1.67	-7.64	-	-
	59.67	-4.50		V		-6.67	-	-
100.100 0	27.00	-58.48	1.60	V	0.33	-57.21	-13.00	-44.21
110.400 0	25.17	-60.66	1.55	H	0.33	-59.44	-13.00	-46.44
262.200 0	22.83	-62.60	1.66	H	0.50	-61.44	-13.00	-48.44
858.100 0	23.72	-63.15	0.03	V	0.67	-63.79	-13.00	-50.79

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

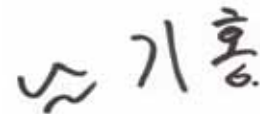
10.4.2.4 Modulated Input Signal: SMR (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.88 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
929.025 0	60.33	-5.72	-0.52	H	1.67	-7.91	-	-
	59.83	-4.25		V		-6.44	-	-
Test Data for Middle Channel								
929.500 0	60.67	-5.94	-0.52	H	1.67	-8.13	-	-
	59.72	-4.58		V		-6.77	-	-
Test Data for High Channel								
929.987 5	60.56	-5.69	-0.50	H	1.67	-7.86	-	-
	59.50	-4.67		V		-6.84	-	-
100.1000	26.17	-59.31	1.60	V	0.33	-58.04	-13.00	-45.04
110.4000	24.83	-61.00	1.55	H	0.33	-59.78	-13.00	-46.78
262.2000	22.50	-62.93	1.66	H	0.50	-61.77	-13.00	-48.77
858.1000	23.33	-63.54	0.03	V	0.67	-64.18	-13.00	-51.18

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

10.4.3 Test Result for 900I+PA (935 MHz ~ 940 MHz)

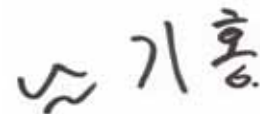
10.4.3.1 Modulated Input Signal: iDEN (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.29 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
935.012 5	60.83	-4.84	-0.51	H	1.67	-7.02	-	-
	59.83	-4.17		V		-6.35	-	-
Test Data for Middle Channel								
937.500 0	60.50	-5.16	-0.50	H	1.67	-7.33	-	-
	60.00	-3.93		V		-6.10	-	-
Test Data for High Channel								
935.987 5	60.25	-5.08	-0.49	H	1.67	-7.24	-	-
	59.50	-4.00		V		-6.16	-	-
100.100 0	26.92	-58.56	1.60	V	0.33	-57.29	-13.00	-44.29
110.400 0	24.50	-61.33	1.55	H	0.33	-60.11	-13.00	-47.11
262.200 0	22.00	-62.93	1.66	H	0.50	-61.77	-13.00	-48.77
858.100 0	23.83	-63.04	0.03	V	0.67	-63.68	-13.00	-50.68

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

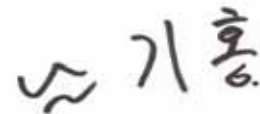
10.4.3.2 Modulated Input Signal: SMR (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.88 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
935.012 5	60.17	-5.50	-0.51	H	1.67	-7.68	-	-
	59.67	-4.33		V		-6.51	-	-
Test Data for Middle Channel								
937.500 0	60.33	-5.33	-0.50	H	1.67	-7.50	-	-
	59.83	-4.10		V		-6.27	-	-
Test Data for High Channel								
935.987 5	60.00	-5.33	-0.49	H	1.67	-7.49	-	-
	59.50	-4.00		V		-6.16	-	-
100.100 0	26.33	-59.15	1.60	V	0.33	-57.88	-13.00	-44.88
110.400 0	24.83	-61.00	1.55	H	0.33	-59.12	-13.00	-46.12
262.200 0	22.72	-62.21	1.66	H	0.50	-60.05	-13.00	-47.05
858.100 0	23.50	-63.37	0.03	V	0.67	-62.67	-13.00	-49.67

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

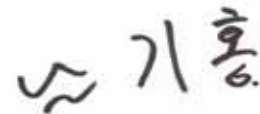
10.4.3.3 Modulated Input Signal: iDEN (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.88 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
935.012 5	60.33	-5.34	-0.51	H	1.67	-7.52	-	-
	59.50	-4.50		V		-6.68	-	-
Test Data for Middle Channel								
937.500 0	60.17	-5.49	-0.50	H	1.67	-7.66	-	-
	59.78	-4.15		V		-6.32	-	-
Test Data for High Channel								
935.987 5	60.52	-4.81	-0.49	H	1.67	-6.97	-	-
	59.91	-3.59		V		-5.75	-	-
100.100 0	26.33	-59.15	1.60	V	0.33	-57.88	-13.00	-44.88
110.400 0	24.83	-61.00	1.55	H	0.33	-59.78	-13.00	-46.78
262.200 0	22.42	-62.51	1.66	H	0.50	-61.35	-13.00	-48.35
858.100 0	23.20	-63.67	0.03	V	0.67	-64.31	-13.00	-51.31

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

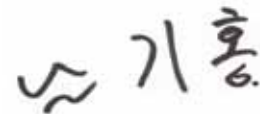
10.4.3.4 Modulated Input Signal: SMR (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -45.04 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
935.012 5	60.67	-5.00	-0.51	H	1.67	-7.18	-	-
	59.72	-4.28		V		-6.46	-	-
Test Data for Middle Channel								
937.500 0	60.33	-5.33	-0.50	H	1.67	-7.50	-	-
	59.92	-4.01		V		-6.18	-	-
Test Data for High Channel								
935.987 5	60.78	-4.55	-0.49	H	1.67	-6.71	-	-
	59.83	-3.67		V		-5.83	-	-
100.100 0	26.17	-59.31	1.60	V	0.33	-58.04	-13.00	-45.04
110.400 0	24.25	-61.58	1.55	H	0.33	-60.36	-13.00	-47.36
262.200 0	22.76	-62.17	1.66	H	0.50	-61.01	-13.00	-48.01
858.100 0	23.52	-63.35	0.03	V	0.67	-63.99	-13.00	-50.99

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

10.4.4 Test Result for 900I+PA (940 MHz ~ 941 MHz)

10.4.4.1 Modulated Input Signal: iDEN (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.88 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
940.025 0	60.78	-4.89	-0.49	H	1.67	-7.05	-	-
	59.70	-4.30		V		-6.46	-	-
Test Data for Middle Channel								
940.500 0	60.42	-5.24	-0.49	H	1.67	-7.40	-	-
	59.50	-4.43		V		-6.59	-	-
Test Data for High Channel								
940.975 0	60.67	-4.66	-0.49	H	1.67	-6.82	-	-
	59.62	-4.31		V		-6.47	-	-
100.100 0	26.33	-59.15	1.60	V	0.33	-57.88	-13.00	-44.88
110.400 0	24.60	-61.23	1.55	H	0.33	-60.01	-13.00	-47.01
262.200 0	22.78	-62.15	1.66	H	0.50	-60.99	-13.00	-47.99
858.100 0	23.48	-63.39	0.03	V	0.67	-64.03	-13.00	-51.03

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical

Tested by: Ki-Hong, Nam / Project Engineer

10.4.4.2 Modulated Input Signal: SMR (AC 120 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.61 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
940.025 0	60.33	-5.34	-0.49	H	1.67	-7.50	-	-
	59.50	-4.50		V		-6.66	-	-
Test Data for Middle Channel								
940.500 0	60.83	-4.83	-0.49	H	1.67	-6.99	-	-
	59.67	-4.26		V		-6.42	-	-
Test Data for High Channel								
940.975 0	60.72	-4.61	-0.49	H	1.67	-6.77	-	-
	59.60	-4.33		V		-6.49	-	-
100.100 0	26.60	-58.88	1.60	V	0.33	-57.61	-13.00	-44.61
110.400 0	24.72	-61.11	1.55	H	0.33	-59.23	-13.00	-46.23
262.200 0	22.42	-62.51	1.66	H	0.50	-60.35	-13.00	-47.35
858.100 0	23.90	-62.97	0.03	V	0.67	-62.27	-13.00	-49.27

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical

Tested by: Ki-Hong, Nam / Project Engineer

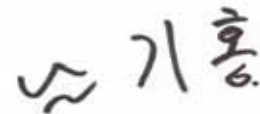
10.4.4.3 Modulated Input Signal: iDEN (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.71 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
940.025 0	60.33	-5.34	-0.49	H	1.67	-7.50	-	-
	59.17	-4.83		V		-6.99	-	-
Test Data for Middle Channel								
940.500 0	60.83	-4.83	-0.49	H	1.67	-6.99	-	-
	59.83	-4.10		V		-6.26	-	-
Test Data for High Channel								
940.975 0	60.33	-5.00	-0.49	H	1.67	-7.16	-	-
	59.20	-4.73		V		-6.89	-	-
100.100 0	26.50	-58.98	1.60	V	0.33	-57.71	-13.00	-44.71
110.400 0	24.80	-61.03	1.55	H	0.33	-59.81	-13.00	-46.81
262.200 0	22.72	-62.21	1.66	H	0.50	-61.05	-13.00	-48.05
858.100 0	23.55	-63.32	0.03	V	0.67	-63.96	-13.00	-50.96

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

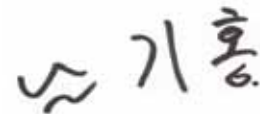
10.4.4.4 Modulated Input Signal: SMR (DC - 48 V)

- . Test Date : March 12, 2009
- . Resolution bandwidth : 1 MHz
- . Video bandwidth : 1 MHz
- . Frequency range : 1 GHz ~ 20 GHz
- . Measurement distance : 3 m
- . Result : PASSED BY -44.43 dB at 100.10 MHz

Frequency (MHz)	Spectrum Reading (dBμV)	Generator Reading (dBm)	Ant. Gain (dBi)	Ant. Pol. (H/V)	Cable Loss (dB)	Total (dBm)	Limit (dBm)	Margin (dB)
Test Data for Low Channel								
940.025 0	60.42	-5.25	-0.49	H	1.67	-7.41	-	-
	59.33	-4.67		V		-6.83	-	-
Test Data for Middle Channel								
940.500 0	60.92	-4.74	-0.49	H	1.67	-6.90	-	-
	59.90	-4.03		V		-6.19	-	-
Test Data for High Channel								
940.975 0	60.25	-5.08	-0.49	H	1.67	-7.24	-	-
	59.30	-4.63		V		-6.79	-	-
100.100 0	26.78	-58.70	1.60	V	0.33	-57.43	-13.00	-44.43
110.400 0	24.52	-61.31	1.55	H	0.33	-60.09	-13.00	-47.09
262.200 0	22.40	-62.53	1.66	H	0.50	-61.37	-13.00	-48.37
858.100 0	23.91	-62.96	0.03	V	0.67	-63.60	-13.00	-50.60

Tabulated test data for Restricted Band

Remark: "H": Horizontal, "V": Vertical



Tested by: Ki-Hong, Nam / Project Engineer

11. FREQUENCY STABILITY WITH TEMPERATURE VARIATION

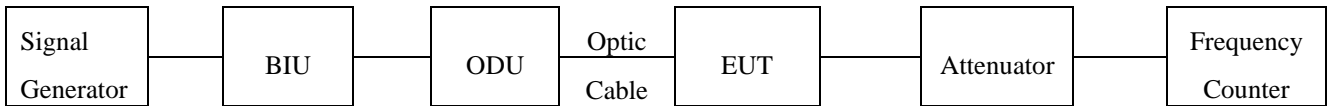
11.1 Operating environment

Temperature : 21.8 °C
Relative humidity : 47.4 %R.H.

11.2 Test set-up

The RF signal from the signal generator(s) was injected to BIU (BTS Interface Unit) and then output signal from the BIU was injected to the input of ODU (Optic Distribution Unit) by coaxial cable and then the output port of the ODU was connected to the input of the EUT by optic cable. The amplified RF signal at the output of the EUT was connected to the spectrum analyzer. The test was performed at three frequencies (low, middle, and high channels) at each band using all applicable modulation.

Turn EUT off and set chamber temperature to -30 °C and then allow sufficient time (approximately 20 to 30 minutes after chamber reach the assigned temperature) for EUT to stabilize. Turn ON EUT and measure the EUT operating frequency and then turn off the EUT after the measurement. The temperature in the chamber was raised 10 °C step from -30 °C to +50 °C. Repeat above method for frequency measurements every 10 °C step and then record all measured frequencies on each temperature step.



11.3 Test equipment used

	Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ -	8564E	HP	Spectrum Analyzer	3650A00756	June 16, 2008
■ -	53152A	HP	Frequency Counter	US39270295	Dec. 05, 2008
■ -	RO-23	Samkun	Chamber	-	Aug. 12, 2008
■ -	SMJ100A	R/S	Vecter Signal Generator	100698	June 16, 2008
■ -	FSP	R/S	Spectrum Analyzer	100017	Mar. 11, 2009

All test equipment used is calibrated on a regular basis.

11.4 Test data

11.4.1 Test Result for 800PS with AC 120 V Power Supply

-. Test Date : March 10~11, 2009

-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	860 000 000	860 000 025	0.029 1	Within the Authorized Frequency block
-20		860 000 024	0.027 9	
-10		860 000 026	0.030 2	
0		860 000 026	0.030 2	
10		860 000 024	0.027 9	
20		860 000 026	0.030 2	
30		860 000 025	0.029 1	
40		860 000 025	0.029 1	
50		860 000 024	0.027 9	

남기홍

Tested by: Ki-Hong, Nam / Project Engineer

11.4.2 Test Result for 800PS with DC - 48 V Power Supply

-. Test Date : March 10~11, 2009
-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	860 000 000	860 000 024	0.027 9	Within the Authorized Frequency block
-20		860 000 025	0.029 1	
-10		860 000 025	0.029 1	
0		860 000 024	0.027 9	
10		860 000 026	0.030 2	
20		860 000 024	0.027 9	
30		860 000 025	0.029 1	
40		860 000 024	0.027 9	
50		860 000 026	0.030 2	

스기홍

Tested by: Ki-Hong, Nam / Project Engineer

11.4.3 Test Result for 900I+PA (929 MHz ~ 930 MHz) with AC 120 V Power Supply

-. Test Date : March 10~11, 2009
-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	929 500 000	929 500 030	0.032 3	Within the Authorized Frequency block
-20		929 500 030	0.032 3	
-10		929 500 031	0.033 4	
0		929 500 032	0.034 4	
10		929 500 030	0.032 3	
20		929 500 031	0.033 4	
30		929 500 032	0.034 4	
40		929 500 031	0.033 4	
50		929 500 030	0.032 3	

남기홍

Tested by: Ki-Hong, Nam / Project Engineer

11.4.4 Test Result for 900I+PA (929 MHz ~ 930 MHz) with DC - 48 V Power Supply

-. Test Date : March 10~11, 2009

-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	929 500 000	929 500 029	0.031 2	Within the Authorized Frequency block
-20		929 500 031	0.033 4	
-10		929 500 031	0.033 4	
0		929 500 030	0.032 3	
10		929 500 031	0.033 4	
20		929 500 032	0.034 4	
30		929 500 031	0.033 4	
40		929 500 031	0.033 4	
50		929 500 030	0.032 3	

스기홍

Tested by: Ki-Hong, Nam / Project Engineer

11.4.5 Test Result for 900I+PA (935 MHz ~ 940 MHz) with AC 120 V Power Supply

-. Test Date : March 10~11, 2009

-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	937 500 000	937 500 029	0.030 9	Within the Authorized Frequency block
-20		937 500 028	0.029 9	
-10		937 500 029	0.030 9	
0		937 500 030	0.032 0	
10		937 500 031	0.033 1	
20		937 500 031	0.033 1	
30		937 500 030	0.032 0	
40		937 500 030	0.032 0	
50		937 500 031	0.033 1	

남기홍

Tested by: Ki-Hong, Nam / Project Engineer

11.4.6 Test Result for 900I+PA (935 MHz ~ 940 MHz) with DC - 48 V Power Supply

-. Test Date : March 10~11, 2009
-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	937500000	937 500 030	0.032 0	Within the Authorized Frequency block
-20		937 500 029	0.030 9	
-10		937 500 031	0.033 1	
0		937 500 030	0.032 0	
10		937 500 031	0.033 1	
20		937 500 031	0.033 1	
30		937 500 030	0.032 0	
40		937 500 029	0.030 9	
50		937 500 031	0.033 1	

스기홍

Tested by: Ki-Hong, Nam / Project Engineer

11.4.7 Test Result for 900I+PA (940 MHz ~ 941 MHz) with AC 120 V Power Supply

-. Test Date : March 10~11, 2009

-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	940 500 000	940 500 030	0.031 9	Within the Authorized Frequency block
-20		940 500 031	0.033 0	
-10		940 500 030	0.031 9	
0		940 500 032	0.034 0	
10		940 500 031	0.033 0	
20		940 500 031	0.033 0	
30		940 500 030	0.031 9	
40		940 500 031	0.033 0	
50		940 500 030	0.031 9	

남기홍

Tested by: Ki-Hong, Nam / Project Engineer

11.4.8 Test Result for 900I+PA (940 MHz ~ 941 MHz) with DC - 48 V Power Supply

-. Test Date : March 10~11, 2009

-. Result : PASSED

Temperature (°C)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
-30	940 500 000	940 500 029	0.030 8	Within the Authorized Frequency block
-20		940 500 029	0.030 8	
-10		940 500 030	0.031 9	
0		940 500 030	0.031 9	
10		940 500 031	0.033 0	
20		940 500 031	0.033 0	
30		940 500 030	0.031 9	
40		940 500 030	0.031 9	
50		940 500 031	0.033 0	

스기홍

Tested by: Ki-Hong, Nam / Project Engineer

12. FREQUENCY STABILITY WITH VOLTAGE VARIATION

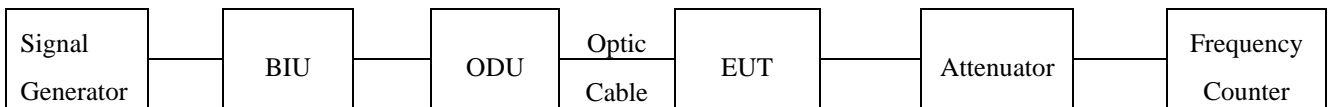
12.1 Operating environment

Temperature : 21.8 °C
Relative humidity : 47.4 %R.H.

12.2 Test set-up

The RF signal from the signal generator(s) was injected to BIU (BTS Interface Unit) and then output signal from the BIU was injected to the input of ODU (Optic Distribution Unit) by coaxial cable and then the output port of the ODU was connected to the input of the EUT by optic cable. The amplified RF signal at the output of the EUT was connected to the spectrum analyzer. The test was performed at three frequencies (low, middle, and high channels) at each band using all applicable modulation.

The RF output port of the EUT was connected to the input of the spectrum analyzer. The signal generator was set to center frequency for each band with an un-modulated signal. The voltage of EUT set to 115 % of the nominal value and then was reduced to 85% of nominal voltage. The output frequency was recorded at each step.



12.3 Test equipment used

	Model Number	Manufacturer	Description	Serial Number	Last Cal.
■ -	8564E	HP	Spectrum Analyzer	3650A00756	June 16, 2008
■ -	53152A	HP	Frequency Counter	US39270295	Dec. 05, 2008
■ -	2350A	HP	30 dB Attenuator Assembly	2350A03133	June 16, 2008
■ -	SMJ100A	R/S	Vecter Signal Generator	100698	June 16, 2008
■ -	FSP	R/S	Spectrum Analyzer	100017	Mar. 11, 2009

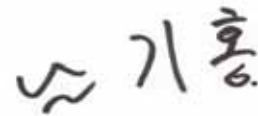
All test equipment used is calibrated on a regular basis.

12.4 Test data

12.4.1 Test Result for 800PS with AC 120 V Power Supply

- Test Date : March 10~11, 2009
- Rated Supply Voltage : 120 Vac
- Result : PASSED

Voltage (Vac)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
138 (115 %)	860 000 000	860 000 025	0.029 1	Within the Authorized Frequency block
120 (100 %)		860 000 026	0.030 2	
102 (85 %)		860 000 026	0.030 2	



Tested by: Ki-Hong, Nam / Project Engineer

12.4.2 Test Result for 800PS with DC - 48 V Power Supply V

- . Test Date : March 10~11, 2009
- . Rated Supply Voltage : - 48 Vdc
- . Result : PASSED

Voltage (Vdc)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
- 55.2 (115 %)	860 000 000	860 000 026	0.030 2	Within the Authorized Frequency block
- 48 (100 %)		860 000 024	0.027 9	
- 40.8 (85 %)		860 000 024	0.027 9	

기홍

Tested by: Ki-Hong, Nam / Project Engineer

12.4.3 Test Result for 900I+PA (929 MHz ~ 930 MHz) with AC 120 V Power Supply

- . Test Date : March 10~11, 2009
- . Rated Supply Voltage : 120 Vac
- . Result : PASSED

Voltage (Vac)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
138 (115 %)	929 500 000	929 500 031	0.033 4	Within the Authorized Frequency block
120 (100 %)		929 500 031	0.033 4	
102 (85 %)		929 500 032	0.034 4	

기홍

Tested by: Ki-Hong, Nam / Project Engineer

12.4.4 Test Result for 900I+PA (929 MHz ~ 930 MHz) with DC - 48 V Power Supply

- . Test Date : March 10~11, 2009
- . Rated Supply Voltage : - 48 Vdc
- . Result : PASSED

Voltage (Vdc)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
- 55.2 (115 %)	929 500 000	929 500 031	0.033 4	Within the Authorized Frequency block
- 48 (100 %)		929 500 032	0.034 4	
- 40.8 (85 %)		929 500 032	0.034 4	

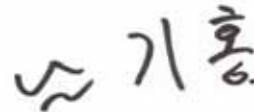
기홍

Tested by: Ki-Hong, Nam / Project Engineer

12.4.5 Test Result for 900I+PA (935 MHz ~ 940 MHz) with AC 120 V Power Supply

- . Test Date : March 10~11, 2009
- . Rated Supply Voltage : 120 Vac
- . Result : PASSED

Voltage (Vac)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
138 (115 %)	937 500 000	937 500 031	0.033 1	Within the Authorized Frequency block
120 (100 %)		937 500 031	0.033 1	
102 (85 %)		937 500 031	0.033 1	



Tested by: Ki-Hong, Nam / Project Engineer

12.4.6 Test Result for 900I+PA (935 MHz ~ 940 MHz) with DC - 48 V Power Supply

- . Test Date : March 10~11, 2009
- . Rated Supply Voltage : 48 Vdc
- . Result : PASSED

Voltage (Vdc)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
- 55.2 (115 %)	937 500 000	937 500 030	0.032 0	Within the Authorized Frequency block
- 48 (100 %)		937 500 031	0.033 1	
- 40.8 (85 %)		937 500 031	0.033 1	

기홍

Tested by: Ki-Hong, Nam / Project Engineer

12.4.7 Test Result for 900I+PA (940 MHz ~ 941 MHz) with AC 120 V Power Supply

- . Test Date : March 10~11, 2009
- . Rated Supply Voltage : 120 Vac
- . Result : PASSED

Voltage (Vac)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
138 (115 %)	940 500 000	940 500 030	0.031 9	Within the Authorized Frequency block
120 (100 %)		940 500 031	0.033 0	
102 (85 %)		940 500 031	0.033 0	

기홍

Tested by: Ki-Hong, Nam / Project Engineer

12.4.8 Test Result for 900I+PA (940 MHz ~ 941 MHz) with DC - 48 V Power Supply

- . Test Date : March 10~11, 2009
- . Rated Supply Voltage : - 48 Vdc
- . Result : PASSED

Voltage (Vdc)	Input Freq. (Hz)	Measured Freq. (Hz)	Result (PPM)	Limit
- 55.2 (115 %)	940 500 000	940 500 030	0.031 9	Within the Authorized Frequency block
- 48 (100 %)		940 500 031	0.033 0	
- 40.8 (85 %)		940 500 030	0.031 9	

기홍

Tested by: Ki-Hong, Nam / Project Engineer